HIOKI

Instruction Manual

IM7580

IMPEDANCE ANALYZER

HIOKI E. E. CORPORATION

September 2014 Edition 1 IM7580A981-00 14-09H

600434510

Contents

Measurement Process

Read “Operating Precautions” (p. 6) before installing and connecting this instrument.
Refer to “Appx. 6 Rack Mounting” (p. A7) for rack mounting.

Install the instrument (p. 6)

↓

Connect test head (p. 17)

↓

Connect power cord (p. 20)

↓

Connect measurement cables, optional Hioki probes or test fixture (p. 21)

↓

Connect external interfaces (as required) (p. 231)

↓

Inspect all the connections (p. 19)

↓

Turn ON the power supply (p. 24)

↓

Perform calibration/compensation (p. 139)

↓

Set measurement conditions

↓

Connect to the test sample

↓

Make measurements

↓

Turn OFF the power supply (p. 24)

After using the instrument, remove the test sample and turn OFF the power supply.

Timing for Calibration and Compensation

- Before measurements
- When the length of measurement cable is changed
- When the measurement sample is changed
- When the fixture is changed

Introduction

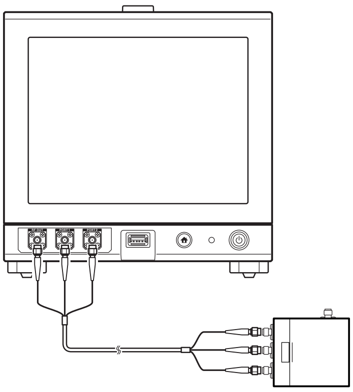
Thank you for purchasing the HIOKI IM7580 Impedance Analyzer. To obtain maximum performance from the instrument, please read this manual first, and keep it handy for future reference.

Verifying Package Contents

- When you receive the instrument, inspect it carefully to ensure that no damage occurred during shipping.
  In particular, check the accessories, panel switches, and connectors. If damage is evident, or if it fails to operate according to the specifications, contact your authorized Hioki distributor or reseller.

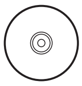
Confirm that the following have been provided.

☐ IM7580 Impedance Analyzer
- Test head
- Connection cable
  (IM7580: 1 m, IM7580-02: 2 m)



☐ Instruction Manual

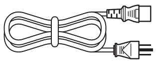
☐ LCR Application Disc



(Communications user manual [PDF], explanation of communications commands, USB driver and sample application)

- The latest version can be downloaded from our web site.

☐ Power Cord



Options (Sold separately)

Contact your authorized Hioki distributor or reseller when ordering.

Test fixtures

- ☐ IM9200 Test Fixture Stand
- ☐ IM9201 SMD Test Fixture (for SMD parts)
- ☐ IM9906 Adapter (3.5 mm/7 mm)

Interfaces

- ☐ Z3000 GP-IB Interface
- ☐ Z3001 RS-232C Interface

Connection Cables

- ☐ 9151-02 GP-IB Connector Cable (2 m)
- ☐ 9637 RS-232C Cable (9pin-9pin/1.8 m)

Safety Information

This instrument is designed to conform to IEC 61010 Safety Standards, and has been thoroughly tested for safety prior to shipment. However, using the instrument in a way not described in this manual may negate the provided safety features.

Before using the instrument, be certain to carefully read the following safety notes.

⚠DANGER

Mishandling during use could result in injury or death, as well as damage to the instrument. Be certain that you understand the instructions and precautions in the manual before use.

⚠ WARNING

With regard to the electricity supply, there are risks of electric shock, heat generation, fire, and arc discharge due to short circuits. If persons unfamiliar with electricity measuring instrument are to use the instrument, another person familiar with such instruments must supervise operations.

Notation

In this manual, the risk seriousness and the hazard levels are classified as follows.

⚠DANGER	Indicates an imminently hazardous situation that will result in death or serious injury to the operator.
⚠WARNING	Indicates a potentially hazardous situation that may result in death or serious injury to the operator.
⚠CAUTION	Indicates a potentially hazardous situation that may result in minor or moderate injury to the operator or damage to the instrument or malfunction.
IMPORTANT	Indicates information related to the operation of the instrument or maintenance tasks with which the operators must be fully familiar.
	Indicates a high voltage hazard. If a particular safety check is not performed or the instrument is mishandled, this may give rise to a hazardous situation; the operator may receive an electric shock, may get burnt or may even be fatally injured.
	Indicates prohibited actions.
	Indicates the action which must be performed.
*	Additional information is explained below.

Symbols on the instrument

⚠	Indicates cautions and hazards. When the symbol is printed on the instrument, refer to a corresponding topic in the Instruction Manual.
∼	Indicates AC (Alternating Current).
I	Indicates the ON side of the power switch.
○	Indicates the OFF side of the power switch.

Symbols for standards

	WEEE marking: This symbol indicates that the electrical and electronic appliance is put on the EU market after August 13, 2005, and producers of the Member States are required to display it on the appliances under Article 11.2 of Directive 2002/96/EC (WEEE).
CE	This symbol indicates that the product conforms to regulations set out by the EC Directive.

Accuracy

We define measurement tolerances in terms of f.s. (full scale), rdg. (reading) and dgt. (digit) values, with the following meanings:

f.s.	(maximum display value or scale length) The maximum displayable value or scale length. This is usually the name of the currently selected range.
rdg.	(reading or displayed value) The value currently being measured and indicated on the measuring instrument.
dgt.	(resolution) The smallest displayable unit on a digital measuring instrument, i.e., the input value that causes the digital display to show a “1” as the least-significant digit.

Measurement categories

To ensure safe operation of measurement instruments, IEC 61010 establishes safety standards for various electrical environments, categorized as CAT II to CAT IV, and called measurement categories.

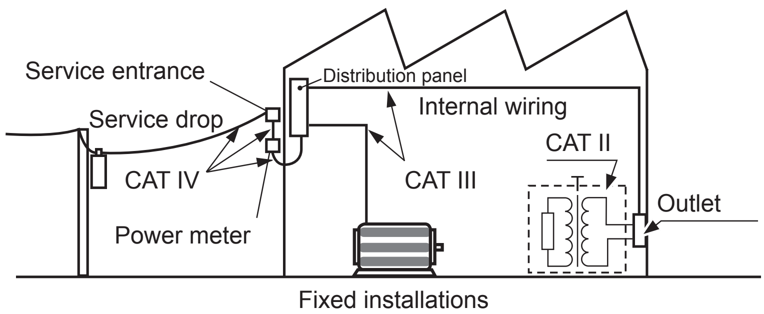
⚠DANGER

- **Using a measuring instrument in an environment designated with a higher-numbered category than that for which the instrument is rated could result in a severe accident, and must be carefully avoided.**
- **Using a measuring instrument without categories in an environment designated with the CAT II to CAT IV category could result in a severe accident, and must be carefully avoided.**

CAT II: When directly measuring the electrical outlet receptacles of primary electrical circuits in equipment connected to an AC electrical outlet by a power cord (portable tools, household appliances, etc.).

CAT III: When measuring the primary electrical circuits of heavy equipment (fixed installations) connected directly to the distribution panel, and feeders from the distribution panel to outlets.

CAT IV: When measuring the circuit from the service drop to the service entrance, and to the power meter and primary overcurrent protection device (distribution panel).



Operating Precautions

Follow these precautions to ensure safe operation and to obtain the full benefits of the various functions.

Preliminary checks

Before using the instrument for the first time, verify that it operates normally to ensure that no damage occurred during storage or shipping. If you find any damage, contact your authorized Hioki distributor or reseller.

⚠ WARNING

Before using the instrument, check that the coating of the probes or cables are neither ripped nor torn and that no metal parts are exposed. Using the instrument under such conditions could result in electrocution. Replace the probes or cables with those specified by our company.

Instrument installation

Installing the instrument in inappropriate locations may cause a malfunction of instrument or may give rise to an accident. Avoid the following locations.

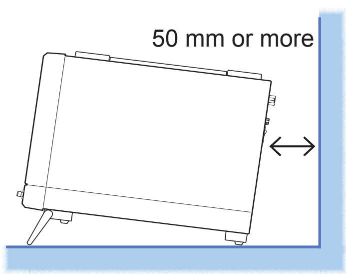
⚠ WARNING

- Exposed to direct sunlight or high temperature
- Exposed to corrosive or combustible gases
- Exposed to water, oil, chemicals, or solvents
- Exposed to high humidity or condensation
- Exposed to a strong electromagnetic field or electrostatic charge
- Exposed to high quantities of dust particles
- Near induction heating systems (such as high-frequency induction heating systems and IH cooking equipment)
- Susceptible to vibration

Installation method

To prevent overheating, be sure to leave the specified clearances around the instrument.

- The instrument should be operated only with the bottom downwards.
- Vents must not be obstructed.
- A distance of 50 mm or more must be maintained between the rear and the surroundings.



⚠ CAUTION

Do not apply strong downward force with the stand extended. The stand may get damaged.

Warranty

Hioki disclaims responsibility for any direct or indirect damages that may occur if this instrument has been combined with other devices by a systems integrator prior to sale or during resale.
Note.

Handling the instrument

⚠DANGER

- **To avoid electric shock, do not remove the instrument's case. The internal components of the instrument carry high voltages and may become very hot during operation.**
- **Do not allow the instrument to get wet, and do not take measurements with wet hands. This may cause an electric shock.**

⚠ CAUTION

- If the instrument exhibits abnormal operation or display during use, review the information given in "13.3 Troubleshooting" (p. 297) and "13.4 Error Display" (p. 303) before contacting your authorized Hioki distributor or reseller. Do not connect charged capacitors, input voltage or current to the measuring terminals.The instrument will get damaged.
- To avoid damage to the instrument, protect it from physical shock when transporting and handling. Be especially careful to avoid physical shock from dropping.
- This instrument is not designed to be entirely water- or dust-proof. Do not use it in an especially dusty environment, nor where it might be splashed with liquid. This may cause damage.
- Do not use excessive force on the touch panel, and do not use sharp objects that could damage the touch screen.
- Do not apply heavy downward pressure with the stand extended. The stand could be damaged.
- To avoid damage to the instrument, do not short-circuit the terminal/ output terminal and do not input voltage to the terminal/ output terminal.
- After use, always turn OFF the power.

IMPORTANT
This instrument may cause interference if used in residential areas. Such use must be avoided unless the user takes special measures to reduce electromagnetic emissions to prevent interference to the reception of radio and television broadcasts.

Before turning ON the power

⚠ WARNING

- **Before turning the instrument on, make sure the supply voltage matches that indicated on its power connector. Connection to an improper supply voltage may damage the instrument and present an electrical hazard.**
- **Be careful to avoid connecting the supply voltage improperly. Doing so may damage the instrument's internal circuitry.**
- **To avoid electrical accidents and to maintain the safety specifications of this instrument, connect the power cord provided only to a 3-contact (two-conductor + ground) outlet.**

Handling of cords and fixtures

⚠ WARNING

Use only the designated power cord with this instrument. Use of other power cords may cause fire.

⚠ CAUTION

- **To avoid damaging the power cord, grasp the plug, not the cord, when unplugging it from the power outlet.**
- **To avoid breaking the cables or probes, do not bend or pull them.**
- **Bare conductors may get exposed if the insulation melts. Keep the cables well away from heat sources.**
- **Keep in mind that, in some cases, conductors to be measured may be hot.**

- **Use only the specified connection cables. Using a non-specified cable may result in incorrect measurements due to poor connection or other reasons.**
- **Read the instruction manual supplied with the product to be used before using a fixture.**

Before connecting to the EXT I/O terminals

⚠ WARNING

To avoid electric shock or damage to the equipment, always observe the following precautions when connecting to the EXT I/O connector.

- **Always turn off the power to the instrument and to any devices to be connected before making connections.**
- **Be careful to avoid exceeding the ratings of EXT I/O connector. (p. 212)**
- **During operation, a wire becoming dislocated and contacting another conductive object can be serious hazard. Use screws to secure the EXT I/O connectors.**
- **Ensure that devices and systems to be connected to the EXT I/O terminals are properly isolated.**
- **ISO_5V pin of the EXT I/O connector is a 5V power output. Do not apply external power to this pin.**

USB flash drives

⚠ CAUTION

- Hioki cannot recover or analyze data from damaged or faulty storage media. We cannot compensate for such data loss, irrespective of the contents or cause for the failure or damage. We recommend you to make a backup of all important data in a computer or other devices.
- Avoid inserting the USB flash drive with the wrong orientation. This can damage the USB flash drive or instrument.
- When a USB flash drive is being accessed, the color of the USB icon changes from blue to red. Do not turn off the power of the instrument while the USB flash drive is being accessed. Also, do not remove the USB flash drive from the instrument while it is being accessed. This may result in loss of data stored in the USB flash drive.
- Do not transport the instrument while a USB flash drive is connected. Damage could result.
- Some USB flash drives are susceptible to static electricity. Exercise care when using such products because static electricity could damage the USB flash drive or cause malfunction of the instrument.
- With some USB flash drives, the instrument may not start up if power is turned on while the USB flash drive is inserted. In such a case, turn power on first, and then insert the USB flash drive. It is recommended to try out operation with a USB flash drive before starting to use it for actual measurements.

USB flash drives have limited usable lifetime. Data reading and writing will fail after long-term use. Replace the USB flash drive in this case.

Input modules (optional)

⚠ WARNING

Always turn both devices OFF when connecting and disconnecting an interface connector. Otherwise, an electric shock accident may occur.

⚠ CAUTION

To connect/disconnect optional interfaces, hold the metal part. Touching the PCB with bare hands could damage the instrument due to static electricity. (It is recommended that an antistatic wrist strap be used during connection/disconnection.)

1 Overview

1.1 Overview and Features

The HIOKI IM7580 Impedance Analyzer is an impedance measuring instrument that has achieved high speed and high accuracy.
The IM7580 combines the functionality of two devices: an impedance analyzer that can perform frequency and sweep measurement of measurement signal, and an LCR meter that can simultaneously display up to four parameters under a single set of measurement conditions.
A wide range of measurement conditions can be set and the instrument can be used across a broad range of applications such as measurement of high frequency inductors.

Wide range of measurement conditions

- Measuring frequency of IM7580 is from 1 MHz to 300 MHz.
- Measurement signal level is from -40 dBm to +7 dBm.

Fast measurement

Measurement speed is 0.6 ms (typical value) at the fastest.

Graph display

The measurement frequency and sweep function of measurement level allow frequency characteristics and level characteristics to be measured and displayed as a graph on the color LCD display of the instrument.
Cole-Cole plot and admittance pie graph can also be easily displayed.

Equivalent circuit analysis

It provides five types of equivalent circuit models for circuit elements and components.

CONTINUOUS measurement mode

Capable of continuous measurements using measurement conditions stored in the memory of the instrument. This function enables making pass/fail judgment with different measurement conditions.
(Example: Performs C-D measurement with 1 MHz and Ls measurement with 100 MHz in succession.)

Various interfaces supported

Support with the most suitable EXT I/O (handler interface), USB, GP-IB, RS-232C, and LAN for production lines.
* GP-IB and RS-232C are optional.

Comparator function

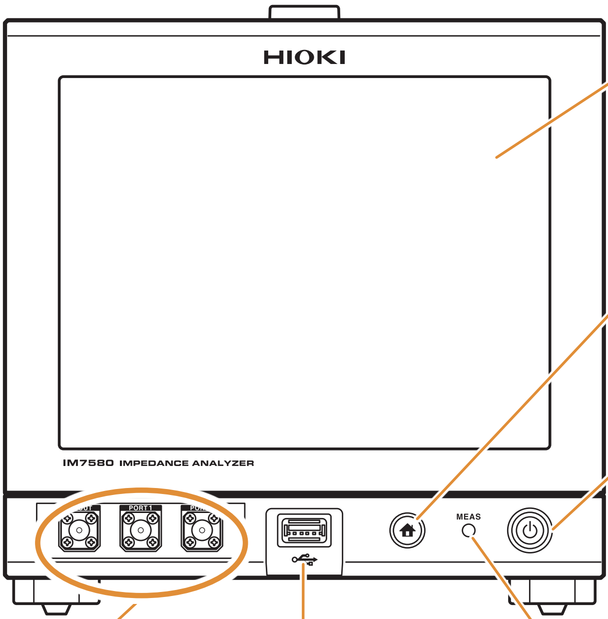
- LCR mode: (p. 46)
  Capable of making HI/IN/LO pass/fail judgments based on the measured values for the four parameters.
- ANALYZER mode: (p. 112)
  Capable of making pass/fail judgment for sweep measurement results.

BIN function

With LCR mode, the rank can be divided up to 10 classifications based on the measured values.

1.2 Names and Functions of Parts

Front panel of the instrument



LCD display
This is a touch panel display.
Press the keys displayed on the screen to operate the instrument.

HOME button
- Returns to the measurement screen.
- Use this button for full reset operation. (p. 301)

Start button (p. 24)
(The main power switch is located at the rear.)

Lamp status	Instrument status
Green	Power supply ON Active
Red	Power supply OFF Inactive

The start button turns the state from inactive to active. Accurate measurement requires at least 60 min of warm-up.

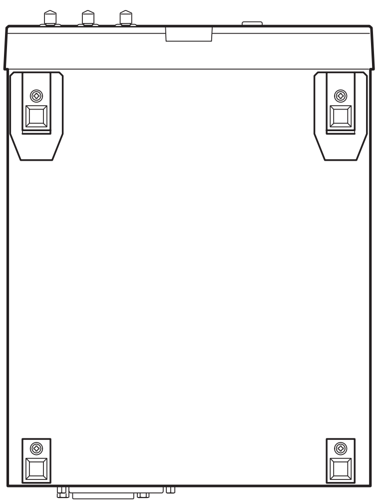
RF OUT (p. 17)
PORT 1
PORT 2

Connector for USB flash drive (p. 239)
Connect a USB flash drive storage device.

Measurement lamp

Lamp status	Instrument status
Green	During measurement
Red	Full reset procedure

Bottom panel of the instrument



This instrument can be rack mounted.
Refer to “Appx. 6 Rack Mounting” (p. A7)

Parts removed from this instrument should be stored in a safe place to enable future reuse.

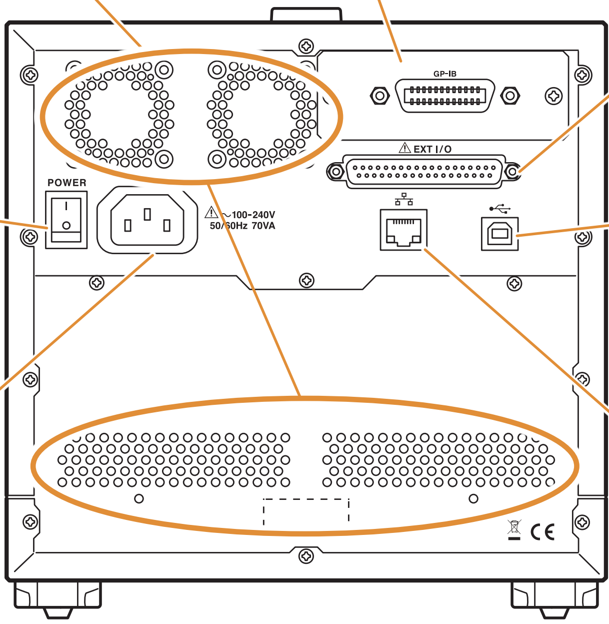
Rear of the instrument

Vents (p. 6)
Install such that the vents are not covered.

Communication interface (option) (p. 231)
Optional interfaces can be installed.
Refer to the Communication Instruction Manual (LCR Application Disk).
- Model Z3000 GP-IB Interface
- Model Z3001 RS-232C Interface

EXT I/O Connector (p. 195)

Main power switch (p. 24)



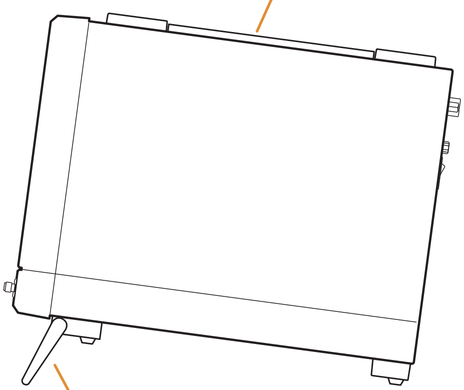
USB cable connector
Refer to the Communication Instruction Manual (LCR Application Disk).

Power inlet (p. 20)
Connect the supplied power cord.

LAN connector
Refer to the Communication Instruction Manual (LCR Application Disk).

Right side panel of the instrument

Handle
Used for carrying the instrument.



Stand
Enables the instrument to be tilted.

When setting up the stand

Open till the end without stopping in between.
Ensure that both stands are straight.

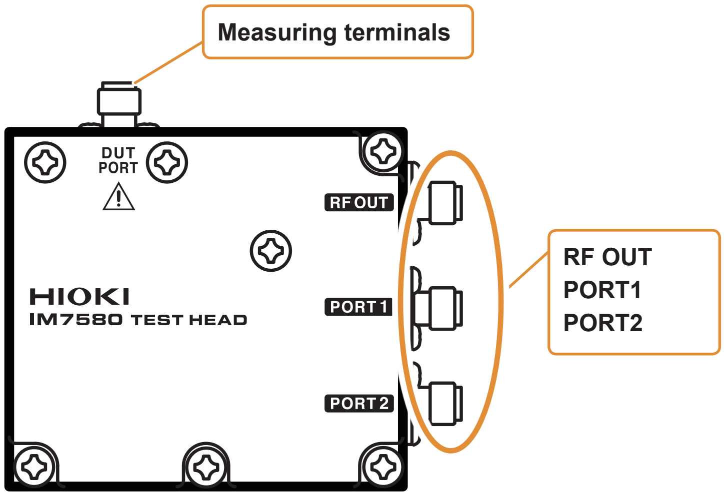
When closing the stand

Close till the end without stopping in between.

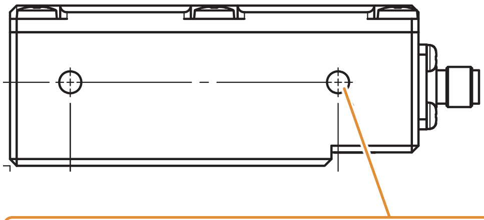
⚠ CAUTION

Do not apply heavy downward pressure with the stand extended. The stand could be damaged.

Side of the test head



Bottom of the test head



Threaded holes for fixing the IM9200 Test Fixture Stand
These holes can also be used when fixing a test head to an automated machine.

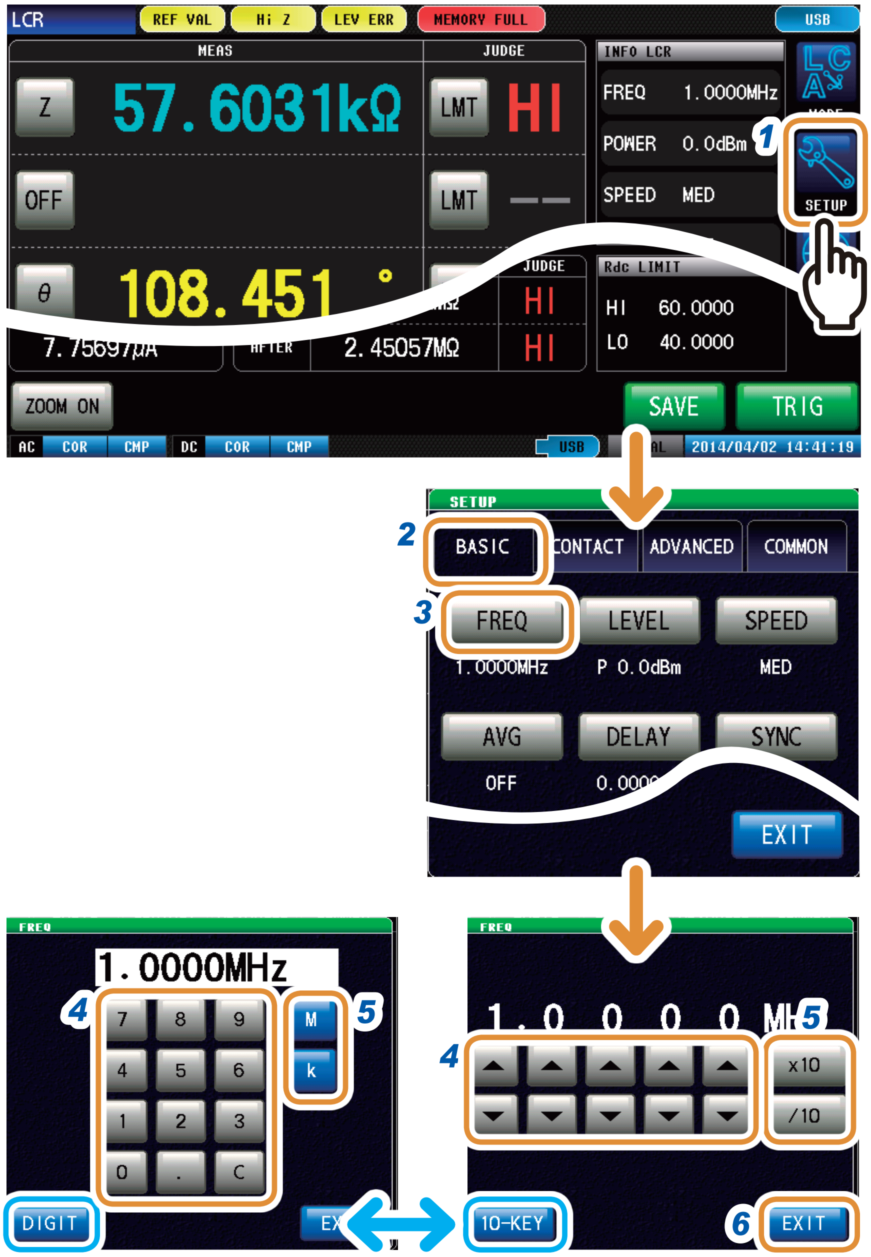
1.3 Screen Operations

This instrument allows you to use a touch panel to set and change all measurement conditions.
Gently touch a key on the screen to select the item or numerical value set for that key.
In this manual, gently touching the screen is referred to as “press”.

⚠CAUTION

Do not use excessive force on the touch panel, and do not use sharp objects that could damage the touch screen.

Example: Setting the measurement frequency in LCR mode



You can select **[DIGIT]** (input with ▲/▼), or **[10-KEY]** (input with the numeric keypad).

1. **Press [SETUP] in the menu key on the LCR mode screen.**
2. **Press [BASIC] tab.**
3. **Press [FREQ].**
4. **Set measurement frequency with ▲/▼, or the numeric keypad.**
5. **Press unit key to confirm the setting.**
6. **Press [EXIT] to close the setting screen.**

Example: Moving the window

You can move the window by pressing the top of the window (green part) and dragging.

2 Measurement Preparations

Please read “Operating Precautions” (p. 6) before installing and connecting this instrument.
See “Rack Mounting” (p. A7) for rack mounting.

2.1 Connecting the Test Head

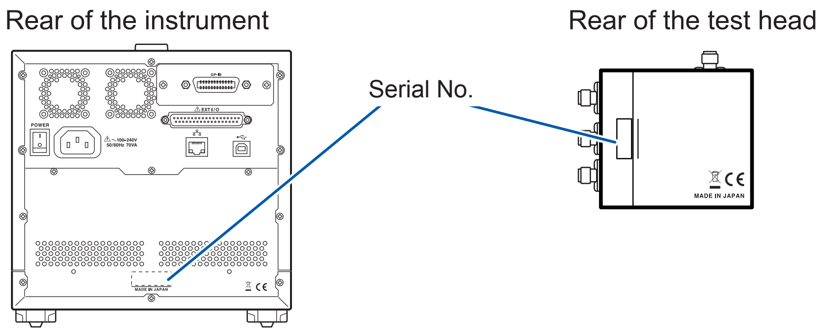
Connect the test head.
See “5 Calibration and Compensation” (p. 139).

⚠ CAUTION

- If the instrument and the connectors of the test head are not correctly connected, the instrument may get damaged or accurate measurements may not be possible.
- Tighten the connector with a torque of 0.56 N.m (recommended value). Tightening the connector with a torque other than the recommended value, may damage the instrument or accurate measurements may not be possible.

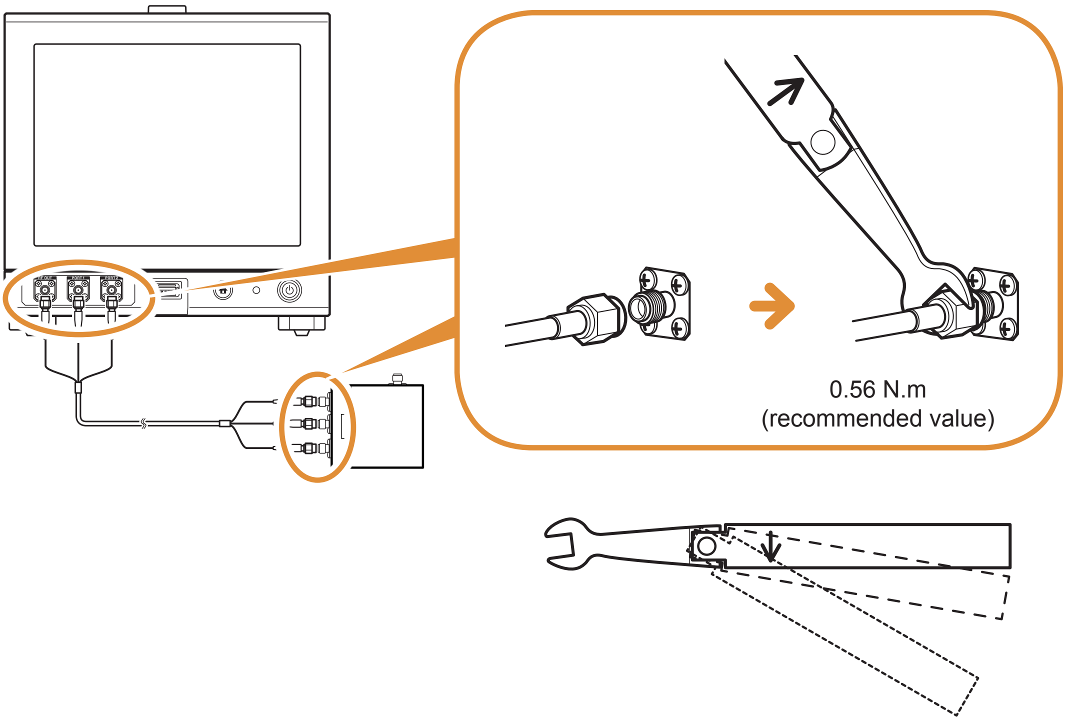
IMPORTANT

- **Check that there are no problems with the connector before connecting the cable. If there is a problem with the connector, you cannot perform accurate measurement due to large measurement errors.**
  Refer to “Appx. 5 Maintenance of Coaxial Connector” (p. A6)
- **The instrument is adjusted in combination with the test head and the connection cable. Make sure to connect the test head having the identical serial number as the instrument via the connection cable included with shipment.**



1 **Check that the power switch of the instrument is turned off.**

2 **Connect RF OUT, PORT1, and PORT2 of the instrument to RF OUT, PORT1, and PORT2 of the test head with the supplied connection cable.**



If the specified torque is applied to the torque wrench, it will rotate to the position shown in the figure.

Do not rotate the cable when connecting the SMA connector of the cable to the instrument and the test head. If the cable is rotated while connecting the connector, the core wires of connector or cable may get damaged. Rotate the nut of the connector and connect.

2.2 Pre-Operation Inspection

Please read “Operating Precautions” (p. 6) before use.

> Before using the instrument for the first time, verify that it operates normally to ensure that no damage occurred during storage or shipping.
> If you find any damage, contact your authorized Hioki distributor or reseller.

Inspection of accessories and options

Inspection item	Solution
Is the power cord insulation torn, or is any metal exposed?	Do not use the instrument if damage is found, as it can result in electric shocks or short-circuit accidents. Contact your authorized Hioki distributor or reseller.
Is the insulation on the measurement cable torn, or is any metal exposed?	If there is any damage, measured values may be unstable and measurement errors may occur. Replace the cable with an undamaged one.

Instrument inspection

Inspection item	Solution
Is the instrument damaged?	If the instrument is damaged, request repairs.
Does the Opening screen appear (Model no., version no.) when the power is turned on? Screen when the power is turned on 	If the Opening screen does not appear, the power cord may be damaged, or the instrument may be damaged internally. Request repairs.
Is there an error displayed on the Opening screen? Error display screen 	If there is an error displayed, the instrument may be damaged internally. Request repairs. Reference: “Troubleshooting” (p. 297), “Error Display” (p. 303) Example: An interface board which cannot be used is installed (LAN board).

2.3 Connecting the Power Cord

Please read “Before turning ON the power” (p. 7), “Handling of cords and fixtures” (p. 8) before connecting the power cord.

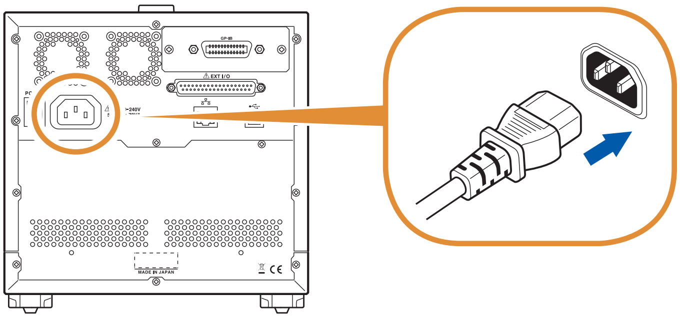
Connect the power cord to the power inlet on the instrument, and plug into an outlet.

Turn OFF the main power switch before disconnecting the power cord.

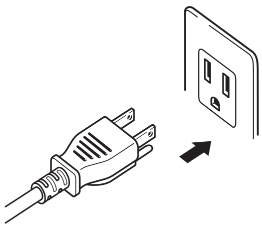
1 **Check that the main power switch of the instrument is turned off.**

2 **Connect a power cord that is compatible with the line voltage to the power inlet on the instrument (100 V to 240 V AC).**

Rear



3 **Plug the other end of the power cord into an outlet.**



2.4 Connecting a Measurement Cable/Fixture

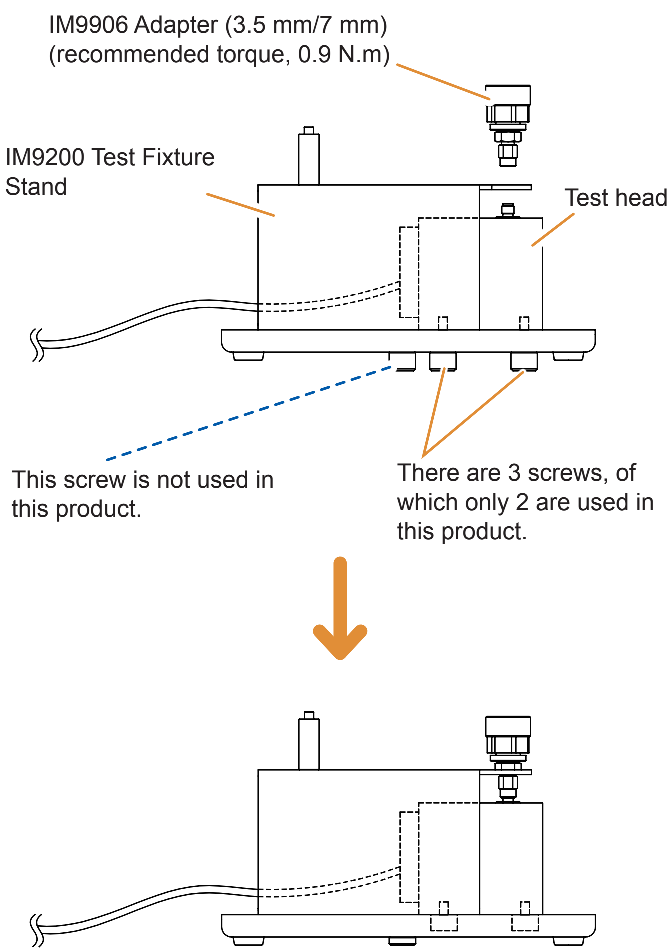
Please read “Before turning ON the power” (p. 7), “Handling of cords and fixtures” (p. 8) before connecting the measurement cable/fixture.

Connect the measurement cables, or optional Hioki test fixture to the measurement terminals.
See “Options (Sold separately)” (p. 2) for options.
See the instructions provided with the fixture for operating details.

Note the following when extending the distance between test sample and measuring terminals.

- Use 50 Ω coaxial cable for the measurement cable.
- Make the length of the cable as short as possible.
- Perform OPEN/SHORT/LOAD calibration using the connecting terminal of the test sample.

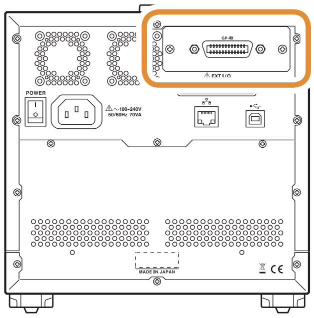
Use the specified probes and fixtures. When you make your own probe, it may not satisfy the specifications of this instrument.
Refer to “Options (Sold separately)” (p. 2)



1. **Fix the test head to the IM9200 Test Fixture Stand.**
2. **Install the IM9906 Adapter (3.5 mm/7 mm) to the measurement terminal of the test head (recommended torque, 0.9 N.m).**
3. **Perform calibration with the calibration kit.**
4. **Place the IM9201 SMD test fixture on the IM9200 Test Fixture Stand, and connect a 7-mm connector. (recommended torque, 1.35 N.m)**

2.5 Connecting an Interface

Rear



- Please read "Input modules (optional)" (p. 9) before connecting the Interface.
- Please read the Instruction Manual of optional interface before installing or replacing an optional interface or to use the instrument after removing the interface.
- You can check the information of the interface installed in the instrument on the screen.
  Reference: "Setting the Interface" (p. 231), "Checking the Instrument Version" (p. 232)

⚠ WARNING

Use the screws (M3×6 mm) which are mounted during shipment for installing the interface to avoid instrument damage and electric shock accidents.
If screws have been lost or damaged, contact the store (distributor) from which you purchased the instrument or your nearest Hioki sales office.

⚠ CAUTION

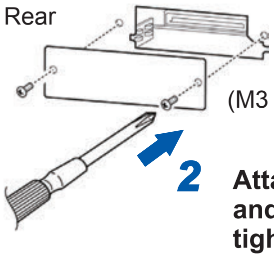
To disconnect, hold the plate of optional interface. If you touch the board directly, it may be damaged due to static electricity. (Antistatic wrist strap is recommended when disconnecting the interface.)

You will need: A Phillips head screwdriver (No. 2)

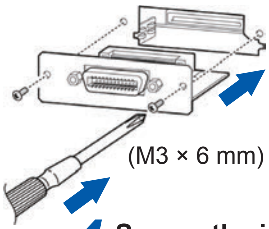
Installing the interface

1 **Unplug the power cord of the instrument from the wall outlet.**
Disconnect the connection cords.

Rear



2 **Attach the blank panel and secure it in place by tightening the two fixing screws with a Phillips head screwdriver.**



3 **Pay attention to the orientation of the interface, insert it firmly into place.**

4 **Secure the interface in place by tightening the two fixing screws with a Phillips head screwdriver.**

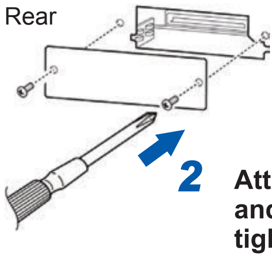
Removing the interface

Unplug the power cord from the wall outlet and perform the above procedure in reverse order to remove the interface.

Attaching the blank panel

1 **Unplug the power cord of the instrument from the wall outlet.**
Disconnect the connection cords.

Rear

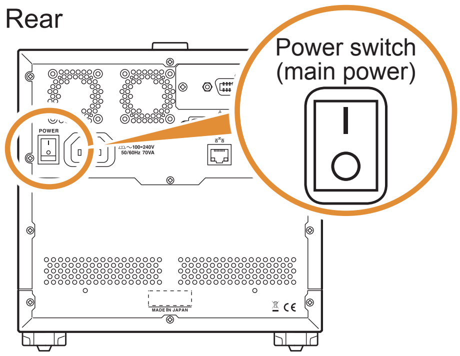


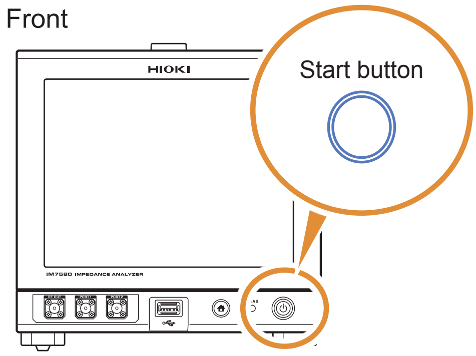
2 **Attach the blank panel and secure it in place by tightening the two fixing screws with a Phillips head screwdriver.**

Attach the blank panel to use the instrument after removing the interface.
Measuring without the blank panel will prevent the instrument from performing to its specifications.

2.6 Turning the Power ON and OFF

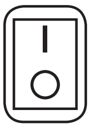
Connect the probe and test fixture before turning the main power on.



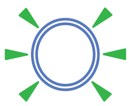


Turning the main power ON

Turn the main power switch ON (|).



The start button on the front will light up in green.

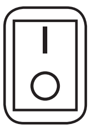


(Lights up in green)

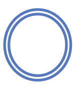
- If the main power switch is turned OFF when the instrument is in the inactive state, the instrument will start up in the inactive state the next time the main power switch is turned ON.
- To measure to the degree of accuracy mentioned in the specifications, allow a warm-up time of 60 minutes or more after cancellation of the inactive state.

Turning the main power OFF

Turn the main power switch OFF (◯).



The start button on the front will turn off.



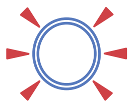
(Turns OFF)

- When the power supply is interrupted by a power failure etc, the instrument will recover to the measurement mode used before the power failure.
- The instrument settings will be retained even if the main power switch is turned OFF. (backup function)

Turning to the inactive state

Press the start button on the front for approximately 1 second in the main power ON state.

The color of the start button on the front changes to red in the inactive state.



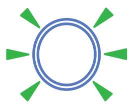
(Lights up in red)

Canceling the inactive state

To measure to the degree of accuracy mentioned in the specifications, allow a warm-up time of 60 minutes or more after cancellation of the inactive state.

Press the start button on the front when the instrument is in the inactive state.

The start button on the front will light up in green.



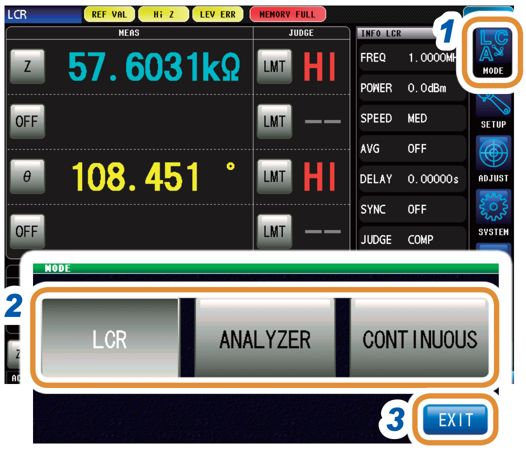
(Lights up in green)

What is inactive state?
The state in which the power supply of the instrument is turned OFF.
(Only the circuit to turn ON the lamp of the start button is active.)

If the instrument is not used for a long duration, the internal battery must be charged. The required charging time is at least 3 hours (recommended, 24 hours) after connecting the power supply and turning ON the power of the instrument.

2.7 Select the Measurement Mode

Select any one of the following 3 measurement modes.



1 Press **[MODE]**.

2 Select the measurement mode.

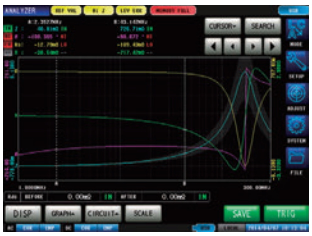
3 Press **[EXIT]**.

[LCR]: LCR function

The LCR function allows you to measure the passive elements of capacitors and coils with a single measurement condition.
This is suitable to make pass/fail judgment and classification on production lines.

- Comparator function: Makes HI/IN/LO pass/fail judgments based on the measured values.
- BIN function: Divides ranks up to 10 classifications based on the measured values.

[ANALYZER]: Analyzer function



The analyzer function allows you to measure component and material characteristics while sweeping the measurement frequency and signal level.
This function provides equivalent circuit analysis based on the results of frequency characteristics.
Pass/fail judgment based on resonant frequency is available on production lines of piezoelectric or similar elements.

- Area judgment: Judges whether the measured values of the sweep points are within the judgment area.
- Peak Judgment: Judges whether the peak value of the sweep result is within the judgment area.
- Equivalent circuit analysis: Equivalent circuit models analysis for circuit elements and components.

[CONTINUOUS]: Continuous measurement function

The continuous measurement function allows you to perform a series of measurements with different conditions.
For example, Consecutive Ls measurement with 1 MHz of and Z measurement with 100 MHz and its pass/fail judgment can be made.
LCR mode and ANALYZER mode measurement conditions can be combined.
Up to 46 measurements (30 for LCR mode, 16 for ANALYZER mode) can be performed continuously.

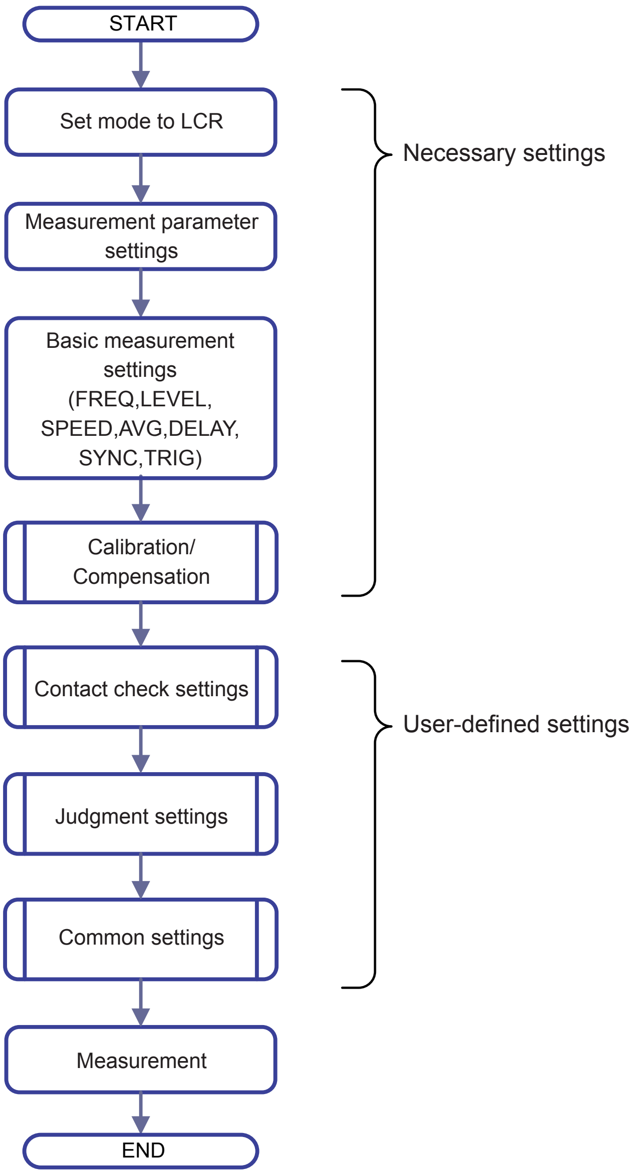
3 LCR Function

3.1 LCR Function

The LCR function allows you to measure the impedance, phase angle, and other items by applying any frequency or level (RMS value) signal to the element you want to measure. This function is suitable for evaluating the passive elements such as capacitors and coils.
It allows you to perform measurement while checking the measurement conditions on the measurement screen. When the power is turned on again, measurement screen will be displayed in accordance with the measurement mode used before the power was turned off.

- Conditions set by the LCR function are not incorporated in the analyzer function.
- When a measured value is outside the guaranteed accuracy range, **REF VAL** is displayed in the error display area.
  Check the guaranteed accuracy range. Consider measured values outside the guaranteed accuracy range as values for reference.
  See “Measurement range” (p. 274).

Flowchart



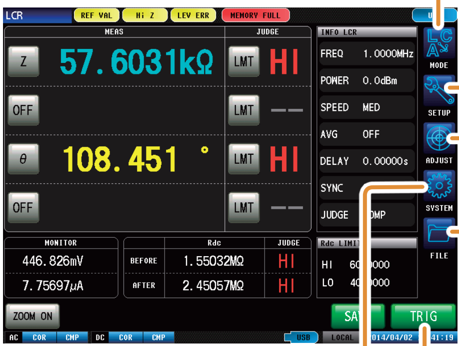
Screen Map

Measurement mode setting screen (p. 25)

Advanced settings screen (p. 33)

Compensation settings screen (p. 139)

[CAL]	Calibration	p. 143
[Rdc LIMIT]	DC measurement limit value	p. 150
[LENGTH]	Electric length compensation	p. 152
[COMPEN]	Compensation	p. 153
[Rdc LIMIT]	DC measurement limit value	p. 157
[SCALE]	Scaling	p. 159

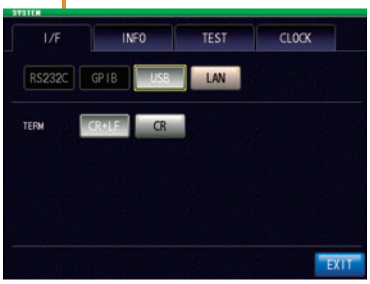


System settings screen (p. 231)

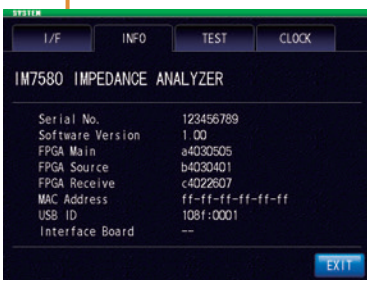
Trigger (p. 70)

Save settings screen (p. 243)

[SETUP]	Sets [SAVE]	p. 243
[SAVE]	Saves the setting conditions	p. 243
[LOAD]	Loads the setting conditions	p. 261
[FORMAT]	Formats USB flash drive	p. 265
[DELETE]	Deletes files	p. 270
[FOLDER]	Creates folders	p. 267
[RENAME]	Changes file names	p. 268
[SELECT]	Selects files	p. 261
[BACK]	Displays the previous screen	

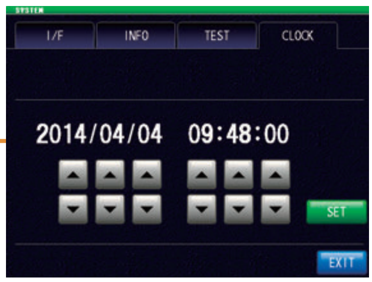


Select an interface. (p. 231)



The version of the instrument can be verified. (p. 232)

Self checks (self diagnosis) are enabled. (p. 233)



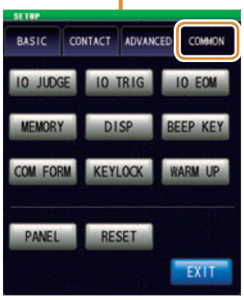
Date and time can be set for the instrument. (p. 238)

Advanced settings screen (p. 37)

[FREQ]	Measurement frequency	p. 37
[LEVEL]	Measurement signal level	p. 38
[SPEED]	Measurement speed	p. 40
[AVG]	Average	p. 41
[DELAY]	Trigger delay	p. 34
[SYNC]	Trigger synchronous output	p. 35
[TRIG]	Trigger	p. 33

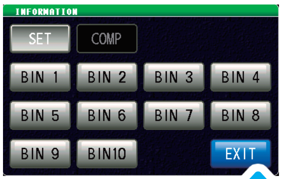
[TIMING]	Contact check timing	p. 169
[AC OUT]	AC signal superimposition	p. 171
[DC WAIT]	Wait time prior to DC measurement	p. 170
[WAVE]	Number of DC samples	p. 171
[AC WAIT]	Wait time prior to AC measurement	p. 170
[LIMIT]	Judgment of DC measured value	p. 172
[ERR ABORT]	Quit function in case of judgment error	p. 172
[JDG EXEC]	Judgment for reference values	p. 172
[Hi Z]	Hi Z reject function	p. 174
[LEV CHECK]	Monitoring function for detection level	p. 175

[JUDGE]	Judgment	p. 44
[DIGIT]	Number of display digits for each parameter	p. 177
[PARA ABS]	Display of absolute value	p. 178
[COM MEAS]	Setting for communication command ":MEASURE?"	p. 179



[IO JUDGE]	I/O output of judgment results	p. 217
[IO TRIG]	IO trigger	p. 215
[IO EOM]	EOM output method	p. 218
[MEMORY]	Saving measurement results	p. 258
[DISP]	LCD display	p. 168
[BEEP KEY]	Beep sound	p. 185
[COM FORM]	Communication measurement data type	p. 191
[KEYLOCK]	Key-lock function	p. 187
[WARM UP]	Warm-up notification function	p. 186
[PANEL]	Panel loading and saving	p. 223
[RESET]	Initializing	

Measurement



Switches information to be displayed on the measurement screen.

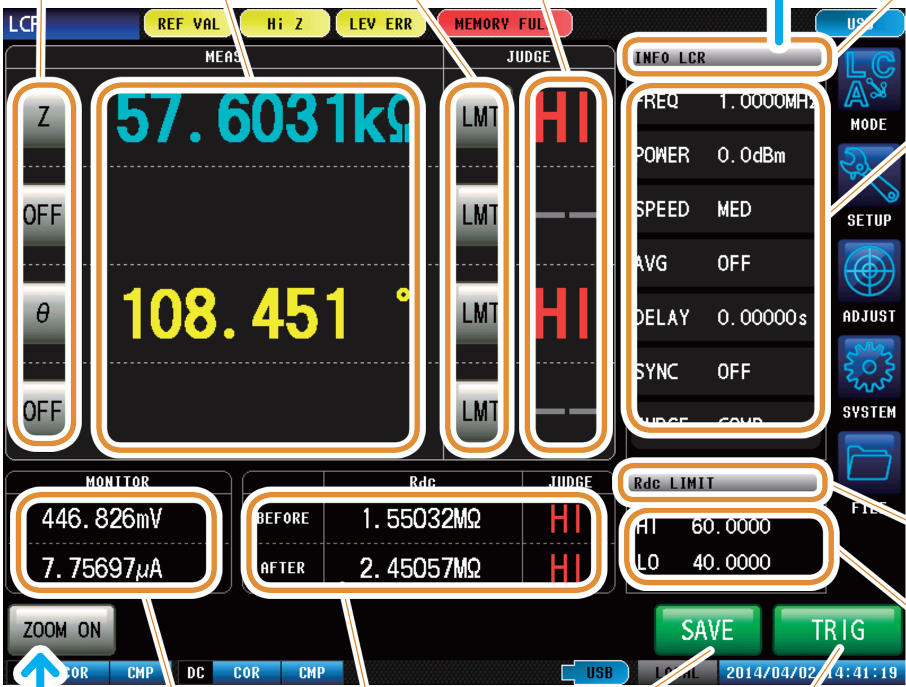
[SET]	Displays information regarding LCR measurement
[COMP]	Displays information on comparator measurement judgment standards.
[BIN1] to [BIN10]	Displays information on BIN judgment standards.

Sets the measurement parameter. (p. 32)

Displays the measured value.

Sets the upper and lower limit values. (p. 46)

Judgment result is displayed. (p. 46)



Display of measurement conditions and the upper and lower limits of comparator judgment/BIN judgment are switched.

Measurement conditions and the upper and lower limits of comparator judgment/BIN judgment are displayed.

The setting window is displayed by pressing a measurement condition area when measurement conditions are displayed.

Sets the upper and lower limit values of DC resistance. (p. 172)

The upper and lower limit values of DC resistance are displayed.

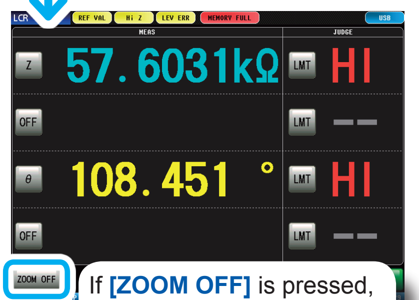
Monitor values are displayed.

Rdc values are displayed.

Saves the measurement data. (p. 259)

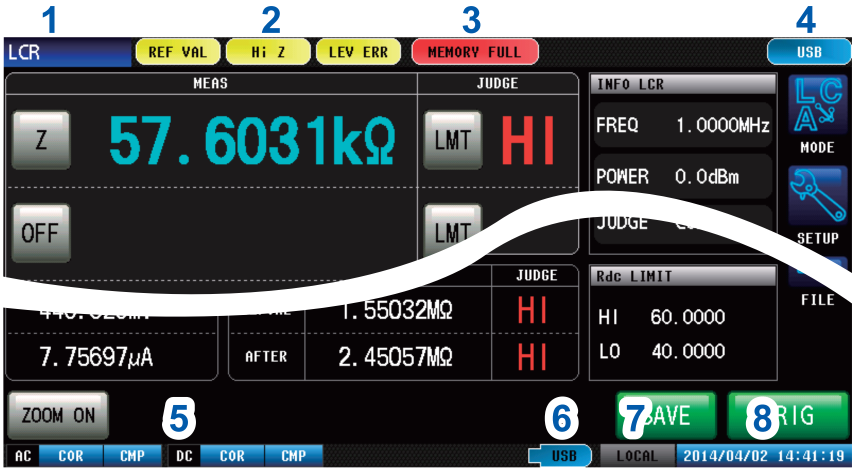
Inputs the trigger of an external trigger. (p. 33)

Enlarges the screen.



If **[ZOOM OFF]** is pressed, the screen turns to normal display.

Status and error display of this instrument



1 Displays the current measurement mode.

LCR	LCR function
ANALYZER	Analyzer function
CONTINUOUS	Continuous measurement function

2 Displays error messages.

REF VAL	Outside guaranteed accuracy
Hi Z	Hi Z reject error
LEV ERR	Error in detection level

3 Displays information saved in internal memory.

1000	Number of memories saved in internal memory
MEMORY FULL	When the instrument memory becomes full

4 Displays the type of interface that is currently connected.

RS232C	RS-232C
GPIB	GP-IB
USB	USB
LAN	LAN

5 Displays the state of calibration/compensation.

AC measurement		
Calibration	UNCAL	Calibration disabled
	COR	Calibration enabled
Compen-sation	CMP	Compensation disabled
	CMP	Compensation enabled
DC measurement		
Calibration	UNCAL	Calibration disabled
	COR	Calibration enabled
Compen-sation	CMP	Compensation disabled
	CMP	Compensation enabled

6 Displays the connection status of the USB memory.

USB	(Blue)	USB memory is connected
USB	(Red)	USB memory is being accessed

7 Displays the communication state.

REMOTE	During communication control
LOCAL	Local

8 Displays the date and time set for the instrument.

3.2 Setting Basic Settings of Measurement Conditions

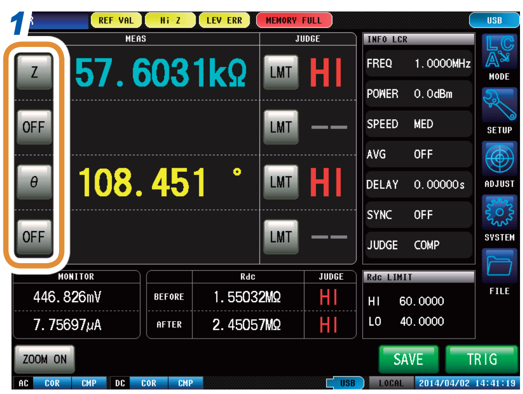
3.2.1 Setting Display Parameters

You can select up to 4 types from the 14 types of measurement parameters to display at any arbitrary location.
The phase angle θ is shown in reference to impedance Z. When performing measurements using admittance Y as the reference, the sign of the phase angle θ of impedance Z will be reversed.

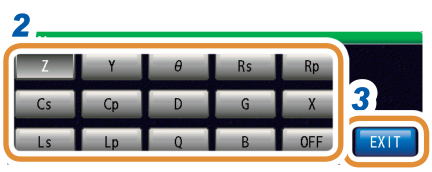
Refer to “Appx. 1 Measurement Parameters and Calculation Formula” (p. A1).
Refer to “Appx. 3 Series Equivalent Circuit Mode and Parallel Equivalent Circuit Mode” (p. A4).

Parameters	Contents
[Z]	Impedance (Ω)
[Y]	Admittance (S)
[θ]	Impedance phase angle (°)
[Rs]	Effective resistance = ESR (Ω) (series equivalent circuit)
[Rp]	Effective resistance (Ω) (parallel equivalent circuit)
[Cs]	Static capacitance (F) (series equivalent circuit)
[Cp]	Static capacitance (F) (parallel equivalent circuit mode)
[D]	Loss coefficient = tanδ

Parameters	Contents
[G]	Conductance (S)
[X]	Reactance (Ω)
[Ls]	Inductance (H) (series equivalent circuit)
[Lp]	Inductance (H) (parallel equivalent circuit)
[Q]	Q factor
[B]	Susceptance (S)
[OFF]	No display



1 **Press the parameter key that you want to set.**



2 **Select parameters.**

3 **Press [EXIT].**

3.2.2 Starting Measurement at Any Arbitrary Timing (Trigger)

Starts measurement at an arbitrary timing. Trigger is the function that controls the measurement start timing with specific signals. The following are the two types of trigger that can be set for the instrument.

Internal trigger ▶	Automatically repeats measurement. (Trigger signals are automatically generated internally.)
External trigger ▶	Measurements are triggered by an external signal. Trigger is controlled by an EXT I/O, interface, or manually (**[TRIG]**).

1 **Press [SETUP].**

2 **Press [BASIC] tab.**

3 **Press [TRIG].**

4 **Select the trigger type.**

[INT]	Internal trigger
[EXT]	External trigger

5 **Press [EXIT] to close the advanced settings screen.**

When EXT is selected

The following are the three types of input method for a trigger.

1 **Press [TRIG] on the screen to manually input a trigger.**

Measurement is performed once.

2 **Input via EXT I/O.**

Measurement is performed once, each time a negative logic pulse signal is applied.
Refer to “8.1 External Input/Output Connector and Signals” (p. 195).

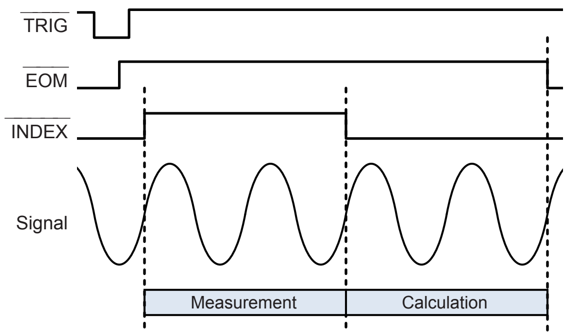
3 **Input from interface.**

Measurement is performed once when `*TRG` is transmitted.
See LCR Application Disk - Communication Commands.

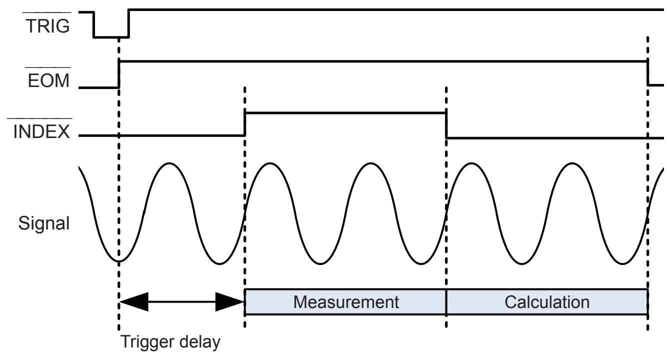
3.2.3 Setting the Delay Time from Trigger to Measurement Start (Trigger Delay)

The delay time period from input of the trigger signal to measurement (delay time) can be set.
With this function, it is possible to ensure that measurement is started after the connection condition of the object to be tested and the test probe (fixture) has stabilized.
Refer to “8.1 External Input/Output Connector and Signals” (p. 195).

Trigger delay: OFF



Trigger delay: ON

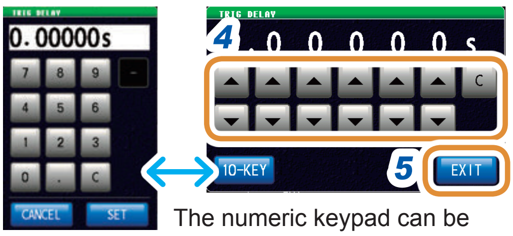


While trigger delay is being used, the LED for indicating that measurement is in progress is lit.

1 **Press [SETUP].**

2 **Press [BASIC] tab.**

3 **Press [DELAY].**



The numeric keypad can be used for input.

4 **Set the delay time with ▲/▼, or the numeric keypad.**
(With the numeric keypad, press **[SET]**.)

Settable range	0 s to 9.99999 s
Resolution	10 μs

[C]	The delay time becomes 0 s and this function is disabled.

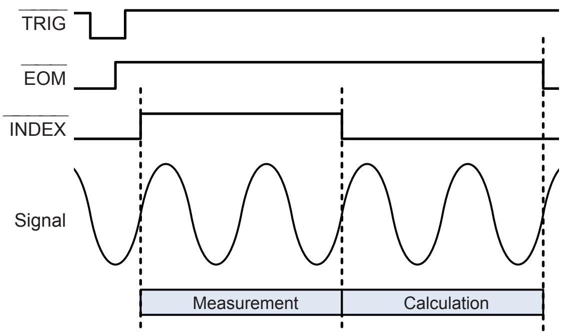
5 **Press [EXIT] to close the trigger delay setting screen.**

6 **Press [EXIT] to close the advanced settings screen.**

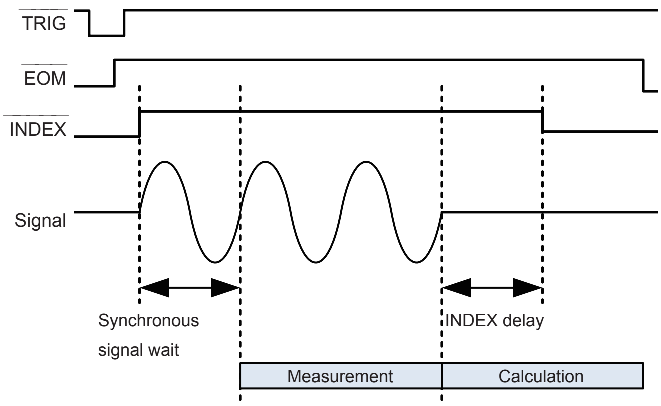
3.2.4 Applying the Signal to the Sample During Measurement Only (Trigger Synchronous Output)

This function outputs measurement signal after the trigger input and applies the signal only to the sample during measurement.
You can also set a delay time to ensure that data is acquired after the sample stabilizes.
Thus reducing the generation of heat in the sample and decreasing electrode wear.
Output of INDEX signals for switching to the next sample can be delayed till after the measurement signal is completely OFF (0 V) after measurement has been completed. (INDEX delay)

Trigger synchronous output: OFF



Trigger synchronous output: ON



1 Press **[SETUP]**.

2 Press **[BASIC]** tab.

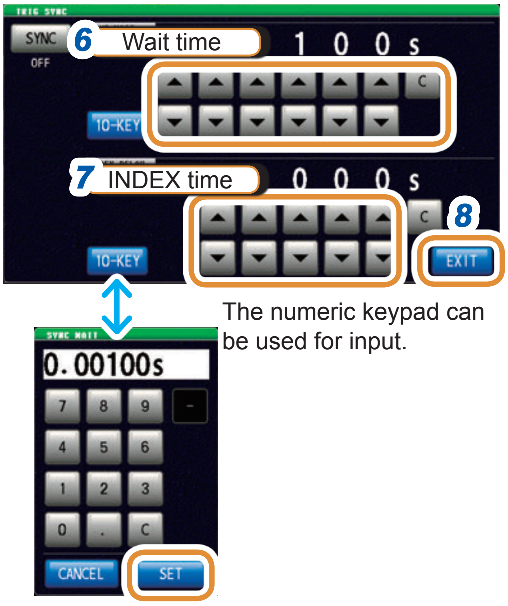
3 Press **[SYNC]**.

4 Press **[SYNC]**.

5 Select ON/OFF for the trigger synchronous output.

[OFF]	Disables the trigger synchronous output.
[ON]	Enables the trigger synchronous output.

Go to the next page.



6 **Use ▲/▼ to set the wait time (time to stabilize) from the time a measurement signal has been output by applying a trigger to the start of the next measurement.**
(With the numeric keypad, press **[SET]**.)

Settable range	0.00000 s to 9.99999 s

[C]	Sets to the default value. (The time is set to 0.001 s.)

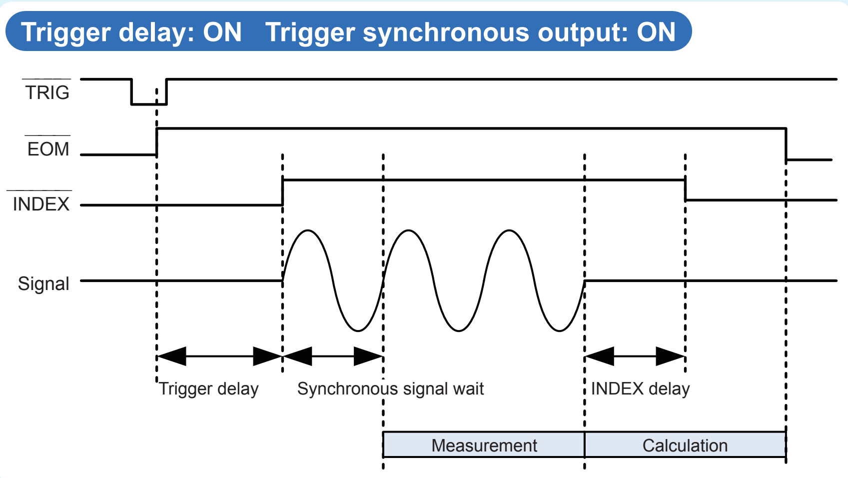
7 **Set the INDEX delay time.**
(With the numeric keypad, press **[SET]**.)

Settable range	0.00000 s to 0.10000 s

8 **Press [EXIT] to close the trigger synchronous output setting screen.**

9 **Press [EXIT] to close the advanced settings screen.**

- When the trigger synchronous output function is set to **[ON]**, the measurement time will increase due to the addition of a wait time between output of the measurement signal and data acquisition.
  See “12.3 Measurement Time” (p. 290).
- If a measurement condition is changed with the trigger synchronous output function is set to **[ON]**, a measurement signal at the set level may be output momentarily.
- The measurement signal is output when the trigger signal is input and stops after measurement ends.
- In CONTINUOUS measurement mode, the measurement condition is set as the setting of the initial pulse after measurement of the last panel is completed.
  If the trigger synchronous function is set to **[ON]** for the initial panel, the measurement signal stops.



3.2.5 Setting the Measurement Frequency

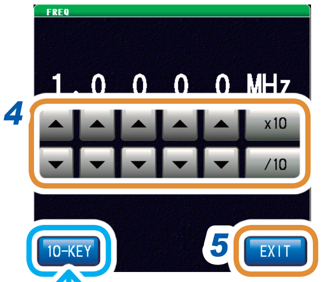
Sets the frequency of the signal applied to the test sample. The value of the measurement frequency level may change according to the sample which is being tested.

1 **Press [SETUP].**

2 **Press [BASIC] tab.**

3 **Press [FREQ].**

When setting with ▲/▼ (each digit)



Input method can be switched between **[DIGIT]** and **[10-KEY]**.

To set the frequency with the numeric keypad

4 **Set the frequency with ▲/▼ or the numeric keypad.**

Settable range	1 MHz to 300 MHz

When setting with ▲/▼ (each digit)
Holding down a digit key changes the value continuously.

Settable range	1 MHz to 300 MHz

[×10]	Sets the measurement frequency to 10×.
[/10]	Sets the measurement frequency to 1/10×.

To set the frequency with the numeric keypad
Changing the unit: **M** (mega)/**k** (kilo)

[C]	Repeats the input.

- Instrument key is enabled if a numerical value is input.
- Frequency is set on pressing the instrument key.
- If the value is set to more than 300 MHz:
  The value is automatically set to 300 MHz.
- If the value is set to less than 1 MHz:
  The value is automatically set to 1 MHz.

5 **Press [EXIT] to close the measurement frequency setting screen.**

6 **Press [EXIT] to close the advanced settings screen.**

3.2.6 Setting the Measurement Signal Level

Sets the Measurement signal level.
The value of the measurement signal level may change based on the sample tested.
This instrument can set the measurement signal applied to the object to be tested using the following three methods.

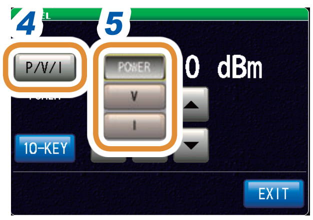
Power (P) mode	Sets measurement signal level with the power (dBm) at the DUT port 50 Ω terminal.
Voltage (V) mode	Sets measurement signal level with the voltage (V) when the DUT port is open. (value of dBm converted into V)
Current (I) mode	Sets measurement signal level with the current (A) when the DUT port is in a short circuit state. (value of dBm converted into I)

- The setting resolution of the signal level is always 0.1 dB irrespective of the setting signal mode.
  When the level is set in the voltage or current mode, input values are automatically converted to the setting value with a resolution of 0.1 dB.
- The measurement accuracy varies according to the measurement signal level.
  See “Measurement range” (p. 274).

1 Press **[SETUP]**.

2 Press **[BASIC]** tab.

3 Press **[LEVEL]**.

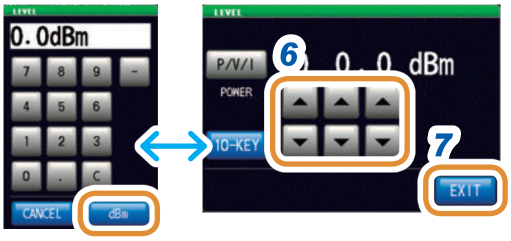


4 Press **[P/V/I]**.

5 **Select the signal setting mode.**

[POWER]	Sets with power (dBm).
[V]	Sets with voltage (V).
[I]	Sets with current (A).

Go to the next page.



The numeric keypad can be used for input.

6 **Set the voltage or current with ▲/▼ or the numeric keypad.**
(With the numeric pad, press [dBm].)

Measurement signal mode	Settable range
Power (P) mode	-40.0 to +7 dBm (resolution, 0.1 dBm)
Voltage (V) mode	4 mV to 1001 mV
Current (I) mode	0.09 mA to 20.02 mA

[C]	Repeats the input.

7 **Press [EXIT] to close the measurement signal level setting screen.**

8 **Press [EXIT] to close the advanced settings screen.**

When a measured value is outside the guaranteed accuracy range, **REF VAL** is displayed in the error display area.
Check the guaranteed accuracy range and change the measurement conditions or consider the measured values as values for reference.
See “Measurement range” (p. 274).

Conversion

The relation between the setting of power and those of voltage, current are converted using the following formula.

$$V = 2\times\sqrt{W\times 50(\Omega)}$$
$$= 2\times\sqrt{10^{\frac{DBM}{10}}\div 1000\times 50(\Omega)}$$

$$I = 2\times\sqrt{W\div 50(\Omega)}$$
$$= 2\times\sqrt{10^{\frac{DBM}{10}}\div 1000\div 50(\Omega)}$$

V: Voltage
I: Current
DBM: Power (dBm) settings value

3.2.7 Setting the Measurement Speed

Change the measurement time.
Setting the measurement speed to **[FAST]** enables high speed measurement. Setting to **[SLOW2]** enables measurement with high accuracy.

- If the measurement speed is changed, calibration and compensation must be performed again.
  See “5 Calibration and Compensation” (p. 139).
- Measurement time varies with the measurement conditions.
  See “12.3 Measurement Time” (p. 290).

1 Press **[SETUP]**.

2 Press **[BASIC]** tab.

3 Press **[SPEED]**.

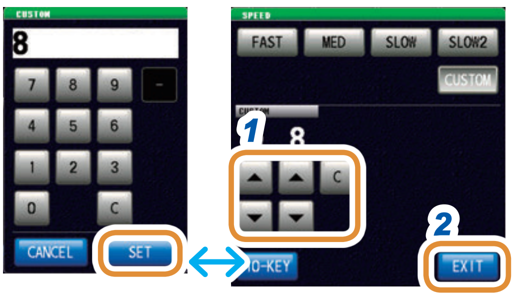
4 Select the measurement speed.

[FAST]	Performs high-speed measurement.
[MED]	Performs normal-speed measurement.
[SLOW]	Increases measurement accuracy.
[SLOW2]	Measurement accuracy is better than SLOW.
[CUSTOM]	Advanced settings for the measurement speed is enabled. Setting range: 8 to 87

5 Press **[EXIT]** to close the measurement speed setting screen.

6 Press **[EXIT]** to close the advanced settings screen.

When selecting [CUSTOM] in step 4



The numeric keypad can be used for input.

1 Set measurement speed with ▲/▼, or the numeric keypad.
(With the numeric keypad, press **[SET]**.)

[C]	Repeats the input.

2 Press **[EXIT]**.

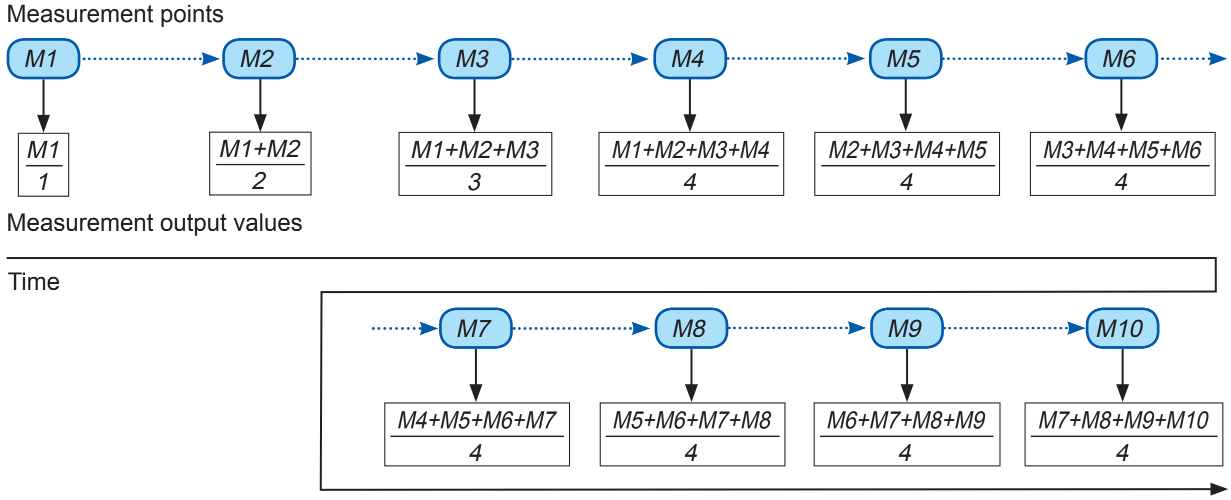
3.2.8 Displaying Average Values (Average)

The measured values can be averaged using the averaging function. The variations in the displayed measured values can be reduced with this function.

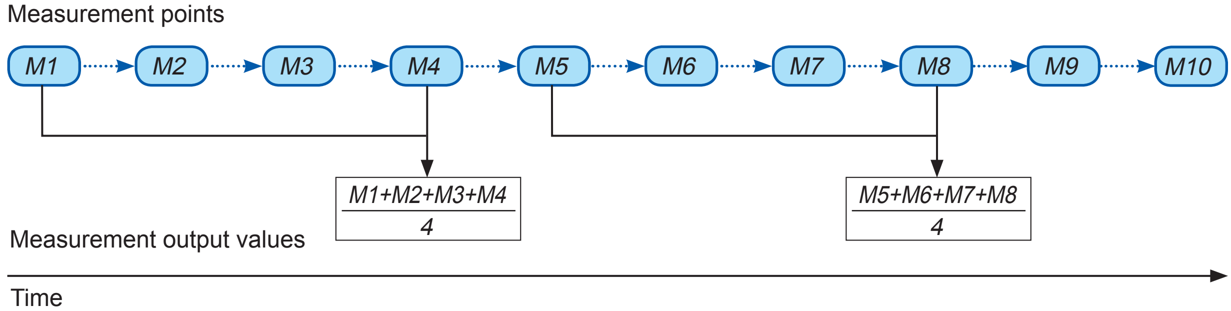
Internal trigger	The measured values are always the moving average from present to before the number of times of averaging. (When the sample to be tested is changed, it takes time for the values to stabilize and the results are reliable.)
External trigger	It is the arithmetic mean of the number of times of averaging from the trigger input.

When averaging is executed 4 times, the number of measurements, measurement output points, and measured value calculation method during output are as follows.

Moving average



Arithmetic mean



1 **Press [SETUP].**

2 **Press [BASIC] tab.**

3 **Press [AVG].**

4 **Use ▲/▼ to enter the averaging number of times.**

Settable range	1 to 256 times

[C]	Setting is turned OFF.

5 **Press [EXIT] to close the average setting screen.**

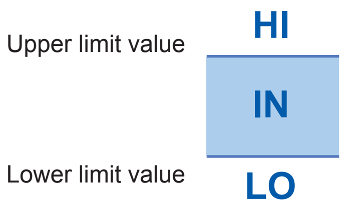
6 **Press [EXIT] to close the advanced settings screen.**

3.3 Judging Measurement Results

The judgment results are displayed after the measurement results are compared to an arbitrarily set reference. This function is useful for processes such as shipping inspection.
This includes the comparator function to make pass/fail judgments (HI/IN/LO) of measured values with one judgment standard, and the BIN function to classify (rank) measured values based on several judgment standards (up to 10).

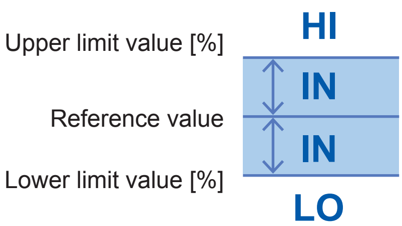
One of the following 3 judgment methods can be used.

Setting the upper and lower limit values (ABS) (p. 48)



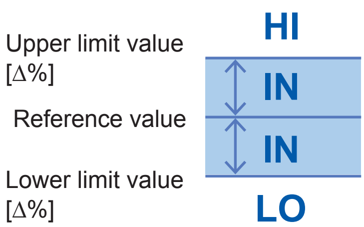
Setting the upper limit and lower limit values for the measurement parameters.
The measured values display the values of the measurement parameters as it is.

Percent (%) Setting (p. 49)



Enter reference values and set the difference between the upper limit and the reference value, and between the lower limit [*1] and the reference value as a ratio (percentage) relative to the reference value.
The measured values display the values of the measurement parameters as it is.

Deviation Percent (Δ%)[*2] Setting (p. 51)



Enter reference values and set the difference between the upper limit and the reference value, and between the lower limit [*1] and the reference value as a ratio (percentage) relative to the reference value.
The measured values display the deviations (Δ%) from the reference value.

*1 The following formula is used to calculate the comparison upper limit value and comparison lower limit value. (For the comparison lower limit value, if a value that is lower compared to the reference value is set, a minus (-) sign is required for the percentage setting value.)

$$\text{Upper limit comparison value (Lower limit comparison value)} = \text{reference value} + |\text{reference value}| \times \frac{\text{Percentage setting value}}{100}$$

*2 The Δ% value is calculated using the following formula:

$$\Delta\% = \frac{\text{measured value - reference value}}{|\text{ reference value}|} \times 100$$

3.3.1 Setting the Judgment Mode

Judgment results can be checked by acquiring the results of beep sounds, screen display, I/O output, and communication commands.

1 **Press [SETUP].**

2 **Press [ADVANCED] tab.**

3 **Press [JUDGE].**

4 **Select the judgment mode.**

[OFF]	Disables comparator and BIN function.
[COMP]	Enables comparator judgment. (p. 46)
[BIN]	Enables BIN judgment. (p. 53)

5 **When a measured value is outside the guaranteed accuracy range, set how the measured value is judged.**

[DO]	Judges when a measured value is outside the guaranteed accuracy range.
[NOT]	Outputs error for HI judgment when a measured value is outside the guaranteed accuracy range.

6 **Sets the beep sounds for judgment results.**

[OFF]	No beep sound.
[IN]	Beeps if all the judgment results are IN.
[NG]	Beeps if one of the judgment results is LO or HI.

7 **With ▲/▼, set the beep tone.**

Settable range	0 to 14

8 **With ▲/▼, set the beep volume.**

Settable range	1 to 3

9 **Press [EXIT] to close the judgment settings screen.**

10 **Press [EXIT] to close the advanced settings screen.**

3.3.2 Judging with Upper and Lower Limit Values (Comparator Judgment Mode)

This mode judges if the measurement results are within the specified range.
The comparator judgment allows you to do the following.

- Preset a judgment reference with reference value, upper and lower limit values, and display the judgment result as HI (higher than the upper limit value), IN (within the range set for the upper and lower limit values), or LO (lower than the lower limit value).
- Output the judgment results to an external device (via the EXT I/O connector).
- Judges up to four parameters with different settings.
- Beeps to notify judgment results.
  Refer to "3.3.1 Setting the Judgment Mode" (p. 44).

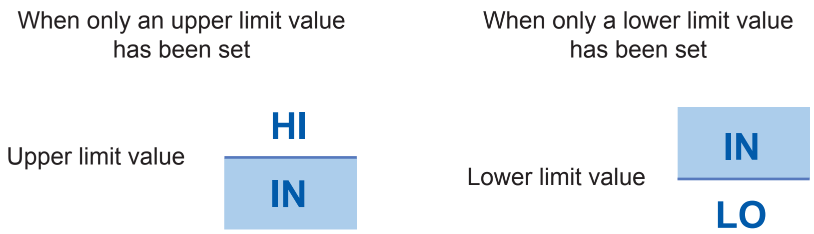
HI	Measured value > upper limit
IN	Upper limit value ≥ measured value ≥ lower limit value
LO	Measured value < lower limit
- - -	If reference standards have not been set

Comparator judgment order

Judgment order	State	Judgment display
1	• When the measured value is **MEAS ERR** • Outside the guaranteed accuracy range (Judgment for a value outside the guaranteed accuracy range is **NOT**)	**HI**
2	When judging if the measured value is higher than the lower limit value, and the judgment is Fail.	**LO**
3	When judging if the measured value is lower than the upper limit value, and the judgment is Fail.	**HI**
4	Other than 1, 2, 3	**IN**

- If measured values are outside the guaranteed accuracy range (**REF VAL**), judgment is performed in order of judgment when the setting of **[JUDGE EXEC]** is **DO**. If **NOT**, judgment is not performed and **HI** judgment is returned.
- There is no comparison performed to check if the upper limit value is greater than the lower limit value, hence an error message will not be displayed if the setting of the upper limit value and lower limit value are reversed.

- Comparator judgment can be used even if only the upper or lower limit value has been set.



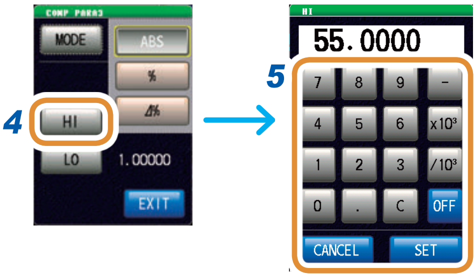
Upper and lower limit values mode

This mode performs judgment with the upper and lower limits (ABS) that have been set.

1 **Press [LMT].**

2 **Press [MODE].**

3 **Press [ABS].**



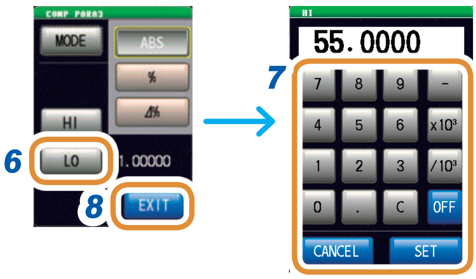
Changing the unit: a/f/p/n/μ/m/None/k/M/G

4 **Press [HI].**

5 **Set the upper limit value with the numeric pad and press [SET].**

Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[×10³]	Increases the prefix of the unit.
[/10³]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.



6 **Press [LO].**

7 **Set the lower limit value with the numeric pad and press [SET].**

Settable range	-9.99999 G to 9.99999 G

8 **Press [EXIT] to close the setting screen.**

Percent mode

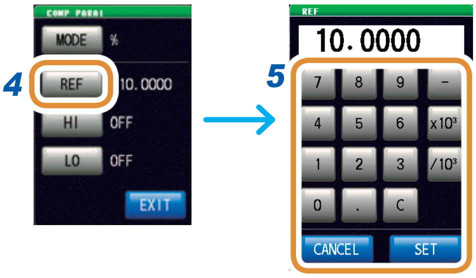
The difference between the upper limit and the reference value, and between the lower limit and the reference value is set as a ratio (percentage) relative to the reference value, and it is judged whether measured values are within the range of the upper and lower limit values.

> The set reference value, upper and lower limit values are common for percentage mode and deviation percentage mode.

1 Press **[LMT]**.

2 Press **[MODE]**.

3 Press **[%]**.



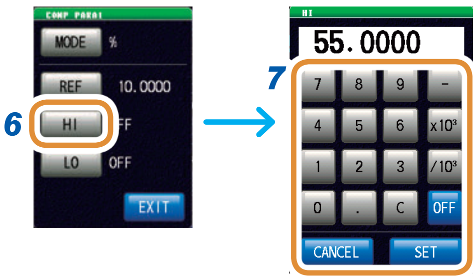
Changing the unit: a/f/p/n/μ/m/None/k/M/G

4 Press **[REF]**.

5 **Set the reference value with the numeric pad and press [SET].**

Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.



6 Press **[HI]**.

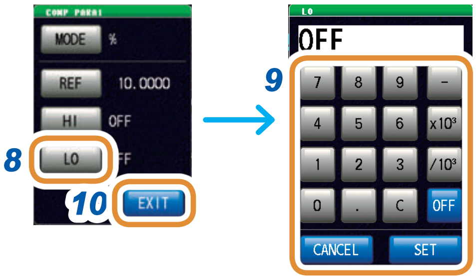
7 **Set the upper limit value with the numeric pad and press [SET].**
Sets the upper limit value as a percentage relative to the reference value.

Settable range	-999.999% to +999.999%

The actual internal operation consists of calculating the comparison upper-limit value using the formula given below, and comparing it to the measured value to enable a decision to be made.

$$\text{Upper limit comparison value (Lower limit comparison value)} = \text{reference value} + |\text{reference value}| \times \frac{\text{Percentage setting value}}{100}$$

Go to the next page.



8 **Press [LO].**

9 **Set the lower limit value with the numeric pad and press [SET].**

Set the lower limit value as a percentage relative to the reference value.

Settable range	-999.999% to 999.999%

The actual internal operation calculates the lower limit comparison value with the following formula, and when a value lower than the reference value is set, the minus (-) sign is required for the percentage setting value.

$$\text{Lower limit comparison value} = \text{reference value} + |\text{reference value}| \times \frac{\text{Percentage setting value}}{100}$$

10 **Press [EXIT] to close the setting screen.**

Δ% mode

The difference between the upper limit and the reference value, and between the lower limit and the reference value is set as a ratio (percentage) relative to the reference value, and it is judged whether measured values are within the range of the upper and lower limit values.
In the deviation percentage mode, the measured values display the deviations (Δ%) from the reference value.
The Δ% value is calculated using the following formula:

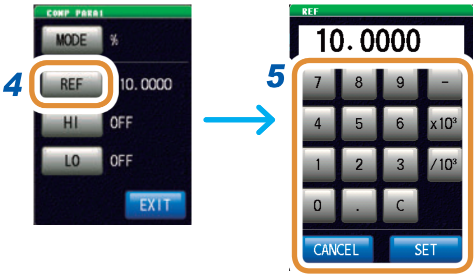
$$\Delta\% = \frac{\text{measured value - reference value}}{|\text{reference value}|} \times 100$$

> The set reference value, upper and lower limit values are common for percentage mode and deviation percentage mode.

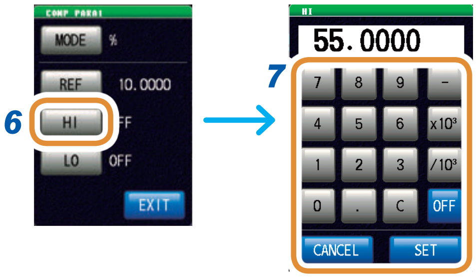
1 Press **[LMT]**.

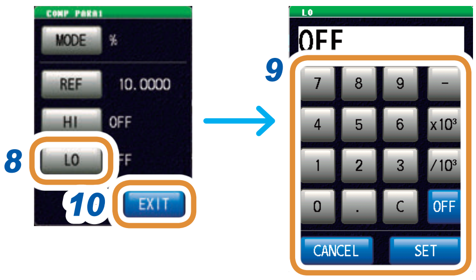
2 Press **[MODE]**.

3 Press **[Δ%]**.



Changing the unit: **a**/**f**/**p**/**n**/**μ**/**m**/None/**k**/**M**/**G**





4 **Press [REF].**

5 **Set the reference value with the numeric pad and press [SET].**

Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

6 **Press [HI].**

7 **Set the upper limit value with the numeric pad and press [SET].**

Settable range	-999.999% to 999.999%

8 **Press [LO].**

9 **Set the lower limit value with the numeric pad and press [SET].**

Settable range	-999.999% to 999.999%

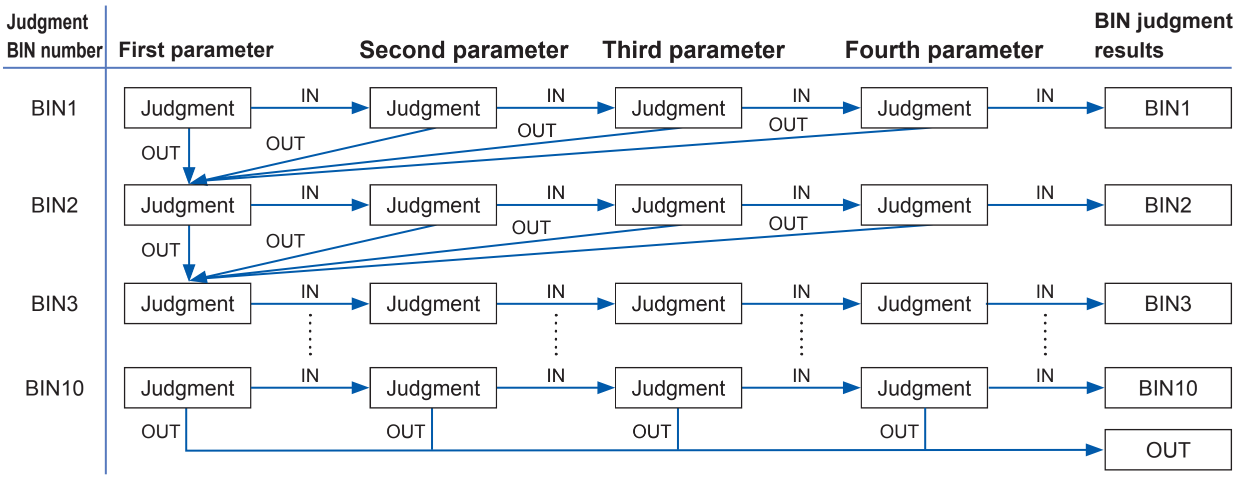
10 **Press [EXIT] to close the setting screen.**

3.3.3 Classifying Measurement Results (BIN Judgment)

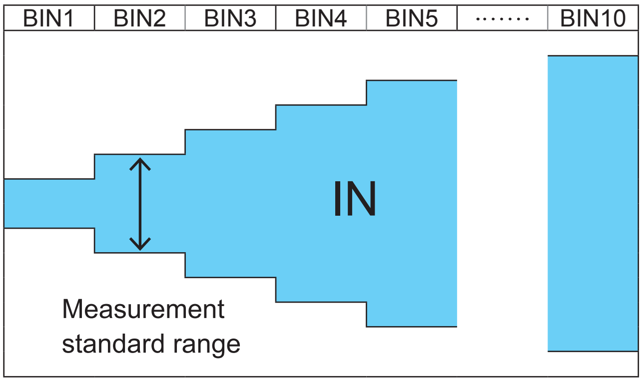
Set the upper and lower limit values for 4 parameters and display up to 10 classifications of judgment results.
You can also output the judgment results to an external device.
Select the BIN judgment mode before setting the judgment conditions. (p. 44)

BIN	In case of BIN judgment
- - -	When BIN is not set
OUT	When not matching any BIN

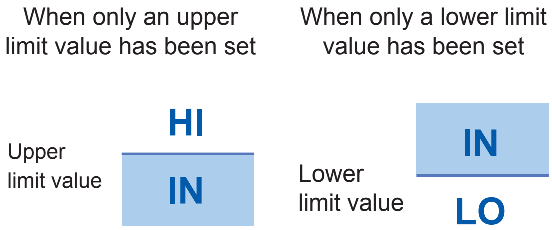
BIN judgment order: Starts with judgment of the first parameter for BIN1 and proceeds in order to BIN10, as described below. The instrument will display the first BIN number for which the measured value is judged to be within the set judgment standard.
If none of the BIN judgments are within the set judgment standard, **[OUT]** will be displayed.



The measurement elements can be ranked by setting a series of severe to lenient judgment standards as shown in the following diagram.

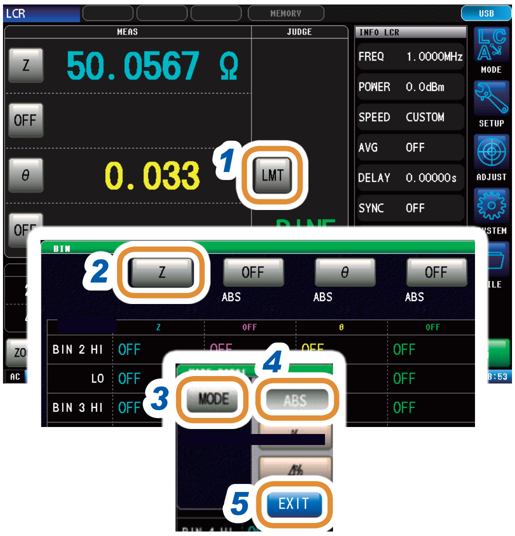


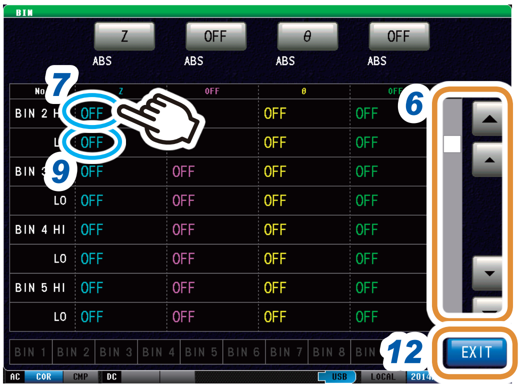
- For more information about HI/IN/LO judgment procedures, see p. 46.
- Set the upper/lower limit values to **[OFF]** for BIN numbers not requiring BIN judgments.
- BIN judgment can be used even if only the upper or lower limit value has been set. (See the following figure.)



Upper and lower limit values mode

This mode performs judgment with the upper and lower limits (ABS) that have been set.





Changing the unit: a/f/p/n/μ/m/None/k/M/G

1 **Press [LMT].**

2 **Press [Z].**
The key display differs depending on the measurement parameter.

3 **Press [MODE].**

4 **Press [ABS].**

5 **Press [EXIT] to return to the BIN setting screen.**

6 **Display the BIN number to be set with ▲/▼ or by scrolling.**

7 **Press the part corresponding to HI of the first parameter**

8 **Use the numeric keypad to set the upper limit value of the first parameter and press [SET].**

Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[×10³]	Increases the prefix of the unit.
[/10³]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

9 **Press the part corresponding to LO of the first parameter.**

10 **Use the numeric keypad to set the lower limit value and press [SET].**

Settable range	-9.99999 G to 9.99999 G

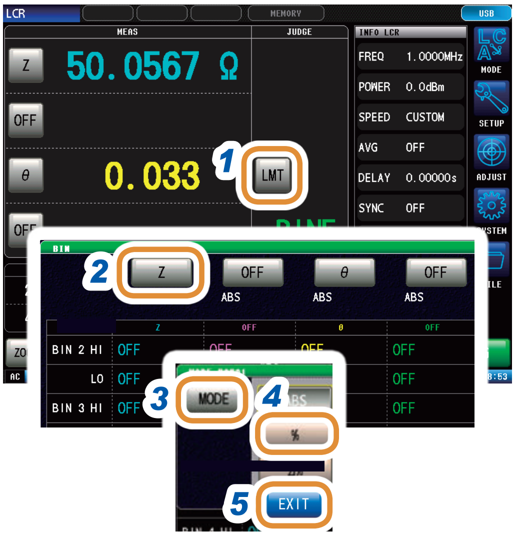
The screen returns to the state in step 4.

11 **Set the upper and lower limit values of the second to fourth parameters, and press [SET].**

12 **Press [EXIT] to close the setting screen.**

Percent mode

The difference between the upper limit and the reference value, and between the lower limit and the reference value is set as a ratio (percentage) relative to the reference value, and it is judged whether measured values are within the range of the upper and lower limit values.



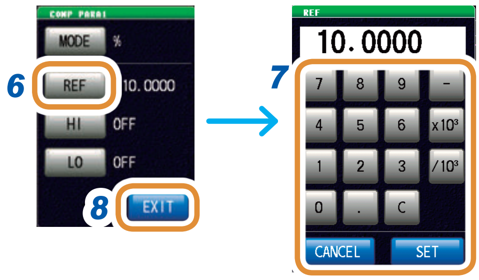
1. **Press [LMT].**

2. **Press [Z].**
The key display differs depending on the measurement parameter.

3. **Press [MODE].**

4. **Press [%].**
The key display differs depending on the measurement parameter.

5. **Press [EXIT].**

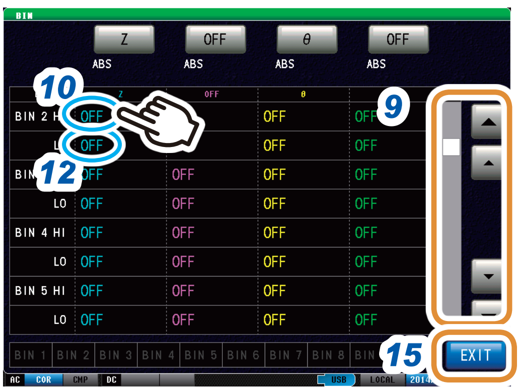


6. **Press [REF].**

7. **Set the reference value with the numeric pad and press [SET].**

Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.



8. **Press [EXIT].**

9. **Display the BIN number to be set with ▲/▼ or by scrolling.**

10. **Press the part corresponding to HI of the first parameter**

Go to the next page.

11 **Use the numeric keypad to set the upper limit value of the first parameter and press [SET].**

Settable range	-999.999% to 999.999%

12 **Press the part corresponding to LO of the first parameter.**

13 **Use the numeric keypad to set the lower limit value and press [SET].**

Settable range	-999.999% to 999.999%

The screen returns to the state in step 7.

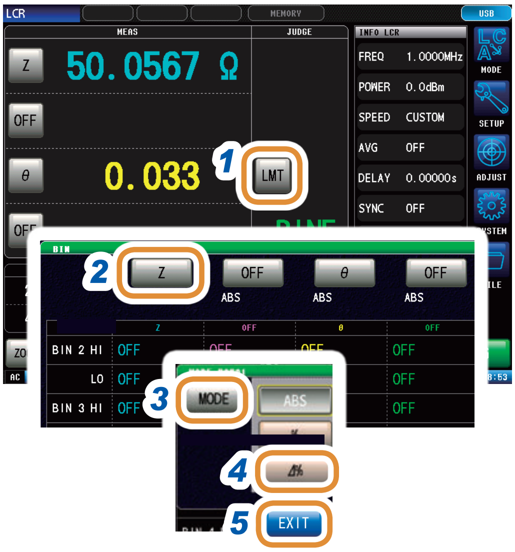
14 **Set the upper and lower limit values of the second to fourth parameters, and press [SET].**

15 **Press [EXIT] to close the setting screen.**

Δ% mode

The difference between the upper limit and the reference value, and between the lower limit and the reference value is set as a ratio (percentage) relative to the reference value, and it is judged whether measured values are within the range of the upper and lower limit values.

> The set reference value, upper and lower limit values are common for percentage mode and deviation percentage mode.



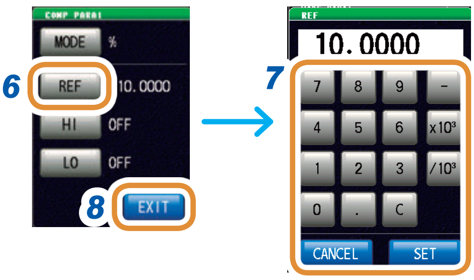
1 Press **[LMT]**.

2 Press **[Z]**.
The key display differs depending on the measurement parameter.

3 Press **[MODE]**.

4 Press **[Δ%]**.
The key display differs depending on the measurement parameter.

5 Press **[EXIT]**.



6 Press **[REF]**.

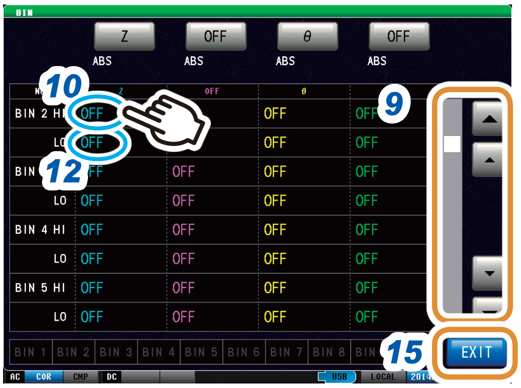
7 **Set the reference value with the numeric pad and press [SET].**

Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

8 Press **[EXIT]**.

Go to the next page.



9 **Display the BIN number to be set with ▲/▼ or by scrolling.**

10 **Press the part corresponding to HI of the first parameter.**

11 **Use the numeric keypad to set the upper limit value of the first parameter and press [SET].**

Settable range	-999.999% to 999.999%

12 **Press the part corresponding to LO of the first parameter.**

13 **Use the numeric keypad to set the lower limit value and press [SET].**

Settable range	-999.999% to 999.999%

The screen returns to the state in step 7.

14 **Set the upper and lower limit values of the second to fourth parameters, and press [SET].**

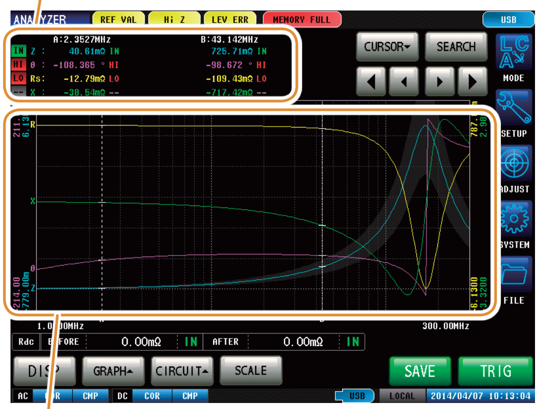
15 **Press [EXIT] to close the setting screen.**

4 Analyzer Function

4.1 Analyzer Function

The analyzer function allows you to perform measurement while sweeping the measurement frequency and signal level.
The measurement results can be displayed as a graph or numerical value. This function is used for measuring frequency characteristics and level characteristics.

You can check the measurement result of each sweep point.

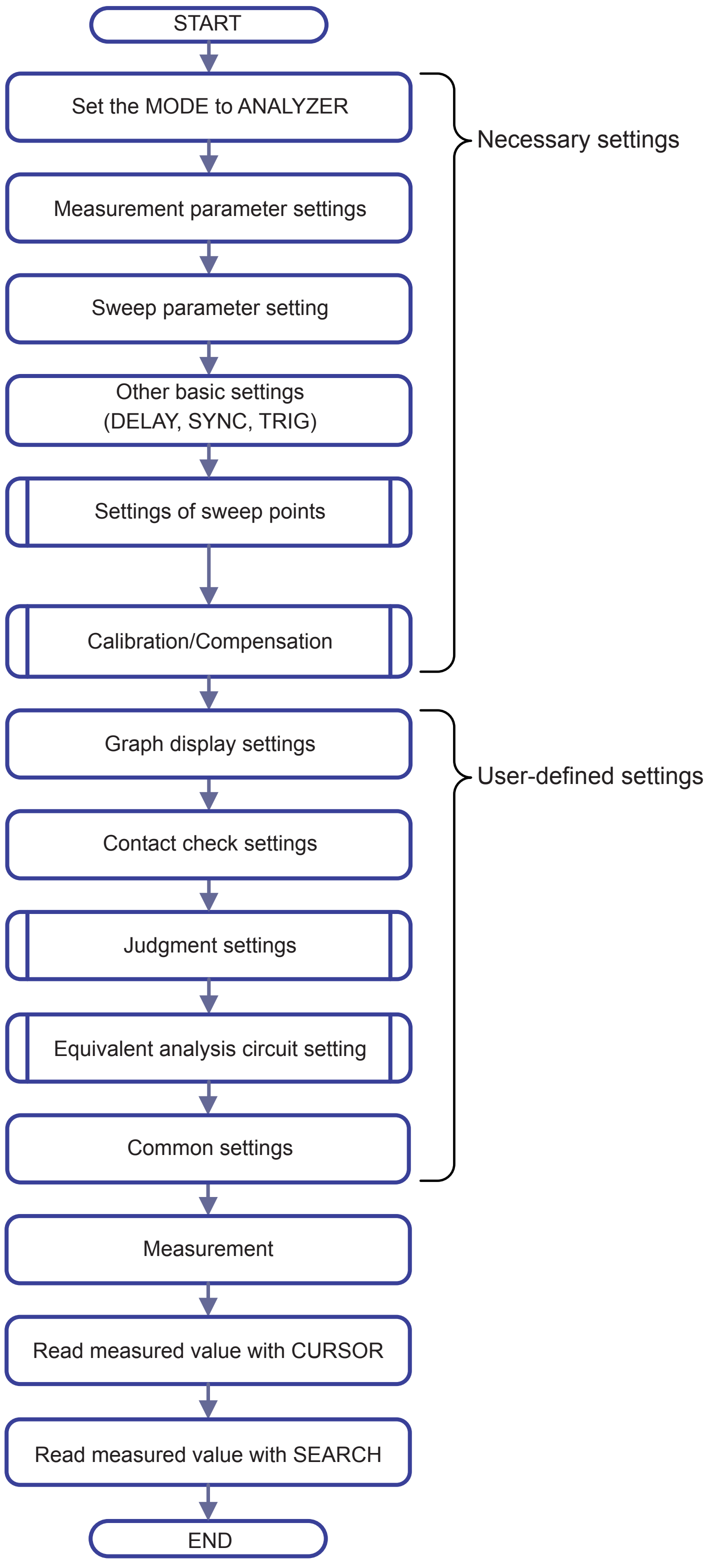


Displays the measurement results in a graph.
Use this function for measuring frequency characteristics and level characteristics.

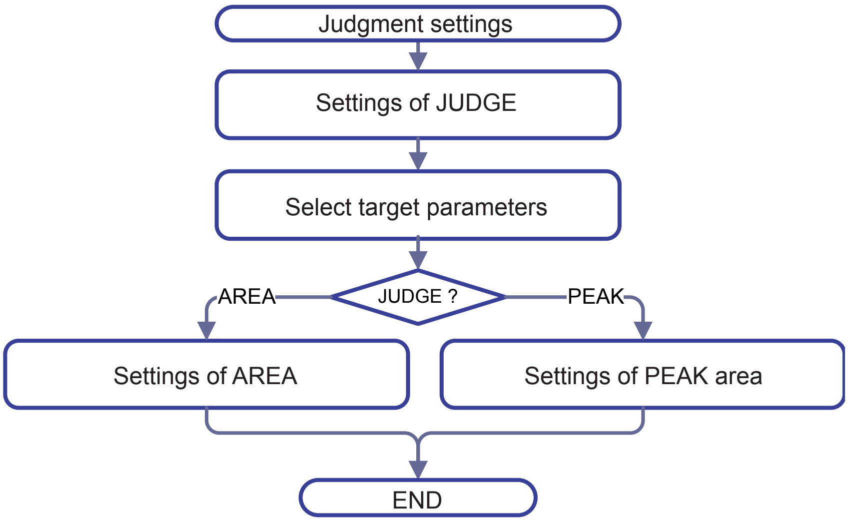
- Conditions set by the analyzer function are not transferred to the LCR function.
- When the power is turned on again, display will be in accordance with the measurement mode used before the power was turned off.

Flowchart

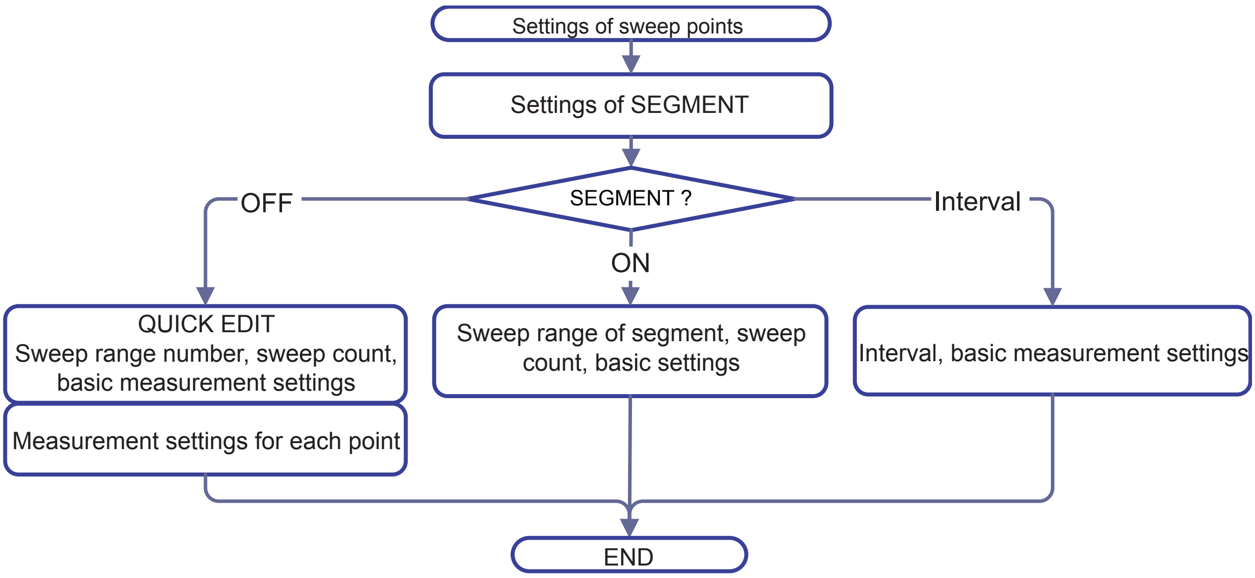
ANALYER measurement



Judgment settings



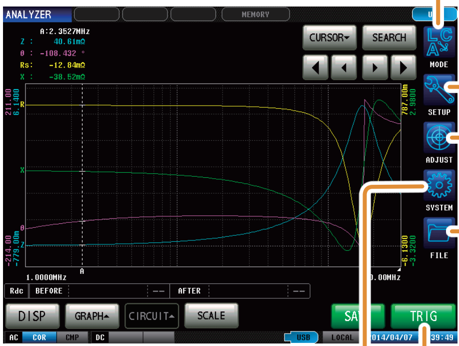
Settings sweep points



Screen map

Measurement mode setting screen (p. 25)

Advanced settings screen (p. 69)

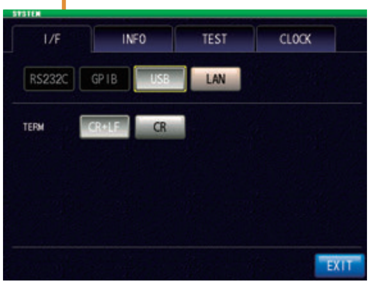


Compen-sation settings screen (p. 139)

[CAL]	Calibration	p. 143
[Rdc LIMIT]	DC measurement limit value	p. 150
[LENGTH]	Electrical length compensation	p. 152
[COMPEN]	Compensation	p. 153
[Rdc LIMIT]	DC measurement limit value	p. 157
[SCALE]	Scaling	p. 159

Trigger (p. 70)

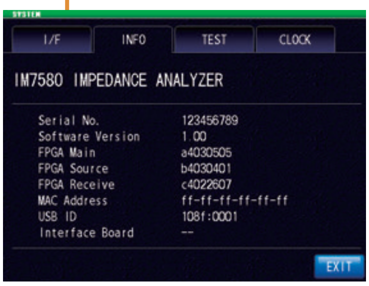
System settings screen (p. 231)



Select an interface. (p. 231)

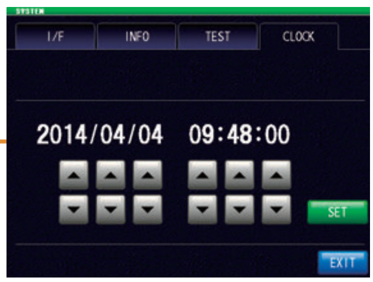
Save settings screen (p. 243)

[SETUP]	Sets [SAVE]	p. 243
[SAVE]	Saves the setting conditions	p. 243
[LOAD]	Loads the setting conditions	p. 261
[FORMAT]	Formats USB flash drive	p. 265
[DELETE]	Deletes files	p. 270
[FOLDER]	Creates folders	p. 267
[RENAME]	Changes file names	p. 268
[SELECT]	Selects files	p. 261
[BACK]	Displays the previous screen	



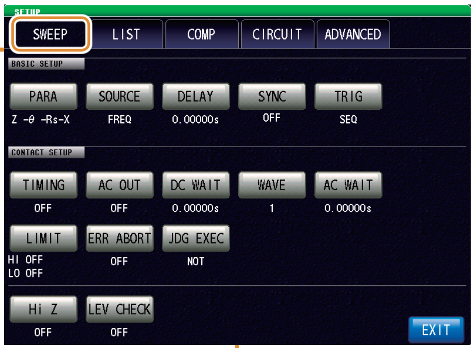
The version of the instrument can be verified. (p. 232)

Self checks (self diagnosis) are enabled. (p. 233)



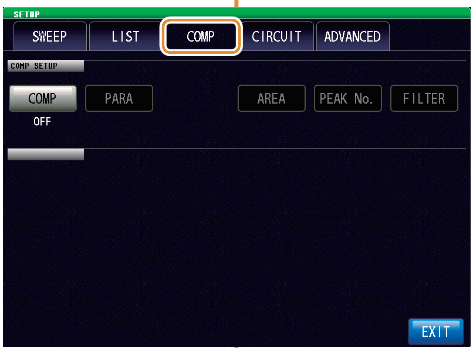
Date and time can be set for the instrument. (p. 238)

Advanced settings screen (p. 69)



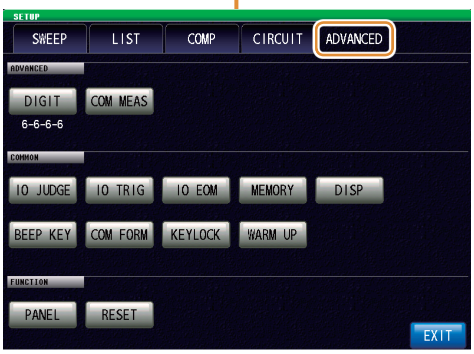
[PARA]	Parameters	p. 69
[SOURCE]	Sweep parameter	p. 74
[DELAY]	Trigger delay	p. 71
[SYNC]	Trigger synchronous output	p. 72
[TRIG]	Trigger	p. 70
[TIMING]	Contact check settings (DC measurement)	p. 169
[Hi Z]	Hi Z reject function	p. 174
[LEV CHECK]	Monitoring function for detection level	p. 175

Settings of sweep points (p. 76)



Search function setting (p. 112)

Equivalent analysis circuit setting (p. 124)



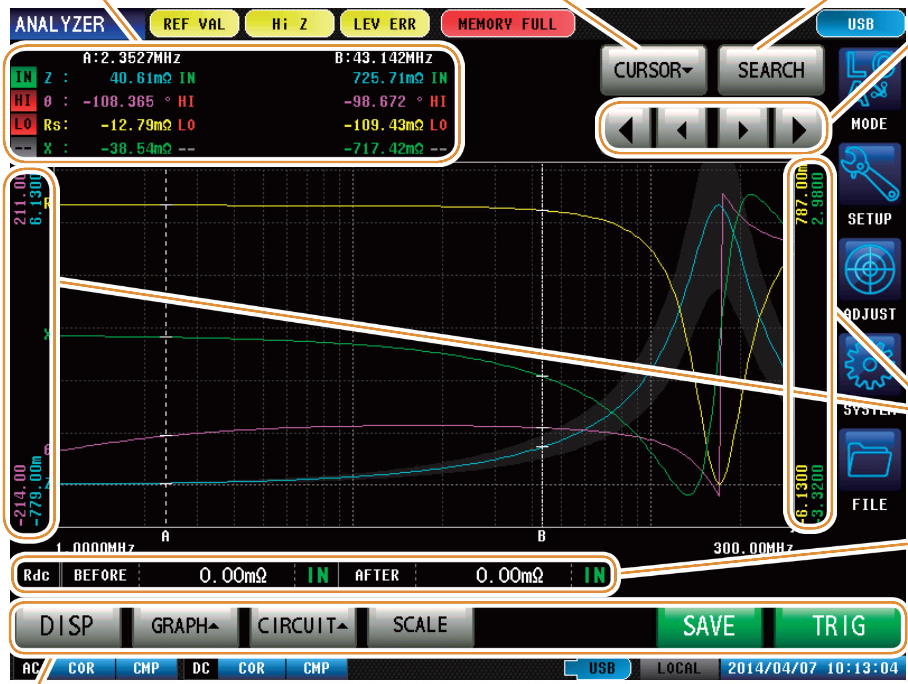
[DIGIT]	Number of display digits for each parameter	p. 177
[COM MEAS]	Setting for communication command “`:MEASURE?`”	p. 179
[IO JUDGE]	I/O output of judgment result	p. 217
[IO TRIG]	IO trigger	p. 215
[IO EOM]	EOM output method	p. 218
[MEMORY]	Saving measurement results	p. 258
[DISP]	LCD display	p. 168
[BEEP KEY]	Beep sound	p. 185
[COM FORM]	Communication measurement data type	p. 191
[KEYLOCK]	Key-lock function	p. 187
[WARM UP]	Warm-up notification function	p. 186
[PANEL]	Panel loading and saving	p. 223
[RESET]	Initializing	

Measurement screen

Displays the measured value at the cursor position.

Sets the cursor. (p. 105)

Executes search. (p. 107)



Moves the cursor.

[◀]	Moves the cursor to the left by ten points.
[◂]	Moves the cursor to the left by one point.
[▸]	Moves the cursor to the right by one point.
[▶]	Moves the cursor to the right by ten points.

Indicates the maximum and minimum values of the vertical axis of the graph.

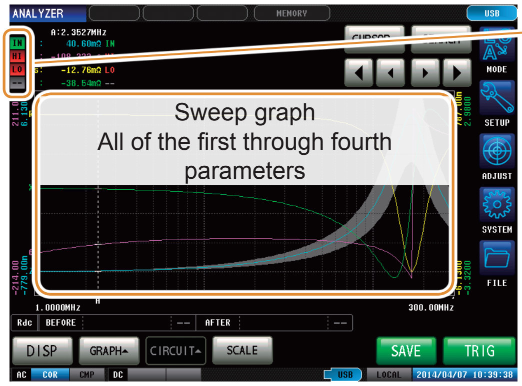
Displays the Rdc value.

[DISP]	Selects the type of graph to display. (p. 67)
[GRAPH▲]	Sets scaling of graph etc. (p. 94)
[CIRCUIT▲]	Performs equivalent circuit analysis. (p. 125)
[SCALE]	Performs auto scaling for vertical axis.
[SAVE]	Saves the measurement data or screen. This is displayed when a USB memory is connected.
[TRIG]	Starts measurement. This is displayed when the setting of trigger is **[SEQ]**, **[STEP]**.

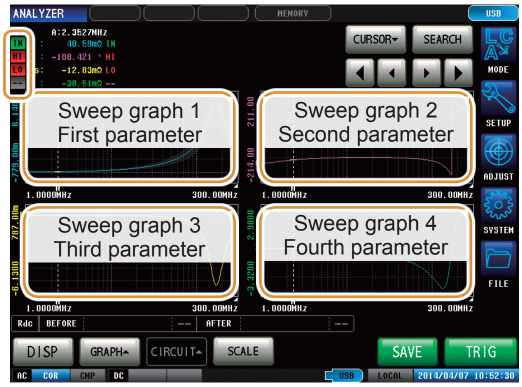
Types of graph

[DISP] on the measurement screen allows you to select the displayed graph.

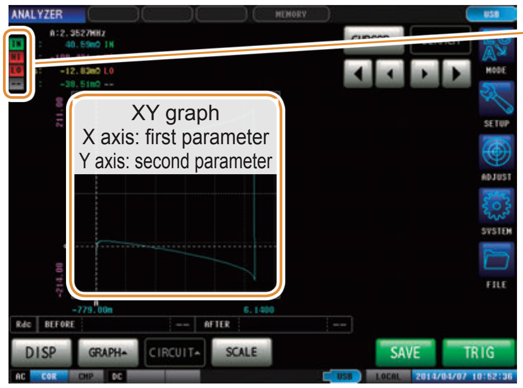
[1 GRAPH]



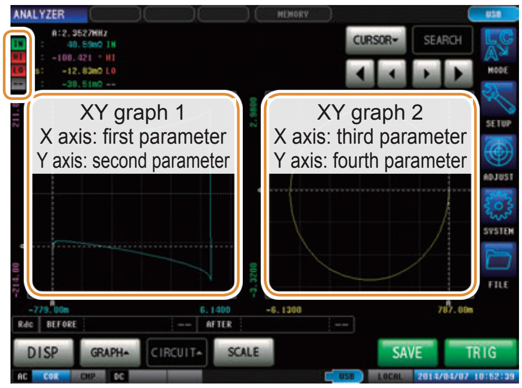
[4 GRAPHs]



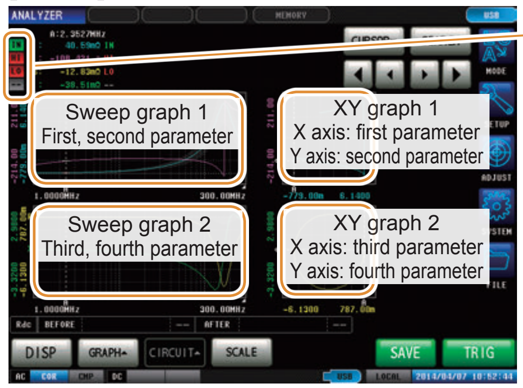
[1 X-Y]



[2 X-Ys]



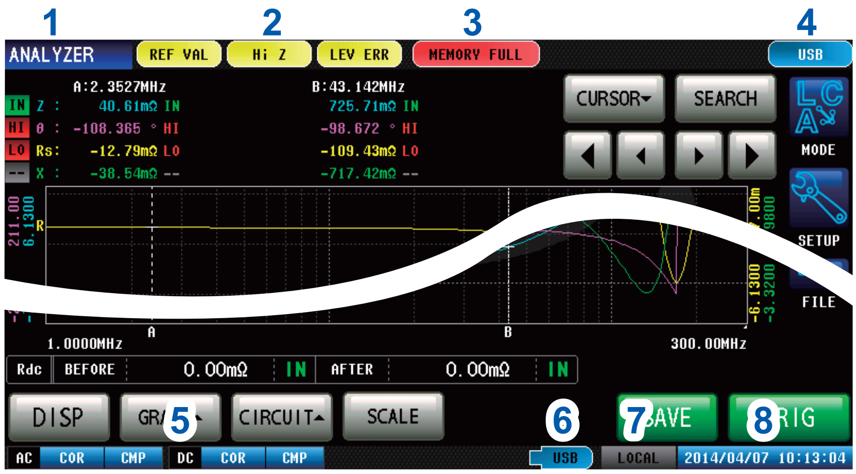
[MULTI]



[NUMERIC]

[PEAK] (p. 120)

Status and error display of this instrument



1 Displays the current measurement mode.

LCR	LCR function
ANALYZER	Analyzer function
CONTINUOUS	Continuous measurement function

2 Displays error messages.

REF VAL	Outside guaranteed accuracy
Hi Z	Hi Z reject error
LEV ERR	Error in detection level

3 Displays information saved in internal memory.

1000	Number of memories saved in internal memory.
MEMORY FULL	When the instrument memory becomes full

4 Displays the type of interface that is currently connected.

RS232C	RS-232C
GPIB	GP-IB
USB	USB
LAN	LAN

5 Displays the state of calibration/ compensation.

AC measurement		
Calibration	UNCAL	Calibration disabled
	COR	Calibration enabled
Compen-sation	CMP	Compensation disabled
	CMP	Compensation enabled
DC measurement		
Calibration	UNCAL	Calibration disabled
	COR	Calibration enabled
Compen-sation	CMP	Compensation disabled
	CMP	Compensation enabled

6 Displays the connection status of the USB memory.

USB	(Blue)	USB memory is connected
USB	(Red)	USB memory is being accessed

7 Displays the communication state.

REMOTE	During communication control
LOCAL	Local

8 Displays the date and time set for the instrument.

4.2 Setting Basic Settings of Measurement

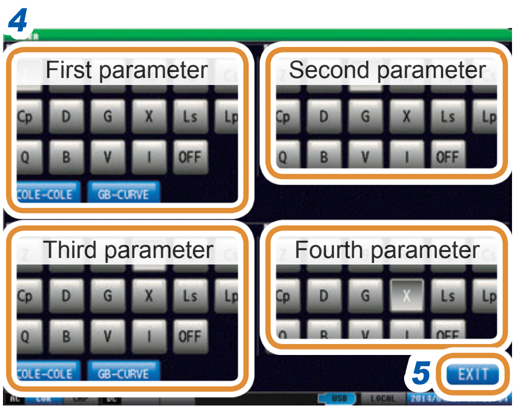
4.2.1 Setting the Measurement Parameters

Select measurement display parameters.
The ANALYZER mode allows four types of parameter measurements; first to fourth parameters.

1 **Press [SETUP].**

2 **Press [SWEEP] tab.**

3 **Press [PARA].**



4 **Press the parameter key that you want to set.**

[COLE-COLE]	Set **[PARA1]** to **[Rs]** (effective resistance in series equivalent circuit mode = ESR [Ω]) and **[PARA2]** to **[X]** (reactance [W]). Reverse the Y-axis. Set X-Y display auto-scaling to **[SAME]**. Also **[PARA3]**, **[PARA4]** can be set.
[GB-CURVE]	Set **[PARA1]** to **[G]** (conductance [S]) and **[PARA2]** to **[B]** (susceptance [S]). Set X-Y display auto-scaling to **[SAME]**. Also **[PARA3]**, **[PARA4]** can be set.

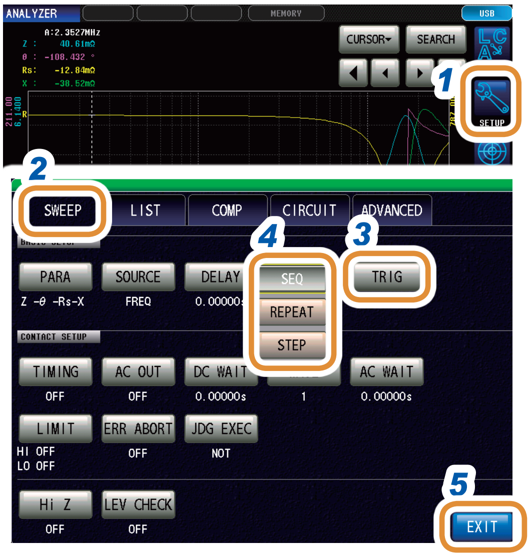
5 **Press [EXIT] to close the setting screen.**

4.2.2 Starting Measurement at Any Arbitrary Timing (Trigger)

Set the trigger. The following are the three types of trigger that can be set for the instrument.
Refer to Step 4 for details on each trigger.

- Sequential sweep
- Repeat sweep
- Step sweep

> The trigger setting that is set here differs from the trigger setting of LCR mode.
> (It does not impact the trigger setting of LCR mode.)



1 Press **[SETUP]**.

2 Press **[SWEEP]** tab.

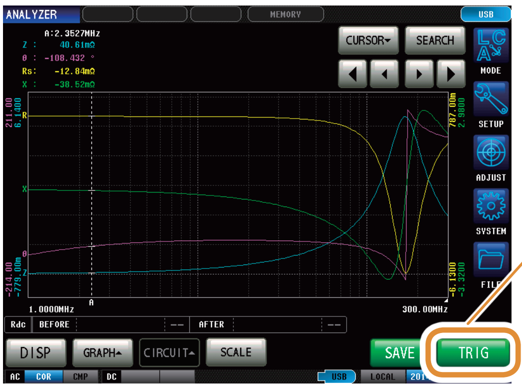
3 Press **[TRIG]**.

4 Select the trigger type.

[SEQ]	Performs a sequential sweep. When an external trigger is input, sweep measurement is performed only once.
[REPEAT]	Performs repeated sweeps. Performs repeated sweeps with an internal trigger.
[STEP]	Performs a step sweep. When an external trigger is input, measurement is performed at the current measurement point and then the process moves to the next measurement point.

5 Press **[EXIT]** to close the setting screen.

When trigger is set to [SEQ] or [STEP]

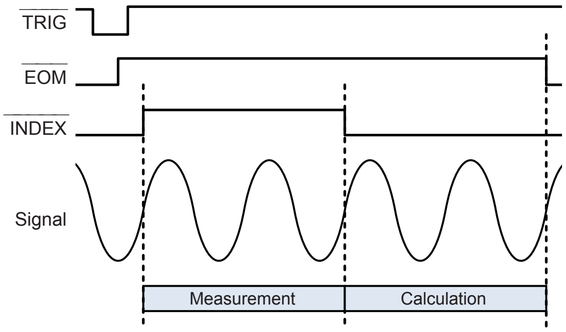


- **[TRIG]** is displayed on the measurement screen.
- Each time you press **[TRIG]**, a sequential sweep or step sweep is performed.

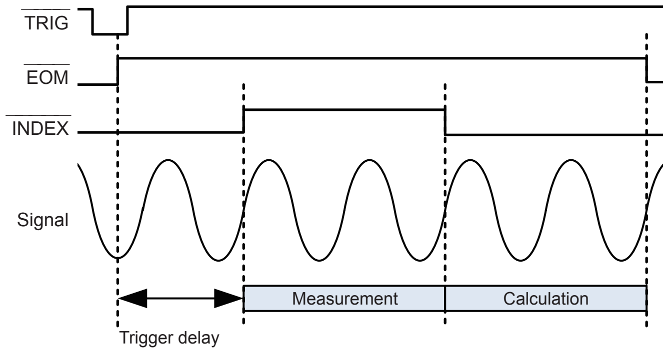
4.2.3 Setting the Delay Time from Trigger to Measurement Start (Trigger Delay)

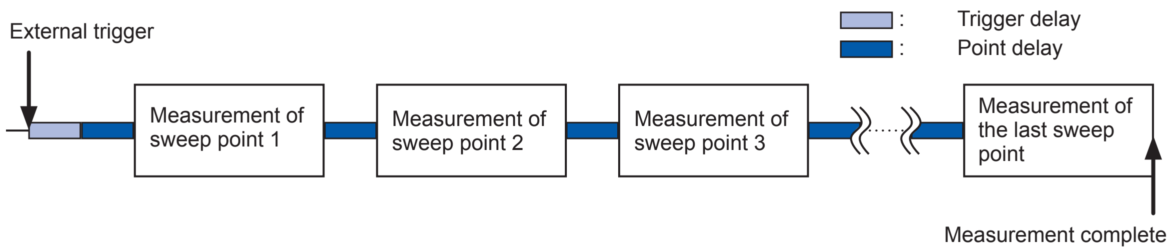
Set the delay time from when a trigger is input until measurement starts.

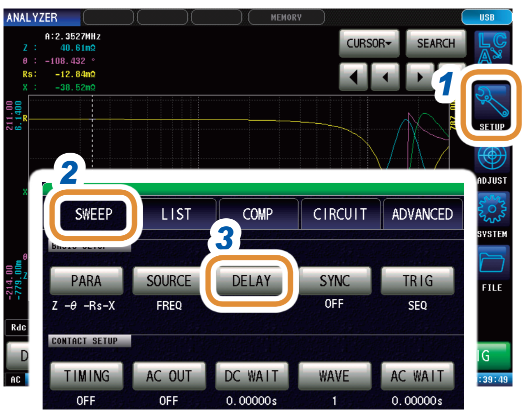
Trigger delay: OFF



Trigger delay: ON



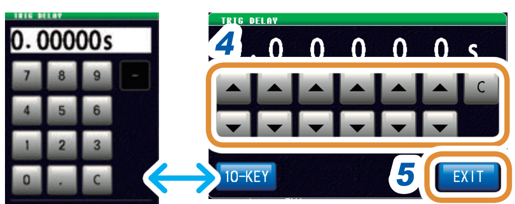




1 Press **[SETUP]**.

2 Press **[SWEEP]** tab.

3 Press **[DELAY]**.



The numeric keypad can be used for input.

4 **Set the delay time with ▲/▼, or with the numeric keypad.**
(With the numeric keypad, press **[SET]**.)

Settable range	0 s to 9.99999 s with resolution 10 ms
[C]	• Disables this function. • The set time is set to 0 s.

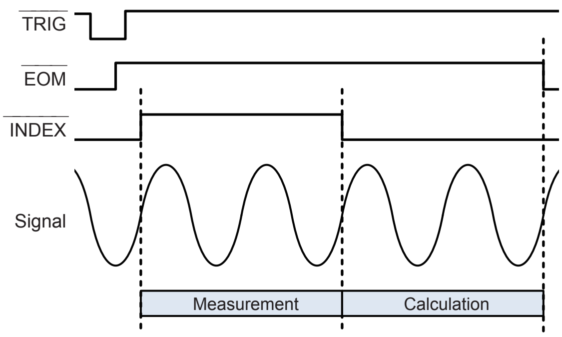
5 **Press [EXIT] to close the setting screen.**

When trigger delay is set, the LED for indicating that measurement is in progress is lit from the time a trigger is input until the measurement ends.

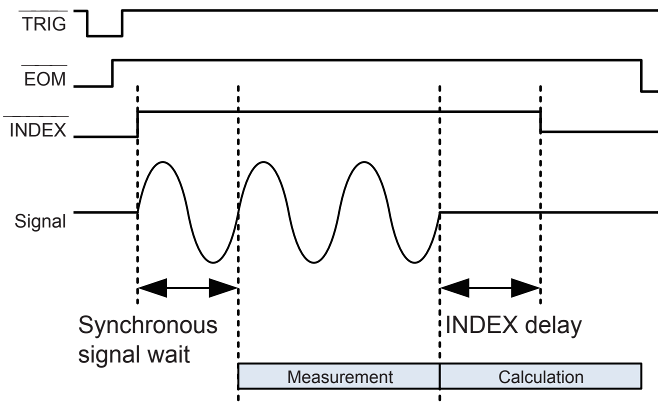
4.2.4 Applying the Signal to the Sample during Measurement Only (Trigger Synchronous Output)

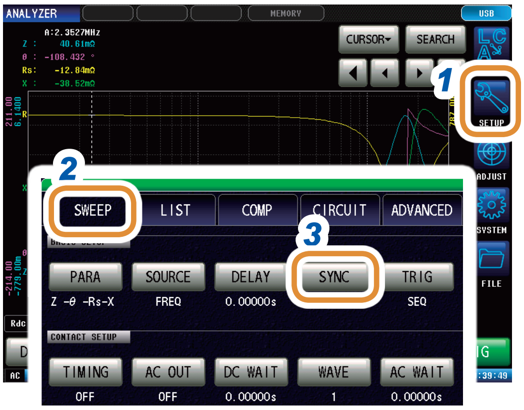
This function enables the measurement signal to be output for only the initial sweep point after measurement is triggered, so that the signal is applied to the sample during measurement only. You can also set a delay time to ensure that data is acquired after the sample stabilizes.
Thus reducing the generation of heat in the sample and decreasing electrode wear.

Trigger synchronous output: OFF

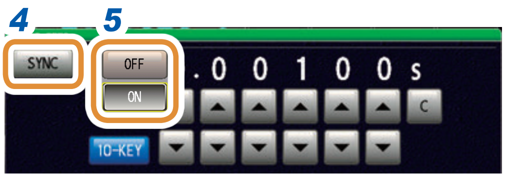


Trigger synchronous output: ON





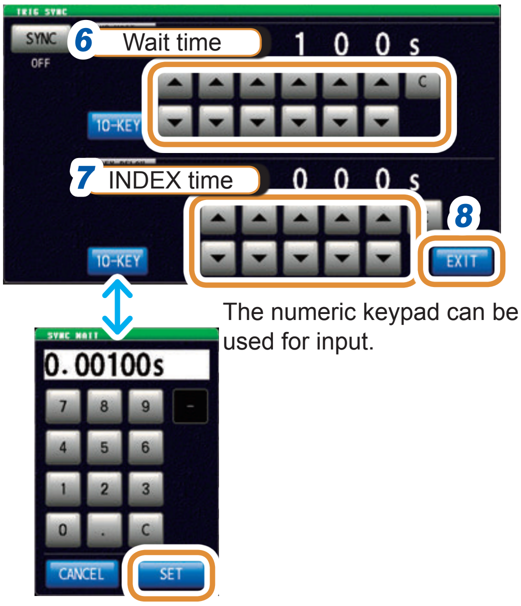
1. Press **[SETUP]**.
2. Press **[SWEEP]** tab.
3. Press **[SYNC]**.



4. Press **[SYNC]**.
5. **Select ON/OFF for the trigger synchronous output.**

[OFF]	Disables the trigger synchronous output.
[ON]	Enables the trigger synchronous output.

Go to the next page.



6 **Use ▲/▼ or the numeric keypad to set the wait time (time to stabilize) from the time a measurement signal has been output by applying a trigger to the start of next measurement.**
(With the numeric keypad, press **[SET]**.)

Settable range	0.00000 s to 9.99999 s

[C]	Sets to the default value. (The time is set to 0.001 s.)

7 **Set the INDEX delay time.**
(With the numeric keypad, press **[SET]**.)

Settable range	0.00000 s to 0.10000 s

8 **Press [EXIT] to close the trigger synchronous output setting screen.**

9 **Press [EXIT] to close the setting screen.**

- When the trigger synchronous output function is set to **[ON]**, the measurement time will increase due to the incorporation of a wait time between output of the measurement signal and data acquisition. See "12.3 Measurement Time" (p. 290).
- When the trigger synchronous output function is set to **[ON]**, the set level may be output momentarily if a measurement condition is changed.
- The measurement signal is output when the trigger signal is input and stops after measurement ends.
- In CONTINUOUS measurement mode, the initial pulse is set after measurement of the last panel ends.
  If the trigger synchronous function is set to **[ON]** for the initial panel, the measurement signal stops.

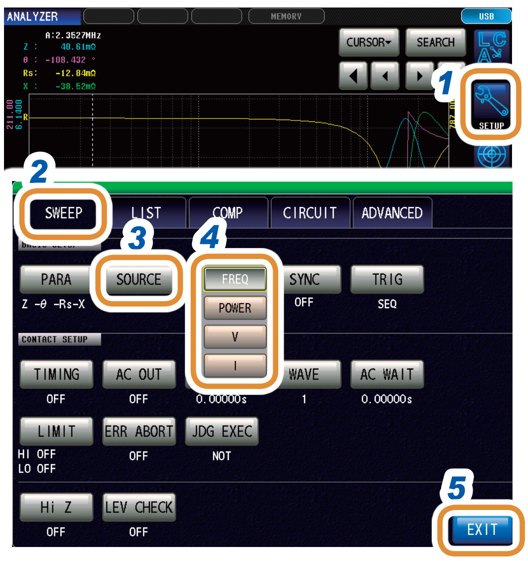
4.2.5 Setting the Sweep Parameter

Select sweep parameters. There are four types of parameters that can be set: frequency, measurement signal level (power [P], voltage [V], and current [A]).

⚠ CAUTION

Do not switch between P, V, and I while the test sample is still connected to the measurement terminals as this may damage the test sample.

- When the sweep parameter is changed, the comparator setting and sweep points are initialized. Compensation is disabled. Perform calibration again.
- When performing equivalent circuit analysis, set the sweep parameter to frequency sweep. (p. 124)



1 **Press [SETUP].**

2 **Press [SWEEP] tab.**

3 **Press [SOURCE].**

4 **Select the sweep parameter.**

[FREQ]	Performs frequency sweep.
[POWER]	Performs measurement signal level (power [P]) sweep.
[V]	Performs measurement signal level (voltage [V]) sweep.
[I]	Performs measurement signal level (current [A]) sweep.

5 **Press [EXIT] to close the setting screen.**

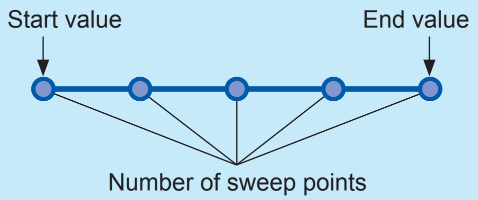
4.3 Sweep Measurement

Sets the sweep range and sweep points and performs sweep measurement.

Types of sweep range

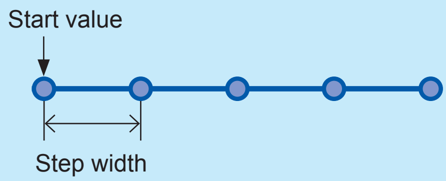
START-STOP

Sets the start value and end value of the sweep.
Each sweep point is automatically calculated from the number of sweep points.



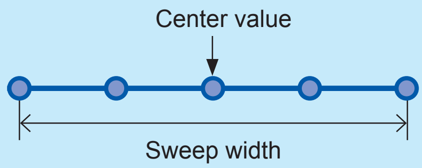
START-STEP

Sets the start value of the sweep and the step width of sweep points.
Each sweep point is automatically calculated from the number of sweep points.



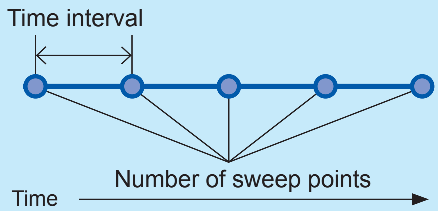
CENTER-SPAN

Sets the center value of the sweep range and the sweep width.
Each sweep point is automatically calculated from the number of sweep points.



INTVL MEAS

Fixes the sweep parameter and performs measurement at a set time interval.



4.3.1 Setting the Sweep Method

Select the sweep method.

Normal sweep **Normal interval sweep** **(p. 82)**	Sets the sweep range and number of sweep points and performs measurement. (It is also possible to fix the sweep parameter and perform “interval measurement”, measurement at a set time interval.)
Segment sweep **Segment interval sweep** **(p. 85)**	Divides the sweep range into ranges called “segments” and performs sweep measurement. (The sweep range, sweep points, and measurement conditions can be set for each segment. In addition, it is also possible to fix the sweep parameter and perform “interval measurement”, measurement at a set time interval.)

What is a segment?
A segment refers to one block for which individual settings such as the sweep range, number of sweep points, and measurement signal level can be set.

1 **Press [SETUP].**

2 **Press [LIST] tab.**

3 **Press [SEGMENT].**

4 **Select the method of sweep.**

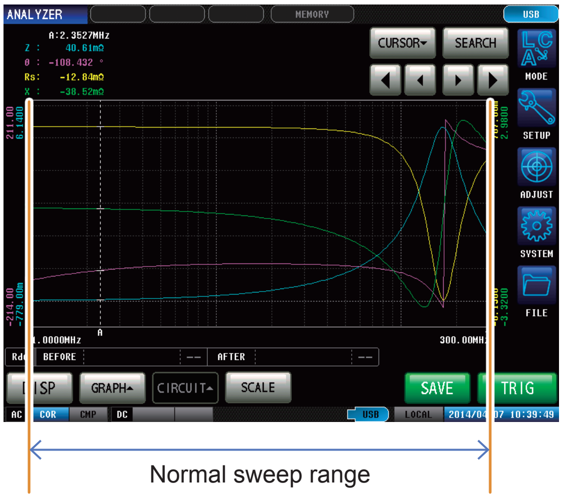
[OFF]	Normal sweep (normal interval sweep) (p. 82)
[SEG ON]	Segment sweep(p. 85)
[SEG INTVL]	Segment interval sweep (p. 85)

5 **Press [EXIT] to close the setting screen.**

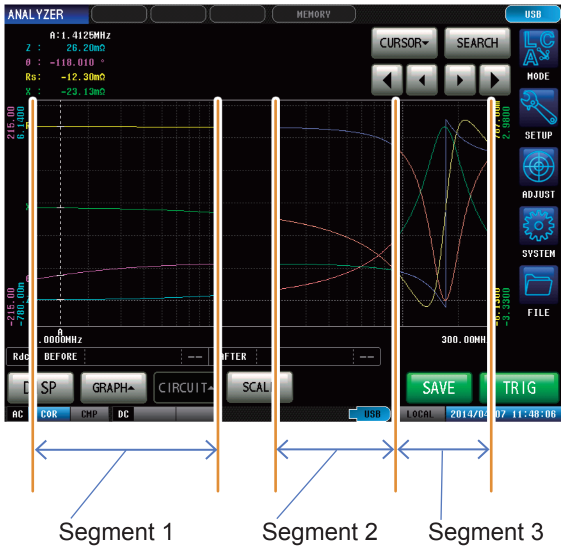
Setting example for normal sweep and segment sweep

Sweep setting items	Normal sweep	Segment sweep		
	Segment	Segment 1	Segment 2	Segment 3
Sweep parameter	Frequency	Frequency	Frequency	Frequency
Sweep range	1.0000 MHz to 300.00 MHz	1.0000 MHz to 5.0000 MHz	10.000 MHz to 50.000 MHz	50.000 MHz to 300.00 MHz
Number of sweep points	801 points	201 points	201 points	399 points
Setting method for sweep points	Log	Log	Log	Linear
Measurement signal type	POWER	POWER	POWER	POWER
Measurement signal level	0.0 dBm	0.0 dBm	1.0 dBm	-1.0 dBm
Average	5 times	10 times	3 times	OFF
Measurement speed	FAST	FAST	MEDIUM	SLOW
Point delay	0.0005 s	0.0005 s	0.0010 s	0.0000 s

Normal sweep



Segment sweep

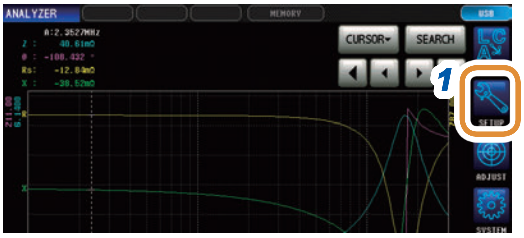


4.3.2 Setting the Sweep Range

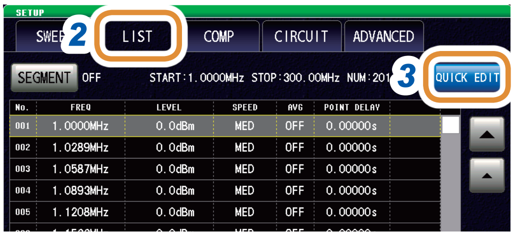
Set the sweep range.

- If the sweep parameter is V or I, **[CENTER-SPAN]** and **[START-STEP]** cannot be set.
- For segment sweep, only **[START-STOP]** and **[INTVL MEAS]** can be set.
- The sweep range settings differ depending on the sweep parameter (**[SOURCE]**) settings. (p. 79)
- Setting is possible from the setting and editing of sweep points.
  Reference: “4.3.3 Normal Sweep” (p. 82), “4.3.4 Segment Sweep, Segment Interval Sweep” (p. 85)

Example: For normal sweep, set [START-STOP] in frequency sweep (with [SOURCE] set to [FREQ]).



1 **Press [SETUP].**



2 **Press [LIST] tab.**

3 **Press [QUICK EDIT].**

* Each common numeric keypad

Changing the unit: **M** (mega)/**k** (kilo)

4 **Select [START-STOP].**

Refer to “Types of sweep range” (p. 75)

5
(1) **Press [START].**
(2) **Use the numeric keypad* to set the start value of sweep and press [Hz].**
(3) **Press [STOP].**
(4) **Use the numeric keypad* to set the end value of sweep and press [Hz].**

[C]	Repeats the input.
[CANCEL]	Cancels the setting.

6 **Press [NUM] to set the sweep points.**

7 **Press [LOG] to set log calculation for sweep points.**

8 **Press [SET] to confirm the setting.**

Sweep range list

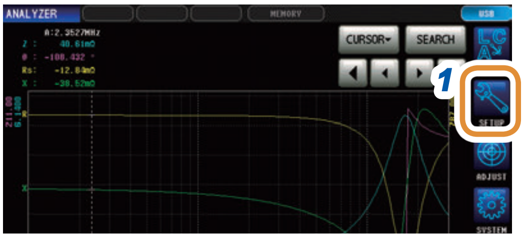
Setting of sweep parameters ([SOURCE])	Sweep range setting	Contents of setting	Settable range
Frequency [FREQ]	[START-STOP]	Start value of sweep [START]	1.0000 MHz to 300.00 MHz
		End value of sweep [STOP]	1.0000 MHz to 300.00 MHz
		Number of sweep points [NUM]	1 to 801
		[LINEAR]	The sweep points are calculated linearly from the setting values of [START], [STOP], and [NUM].
		[LOG]	The sweep points are calculated logarithmically from the setting values of [START], [STOP], and [NUM].
	[CENTER-SPAN]	Center value of sweep range [CENTER]	1.0000 MHz to 300.00 MHz * The setting range of [SPAN] varies according to the frequency to be set.
		Sweep width [SPAN]	0 MHz to 300.00 MHz * The setting range varies based on the value set in [CENTER].
		Number of sweep points [NUM]	1 to 801
	[START-STEP]	Start value of sweep [START]	1.0000 MHz to 300.00 MHz
		Step width of sweep point [STEP]	0 MHz to 300.00 MHz * The setting range varies based on the value set in [START], [NUM].
		Number of sweep points [NUM]	1 to 801
	[INTVL MEAS]	Start value of sweep [POINT]	1.0000 MHz to 300.00 MHz
		Measurement time interval [INTERVAL]	0.00000 s to 1000.00 s
		Number of measurements [NUM]	1 to 801

Setting of sweep parameters ([SOURCE])	Sweep range setting	Contents of setting	Settable range
Power [POWER]	[START-STOP]	Start value of sweep [START]	-40.0 dBm to 7.0 dBm
		End value of sweep [STOP]	-40.0 dBm to 7.0 dBm
		Number of sweep points [NUM]	1 to 801 * Setting method for sweep points is fixed to [LINEAR].
	[CENTER-SPAN]	Center value of sweep range [CENTER]	-40.0 dBm to 7.0 dBm
		Sweep width [SPAN]	0.0 dB to 7.0 dB * The setting range varies based on the value set in [CENTER].
		Number of sweep points [NUM]	1 to 801
	[START-STEP]	Start value of sweep [START]	-40.0 dBm to 7.0 dBm
		End value of sweep [STEP]	0.1 dB to 7.0 dB * The setting range varies based on the value set in [START], [NUM].
		Number of sweep points [NUM]	1 to 801
	[INTVL MEAS]	Start value of sweep [POINT]	-40.0 dBm to 7.0 dBm
		Measurement time interval [INTERVAL]	0.00000 s to 1000.00 s
		Number of measurements [NUM]	1 to 801

Setting of sweep parameters ([SOURCE])	Sweep range setting	Contents of setting	Settable range
Voltage [V]	[START-STOP]	Start value of sweep [START]	4 mV to 1001 mV
		End value of sweep [STOP]	4 mV to 1001 mV
		Number of sweep points [NUM]	1 to 801 * Setting method for sweep points is fixed to [LINEAR].
	[INTVL MEAS]	Start value of sweep [POINT]	4 mV to 1001 mV
		Measurement time interval [INTERVAL]	0.00000 s to 1000.00 s
		Number of measurements [NUM]	1 to 801 *The measurement interval for INTERVAL measurement is reflected in the point delay time.
Current [I]	[START-STOP]	Start value of sweep [START]	0.09 mA to 20.02 mA
		End value of sweep [STOP]	0.09 mA to 20.02 mA
		Number of sweep points [NUM]	1 to 801 * Setting method for sweep points is fixed to [LINEAR].
	[INTVL MEAS]	Start value of sweep [POINT]	0.09 mA to 20.02 mA
		Measurement time interval [INTERVAL]	0.00000 s to 1000.00 s
		Number of measurements [NUM]	1 to 801

4.3.3 Normal Sweep

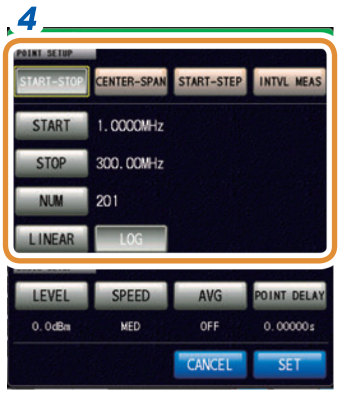
Batch setting for normal sweep



1 **Press [SETUP].**

2 **Press [LIST] tab.**

3 **Press [QUICK EDIT].**

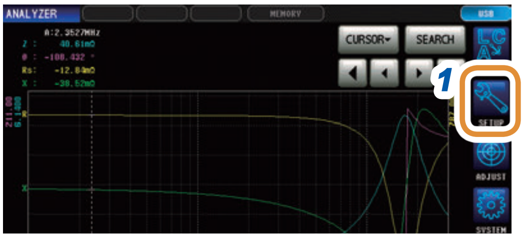


4 **Setting the sweep range.**
See “4.3.2 Setting the Sweep Range” (p. 78).

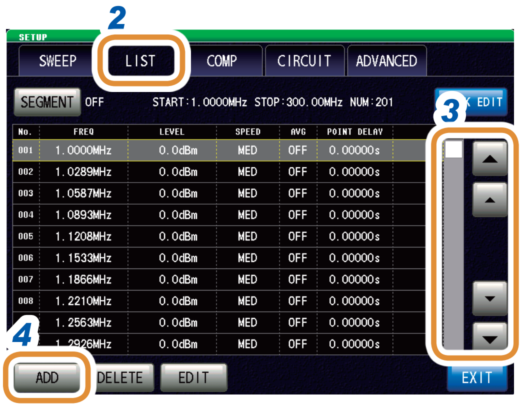
5 **Batch setting for measurement conditions.**
See “4.4 Set Measurement Conditions for Sweep Points” (p. 88).

6 **Press [SET] to confirm the setting.**

Adding sweep points



1 **Press [SETUP].**



2 **Press [LIST] tab.**

3 **Move the cursor to the point to be added in the list of sweep point with ▲/▼ or by scrolling.**
To add a sweep point on the next point in the selected row.

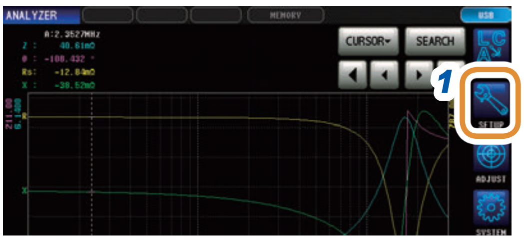
4 **Press [ADD].**

5 **Set the measurement conditions for the sweep points added.**
See “4.4 Set Measurement Conditions for Sweep Points” (p. 88).

- The setting range ([POINT]) of the sweep parameter is a value between the selected row and the next point of the selected row.
- [POINT] and [POINT DELAY] cannot be set for interval measurements.

6 **Press [SET] to confirm the setting.**

Deleting sweep points



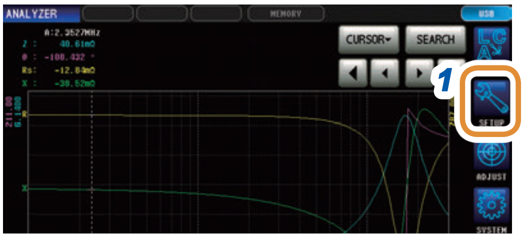
1 **Press [SETUP].**

2 Press **[LIST]** tab.

3 Move the cursor to the point to be deleted in the list of sweep point with ▲/▼ or by scrolling.

4 Press **[DELETE]**.

Editing sweep points



1 Press **[SETUP]**.

2 Press **[LIST]** tab.

3 Move the cursor to the point to be edited with ▲/▼ or by scrolling.

4 Press **[EDIT]**.

5 **Set the measurement conditions for the sweep points to be edited.**

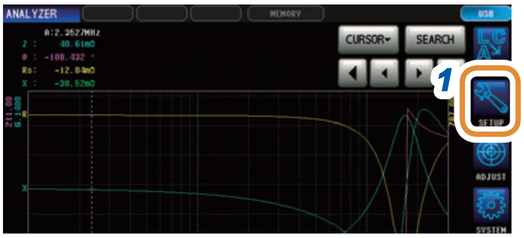
See “4.4 Set Measurement Conditions for Sweep Points” (p. 88).

- The setting range (**[POINT]**) of the sweep parameter is a value between the selected row and the next point of the selected row.
- **[POINT]** and **[POINT DELAY]** cannot be set for interval measurements.

6 Press **[SET]** to confirm the setting.

4.3.4 Segment Sweep, Segment Interval Sweep

Adding segments



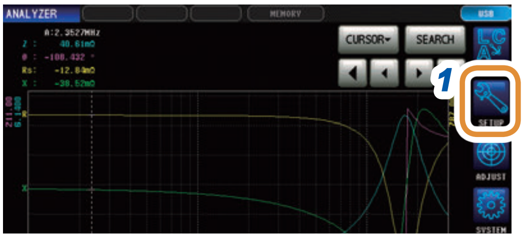
1 **Press [SETUP].**

2 **Press [LIST] tab.**

3 **Move the cursor to the point to be added with ▲/▼ or by scrolling.**
Add a segment on the next point in the selected row.

4 **Press [ADD].**
A segment is added with the default value.

Deleting segments



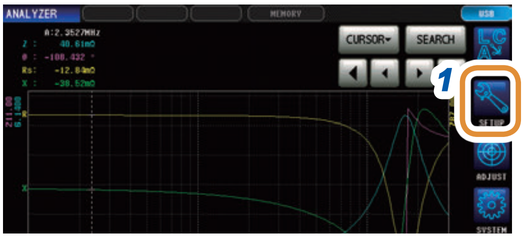
1 **Press [SETUP].**

2 **Press [LIST] tab.**

3 **Move the cursor to the point to be deleted with ▲/▼ or by scrolling.**

4 **Press [DELETE].**

Editing segments

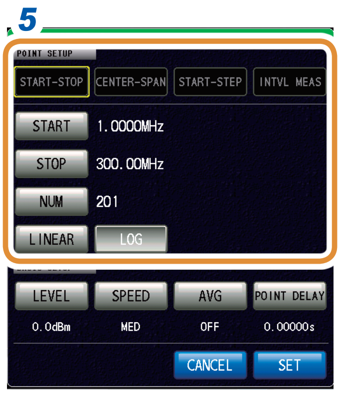


1 **Press [SETUP].**

2 **Press [LIST] tab.**

3 **Move the cursor to the point to be edited with ▲/▼ or by scrolling.**

4 **Press [EDIT].**

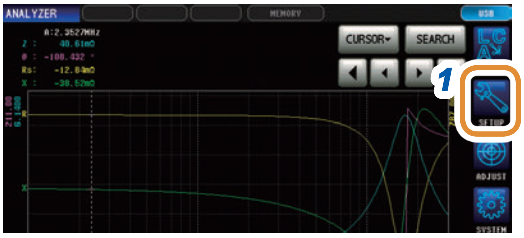


5 **Setting the sweep range.**
See "4.3.2 Setting the Sweep Range" (p. 78).
The setting of sweep range is fixed to **[START-STOP]** in segment sweep, and **[INTVL MEAS]** in segment interval sweep.

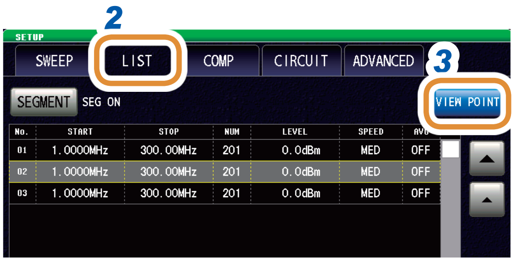
6 **Batch setting for measurement conditions.**
"4.4 Set Measurement Conditions for Sweep Points" (p. 88)

7 **Press [SET] to confirm the setting.**

Checking the set sweep points

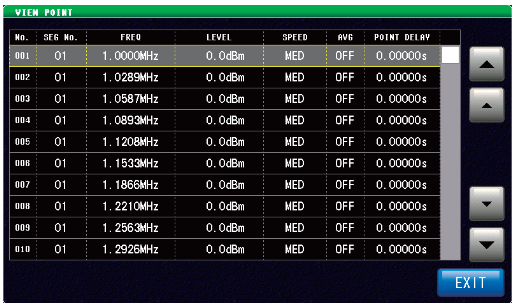


1 **Press [SETUP].**



2 **Press [LIST] tab.**

3 **Press [VIEW POINT].**



The set sweep points can be checked.

4

Analyzer Function

4.4 Set Measurement Conditions for Sweep Points

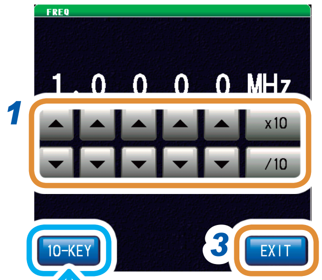
Sets the measurement conditions for sweep points.

> Setting is possible from the setting and editing of sweep points.
> Reference: “4.3.3 Normal Sweep” (p. 82), “4.3.4 Segment Sweep, Segment Interval Sweep” (p. 85)

4.4.1 Setting Measurement Signal Frequency

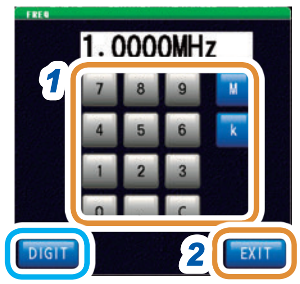
Sets the measurement signal frequency.

▲/▼ When setting with (each digit)



Input method can be switched between **[DIGIT]** and **[10-KEY]**.

To set the frequency with the numeric keypad



Changing the unit: **M** (mega)/**k** (kilo)

1 **Set the frequency with ▲/▼ or with the numeric keypad.**

Settable range	1 MHz to 300 MHz

▲/▼ When setting with (each digit)
Holding down a digit key changes the value continuously.

Settable range	1 MHz to 300 MHz

[×10]	Sets the measurement frequency to 10×.
[/10]	Sets the measurement frequency to 1/10×.

To set the frequency with the numeric keypad

[C]	Repeats the input.

- Instrument key is enabled if a numerical value is input.
- Frequency is set on pressing the instrument key.
- If the value is set to more than 300 MHz:
  The value is automatically set to 300 MHz.
- If the value is set to less than 1 MHz:
  The value is automatically set to 1 MHz.

2 **Press [EXIT] to close the measurement frequency setting screen.**

3 **Press [EXIT] to close the advanced settings screen.**

4.4.2 Setting the Measurement Signal Level

The value of the test signal level may change based on the sample tested.

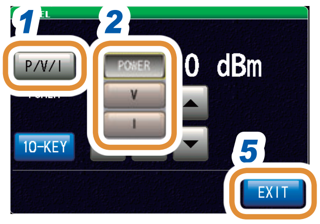
⚠CAUTION

Do not switch between P, V, and I while the test sample is still connected to the measurement terminals as this may damage the test sample.

The following are the three types of measurement signal levels that can be applied to the object under test with this instrument.

Power (P) mode	Sets with the power (dBm) at the DUT port 50 Ω terminal.
Voltage (V) mode	Sets with the voltage (V) when the DUT port is open. (value of dBm converted into V)
Current (I) mode	Sets with current (A) when the DUT port is in a short circuit state. (value of dBm converted into I)

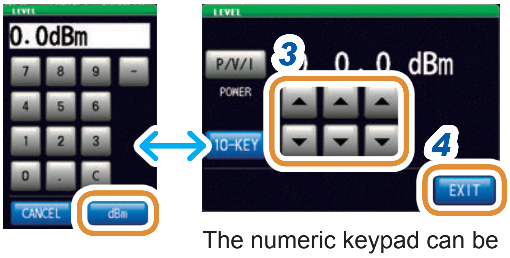
- The setting resolution of the signal level is always 0.1 dB regardless of setting signal mode.
  When the level is set in the voltage or current mode, input values are automatically converted to the setting with a resolution of 0.1 dB.
- The measurement accuracy varies according to the measurement signal level.
  See “Measurement range” (p. 274).
- For details on calculation, refer to “Conversion” (p. 39).
- The measurement signal mode is common for all points.
- When the sweep parameter is POWER/V/I, the measurement signal mode cannot be changed.



1 **Press [P/V/I].**

2 **Select the signal setting mode.**

[POWER]	Sets with power (dBm).
[V]	Sets with voltage (V).
[I]	Sets with current (A).



The numeric keypad can be used for input.

3 **Set the voltage or current with ▲/▼ or the numeric pad.**
(With the numeric pad, press **[dBm]**.)

Measurement signal mode	Settable range
Power (P) mode	-40.0 dBm to +7 dBm (resolution, 0.1 dBm)
Voltage (V) mode	4 mV to 1001 mV
Current (I) mode	0.09 mA to 20.02 mA

[C]	Repeats the input.

4 **Press [EXIT] to close the measurement signal level setting screen.**

5 **Press [EXIT] to close the advanced settings screen.**

When a measured value is outside the guaranteed accuracy range, **REF VAL** is displayed in the error display area.
In this case, the measurement signal level is considered to be low. Check the guaranteed accuracy range and change the measurement conditions or consider the measured values as values for reference.
See “Measurement range” (p. 274).

4.4.3 Setting the Measurement Speed

Change the measurement time.
When the measurement speed is set to **[SLOW]** or **[SLOW2]**, the measurement accuracy improves.

- Perform calibration or compensation again if there is a change in the measurement speed.
  See “5 Calibration and Compensation” (p. 139).
- Measurement time varies with the measurement conditions.
  See “12.3 Measurement Time” (p. 290).

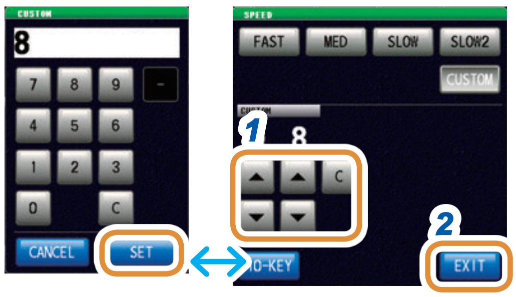
1 **Select the measurement speed.**

[FAST]	Performs high-speed measurement.
[MED]	Performs normal-speed measurement.
[SLOW]	Increases measurement accuracy.
[SLOW2]	Measurement accuracy is better than SLOW.
[CUSTOM]	Advanced settings for the measurement speed is enabled. Setting range: 8 to 87

2 **Press [EXIT] to close the measurement speed setting screen.**

3 **Press [EXIT] to close the advanced settings screen.**

If [CUSTOM] has been selected in step 1



The numeric keypad can be used for input.

1 **Set measurement speed with ▲/▼, or with the numeric keypad.**
(With the numeric keypad, press **[SET]**.)

[C]	Repeats the input.

2 **Press [EXIT].**

4.4.4 Displaying Average Values (Average)

The measured values can be averaged using the averaging function. The variations in the displayed measured values can be reduced with this function.

- The measured values are averaged by arithmetic averaging during analyzer measurement irrespective of the trigger setting. (p. 41)
- When averaging is enabled, the maximum, minimum, and peak values (local maximum and local minimum values) during search function operation use the averaged values.

1 **Use ▲/▼ to enter the averaging number of times.**

Settable range	1 to 256 times
[C]	Setting is turned OFF.

2 **Press [EXIT] to close the average setting screen.**

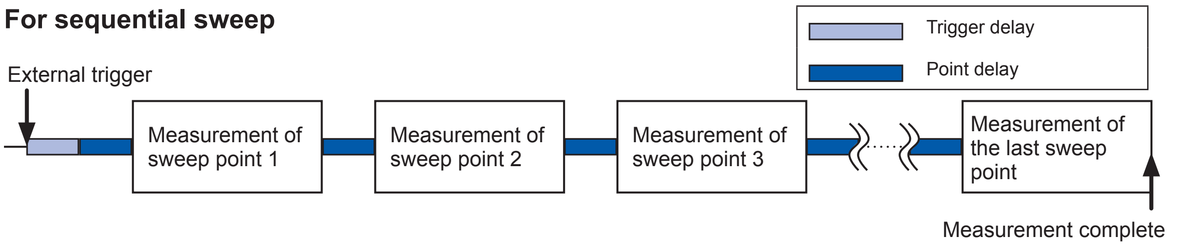
3 **Press [EXIT] to close the advanced settings screen.**

4.4.5 Setting the Delay Time for Each Sweep Point (Point Delay)

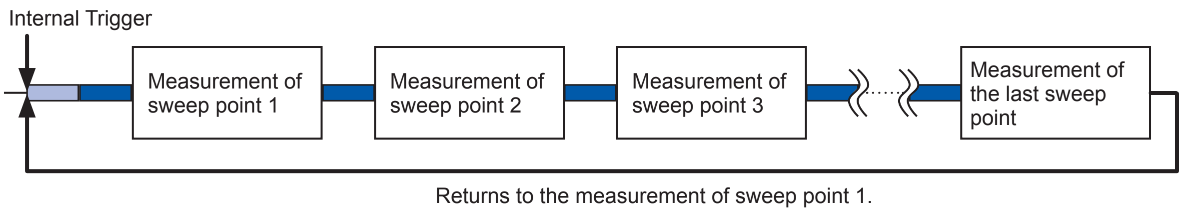
Set the delay time for each sweep point in the point delay setting.

> In sweep measurement, some measurement samples may require time for the measured value to stabilize due to transient response. For such cases, set a point delay time.
> See “3.2.3 Setting the Delay Time from Trigger to Measurement Start (Trigger Delay)” (p. 34).

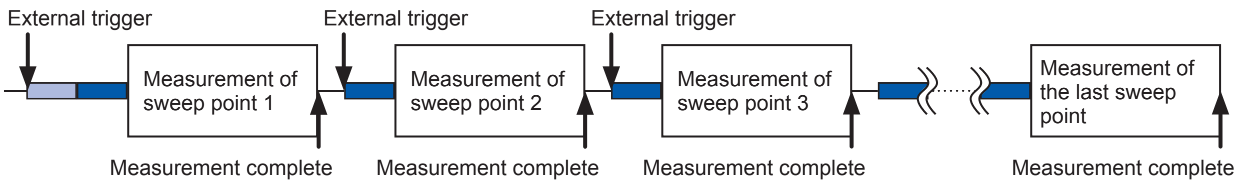
For sequential sweep

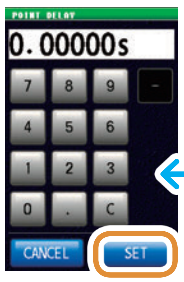


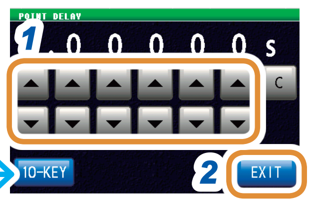
For repeat sweep



For step sweep







The numeric keypad can be used for input.

1 **Use ▲/▼ to enter the delay time.**
(With the numeric keypad, press **[SET]**.)

Settable range	0.00000 s to 9.99999 s

[C]	Sets to the default value. (0.00000 s)

2 **Press [EXIT] to close the setting screen.**

3 **Press [EXIT] to close the advanced settings screen.**

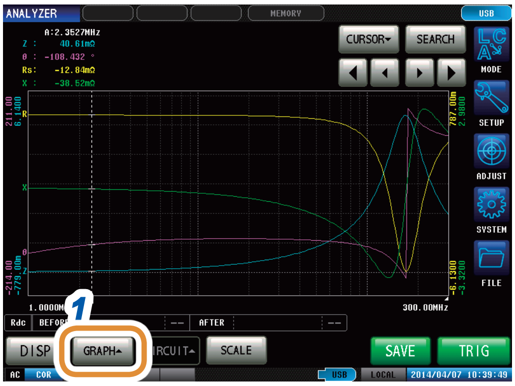
4

Analyzer Function

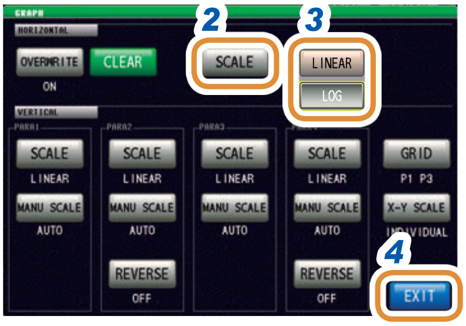
4.5 Setting the Graph Display Method

4.5.1 Setting the Horizontal Axis

Horizontal axis scale setting



1 **Press [GRAPH▲].**



2 **Press [SCALE].**

3 **Select the drawing type.**

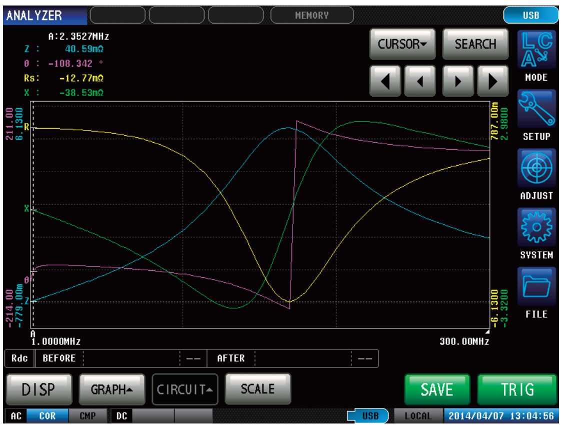
[LINEAR]	Sets the horizontal axis to linear (linear axis).
[LOG]	Sets the horizontal axis to log (logarithmic axis).

4 **Press [EXIT] to close the setting screen.**

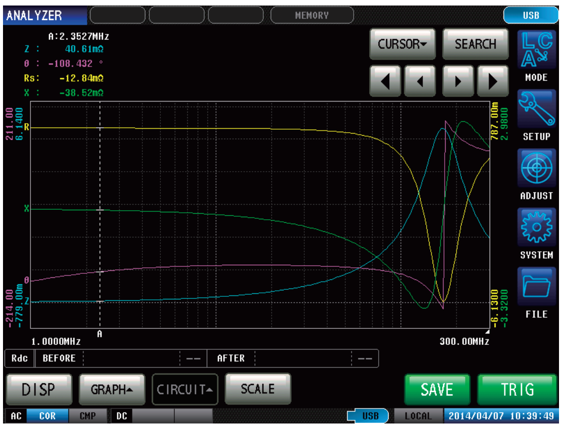
How to check the set horizontal axis scale?

If the horizontal axis display scale is changed, the horizontal axis scale of the graph display screen changes as shown in the figures below.

When the horizontal axis scale is set to linear ([LINEAR])



When the horizontal axis scale is set to log ([LOG])

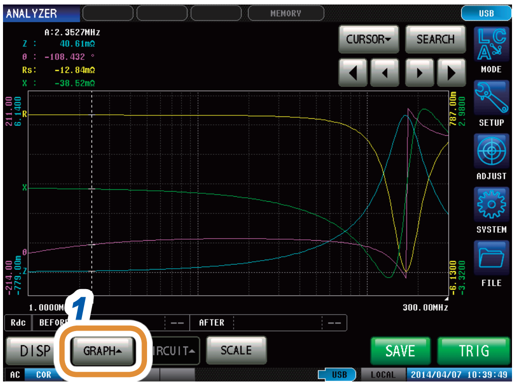


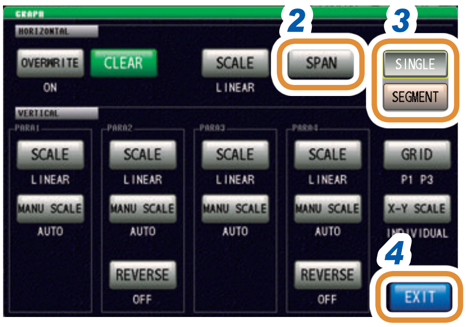
Span setting

You can select single span mode and segment span mode.

> Span can only be set for segment sweep.
> Set segment to **[SEG ON]** or **[SEG INTVL]** beforehand in "4.3.1 Setting the Sweep Method" (p. 76).

Single span mode ▶	Draws the measurement result of each segment on the same horizontal axis.
Segment span mode ▶	Draws a graph for each segment.





1 **Press [GRAPH▲].**

2 **Press [SPAN].**

3 **Select the span mode.**

[SINGLE]	Sets single span mode.
[SEGMENT]	Sets segment span mode.

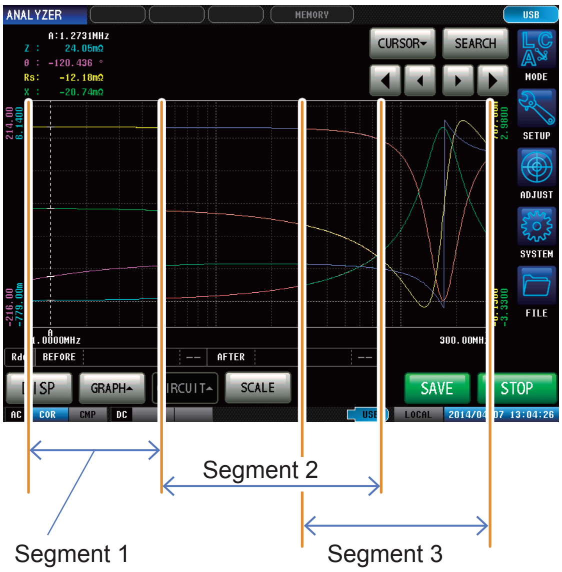
4 **Press [EXIT] to close the setting screen.**

Comparison example between single span mode and segment span mode

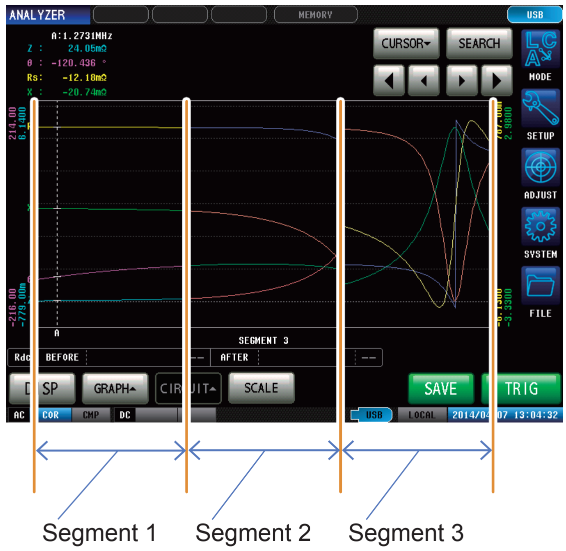
Setting example:

Sweep settings	Segment 1	Segment 2	Segment 3
Sweep parameter	Frequency	Frequency	Frequency
Sweep range	1.0000 MHz to 5.0000 MHz	5.0000 MHz to 80.000 MHz	30.000 MHz to 300.00 MHz

Single span mode



Segment span mode

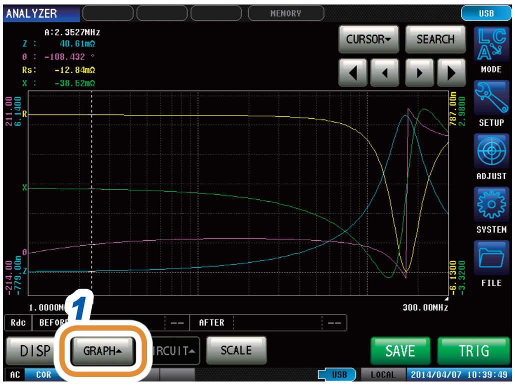


4.5.2 Setting the Vertical Axis

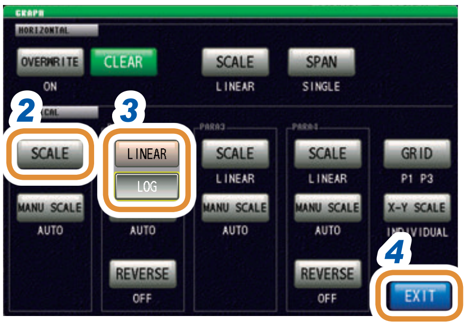
Setting the vertical axis scale

Set the drawing method for the vertical axis scale to linear (linear axis) or log (logarithmic axis).

- When measurement starts, the display range of the scale is set to the range from the maximum value to the minimum value or the scaling that was set when measurement ended the previous time. To set the optimal scaling in accordance with the measured results, press **[SCALE]** in the measurement screen.
- When set to log (logarithmic axis), negative measured values will not be drawn on the graph.



1 **Press [GRAPH▲].**



2 **Press [SCALE].**

3 **Select the drawing type.**

[LINEAR]	Sets the horizontal axis to linear (linear axis).
[LOG]	Sets the horizontal axis to log (logarithmic axis).

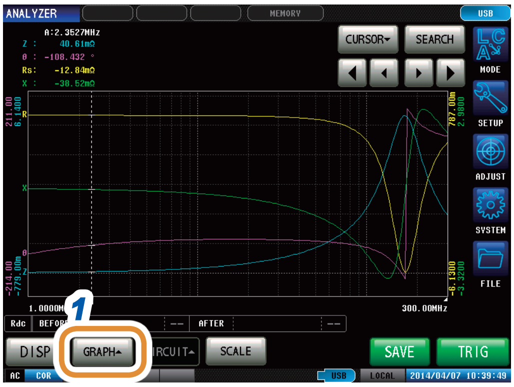
Other parameters can be set in the same way.

4 **Press [EXIT] to close the setting screen.**

Manual scaling setting

Set the upper and lower limit values for the vertical axis.

When measurement starts, the display range of the scale is set to the range from the maximum value to the minimum value or the scaling that was set when measurement ended the previous time.
To set the optimal scaling in accordance with the measurement results, press **[SCALE]** in the measurement screen.



1 **Press [GRAPH▲].**

2 **Press [MAN SCALE].**

3 **Select the drawing mode.**

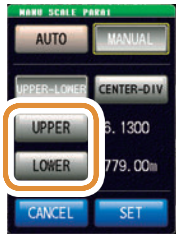
[MANUAL]	Sets the upper and lower limit values manually. (p. 99)
[AUTO]	Sets the upper and lower limit values automatically from the measured values. (p. 99)

Other parameters can be set in the same way.

4 **Press [SET] to close the setting screen.**

When [MANUAL] is selected

- **[UPPER-LOWER]**: Sets the upper and lower limit values.



Use the numeric keypad to input numerical values and press **[SET]**.

Contents of setting	Setting range
[UPPER] (Upper limit value)	-9.9999 G to 9.9999 G (**[LINEAR]**) 100.00 a to 9.9999 G (**[LOG]**)
[LOWER] (Lower limit value)	-9.9999 G to 9.9999 G (**[LINEAR]**) 100.00 a to 9.9999 G (**[LOG]**)

[C]	Repeats the input.

- **[CENTER-DIV]: Sets the center value and width of the vertical axis.**
  (Disabled when **[LOG]** is selected in **[SCALE]** setting.)

Use the numeric keypad to input numerical values and press **[SET]**.

Contents of setting	Setting range
[CENTER] (Center value of vertical axis)	-9.9999 G to 9.9999 G
[DIV] (Width of vertical axis)	-9.9999 G to 9.9999 G * The setting range varies based on the value set in **[CENTER]**.

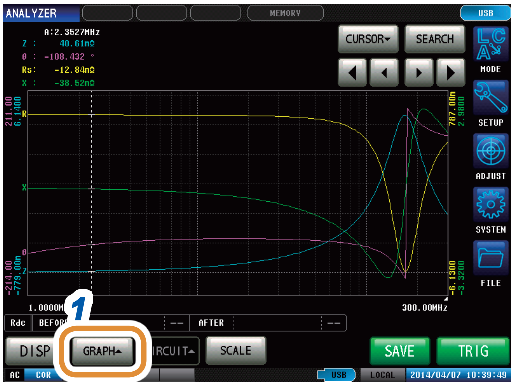
When [AUTO] is selected

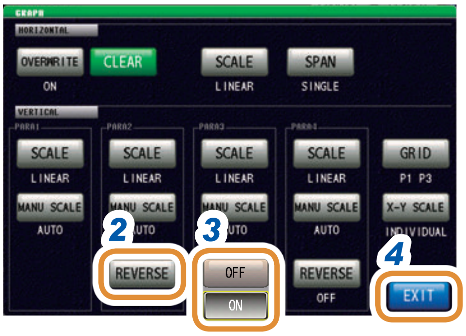
When **[SCALE]** is pressed on the measurement screen, the upper and lower limit values are automatically calculated and displayed so that that the measurement results of parameters set in **[AUTO]** are optimal.

When the trigger setting is [REPEAT], performs auto scaling after one sweep.

4.5.3 Configuring the X-Y Display Vertical Axis Reversal Setting

This section describes how to use the X-Y display vertical axis reversal setting.
[ON] setting is recommended to display a Cole-Cole plot.





1 **Press [GRAPH▲].**

2 **Press [REVERSE].**

3 **Select if X-Y display vertical axis reversal has to be performed.**
(This setting is available for the second and fourth parameters.)

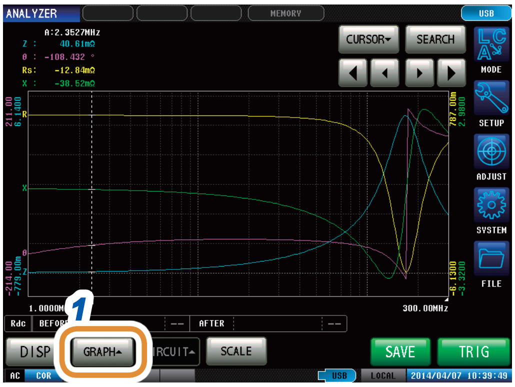
[OFF]	Vertical axis of X-Y display is not reversed.
[ON]	Vertical axis of X-Y display is reversed.

4 **Press [EXIT] to close the setting screen.**

4.5.4 Setting the X-Y Display Scale Width

This section describes how to set the scaling method when performing auto-scaling by pressing **[SCALE]** on the X-Y display.
When rendering a Cole-Cole plot or admittance circle, set the upper and lower limit values while maintaining the same X- and Y-axis grid sizes.

- This setting is valid only if both of the X- and Y-axis upper and lower limit value settings are set to **[AUTO]**.
- If the setting for either axis is **[MANUAL]**, **[INDIVIDUAL]** (normal auto-scaling) will be performed.



1 **Press [GRAPH▲].**

2 **Press [XY SCALE].**

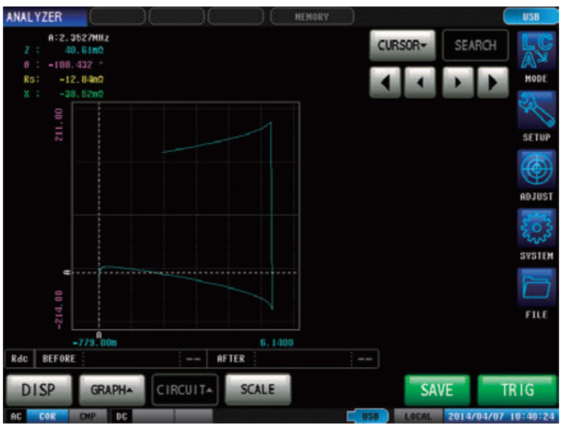
3 **Select the scaling method.**

[INDIVIDUAL]	Sets the X- and Y-axis upper and lower limit values to individual appropriate values when auto-scaling is performed.
[SAME]	When auto-scaling is performed, sets the X- and Y-axis upper and lower limit values to appropriate values while maintaining the same grid sizes.

4 **Press [EXIT] to close the setting screen.**

Examples of screen:

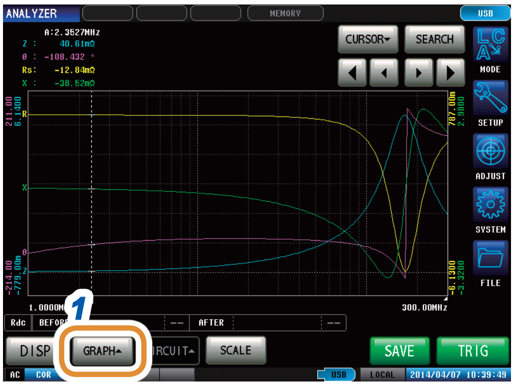
When the value is set to **[INDIVIDUAL]**



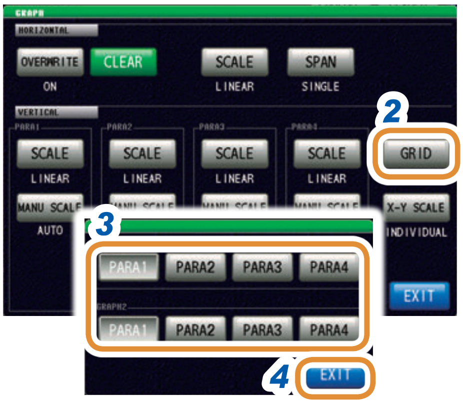
When the value is set to **[SAME]**

4.5.5 Setting Grid Display

Sets the sweep parameter which displays the grid lines.



1 **Press [GRAPH▲].**



2 **Press [GRID].**

3 **Select the sweep parameter for which grid lines is to be displayed.**

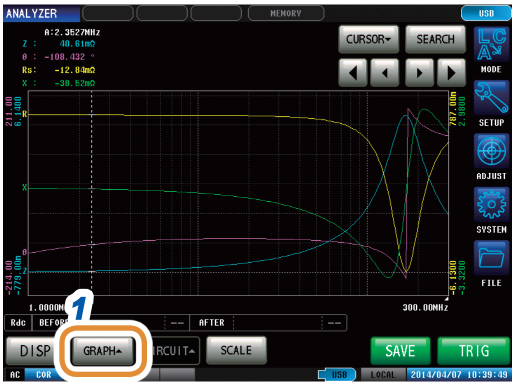
[PARA1]	Displays grid lines for sweep parameter 1.
[PARA2]	Displays grid lines for sweep parameter 2.
[PARA3]	Displays grid lines for sweep parameter 3.
[PARA4]	Displays grid lines for sweep parameter 4.

Selects the sweep parameter to display grid line on the second normal sweep graph if the graph display setting is **[MULTI]** in the grid setting of “GRAPH2”.

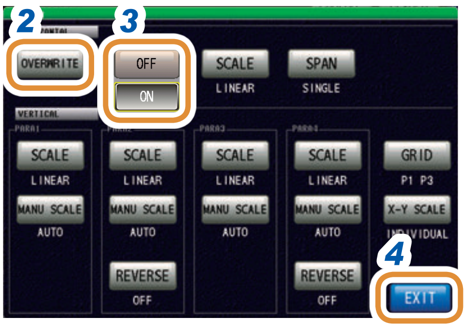
4 **Press [EXIT] to close the setting screen.**

4.5.6 Setting Overwrite

When sweep measurement is to be performed repeatedly, set the graph drawing method.
If you set overwrite, you can check the variations of the element in the graph.



1 **Press [GRAPH▲].**



2 **Press [OVERWRITE].**

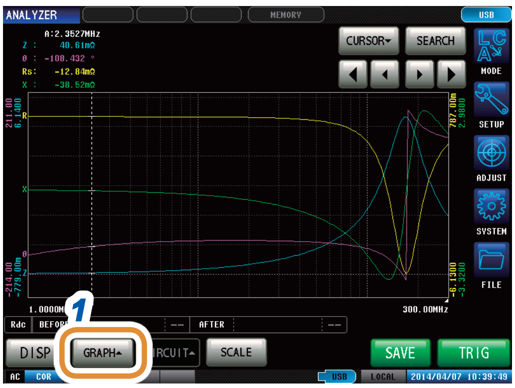
3 **Select the overwrite setting.**

[OFF]	When sweep measurement is performed repeatedly, the graph drawn for the last measurement is deleted and a graph of the most recent measurement results will be drawn.
[ON]	When sweep measurement is performed repeatedly, the graph drawn for the last measurement is retained and will be overlaid with a graph of the most recent measurement results.

4 **Press [EXIT] to close the setting screen.**

Deleting an overlaid graph

Delete an overlaid graph.



1 **Press [GRAPH▲].**

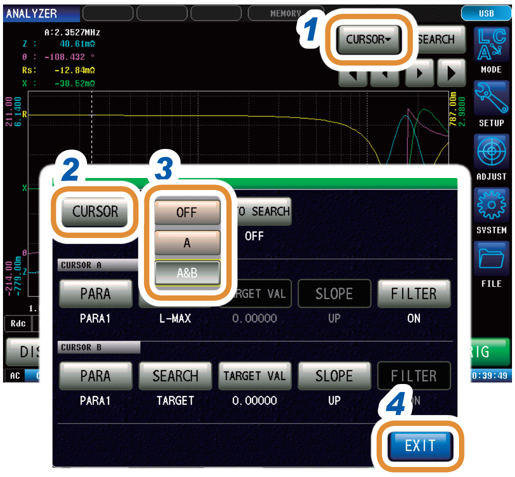
2 **Press [CLEAR].**
An overlaid graph is deleted, and the latest measurement result is retained.

> If operations such as execution of auto scale, moving the cursor and changing the settings are performed, the overwritten graph will be erased.

4.6 Setting the Cursor

You can display a cursor in the measurement screen to check the measured value of a measurement point.
The search function can be used to simplify the task of finding measured value maximum, minimum, and peak values (local maximum and local minimum values).

4.6.1 Selecting the Cursor to Display in the Screen



1 **Press [CURSOR▼].**

2 **Press [CURSOR].**

3 **Select the cursor to display in the screen.**

[OFF]	Cursor is not displayed.
[A]	Displays only cursor A.
[A&B]	Displays cursors A and B.

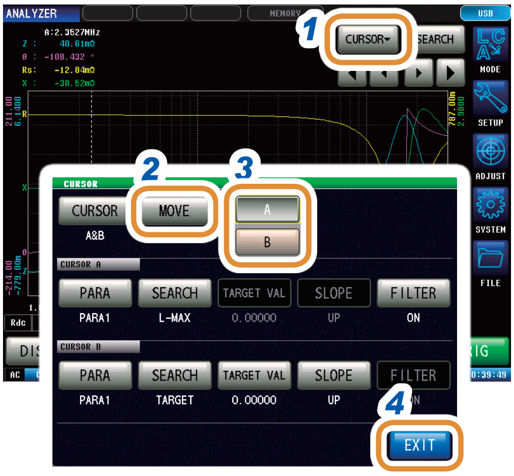
4 **Press [EXIT] to close the setting screen.**

4
Analyzer Function

4.6.2 Setting Cursor Move

Select movable cursors when the measurement screen is displayed.
Moving cursors allows you to check the measured value of the cursor position.

This can only be set when **[A&B]** is selected for the display cursor setting.



1 **Press [CURSOR▼].**

2 **Press [MOVE].**

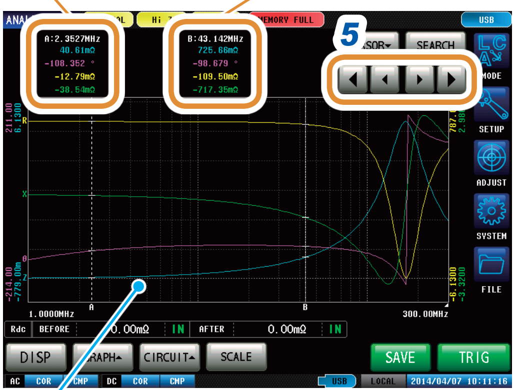
3 **Select the cursor to move in the screen.**

[A]	Moves cursor A.
[B]	Moves cursor B.

4 **Press [EXIT].**

Measured value of cursor A

Measured value of cursor B



The cursor can be moved to any arbitrary position on the screen by touching the graphical display screen.

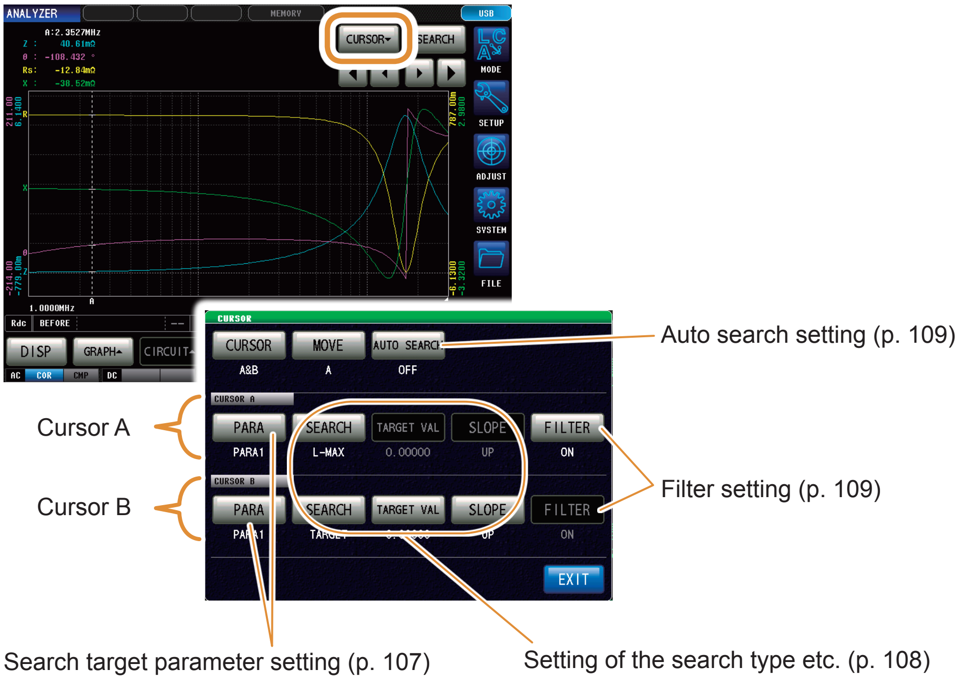
5 **Move the cursor.**

Press and hold the key to continuously move the cursor.

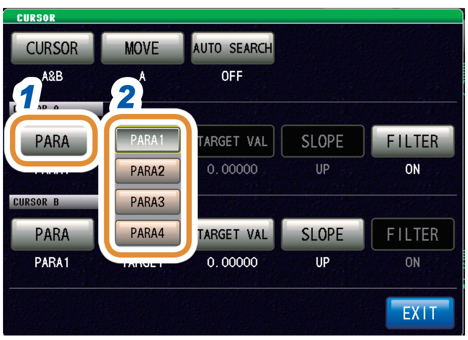
[◀] (large)	Moves the cursor to the left by ten points.
[◀]	Moves the cursor to the left by one point.
[▶]	Moves the cursor to the right by one point.
[▶] (large)	Moves the cursor to the right by ten points.

4.7 Performing Measured Value Search

When you perform a search, the cursor moves to the search result point and you can check the search result.
You can perform search for the measurement results of one sweep using the method set in “4.7.2 Setting the Search Type” (p. 108).
The search target parameter is the parameter set in “4.7.1 Setting the Search Target Parameter” (p. 107).



4.7.1 Setting the Search Target Parameter

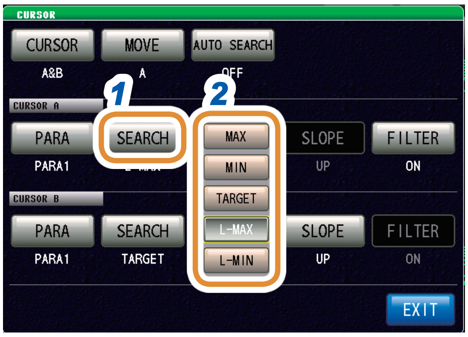


1 **Press [PARA] of the target cursor.**

2 **Set the search target parameter.**

[PARA1]	Sets the measurement result of parameter 1 as the search target.
[PARA2]	Sets the measurement result of parameter 2 as the search target.
[PARA3]	Sets the measurement result of parameter 3 as the search target.
[PARA4]	Sets the measurement result of parameter 4 as the search target.

4.7.2 Setting the Search Type



1 **Press [SEARCH] of the target cursor.**

2 **Set the search type.**

[MAX]	Searches the maximum value of measurement result.
[MIN]	Moves the cursor to the minimum value of the measurement results.
[TARGET]	Searches the measured value set in the target measured value.
[L-MAX]	Searches the local maximum value of the measurement result. Filter setting is available. (p. 109)
[L-MIN]	Searches the local minimum value of the measurement result. Filter setting is available. (p. 109)

Setting the measured value to be searched

- The value is set when **[TARGET]** is selected in “Setting the Search Type” (p. 108).
- Set the target value to search when executing a target search.

1 **Use the numeric keypad to set the measured value to be searched.**

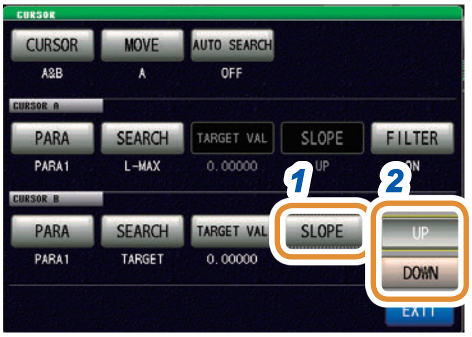
2 **Press [SET] to confirm the setting.**

Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

Setting target slope

Sets the target slope when **[TARGET]** is selected in the setting of search type.



1 **Press [SLOPE] of the target cursor.**

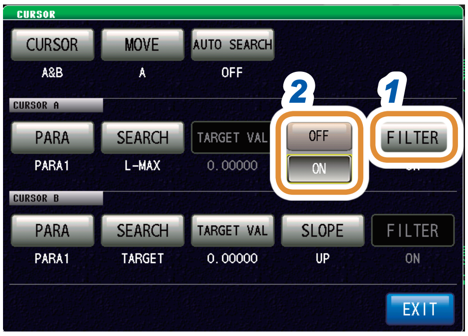
2 **When executing a target search, set if search has to be performed in rising waveform or falling waveform for the value to be searched.**

[UP]	Searches in rising waveform.
[DOWN]	Searches in falling waveform.

Filter settings

- This is set when **[L-MAX]** or **[L-MIN]** is selected for the search function setting.
- Set a filter to judge the local maximum value or local minimum value.
- Applying a filter allows you to reduce the misjudgments of variations in measured values caused by noise and other interference being judged as local maximum values or local minimum values.

The filter setting is common to cursors A and B.



1 **Press [FILTER].**

2 **Select ON/OFF.**

[OFF]	Disables the filter function.
[ON]	Enables the filter function.

4.7.3 Using the Auto Search Function

If you set the auto search function to **[ON]**, the search is executed after sweep measurement ends, and the cursors automatically move in accordance with the search settings.

1 **Press [AUTO SEARCH].**

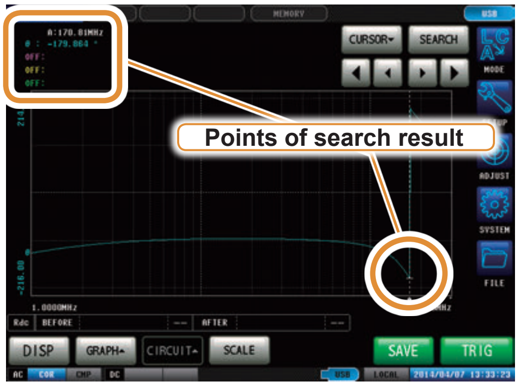
2 **Select ON/OFF.**

[OFF]	Disables the auto search function.
[ON]	Enables the auto search function.

4.7.4 Executing Search

- When the setting of trigger is **[REPEAT]**, search cannot be performed.
  See "4.2.2 Starting Measurement at Any Arbitrary Timing (Trigger)" (p. 70).
- If more than one sweep point matches the condition, the cursor moves each time you press **[SEARCH]**.

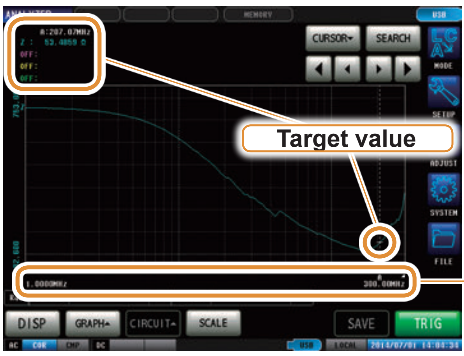
Press **[SEARCH]**.



The cursor moves to the search result point.
In the search example, only parameter 1 is enabled.

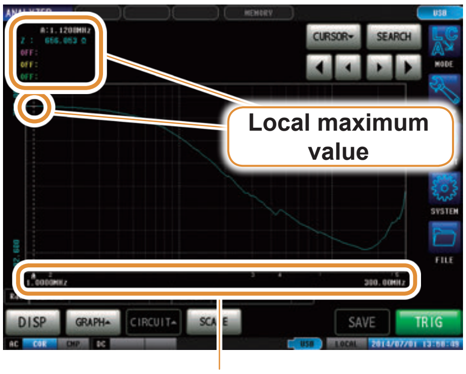
Search execution results

Target point



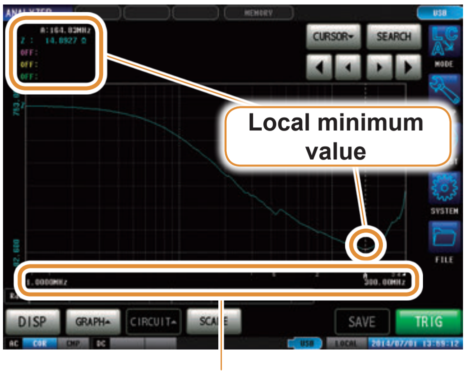
The sweep point matching the condition is indicated by a bar (|) below the X axis.

Local maximum point



In the search results, the sweep point that is considered to be the local maximum value is indicated below the X axis.
The local maximum points are indicated in order from the largest measurement value to the smallest as “1, 2, 3,...,” and from the sixth point by a bar (|).

Local minimum point



In the search results, the sweep point that is considered to be the local minimum value is indicated below the X axis.
The local minimum points are indicated in order from the smallest measurement value to the largest as “1, 2, 3,...,” and from the sixth point by a bar (|).

4

Analyzer Function

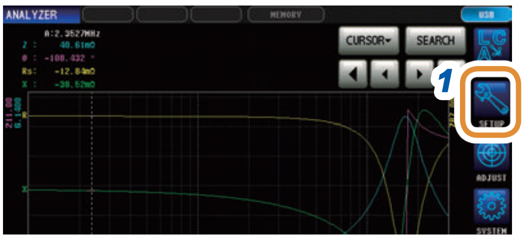
4.8 Judging Measurement Results (Comparator Function)

With the comparator function, you can preset a judgment area and judge whether the measured values are within the judgment area.

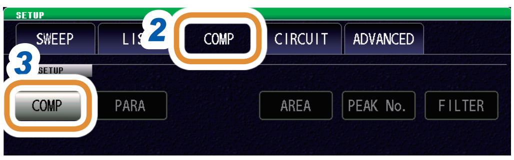
Area judgment	Judges whether the measured values of sweep points are within the judgment area. (p. 116)
Peak judgment	Judges whether the peak value of one sweep result is within the judgment area. (p. 120)

With the comparator function of the analyzer function, as far as possible set trigger setting to **[SEQ]** and perform a sweep once before setting the comparator function as there are items etc. that use the sweep results for configuring the settings of the judgment area.

4.8.1 Setting the Judgment Mode

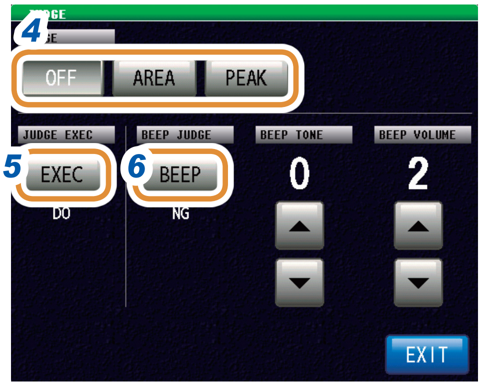


1 **Press [SETUP].**



2 **Press [COMP] tab.**

3 **Press [COMP].**
Go to the next page.



4 **Select the judgment mode.**

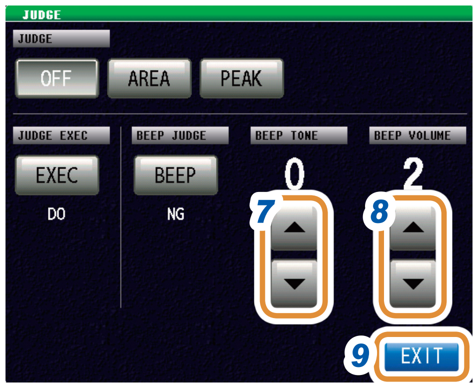
[OFF]	Disables comparator function.
[AREA]	Enables area judgment. (p. 116)
[PEAK]	Enables peak judgment. (p. 120)

5 **When a measured value is outside the guaranteed accuracy range, set how the measured value is judged.**

[DO]	Judges when a measured value is outside the guaranteed accuracy range.
[NOT]	Outputs error for HI judgment when a measured value is outside the guaranteed accuracy range.

6 **Sets the beep sounds for judgment results.**

[OFF]	No beep sound.
[IN]	Beeps if all the judgment results are IN.
[NG]	Beeps if one of the judgment results is LO or HI.



7 **With ▲/▼, set the beep tone.**

Settable range	0 to 14

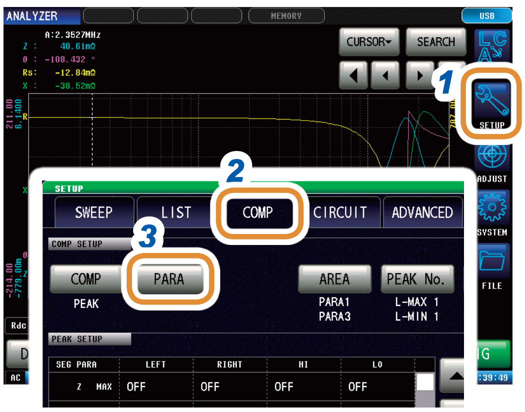
8 **With ▲/▼, set the beep volume.**

Settable range	1 to 3

9 **Press [EXIT] to close the judgment settings screen.**

10 **Press [EXIT] to close the advanced settings screen.**

4.8.2 Setting the Parameter to be Judged



1 **Press [SETUP].**

2 **Press [COMP] tab.**

3 **Press [PARA].**

4 **Select the parameter to be judged.**

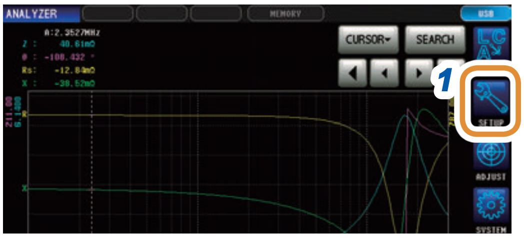
5 **Select ON/OFF for the parameter to be judged.**

[OFF]	Disables judgment of the selected parameter.
[ON]	Enables judgment of the selected parameter.

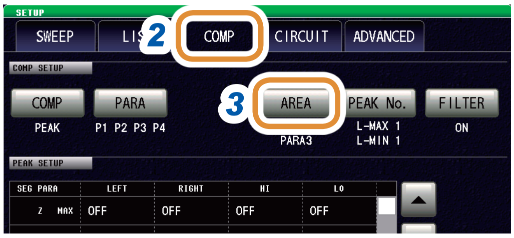
6 **Press [EXIT] to close the judgment settings screen.**

7 **Press [EXIT] to close the advanced settings screen.**

4.8.3 Setting the Judgment Area to Display in the Measurement Screen



1 **Press [SETUP].**



2 **Press [COMP] tab.**

3 **Press [AREA].**

4 **Select the parameter that will display the judgment areas.**

[PARA1]	Displays the judgment area for parameter 1.
[PARA2]	Displays the judgment area for parameter 2.
[PARA3]	Displays the judgment area for parameter 3.
[PARA4]	Displays the judgment area for parameter 4.
[OFF]	Judgment area is not displayed.

Selects the sweep parameter to display judgment area on the second normal sweep graph if the graph display setting is [MULTI] in the area setting of “GRAPH2”.

5 **Press [EXIT] to close the judgment settings screen.**

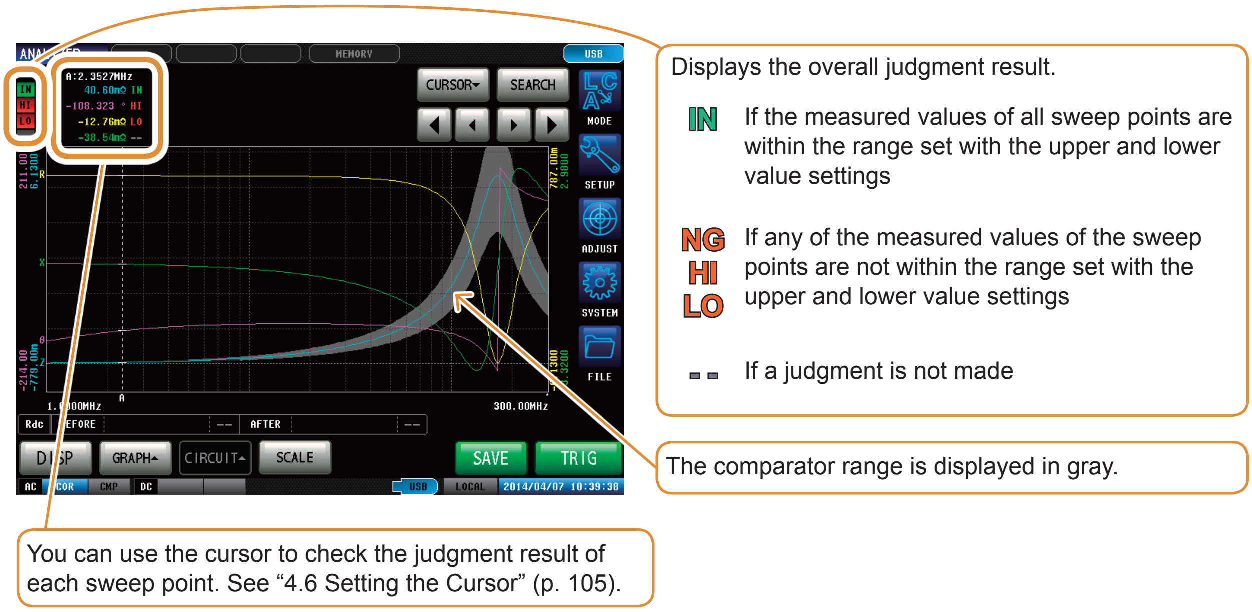
6 **Press [EXIT] to close the advanced settings screen.**

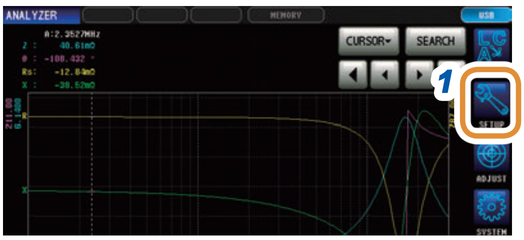
If it is difficult to see the judgment area of the graphical screen, increasing the brightness will improve the visibility.
See “Setting the screen brightness” (p. 183)

4.8.4 Area Judgment

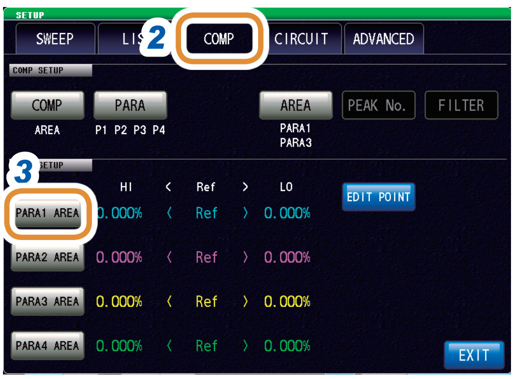
With area judgment, you can set the range for the upper and lower limit values to enable IN or NG to be displayed as the judgment result.

> Set trigger setting to **[SEQ]** and perform a sweep once before setting the area judgment function because there are items etc that use the sweep results in the area judgment function for configuring the settings of the judgment area.



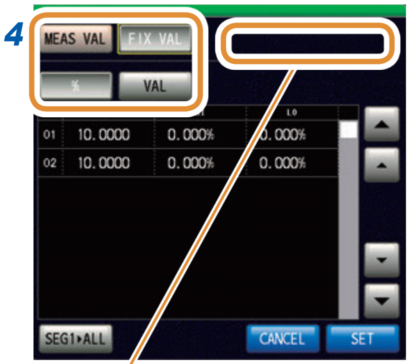


1 Press **[SETUP]**.



2 Press **[COMP]** tab.

3 Press **[PARA1 AREA]**.



4 **Sets the judgment area for sweep parameter 1.**

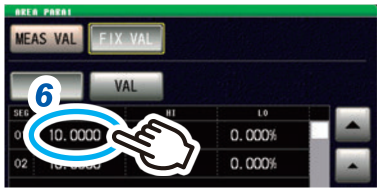
[MEAS VAL]	Sets the upper and lower limit values with the current measured values as reference.
[FIX VAL]	Sets the reference value, upper limit value, and lower limit value.
[%]	Sets the upper and lower limit values as percentage values relative to the reference value.
[VAL]	Sets the upper and lower limit values as absolute values relative to the reference value.

A message such as the following may be displayed when **[MEAS VAL]** is selected.
In this case, set trigger settings to **[SEQ]** and perform a sweep once.

TRIG setting is REPEAT	Measured values cannot be referenced correctly because trigger setting is REPEAT.
Some points have no Meas Value	Measured values cannot be referenced correctly because there is a sweep point where the measured value is invalid.

5 **Displays the segment number to be set with ▲/▼ or by scrolling.**

Only one row is displayed when the segment function is OFF.

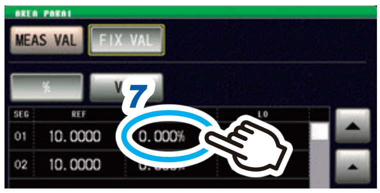


6 (This is enabled only when the setting of judgment area is **[FIX VAL]**.)

(1) **Press the cell corresponding to REF of any arbitrary segment.**

(2) **Set the reference value with the numeric pad* and press [SET].**

Settable range	-9.99999 G to 9.99999 G

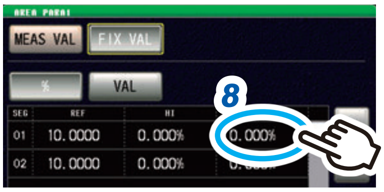


7 **(1)** **Press the cell corresponding to HI of any arbitrary segment.**

(2) **Set the upper limit value with the numeric pad* and press [SET].**

Settable range (set as % value)	-999.999% to 999.999%
Settable range (set as absolute value)	-9.99999 G to 9.99999 G

Go to the next page.



8

(1) Press the cell corresponding to LO of any arbitrary segment.

(2) Set the lower limit value with the numeric pad* and press [SET].

Settable range (set as % value)	-999.999% to 999.999%
Settable range (set as absolute value)	-9.99999 G to 9.99999 G

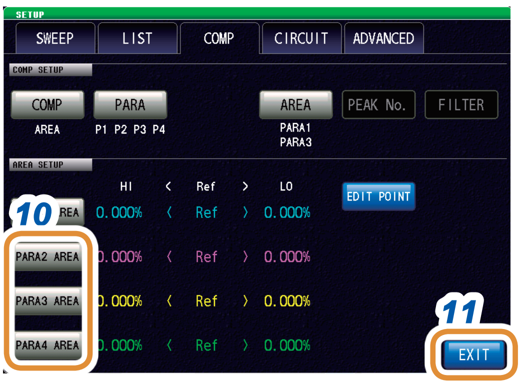
If the setting is such that upper limit value < the lower limit value, the values are automatically switched and set.

* Each common numeric keypad

[-]	Inputs the unit with a minus (-) sign.
[×10³]	Increases the prefix of the unit.
[/10³]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

9 **Set a limit value for each segment in the same way and press [SET].**

If you press [SEG1>ALL], the setting value of the first segment is copied to all the other segments.

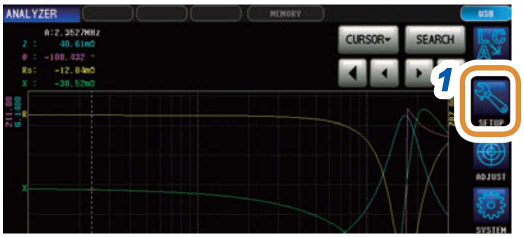


10 **Set the judgment area for the second to fourth parameters in the same way.**

11 **Press [EXIT] to close the judgment settings screen.**

12 **Press [EXIT] to close the advanced settings screen.**

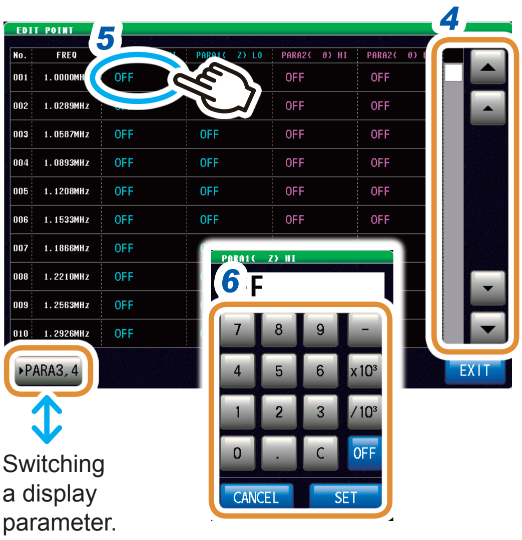
Changing the upper and lower limit values of each sweep point individually



1 **Press [SETUP].**

2 **Press [COMP] tab.**

3 **Press [EDIT POINT].**



Switching a display parameter.

4 **Displays the sweep number to be set with ▲/▼.**

5 **Press the limit value cell for each sweep point.**

6 **Set the limit value with the numeric pad and press [SET].**

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

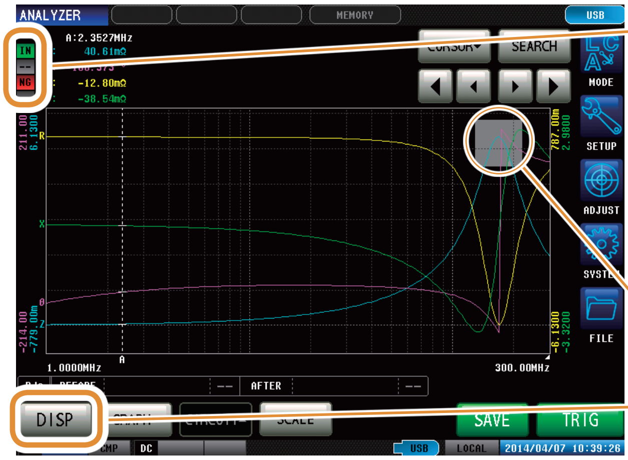
7 **Set the limit value for each parameter in the same way.**

4

Analyzer Function

4.8.5 Peak Judgment

With peak judgment, you can judge whether the peak value is within the judgment area. The judgment area can be set with the upper, lower, left, and right limit values.

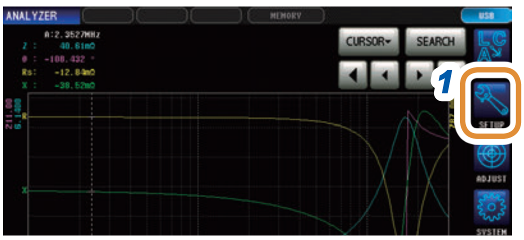


Displays the overall judgment result.

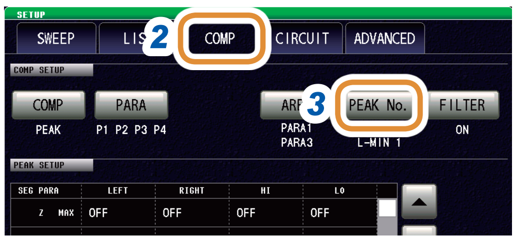
- IN — If all of the peak values are within the judgment area.
- NG — If any of the peak values are not within the judgment area.
- - - — If a judgment is not made

The comparator range is displayed in gray.

[PEAK]display setting in **[DISP]** displays details of the judgment results.
See “How to read the peak judgment result details” (p. 123).



1 Press **[SETUP]**.



2 Press **[COMP]** tab.

3 Press **[PEAK No.]**.

4 **Use ▲/▼ to select the No. of the local maximum value or local minimum value for peak judgment.**
See “4.7 Performing Measured Value Search” (p. 107).

L-MAX	• Selects the No. of the local maximum value. The values are numbered as “1, 2, 3...” (No.) starting in order from the largest measured value of the detected local maximum values. • Settable range:1 to 5
L-MIN	• Selects the No. of the local minimum value. The values are numbered as “1, 2, 3...” (No.) starting in order from the smallest measured value of the detected local minimum values. • Settable range:1 to 5

5 **Press [EXIT] to confirm the setting.**

6 **Press [FILTER].**

7 **Select enable or disable for the filter.**

OFF	Disables the filter function.
ON	Enables the filter function.

• Applying a filter allows you to reduce the misjudgments of variations in measured values caused by noise and other interference being judged as local maximum values or local minimum values.
• The filter setting is synchronized with “4.7.2 Setting the Search Type” (p. 108).

8 **Display the conditions to set the judgment area with ▲/▼ or by scrolling.**

Select any of the following items as the condition to be set for the judgment area.
- Segment No.
- Measurement parameters
- Local maximum value/Local minimum value

Changing the unit: **M** (mega)/**k** (kilo)

9 **Press the cell for LEFT/RIGHT of user-defined conditions.**

10 **Use the numeric keypad to set the left and right limit values.**

The range that can be set varies depending on the sweep parameter.

Refer to the following for each of the parameters.

- See “4.4.1 Setting Measurement Signal Frequency” (p. 88) for frequency.
- See “4.4.2 Setting the Measurement Signal Level” (p. 89) for POWER/V/I.

If the setting is such that right limit value < the left limit value, they are automatically switched, set, and displayed.

[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

11 **Press the cell for HI/LO corresponding to user-defined conditions.**

12 **Use the numeric keypad to set the left and right limit values.**

Settable range	-9.99999 G to 9.99999 G

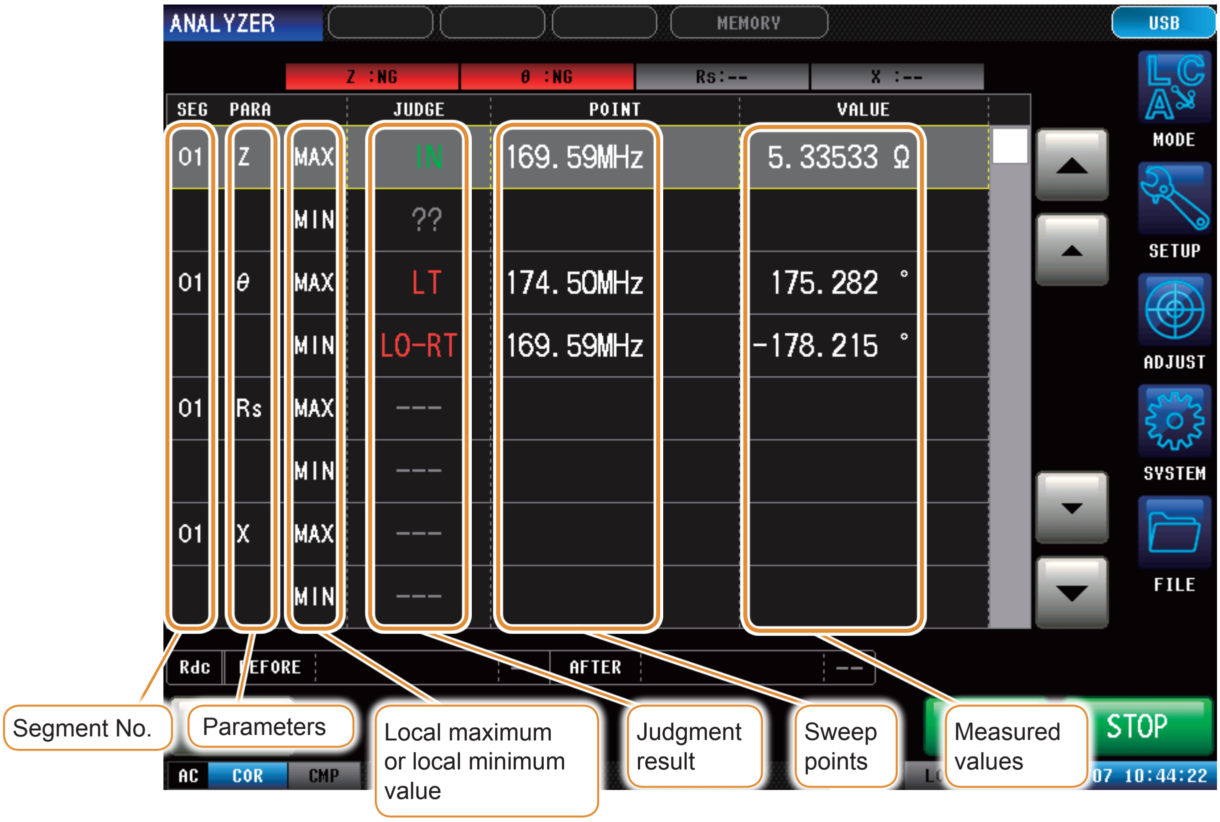
If the setting is such that upper limit value < the lower limit value, they are automatically switched, set, and displayed.

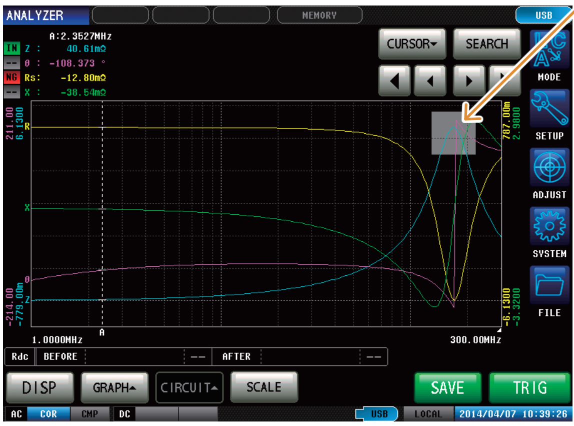
[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

13 **Press [EXIT] to close the judgment settings screen.**

14 **Press [EXIT] to close the advanced settings screen.**

How to read the peak judgment result details





The gray part is the judgment area.
The judgment result indicates the position of the detected peak in relation to the judgment area.

HI-LT	HI	HI-RT
LT	IN	RT
LO-LT	LO	LO-RT

- If the peak could not be detected, “??” is displayed.
- If the judgment conditions are not set, “---” is displayed.

- The segment No. is not displayed if the segment function is OFF.
- When the judgment area setting is **[OFF]**, the judgment result is displayed as [- - -].
- This is not displayed for area judgment.

4.9 Equivalent Circuit Analysis Function

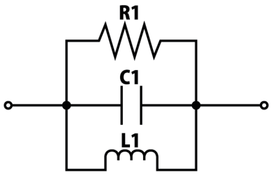
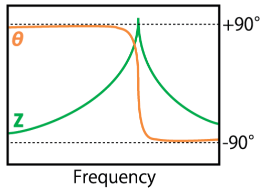
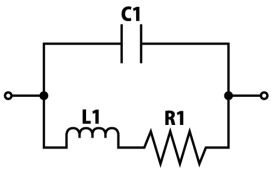
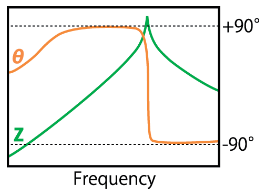
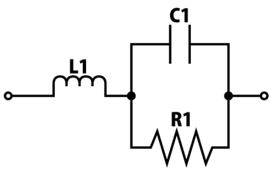
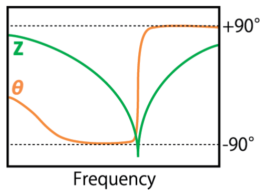
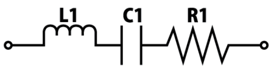
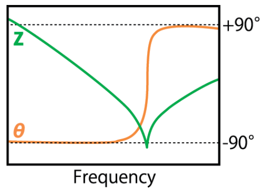
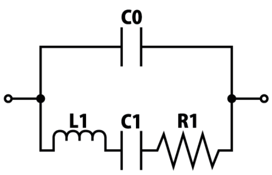
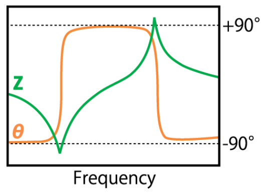
4.9.1 Equivalent Circuit Analysis Function

The equivalent circuit analysis function estimates equivalent circuit constants based on the measurement results.
This instrument can estimate constants for the following five equivalent circuit models.

Models A to E: Used primarily in the analysis of circuit elements.

You can display ideal values for frequency characteristics using estimation results or user-configured constants by using the simulation function.
Furthermore, you can judge whether estimation results fall within a predefined judgment area by using the comparator function.

Circuit elements

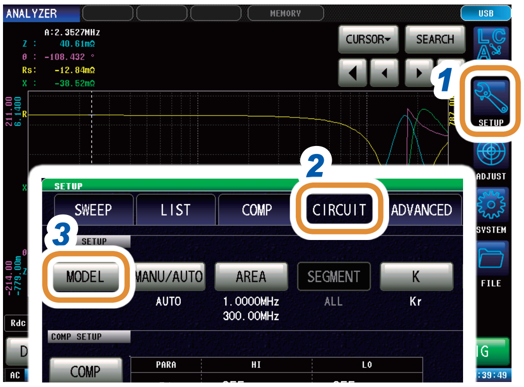
Model	Equivalent circuit model	Representative frequency characteristics*	Example of sample	
A			Inductor	Inductor with high core loss and low ESR
B			Inductor	Inductor with comparatively high ESR
			Resistor	Resistor with low resistance value and significant wiring inductance effect
C			Capacitor	Capacitor with significant leak resistance effect
			Resistor	Resistor with high resistance value and significant stray capacitance effect
D			Capacitor	Typical capacitor
E			Piezoelectric element	

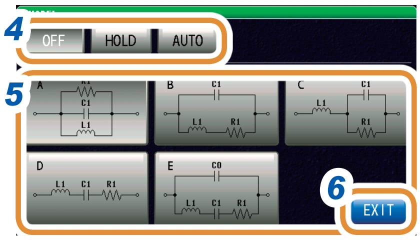
*Typical frequency characteristics graphs
Model A to D horizontal axis: Logarithmic scale, vertical axis: Z is on a logarithmic scale, θ is on a linear scale
Model E horizontal axis: Linear or logarithmic scale, vertical axis: Z is on a logarithmic scale, θ is on a linear scale

4.9.2 Configuring Basic Settings for Analysis

(1) Setting the equivalent circuit model

Select the equivalent circuit model you wish to use for equivalent circuit analysis.
You will be able to estimate constants more accurately by selecting the appropriate equivalent circuit model.





1 **Press [SETUP].**

2 **Press [CIRCUIT] tab.**

3 **Press [MODEL].**

4 **Select the model to be used in equivalent circuit analysis.**

[OFF]	Turns off the equivalent circuit function.
[HOLD]	Selects the equivalent circuit model manually.
[AUTO]	Selects the most suitable equivalent circuit model automatically.

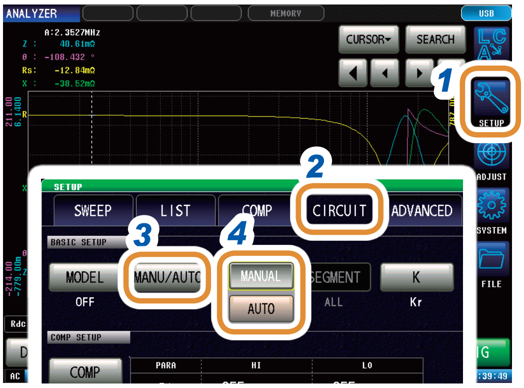
5 (If **[HOLD]** is selected in step **4**)
Select an equivalent circuit model to be used.

6 **Press [EXIT] to close the setting screen.**

- When the equivalent circuit model A to E is selected, HOLD is automatically set.
- For more information on how to select the equivalent circuit model, refer Refer to “Appx. 4 Selecting the Equivalent Circuit Model” (p. A5).

(2) Setting the analysis method

This section describes how to set whether to perform equivalent circuit analysis automatically after measurement completes or to wait until **[RUN]** is pressed.



1 **Press [SETUP].**

2 **Press [CIRCUIT] tab.**

3 **Press [MANU/AUTO].**

4 **Selects the analysis method .**

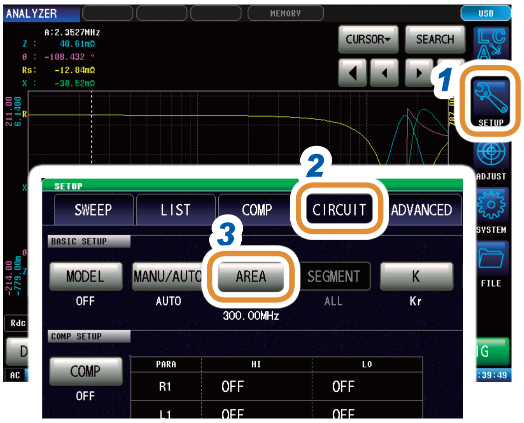
[MANUAL]	Press **[RUN]** to perform analysis.
[AUTO]	Analysis is automatically performed after completion of measurement.

5 **Press [EXIT] to close the setting screen.**

Equivalent circuit analysis cannot be performed with **[MANUAL]** in the continuous measurement screen. To perform equivalent circuit analysis during continuous measurement, change the setting to **[AUTO]** and save the panel.
Refer to “4.2.2 Starting Measurement at Any Arbitrary Timing (Trigger)” (p. 70)

(3) Setting the frequency range for analyses

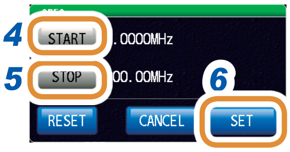
This section describes how to set the frequency range used to perform equivalent circuit analysis when using normal sweep. This function allows you to restrict local extreme values to be used for the analysis in case several local extreme values exist in the sweep range. Configures the setting so that local extreme values are included in the analysis range. This setting is valid only during normal sweep operation.



1 Press **[SETUP]**.

2 Press **[CIRCUIT]** tab.

3 Press **[AREA]**.



Changing the unit: **M** (mega)/**k** (kilo)

4 Press **[START]**, use the numeric keypad to enter the frequency at which to start analysis, and press **[Hz]**.

Settable range	1.0000 MHz to 300.00 MHz

[C]	Repeats the input.
[CANCEL]	Closes the window without setting the analysis range.
[RESET]	Resets the analysis range that has been set.

5 Press **[STOP]**, use the numeric keypad to enter the frequency at which to end analysis, and press **[Hz]**.

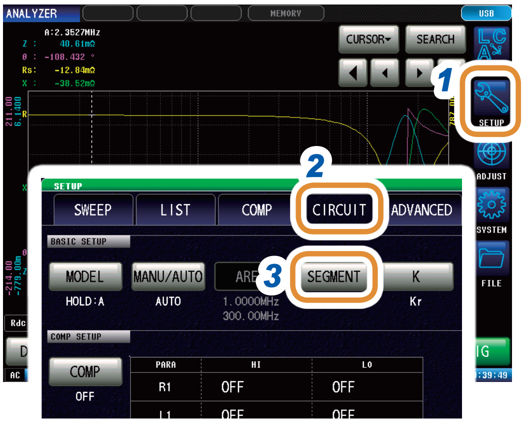
Settable range	1.0000 MHz to 300.00 MHz

6 Press **[SET]** to accept the frequency range.

The accuracy of the analysis may deteriorate if a very narrow frequency range is set.

(4) Selecting the segment for analysis

This section describes how to select the target segment for estimation during a segment sweep. You can specify the segments to be used in analysis when dividing the frequency range into multiple segments for measurement by using this function. Set the segment that includes local extreme values. This setting is valid only during segment sweep operation.



1 **Press [SETUP].**

2 **Press [CIRCUIT] tab.**

3 **Press [SEGMENT].**

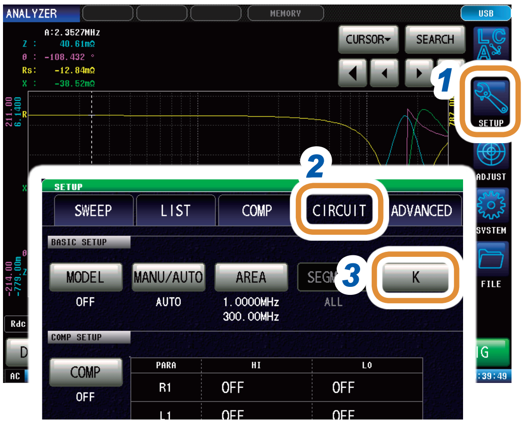
4 **Use ▲/▼ to select the segment number to use in equivalent circuit analysis.**

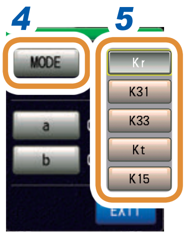
ALL	Targets all segments for analysis.
1 to 20	Targets only the set segment No. for analysis.

5 **Press [EXIT] to close the setting screen.**

(5) Settings for electromechanical coupling coefficient (K) calculation

Make necessary settings to calculate the electromechanical coupling coefficient (K) using model E.





1 **Press [SETUP].**

2 **Press [CIRCUIT] tab.**

3 **Press [K].**

4 **Press [MODE].**

5 **Select the oscillation mode.**

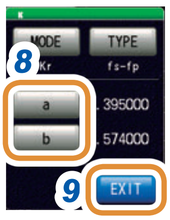
[Kr]	Electromechanical coupling coefficient for planar oscillation $Kr = \sqrt{\dfrac{f_p - f_s}{a\times f_s + b\times\left(f_p - f_s\right)}}$
[K31]	Electromechanical coupling coefficient for longitudinal direction extension oscillation $K31 = \sqrt{\dfrac{\dfrac{\pi}{2}\times\dfrac{f_p}{f_s}}{\dfrac{\pi}{2}\times\dfrac{f_p}{f_s} - \tan\left(\dfrac{\pi}{2}\times\dfrac{f_p}{f_s}\right)}}$
[K33]	Electromechanical coupling coefficient for vertical direction oscillation $K33 = \sqrt{\dfrac{\pi}{2}\times\dfrac{f_s}{f_p}\cot\left(\dfrac{\pi}{2}\times\dfrac{f_s}{f_p}\right)}$
[Kt]	Electromechanical coupling coefficient for thickness direction oscillation $Kt = \sqrt{\dfrac{\pi}{2}\times\dfrac{f_s}{f_p}\cot\left(\dfrac{\pi}{2}\times\dfrac{f_s}{f_p}\right)}$
[K15]	Electromechanical coupling coefficient for shearing oscillation $K15 = \sqrt{\dfrac{\pi}{2}\times\dfrac{f_s}{f_p}\cot\left(\dfrac{\pi}{2}\times\dfrac{f_s}{f_p}\right)}$

Go to the next page.

6 **Press [TYPE].**

7 **Select the frequency type.**
Select the resonant frequency type to be used when calculating the electromechanical coupling coefficient.

[fs-fp]	Selects the series/parallel resonant frequency.
[fr-fa]	Selects the resonant/anti-resonant frequency. (Substitutes fs with fr and fp with fa in the formula of Step **4**.)



8 (If [planar oscillation] is selected in the oscillation mode)
Sets a different coefficient for Poisson's ratio.

Settable range	0.000001 to 1.000000

(1) **Press [a], set the coefficient with the numeric keypad, and press [SET].**

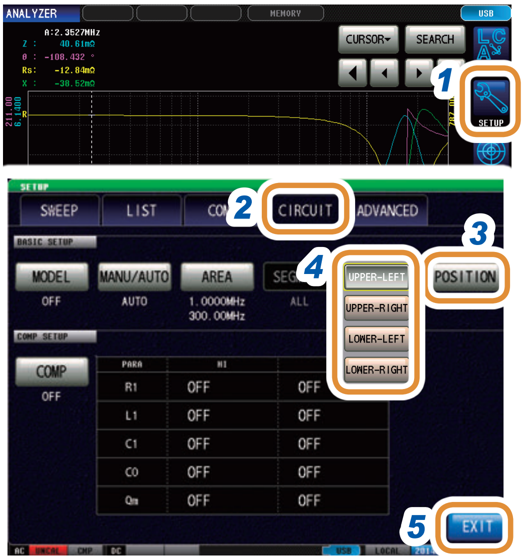
(2) **Press [b], set the coefficient in the same way as [a], and press [SET].**

[C]	Repeats the input.
[CANCEL]	Cancels the setting.

9 **Press [EXIT] to close the setting screen.**

(6) Setting the position at which to display analysis results

This section describes how to set the position at which to display analysis results. If the graph and analysis results displays overlap, set the position so that estimated values are easy to read.



1 Press **[SETUP]**.

2 Press **[CIRCUIT]** tab.

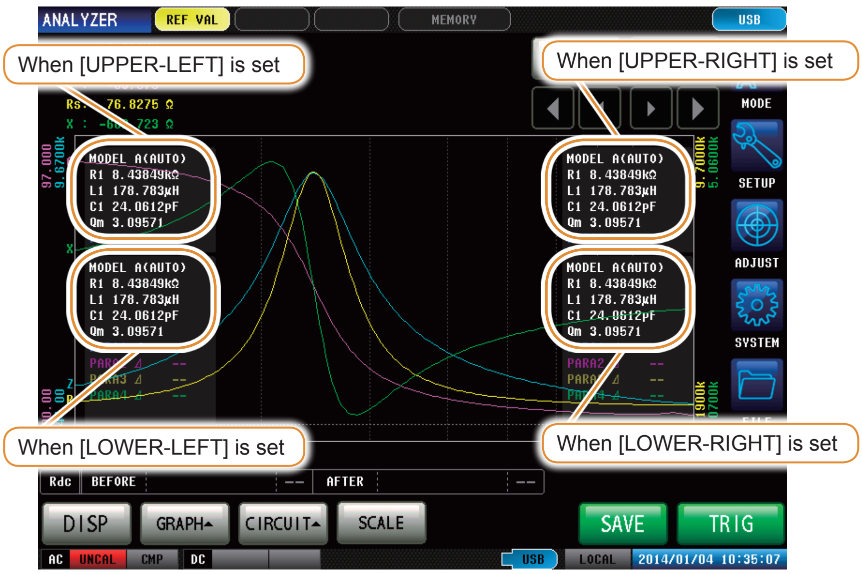
3 Press **[POSITION]**.

4 Select the position at which to display analysis results.

[UPPER-LEFT]	Displays analysis results on the upper left of the screen.
[UPPER-RIGHT]	Displays analysis results on the upper right of the screen.
[LOWER-LEFT]	Displays analysis results on the lower left of the screen.
[LOWER-RIGHT]	Displays analysis results on the lower right of the screen.

5 Press **[EXIT]** to close the setting screen.

Analysis result display position



Analysis results are always shown on the upper right side for **[1 X-Y]** and **[MULTI]** display.

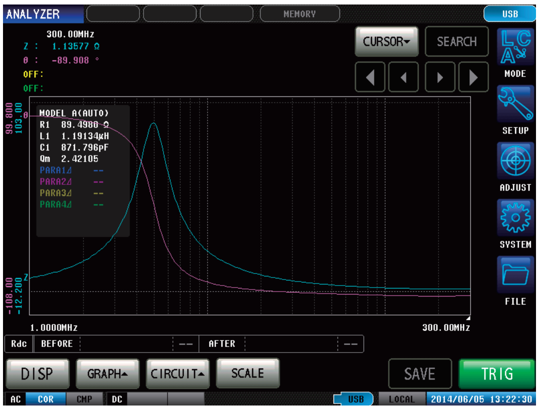
4.9.3 Performing Equivalent Circuit Analysis

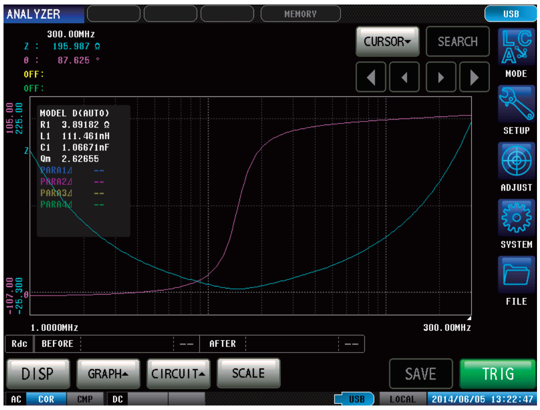
(1) Performs frequency sweep measurement

> **Before performing equivalent circuit analysis**
> Set the sweep parameter to “frequency” and acquire frequency characteristics of elements to be analyzed.
> Refer to “4.2.5 Setting the Sweep Parameter” (p. 74)

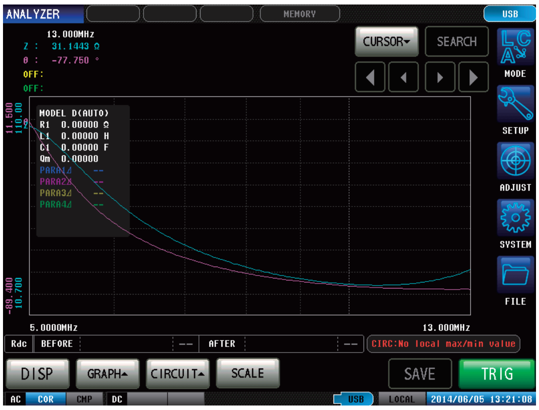
Because the local maximum and local minimum measurement points are used when performing equivalent circuit analysis with this instrument, the frequency range should be set to the range for which the local extreme values can be measured. Since low frequency values are used when performing analysis with Model B or Model C, configure the settings so that the lowest possible frequencies are measured.
Additionally, when performing analysis using E model, set the range so that it includes the resonance points for series resonance and parallel resonance.

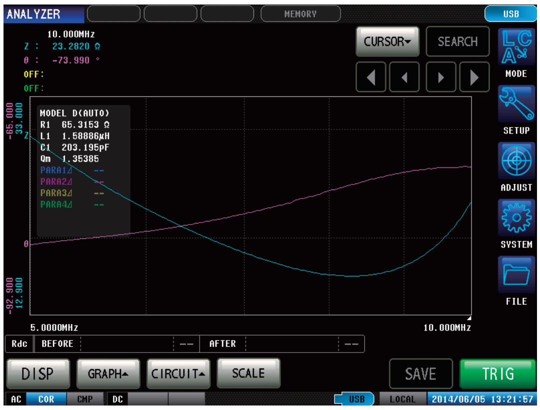
Examples of appropriate sweep range settings





Examples of inappropriate sweep range settings



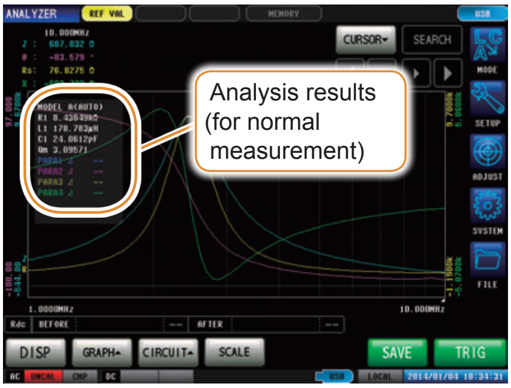


Performing equivalent circuit analysis

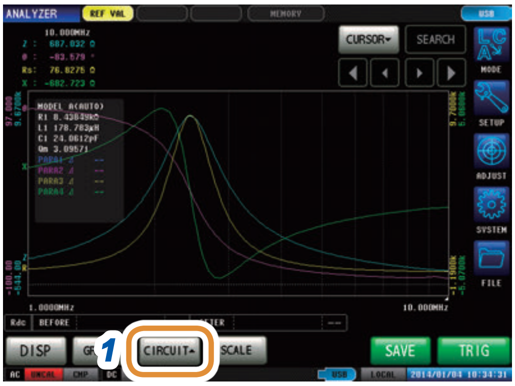
Qm indicates the sharpness of the mechanical vibration at the resonant frequency (Mechanical quality coefficient).

When analysis method is set to AUTO

Analysis is automatically performed after the completion of measurement and the result is displayed.



When analysis method is set to MANUAL

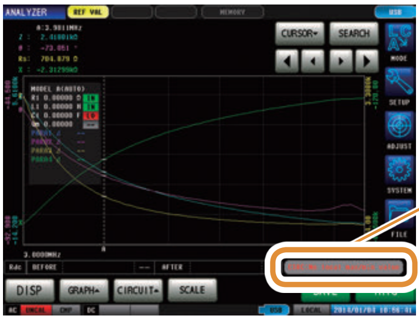


1 **Press [CIRCUIT▲].**

2 **Press [RUN] to perform analysis.**

If resonance points cannot be detected

If the instrument cannot detect the resonance points that are used in analysis, the following error message will be displayed.
Configure the settings so that the sweep range includes resonance points.
Additionally, verify that the frequency range and segments used in the analysis are appropriately configured.
See “Setting the frequency range for analyses” (p. 127), “Selecting the segment for analysis” (p. 128).



CIRC: No local max/min value

If the sweep parameter is set to a value other than “Frequency”

If the sweep parameter is set to a value other than “Frequency,” the following error message will be displayed.
Set the sweep parameter to “frequency”.
See “4.2.5 Setting the Sweep Parameter” (p. 74).

CIRC: Frequency sweep only

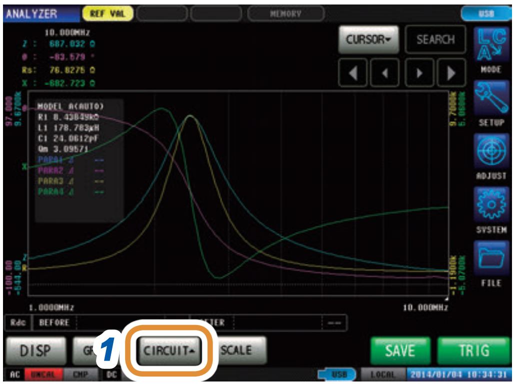
If there are no measured values that can be analyzed

If there are no measured values that can be analyzed, the following error message will be displayed.
If measurement has not been performed, perform equivalent circuit analysis after measurement.

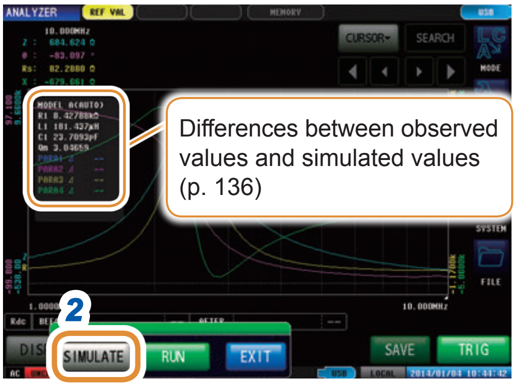
CIRC: Analysis not available

4.9.4 Simulating Frequency Characteristics

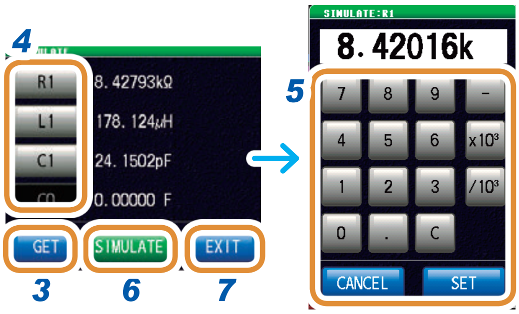
This section describes how to simulate frequency characteristics using estimated constants or arbitrary constants.



1 **Press [CIRCUIT▲].**



2 **Press [SIMULATE].**



3 **Press [GET].**
Acquires the values for which equivalent circuit analysis has been performed.

4 **Press the key of a constant to be changed.**

5 **Use the numeric keypad to input values and press [SET].**

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

6 **Press [SIMULATE] to execute simulation.**

7 **Press [EXIT].**

The simulation graph will be cleared if you change the constants or perform a new measurement. Press **[SIMULATE]** to perform simulation again.

Differences between observed values and simulated values

The difference between observed values and simulated values is calculated for each measurement parameter in order to judge the suitability of equivalent circuit analysis results. The range for calculating this difference is the frequency range that is analyzed or the frequency range for the segment No. that is analyzed. The difference is calculated using the following procedure:

(1) The squares of the difference between each observed and simulated value pair for the frequency sweep count are added together.

(2) The result is divided by the frequency sweep count to obtain the mean residual sum of squares.

(3) The square root is calculated.

This can be specifically expressed with the following formula (A).

$$A = \sqrt{\Sigma\,(\text{observed value - simulated value})^2/n}$$

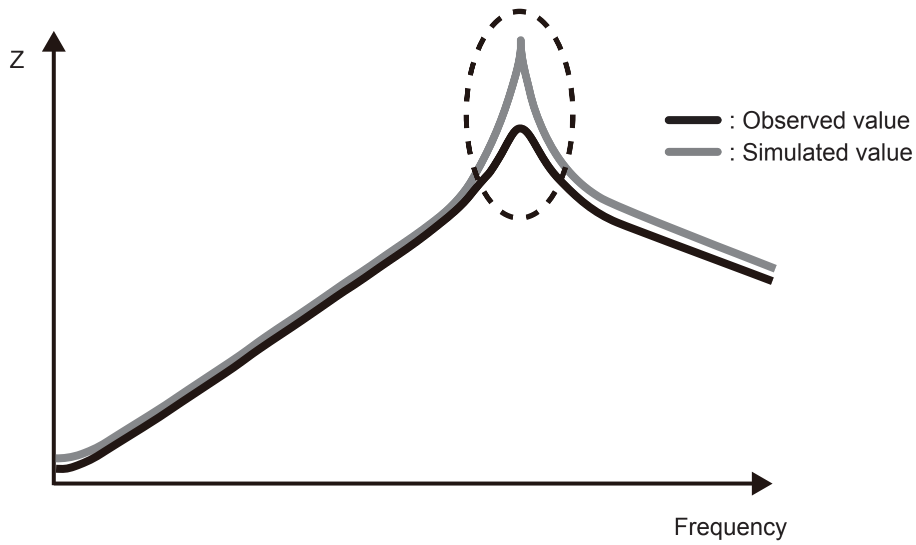
n: sweep count

However, when using this method with circuits whose impedance frequency characteristics exhibit local extreme values (local maximum or local minimum values), difference values for frequency ranges that do not contain local extreme values will be less than difference values for frequency ranges near local extreme values, as shown in the figure below. Consequently, the area enclosed with the dotted line in the figure is excluded when calculating the difference between observed and simulated values. The following calculation procedure is used for the area enclosed with the dotted line.

(1) The difference value calculated by adding quantity A to the observed value for the measurement frequency that generated the local extreme value is used as the upper limit value, and the difference calculated by subtracting the quantity A from the observed value for the measurement frequency that generated the local extreme value is used as the lower limit value.

(2) If the simulated value for the measurement frequency that generated the local extreme value falls outside the range defined by the upper and lower limit values calculated in (1) above, the upper and lower limit values for the observed values before and after the local extreme value are calculated as in (1) above and repeatedly compared to the simulated values.

(3) If the simulated value falls inside the range defined by the upper and lower limit values for the measurement frequencies before and after the local extreme value, the area is used to calculate the difference, and the areas used in (1) and (2) above become the area shown with the dotted line.

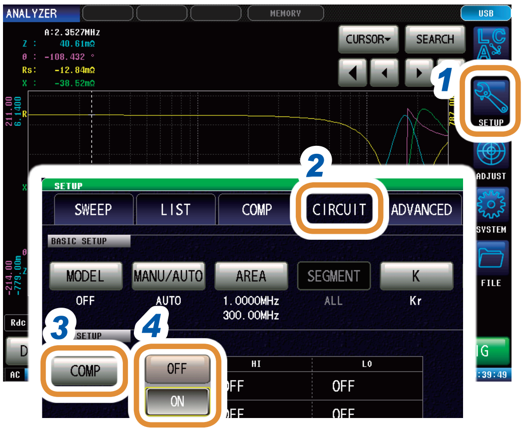


4.9.5 Settings to Judge Analysis Results

You can judge whether estimation results fall within a predefined judgment standard using the comparator function.

Setting the upper or lower limit value

You must set upper and lower limit values for the judgment standards before using the comparator function.



1 Press [SETUP].

2 Press [CIRCUIT] tab.

3 Press [COMP].

4 Select comparator function ON/OFF.

[OFF]	Disables comparator function.
[ON]	Enables comparator function.

5 Select the constants to set judgment standard.

(1) Press the cell corresponding to HI of any arbitrary parameter.

(2) Set the upper limit value with the numeric pad* and press [SET].

Settable range	-9.99999 G to 9.99999 G

* Each common numeric keypad

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

6

(1) Press the cell corresponding to LO of any arbitrary parameter.

(2) Set the lower limit value with the numeric pad* and press [SET].

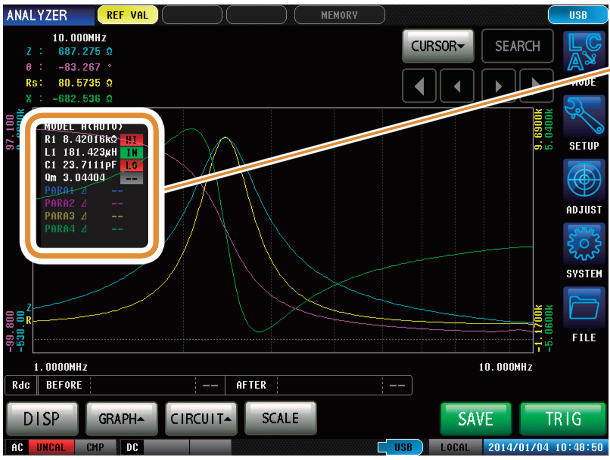
Settable range	-9.99999 G to 9.99999 G

> If the setting is such that upper limit value < the lower limit value, the values are automatically switched and set.

7 Press [EXIT] to close the setting screen.

Judge using analysis results

When the comparator is ON and the judgment area has been set, the estimated values and judgment results will be displayed after equivalent circuit estimation. Judgment results can also be acquired using communications commands or external output (EXT I/O).



HI Estimated value > upper limit

IN Upper limit ≥ estimated value ≥ lower limit

LO Estimated value < lower limit

- - - If reference standards have not been set

The overall judgment result is output from EXT I/O pin 14.
See “8 External Control” (p. 195).
However, the judgment content differs depending on whether analysis method is **[MANUAL]** or **[AUTO]**.
For more information, refer to the following table:

Method of analysis	Judgment timing	Overall judgment result
MANUAL	On measurement completion	The area comparator or peak comparator judgment result is output. There is no outputs if the area comparator or peak comparator have not been configured.
	If equivalent circuit analysis is performed manually	Clears the area comparator or peak comparator judgment results and outputs the overall judgment result for the equivalent circuit analysis results.
AUTO	If equivalent circuit analysis is performed after completion of measurement	The area comparator or peak comparator judgment results as well as the overall judgment result for the equivalent circuit analysis results can be output.

5 Calibration and Compensation

5.1 Calibration and Compensation Function Overview

It is necessary to perform open/short/load calibration on the instrument prior to measurement.
In addition, electric length compensation, and open/short compensation are performed when necessary.

Open/Short/Load Calibration

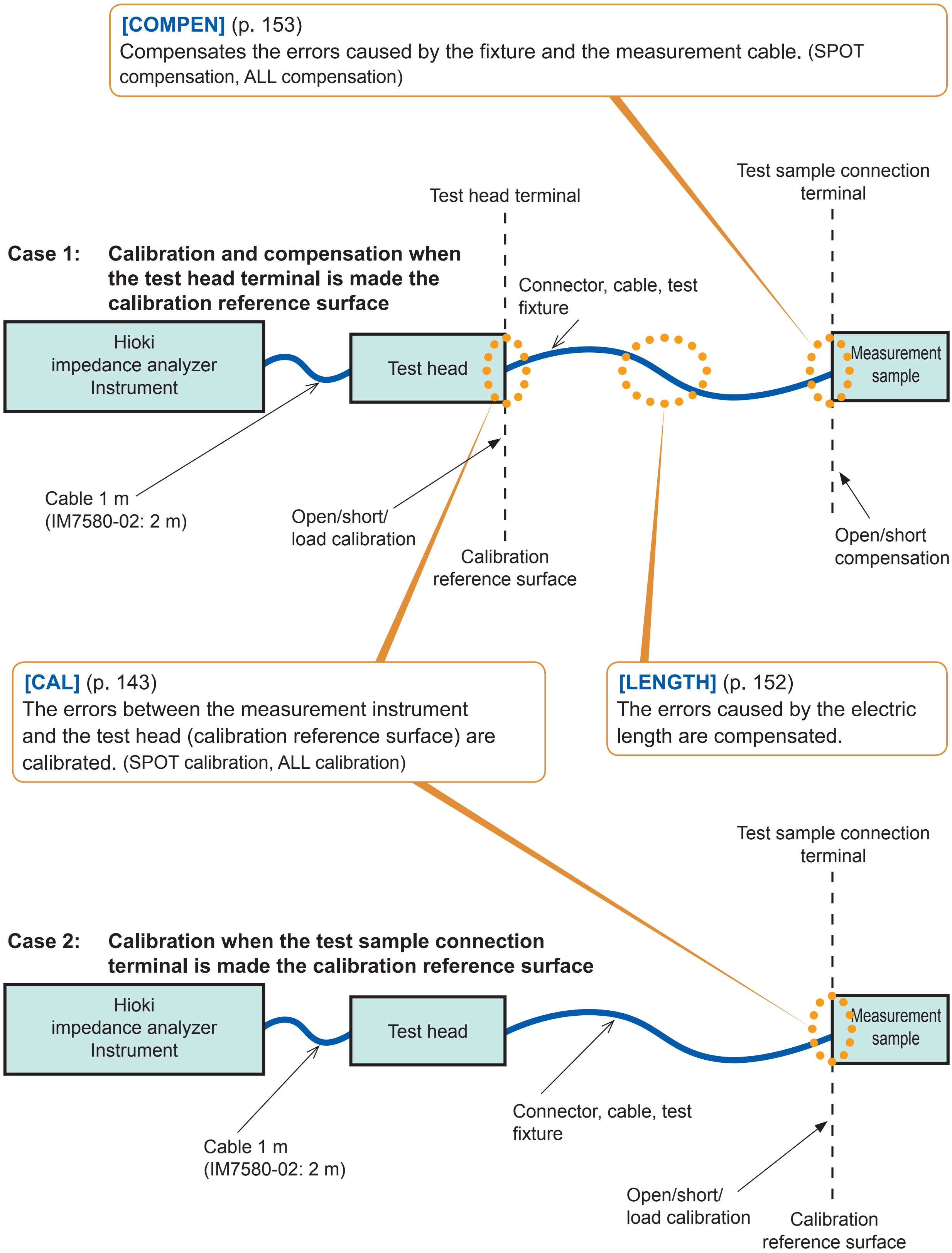
Connect the 3 standards, open, short and load to the reference surface (terminal) one by one, and measure respective calibration data. The reference surface is referred to as the “calibration reference surface”. The cause of errors between the measurement instrument and the calibration reference surface is eliminated. If this calibration is performed for the terminal connected to a test sample, other calibration or compensation is not required.

Electric Length Compensation

The electric length is entered as a numerical value between the calibration reference surface on which open/short/load calibration was performed to the surface where a measurement sample is connected. The error caused by the phase shift between the calibration reference surface and the measurement sample connection surface is compensated.
If a test fixture is to be used by connecting to the calibration reference surface of the test head, the electric length of the fixture is required to be input.

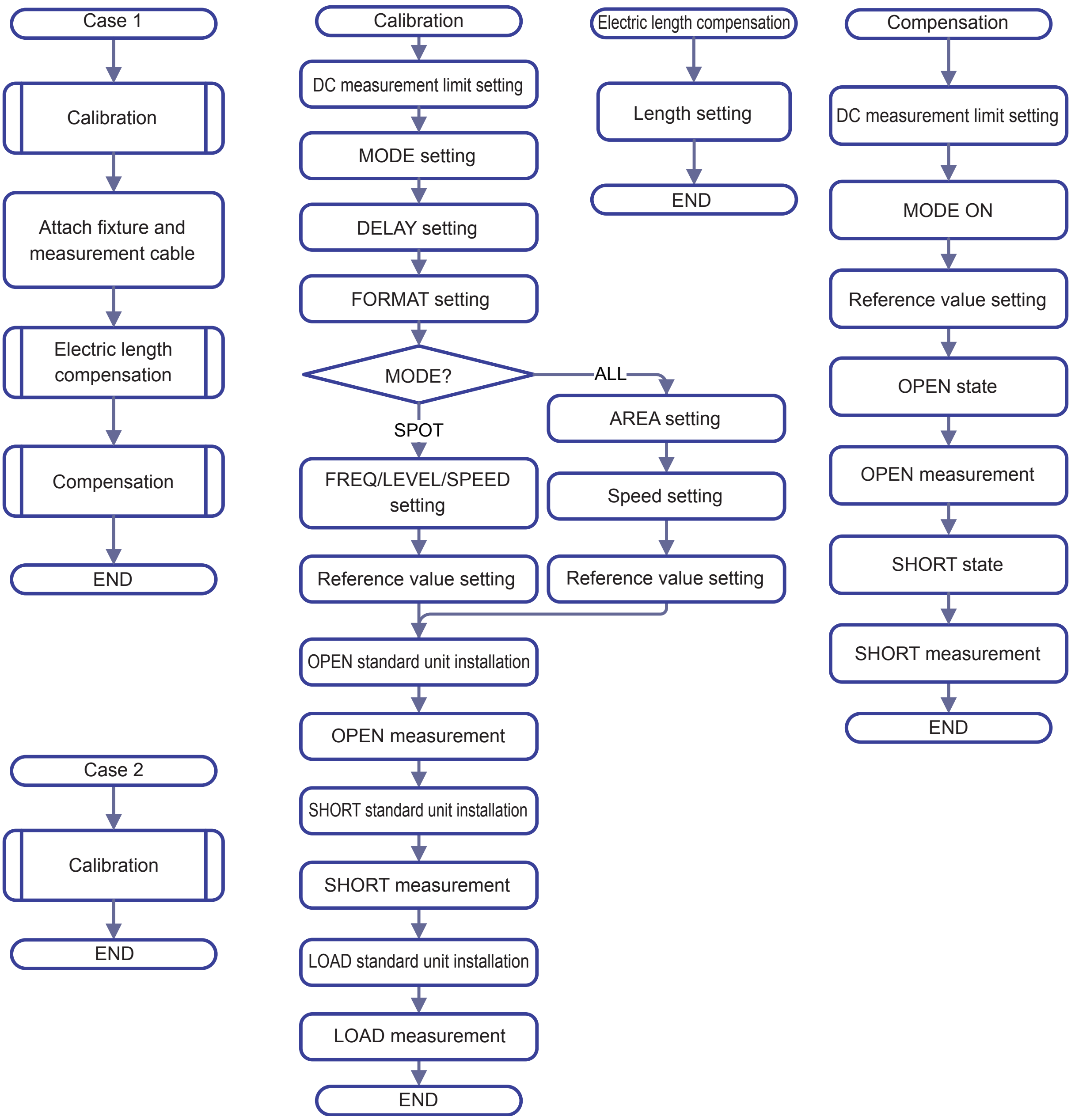
Open/Short Compensation

If a test sample is to be connected to the terminal extended from the calibration reference surface on which open/short/load calibration was performed, compensation data is measured keeping the test sample connection terminal in the open state. In addition, the terminal is shorted, and the compensation data is measured. The cause of errors between the calibration reference surface and the surface on which open/short compensation was performed is eliminated. This compensation is required to be performed if the coaxial terminal of the test head is the calibration reference surface.

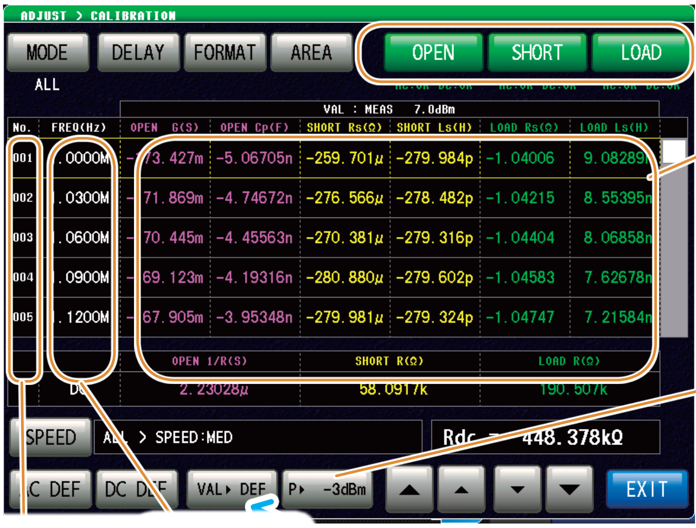

[COMPEN] (p. 153)
Compensates the errors caused by the fixture and the measurement cable. (SPOT compensation, ALL compensation)
Test head terminal
Test sample connection terminal
Case 1: Calibration and compensation when the test head terminal is made the calibration reference surface
Hioki impedance analyzer Instrument
Test head
Connector, cable, test fixture
Measurement sample
Cable 1 m (IM7580-02: 2 m)
Open/short/ load calibration
Calibration reference surface
Open/short compensation
[CAL] (p. 143)
The errors between the measurement instrument and the test head (calibration reference surface) are calibrated. (SPOT calibration, ALL calibration)
[LENGTH] (p. 152)
The errors caused by the electric length are compensated.
Test sample connection terminal
Case 2: Calibration when the test sample connection terminal is made the calibration reference surface
Hioki impedance analyzer Instrument
Test head
Measurement sample
Cable 1 m (IM7580-02: 2 m)
Connector, cable, test fixture
Open/short/ load calibration
Calibration reference surface

Calibration and compensation flowchart

Press each of **[OPEN]**, **[SHORT]**, and **[LOAD]** keys to start compensation after performing the setting explained in this section.



Screen



Start compensation

Compensation results

Switching the measurement signal level

[P > 7 dBm]	Measured value at 7 dBm
[P > -3 dBm]	Measured value at -3 dBm
[P > -23 dBm]	Measured value at -23 dBm
[P > -30 dBm]	Measured value at -30 dBm

Compensation value No.

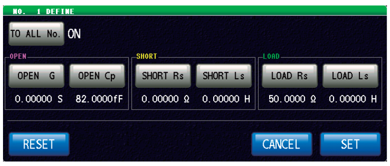
Measurement frequency

Changing the display of reference values and measured values

[VAL > DEF]	Reference value display
[VAL > MEAS]	Measured value display

Press **[AD DEF]**, **[DC DEF]** to change the calibration definition values.

Example: **[AD DEF]**

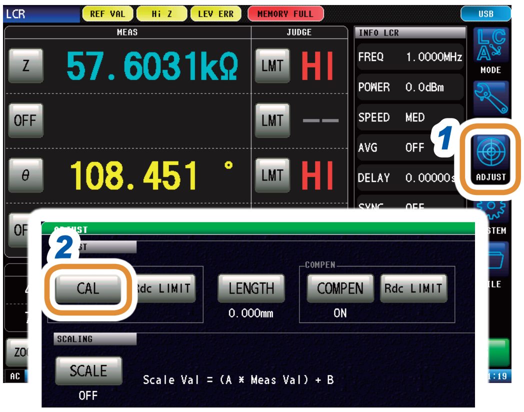


5.2 Calibration

5.2.1 Setting the Calibration [CAL]

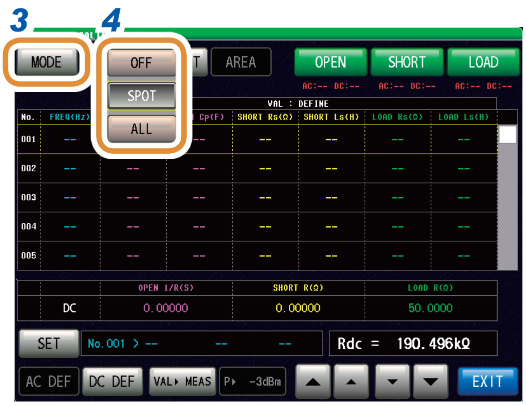
The errors between the measurement instrument and the calibration reference surface are eliminated.

Connect the three types of standard units (open/short/load) one by one with the reference surface (terminal) to be calibrated, and obtain respective measurements.
In case of DC resistance measurements, if different standard units are used, perform AC measurement and DC measurement separately.
To avoid improper connection of the three types of standard units (open/short/load), judgment can be made by setting the limit with DC measurement.
See “Prevention of improper standard unit connection” (p. 150).
When calibration is performed with the terminal connected to the test sample, electric length compensation, open compensation, and short compensation are not necessary.



1 **Press [ADJUST].**

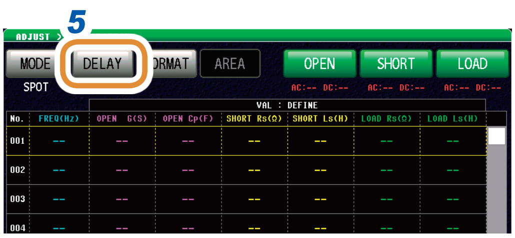
2 **Press [CAL].**



3 **Press [MODE].**

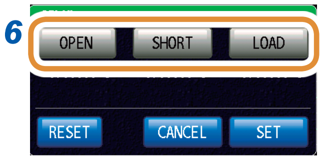
4 **Selects the calibration method.**

[OFF]	Calibration is not performed.
[SPOT]	Acquires the compensation values at the set measurement frequencies. LCR mode: Measurement frequencies can be set for up to five points. ANALYZER mode: Linked to the sweep points (MAX 801 points).
[ALL]	Acquires all the calibration of measurement frequencies (LCR mode) in a batch.



5 **Press [DELAY].**

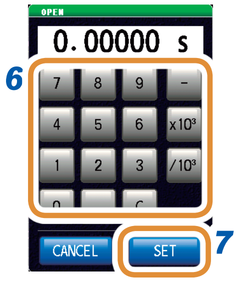
Go to the next page.



6 **For each of [OPEN], [SHORT], and [LOAD], the offset delay values* of a random calibration kit is set with the numeric keypad.**

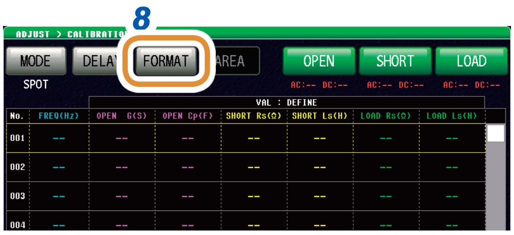
[RESET]	The set value becomes 0.
[CANCEL]	Cancels the setting.

Example: In case of **[OPEN]**



7 **Press [SET].**

[C]	The numerical value is entered again.



8 **Press [FORMAT].**

9 **Select the input parameter pattern for the reference value set by [OPEN], [SHORT], and [LOAD] respectively.**
See "3.2.1 Setting Display Parameters" (p. 32).

[OPEN]	G-Cp, G-B
[SHORT]	Rs-Ls, Rs-X
[LOAD]	Z-θ, Cs-D, Rs-Cs, Cp-D, Rp-Cp, Ls-Q, Rs-Ls, Lp-Q, Rp-Lp, Rs-X

10 **Press [EXIT] to close the setting screen.**

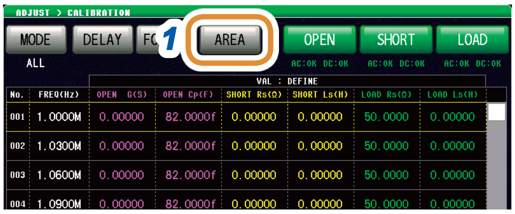
What is an offset delay value?
The offset delay value is the one-way propagation time (s) from the calibration surface of the standard unit to the definition surface. It affects the definition value. Use the value provided in the calibration kit specifications.

Limiting the calibration range

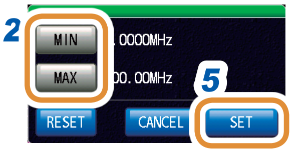
(This is set only when the calibration method [ALL] is selected in step 4.)

In ALL calibration, calibration is performed for the entire frequency range.
By setting the minimum and maximum frequencies in ALL calibration, the time required for calibration can be reduced.

- The calibration range setting is common with **[COMPEN]** (Compensation).
- If the maximum calibration frequency is lower than the minimum calibration frequency, the minimum calibration frequency and the maximum compensation frequency will be automatically interchanged.



1 **Press [AREA].**



2 Select the minimum or maximum calibration frequencies.

[MIN]	Sets the minimum calibration frequency.
[MAX]	Sets the maximum calibration frequency.

[RESET]	Returns to the default value. (MIN: 1 MHz, MAX: 300 MHz)
[CANCEL]	Cancels the setting.

3 The frequency is set with the numeric keypad.

4 Press **[Hz]**.
- The frequency does not get confirmed until the instrument key (**[Hz]**) is pressed.
- If the value is set to more than 300 MHz:
  The value is automatically set to 300 MHz.
- If the value is set to less than 1 MHz:
  The value is automatically set to 1 MHz.

5 **Press [SET] to close the setting screen.**

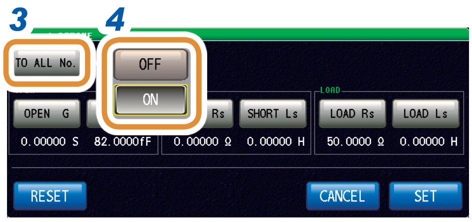
Setting the reference value

1 **Use ▲/▼ or scroll to select the item to be changed.**

2 **To change the reference value for AC measurement:**
Press [AC DEF].

To change the reference value for DC measurement:
Press [DC DEF].

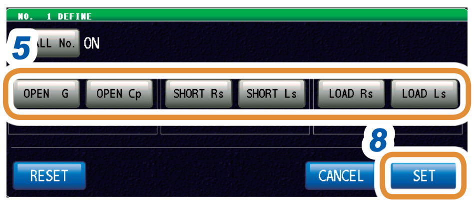
When the list does not display the reference value (When the display at the top of the list is not **VAL:DEFINE**), press **[VAL▶DEF]** to change the display.

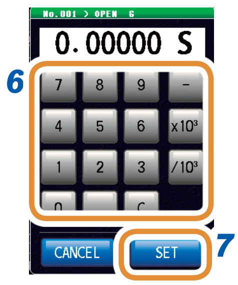


3 **Press [TO ALL No.].**
(Only for **[AC DEF]**)

4 **Select ON/OFF.**

[OFF]	Sets the reference value only for the calibration No. currently being set.
[ON]	Sets the same definition value for all calibration points.





5 **Select the reference value to be changed.**

6 **Set the definition value with the numeric keypad.**

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

7 **Press [SET].**

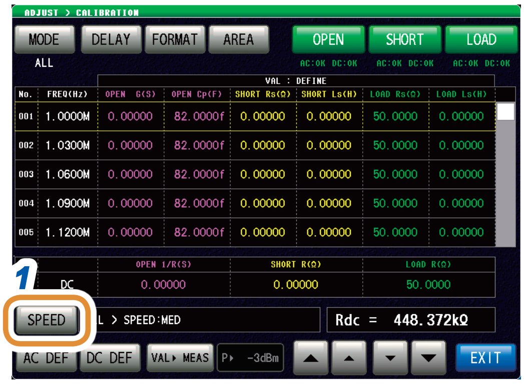
8 **Press [SET] to close the setting screen.**

What is a reference value?
The reference value is the defined value in the calibration kit, or the value of a known reference sample.

Setting the measurement conditions

This setting is possible only in LCR mode.
In ANALYZER mode, sweep setting conditions are set automatically.

ALL calibration



1 Press **[SPEED]**.

2 Select the calibration speed.

3 Press **[SET]**.

SPOT calibration

1 Use ▲/▼ or scroll to select the item to be changed.

2 Press **[SET]**.

3 Press **[FREQ]**, **[LEVEL]**, **[SPEED]** to perform each setting.

[GET]	The numerical value is entered again.
[RESET]	Cancels the setting.
[CANCEL]	Cancels the setting, and closes the screen.

4 Press **[SET]** to close the setting screen.

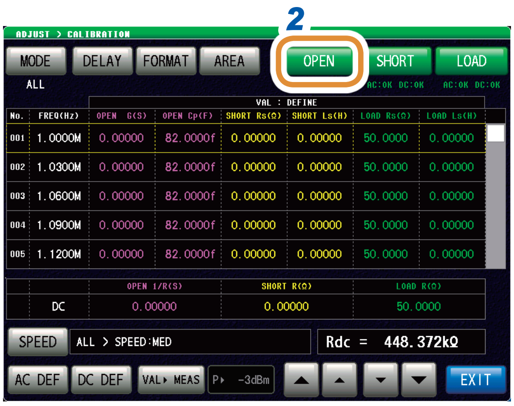
5

Calibration and Compensation

Perform measurement

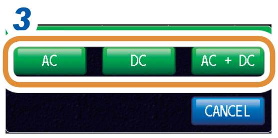
Performs the calibration measurement.
To avoid improper connection of the standard units, perform “Prevention of improper standard unit connection” (p. 150) setting in advance.

Open measurement



1 **Connects the standard unit for open to the test sample connection terminal.**

2 **Press [OPEN].**



3 **Press [AC + DC].**
Starts measurement.

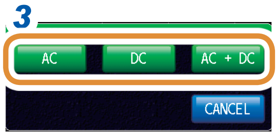
If the standard unit used in AC measurement is different from that the one used in DC measurement, press **[AC]**, **[DC]**.
The results are displayed under **[OPEN]** after completion of measurement.

[CANCEL]	Cancels the setting, and closes the screen.

Short measurement

1 **Connect the standard unit for short to the test sample connection terminal.**

2 **Press [SHORT].**



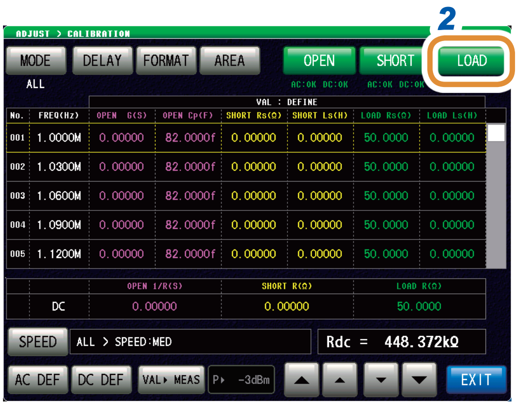
3 Press [AC + DC].

Starts measurement.

If the standard unit used in AC measurement is different from that the one used in DC measurement, press [AC], [DC].
The results are displayed under [SHORT] after completion of measurement.

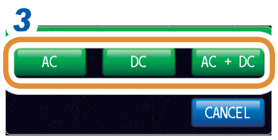
[CANCEL]	Cancels the setting, and closes the screen.

Load measurement



1 Connect the standard unit for load to the test sample connection terminal.

2 Press [LOAD].



3 Press [AC + DC].

Starts measurement.

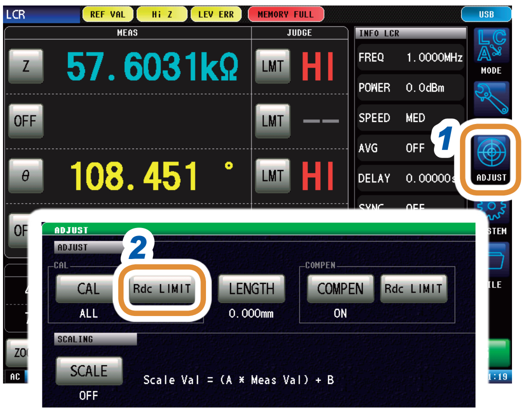
If the standard unit used in AC measurement is different from that the one used in DC measurement, press [AC], [DC].
The results are displayed under [LOAD] after completion of measurement.

[CANCEL]	Cancels the setting, and closes the screen.

Prevention of improper standard unit connection

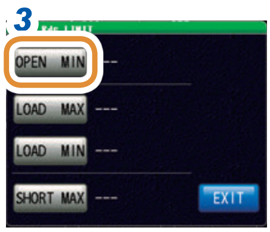
To avoid improper connection of the three types of standard units (open/short/load), judgment can be made by setting the limit with DC measurement.
During calibration measurement, if the limit values are set, exceeding the limit will result in an error, and the calibration measurement will be stopped.
In case of an error, check that an appropriate standard unit is connected.

> If the standard unit having a coaxial structure like the calibration kit is to be connected, connect the standard unit by rotating the connector nut of the standard unit. The standard unit and the central conductor of the connector will get damaged if the standard unit itself is rotated and connected.



1 Press **[ADJUST]**.

2 Press **[Rdc LIMIT]**.



3
(1) **Press [OPEN MIN].**

(2) **Set the limit values with the numeric keypad*.**

Settable range	-9.99999 G to 9.99999 G

(3) **Press [SET] to close the setting screen.**

During open calibration measurement, an error occurs if the DC measured value falls below this limit, and the measurement is stopped.

4
(1) **Press [LOAD MAX].**

(2) **Set the limit values with the numeric keypad*.**

Settable range	-9.99999 G to 9.99999 G

(3) **Press [SET] to close the setting screen.**

During load calibration measurement, an error occurs when the DC measured value exceeds this limit, and the measurement is stopped.

Go to the next page.

5 **(1) Press [LOAD MIN].**

(2) Set the limit values with the numeric keypad*.

Settable range	-9.99999 G to 9.99999 G

(3) Press [SET] to close the setting screen.

During load calibration measurement, an error occurs if the DC measured value falls below this limit, and the measurement is stopped.

6 **(1) Press [SHORT MAX].**

(2) Set the limit values with the numeric keypad*.

Settable range	-9.99999 G to 9.99999 G

(3) Press [SET] to close the setting screen.

During short calibration measurement, an error occurs when the DC measured value exceeds this limit, and the measurement is stopped.

7 **Press [EXIT] to close the setting screen.**

* Each common numeric keypad

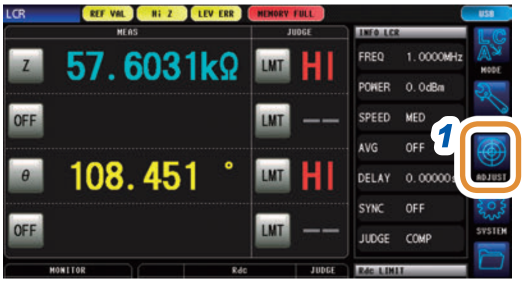
[-]	Inputs the unit with a minus (-) sign.
[×10³]	Increases the prefix of the unit.
[/10³]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

5.2.2 Setting the Electric Length [LENGTH]

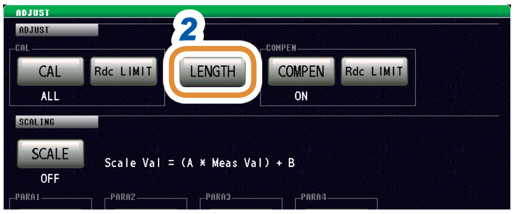
Compensation is performed for the error caused by the phase shift occurring between the calibration reference surface and the measurement sample connection surface.

Enter the electric length between the calibration reference surface on which open calibration, short calibration, and load calibration were performed for the surface where the measurement sample is connected.

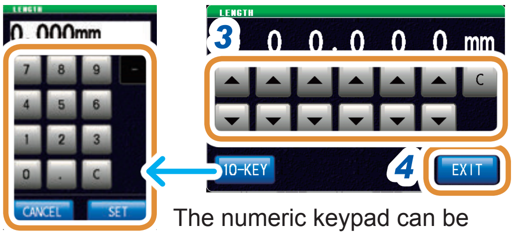
The guaranteed accuracy range differs depending on the electric length.
See “Electrical length compensation” (p. 279).



1 **Press [ADJUST].**



2 **Press [LENGTH].**



The numeric keypad can be used for input.

3 **Set the electric length with ▲/▼ or the numeric keypad.**
(when the numeric keypad is used, press [SET].)

[C]	Repeats the input.
[CANCEL]	Cancels the setting.

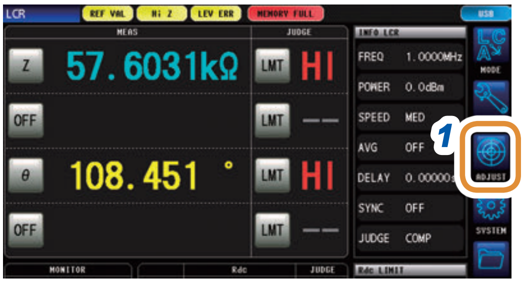
4 **Press [EXIT] to close the setting screen.**

5.3 Error Compensation

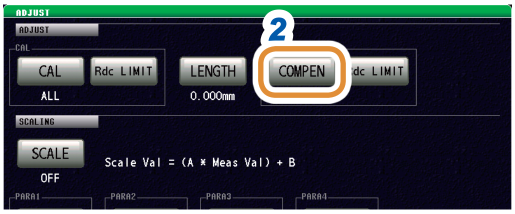
5.3.1 Setting the Compensation [COMPEN]

The errors between the calibrated calibration reference surface and the measurement terminal are eliminated.

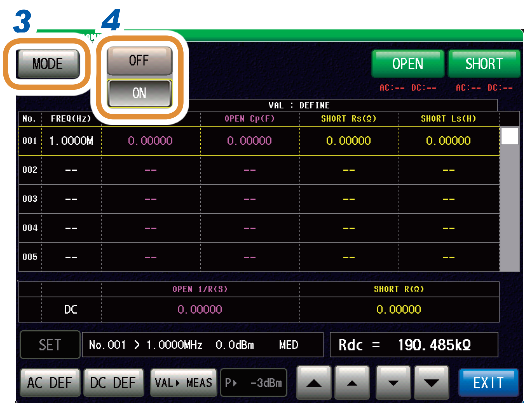
When the test sample is connected to the measurement terminal extended from the calibration reference surface on which open calibration, short calibration, and load calibration were performed, perform the measurement when the terminal to connect the test sample is shorted and opened respectively.



1 **Press [ADJUST].**



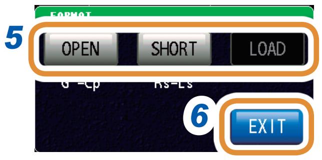
2 **Press [COMPEN].**



3 **Press [MODE].**

4 **Selects the compensation method.**

[OFF]	Compensation is not performed.
[ON]	Performs compensation. The points of compensation are the same as those of [CAL] calibration.



5 **Select the input parameter pattern for the reference value set by [OPEN] and [SHORT] respectively.**
See "3.2.1 Setting Display Parameters" (p. 32).

[OPEN]	G-Cp, G-B
[SHORT]	Rs-Ls, Rs-X

6 **Press [EXIT] to close the setting screen.**

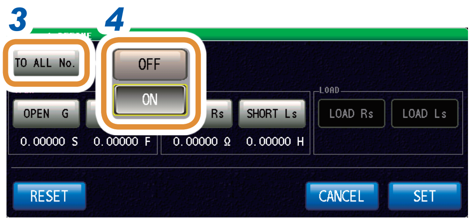
Set the reference value

1 **Use ▲/▼ to select the item to be changed.**
(AC measurement)

2 **To change the reference value for AC measurement:**
Press [AC DEF].

To change the reference value for DC measurement:
Press [DC DEF].

When the list does not display the reference value (When the display at the top of the list is not **VAL:DEFINE**), press **[VAL▶DEF]** to change the display.



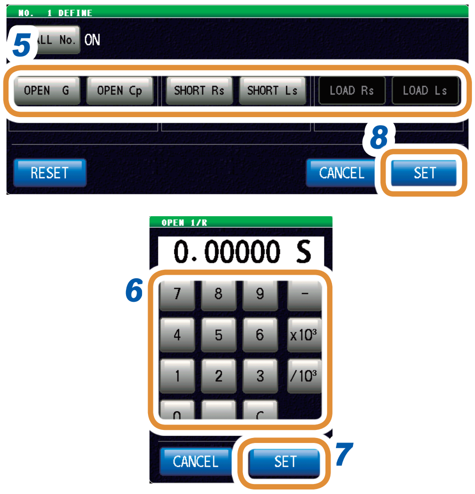
3 **Press [TO ALL No.].**
(Only for **[AC DEF]**)

4 **Select ON/OFF.**

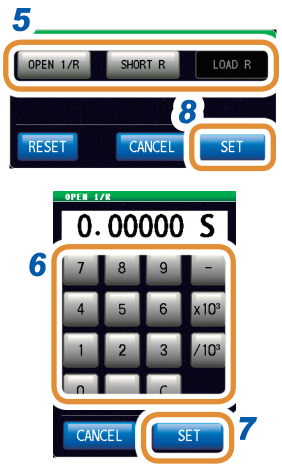
[OFF]	Sets the reference value only for the compensation No. currently being set.
[ON]	Sets the same definition value for all compensation points.

Go to the next page.

[AC DEF]



[DC DEF]



5 **Select the reference value to be changed.**

6 **Set the definition value with the numeric keypad.**

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

7 **Press [SET].**

8 **Press [SET] to close the setting screen.**

[RESET]	The reference value becomes 0.
[CANCEL]	Closes the screen without making the setting.

5

Calibration and Compensation

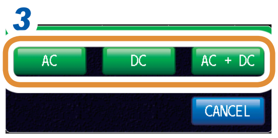
Perform measurement

Performs compensation measurement.
To avoid improper connection of the standard units, perform “Prevention of Improper Standard Unit Connection” setting in advance.

Open measurement

1 **Connects the standard unit for open to the test sample connection terminal.**

2 **Press [OPEN].**



3 **Press [AC + DC].**
Starts measurement.

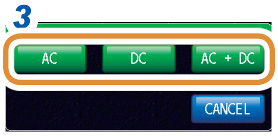
If the standard unit used in AC measurement is different from that of DC measurement, press **[AC]**, **[DC]**.
The results are displayed under **[OPEN]** after completion of measurement.

[CANCEL]	Cancels the setting, and closes the screen.

Short measurement

1 **Connect the standard unit for short to the test sample connection terminal.**

2 **Press [SHORT].**



3 **Press [AC + DC].**
Starts measurement.

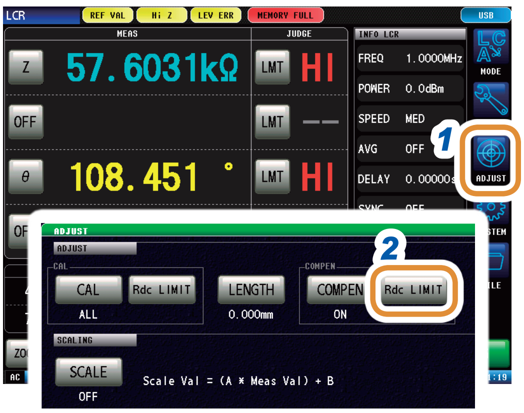
If the standard unit used in AC measurement is different from that of DC measurement, press [AC], [DC].
The results are displayed under [SHORT] after completion of measurement.

[CANCEL]	Cancels the setting, and closes the screen.

Prevention of improper standard unit connection

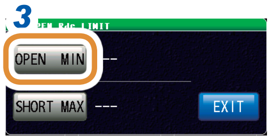
To avoid improper connection of the two types of standard unit (open/short), judgment can be made by setting the limit with DC measurement.
During compensation measurement, if the limit values are set, exceeding the limit will result in an error, and the compensation measurement will be stopped.
In case of an error, check that an appropriate standard unit is connected.

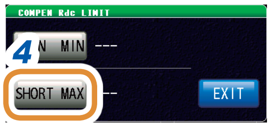
> If the standard unit having a coaxial structure like the calibration kit is to be connected, connect the standard unit by rotating the connector nut of the standard unit. The standard unit and the central conductor of the connector will get damaged if the standard unit itself is rotated and connected.



1 **Press [ADJUST].**

2 **Press [Rdc LIMIT].**





* Each common numeric keypad

[-]	Inputs the unit with a minus (-) sign.
[$\times 10^3$]	Increases the prefix of the unit.
[$/10^3$]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

3

(1) **Press [OPEN MIN].**

(2) **Set the limit values with the numeric keypad*.**

Settable range	-9.99999 G to 9.99999 G

(3) **Press [SET] to close the setting screen.**

During open calibration measurement, an error occurs if the DC measured value falls below this limit, and the measurement is stopped.

4

(1) **Press [SHORT MAX].**

(2) **Set the limit values with the numeric keypad*.**

Settable range	-9.99999 G to 9.99999 G

(3) **Press [SET] to close the setting screen.**

During short calibration measurement, an error occurs when the DC measured value exceeds this limit, and the measurement is stopped.

5 **Press [EXIT] to close the setting screen.**

5.4 Calculating Values (Scaling)

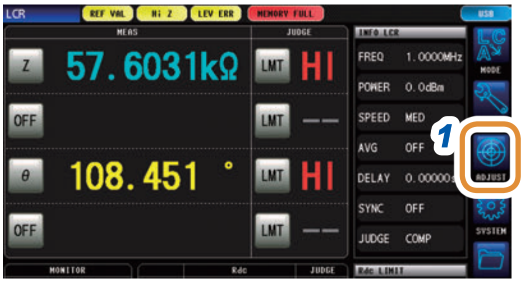
Scaling function applies compensation to the measured value. This function can be used to provide compatibility between measurement instruments.
Set the compensation coefficients a and b for the measured values of the first to fourth parameters and compensates with the following formula.
Refer to “Appx. 1 Measurement Parameters and Calculation Formula” (p. A1)

$Y = a \times X + b$

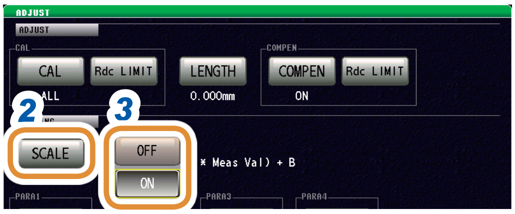
However, if the parameter corresponding to X is either D or Q, scaling is applied to θ as shown in the following formula, and D or Q is obtained from θ'.

$\theta' = a \times \theta + b$

X: Parameter measured value
Y: Last measured value
θ': Compensation value of θ
a: Integration value of the measured value X
b: The value added to measured value X



1 **Press [ADJUST].**



2 **Press [SCALE].**

3 **Select [ON].**

[OFF]	Disables the setting of scaling.
[ON]	Enables the setting of scaling.

4 **Press [A], [B] for each parameter to be changed.**

Go to the next page.

5
Calibration and Compensation

5


Changing the unit: **a**/**f**/**p**/**n**/**μ**/**m**/None/**k**/**M**/**G**

5 Set each compensation coefficient with the numeric keypad, and press [SET].

Settable range	A: -999.999 to 999.999 B: -9.99999 G to 9.99999 G

To return to the previous screen without changing the setting value, press **[SET]** when the screen is blank (the state after **[C]** is pressed).

[-]	Inputs the unit with a minus (-) sign.
[×10^3]	Increases the prefix of the unit.
[/10^3]	Decreases the prefix of the unit.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

6 Press [EXIT] to close the setting screen.

[RESET]	Will be set to the default value. (A: 1, B: 0)

- If the same parameter is selected multiple times and a different compensation coefficient is set for each of them, the compensation coefficient of the parameter with the smallest number is used to perform scaling for the parameters of all the parameter numbers. (The compensation coefficients of the other parameter numbers become invalid.)
- In case of the following settings, scaling is performed using the compensation coefficient of parameter 1 for “Z” of parameters 1, 2, and 4. (The compensation coefficients of parameters 2 and 4 become invalid.)
  Reference value 1

Display Parameter Setting	Compensation Coefficient Setting
Parameter 1: Z	a = 1.500, b = 1.50000
Parameter 2: Z	a = 1.700, b = 2.50000
Parameter 3: θ	a = 0.700, b = 1.00000
Parameter 4: Z	a = 1.900, b = 3.50000

5.5 Troubleshooting of Compensation

When an error occurs in calibration or compensation measurement

If **[RdcLIMIT]** has been set, an error occurs during measurement when wrong standard units are connected. Check the type to execute (OPEN/SHORT/LOAD) with the standard unit.

In case of unusual measured values after compensation

Compensation may have been performed with wrong standard units connected during calibration and compensation.
See “Prevention of improper standard unit connection” (p. 150).

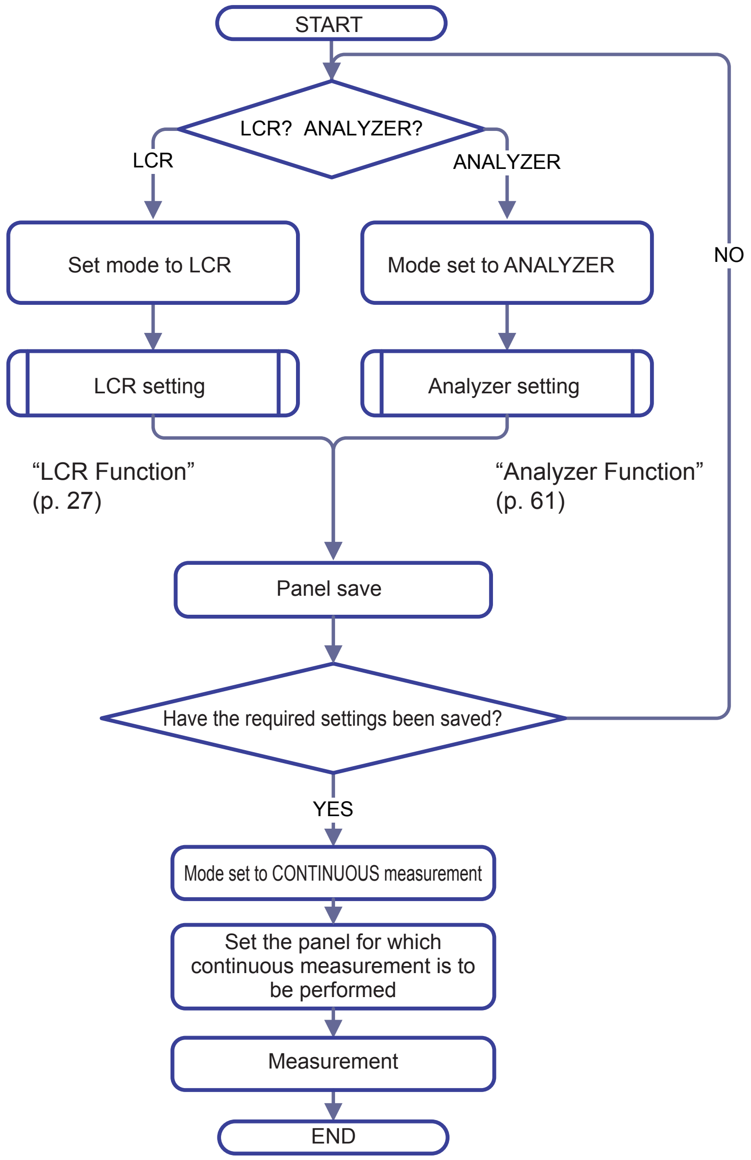
6 Continuous Measurement Function

6.1 Continuous Measurement Function

The continuous measurement function loads measurement conditions saved using the panel save function in order and performs a series of measurements. LCR mode and ANALYZER mode measurement conditions can be mixed.
Up to 46 continuous measurements can be performed. (LCR 30 items, Analyzer 16 items)
When the power is turned on again, measurement screen will be displayed in accordance with the measurement mode used before the power was turned off.

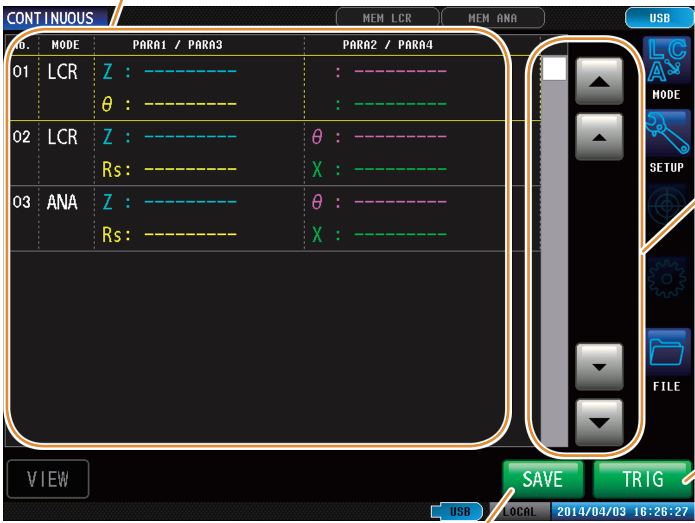
- Setting the measurement conditions so that the measurement frequency and measurement signal level differs for each panel enables simple characteristic evaluation of the test sample.
- Continuous measurement can also be performed from an EXT I/O. (p. 195)
- If the power is cut off when the [Continuous measurement screen] is displayed, the [Continuous measurement screen] will be displayed when the instrument starts the next time you turn the power on.

Operation flow



Measurement screen

Displays a list of panels for which continuous measurement is to be performed.



Scrolls the list.

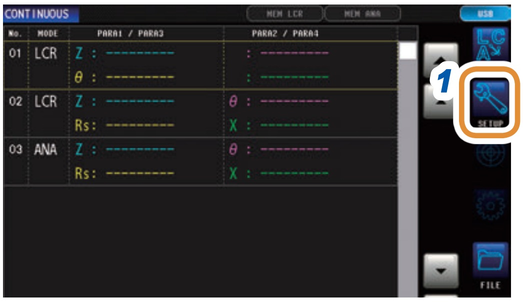
Starts continuous measurement.

Saves the measurement data. (p. 180)

[SAVE] will not be displayed without save settings and if a USB flash drive is not inserted.

6.2 Configuring Continuous Measurement Basic Settings

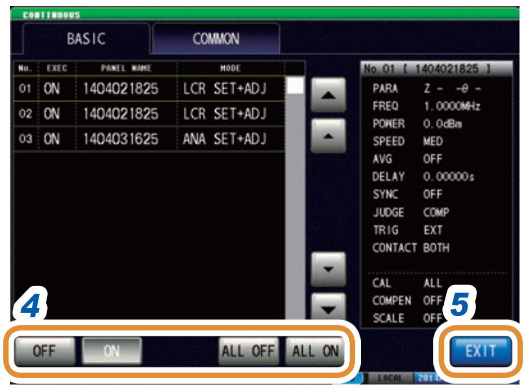
Set the panels targeted for continuous measurement before performing continuous measurement.
Save the measurement conditions with the panel save function in LCR mode or ANALYZER mode in advance.
See "9.1 Saving Measurement Conditions (Panel Save Function)" (p. 224).



1 **Press [SETUP].**

2 **Press [BASIC] tab.**
A list of the measurement conditions saved with LCR mode and ANALYZER mode is displayed.
Panels for which only the compensation value (ADJ) was saved are not displayed.

3 **Use ▲/▼, or scroll to select the panel for continuous measurement.**



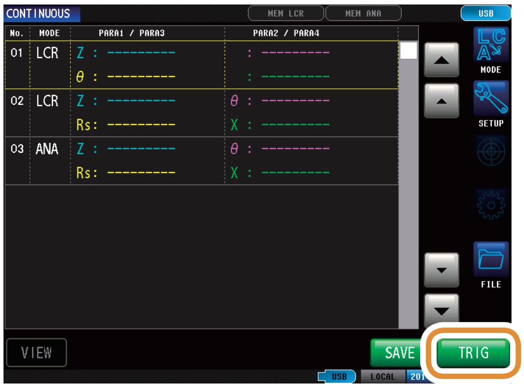
4 **Select the display method.**

[OFF]	Removes the selected panel from the target of continuous measurement.
[ON]	Sets the selected panel as a target for continuous measurement.
[ALL OFF]	Removes all panels from the target of continuous measurement.
[ALL ON]	Sets all panels as targets for continuous measurement.

5 **Press [EXIT].**

6.3 Executing and Stopping Continuous Measurement

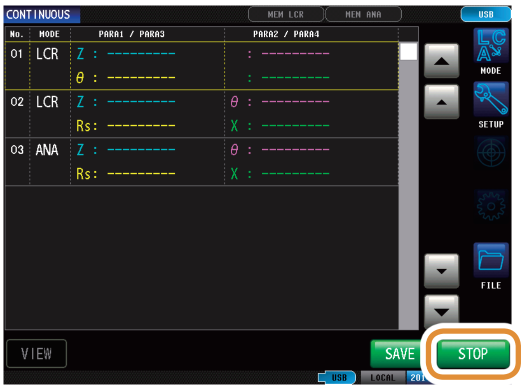
Executing



Panels that were set to **[ON]** in the setting screen are displayed in a list.

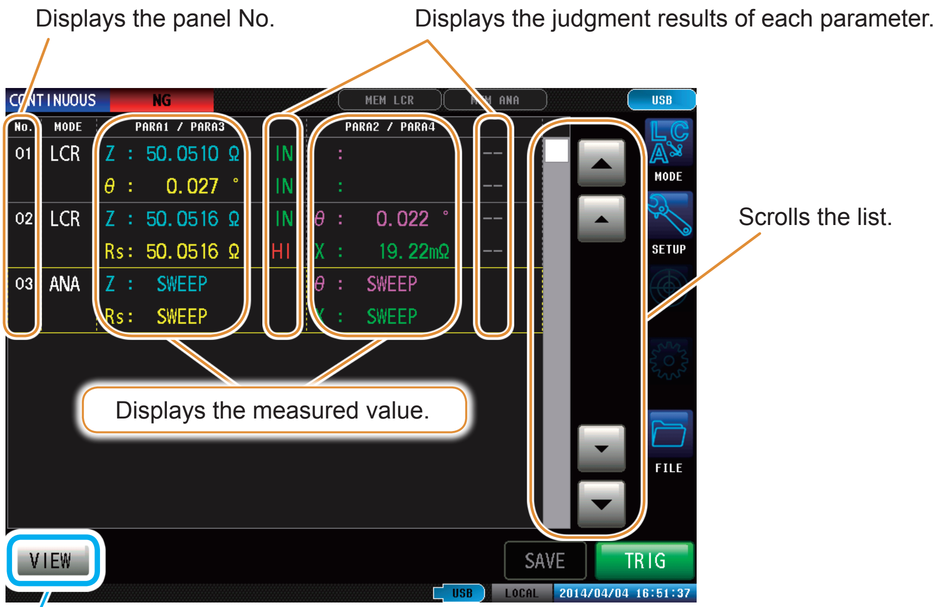
Press [TRIG].

Stop



Press [STOP].

6.4 Checking Continuous Measurement Results



[VIEW]	LCR	Displays the measurement results and measurement conditions.
	ANALYZER	Displays the measurement results in a graph.

Example: To check measurement results in ANALYZER mode with waveforms

Select the ANALYZER mode panel with ▲/▼ and press [VIEW].

To return to the list of measurement results: Press [RETURN].

6.5 Continuous Measurement Application Settings

6.5.1 Cancels the Measurement if an Error is Detected

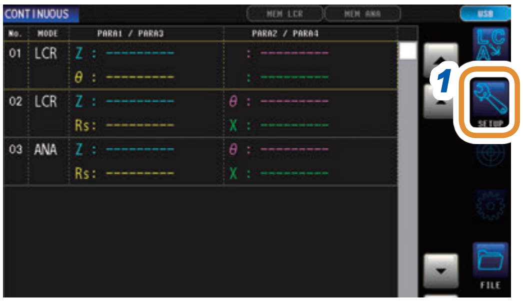
When an error is detected during continuous measurement, select whether to cancel or continue the measurement.
The measurement will be canceled if the set judgment functions of the panel satisfy the following conditions.

LCR mode

- The comparator or BIN is enabled.
- If the judgment result is Fail (HI/LO/OUT).

ANALYZER mode

- Area judgment or peak judgment is enabled.
- If the judgment result is fail (HI/LO/OUT).



1 **Press [SETUP].**

2 **Press [COMMON] tab.**

3 **Press [ERR ABORT].**

4 **Select OFF/ON.**

[OFF]	Continuous measurement is performed for all panels, irrespective of the judgment results.
[ON]	The continuous measurement is canceled when the judgment result is Fail.

5 **Press [EXIT].**

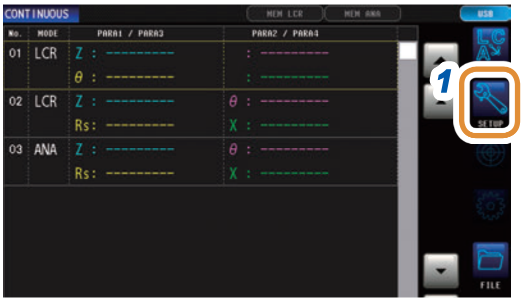
When the contact check function has been set, the measurement will be canceled irrespective of the settings mentioned above when all four of the following conditions apply.
See "7.1 Checking Contact Defects and the Contact State (Contact Check Function)" (p. 169).
- If the contact check timing has been set to **[BEFORE]** or **[BOTH]**.
- If LIMIT has been set.
- If ERR ABORT has been set to ON.
- If LIMIT judgment detected an error at the timing of BEFORE.

6

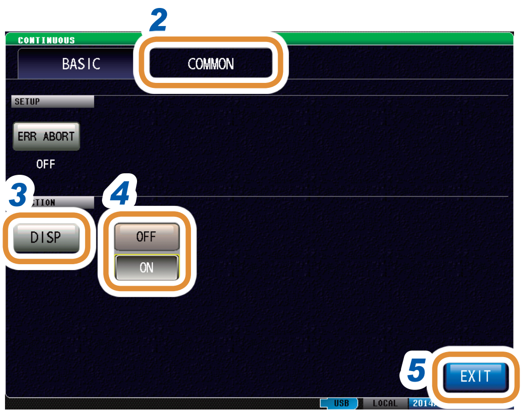
Continuous Measurement Function

6.5.2 Setting the LCD Display to ON/OFF

LCD display can be set to ON/OFF.
Setting the LCD display to **[OFF]** saves power because the LCD display is switched off if the panel is idle for approximately 10 seconds.



1 **Press [SETUP].**



2 **Press [COMMON] tab.**

3 **Press [DISP].**

4 **Select the LCD display setting.**

[OFF]	Turns OFF the LCD display. LCD display turns off after approximately 10 seconds has elapsed since the touch panel was last touched.
[ON]	Sets the LCD display to always on.

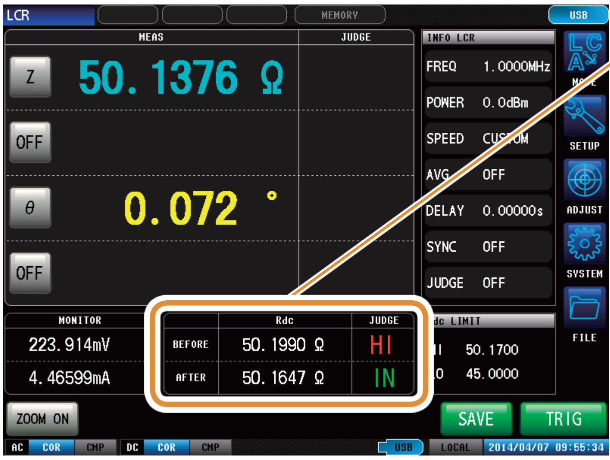
If you want to turn the back light on again:
If you touch the touch panel while the back light is off, the back light will turn on again.

5 **Press [EXIT].**

7 Application Function

7.1 Checking Contact Defects and the Contact State (Contact Check Function)

This function checks contact defects and the contact state.
This function allows you to detect contact defects between the terminals and the sample during 2-terminal measurement.



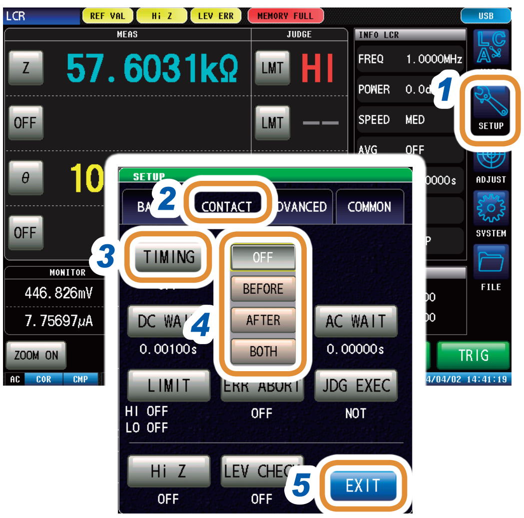
Judgment results for BEFORE and AFTER are displayed respectively.

HI	Measured value > upper limit
IN	Upper limit value ≥ measured value ≥ lower limit value
LO	Measured value < lower limit
- - -	If reference standards have not been set

7.1.1 Setting the DC Measurement

DC measurement is performed to verify the contact check before starting L measurement.

Set the check timing



Measurement time varies with the measurement conditions.
See “12.3 Measurement Time” (p. 290).

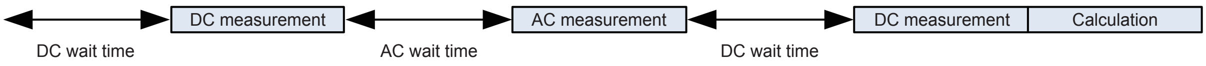
1. **Press [SETUP].**
2. **Press [CONTACT] tab.**
   Press [SWEEP] tab for the ANALYZER mode.
3. **Press [TIMING].**
4. **Selects the timing at which to perform contact check operation.**

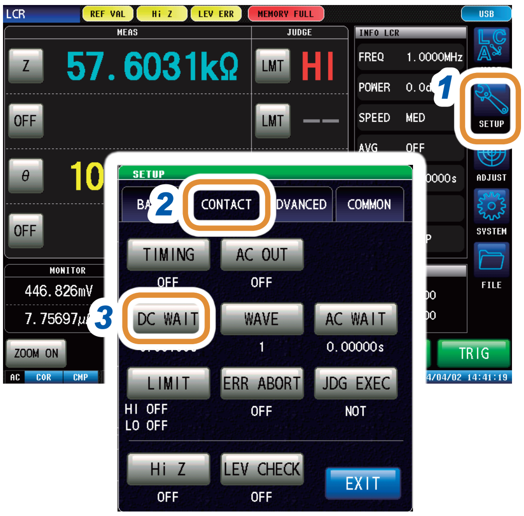
[OFF]	Disables the contact check function.
[BEFORE]	Performs a contact check before measuring the test sample.
[AFTER]	Performs a contact check after measuring the test sample.
[BOTH]	Performs a contact check before and after measuring the test sample.

5. **Press [EXIT] to close the setting screen.**

Set the wait time

Incorporates the wait time for switching the measurement.

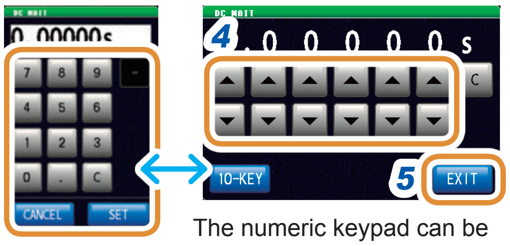




1 Press **[SETUP]**.

2 Press **[CONTACT]** tab.
Press **[SWEEP]** tab for the ANALYZER mode.

3 Press **[DC WAIT]**.



The numeric keypad can be used for input.

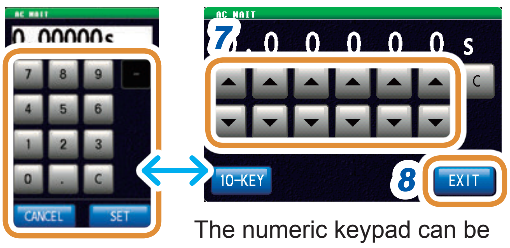
4 Set the wait time for switching the measurement with ▲/▼ or the numeric keypad.
(With the numeric keypad, press **[SET]**.)

Settable range	0.00000 s to 9.99999 s

[C]	Sets to the default value. (The time is set to 0.001 s.)

5 Press **[EXIT]** to close the setting screen.

6 Press **[AC WAIT]**.



The numeric keypad can be used for input.

7 Set the wait time for switching the measurement with ▲/▼ or the numeric keypad.
(With the numeric keypad, press **[SET]**.)

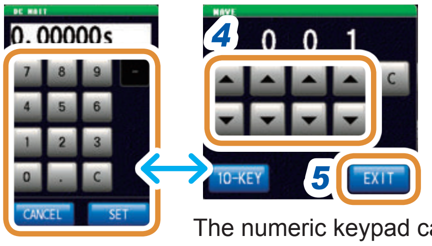
Settable range	0.00000 s to 9.99999 s

8 Press **[EXIT]** to confirm the setting.

9 Press **[EXIT]** to close the setting screen.

Set the number of samples

1. Press [SETUP].
2. Press [CONTACT] tab.
   Press [SWEEP] tab for the ANALYZER mode.
3. Press [WAVE].



The numeric keypad can be used for input.

4. Set the value with ▲/▼ or the numeric keypad.
   (With the numeric keypad, press [SET].)

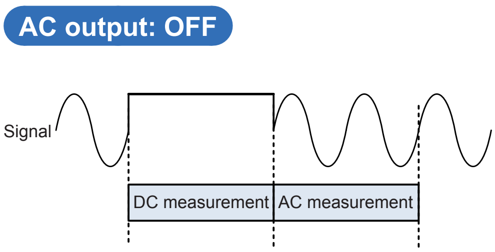
Settable range	1 to 9,999

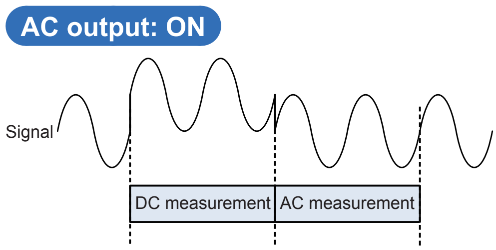
[C]	Sets to the default value. (The time is set to 1.)

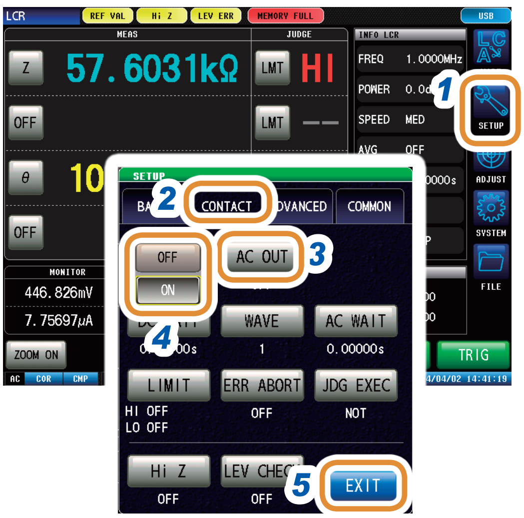
5. Press [EXIT] to close the setting screen.

Set the AC output

The AC signal is superimposed during DC measurement.







1. Press [SETUP].
2. Press [CONTACT] tab.
   Press [SWEEP] tab for the ANALYZER mode.
3. Press [AC OUT].
4. Select ON/OFF for the AC output.

[OFF]	Disables the AC output.
[ON]	Enables the AC output.

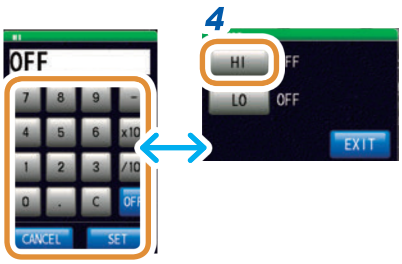
5. Press [EXIT] to close the setting screen.

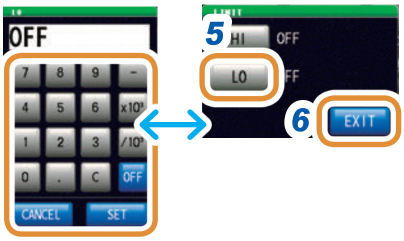
7.1.2 Setting the Judgment

1 **Press [SETUP].**

2 **Press [CONTACT] tab.**
Press [SWEEP] tab for the ANALYZER mode.

3 **Press [LIMIT].**
Sets the judgment reference value.





4 **Press [HI].**
Set the upper limit value with the numeric pad and press [SET].

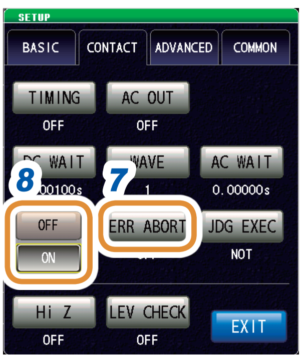
Settable range	-9.99999 G to 9.99999 G

[-]	Inputs the unit with a minus (-) sign.
[$\times 10^3$]	Increases the prefix of the unit.
[$/10^3$]	Decreases the prefix of the unit.
[OFF]	Value is not set.
[C]	Repeats the input.
[CANCEL]	Cancels the setting.

5 **Press [LO] in the same way as step 4.**
Use the numeric keypad to set the lower limit value and press [SET].

Settable range	-9.99999 G to 9.99999 G

6 **Press [EXIT] to close the setting screen.**

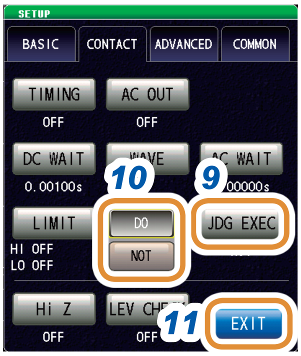


7 **Press [ERR ABORT].**

8 **If an error is detected during judgment, select whether to stop or continue the measurement.**

[OFF]	If an error is detected during judgment, the measurement will not be canceled.
[ON]	If an error is detected during judgment, the measurement will be canceled.

Go to the next page.



9 **Press [JDG EXEC].**

10 **If the DC measured value is UNCAL, select whether to perform a judgment or not.**

[DO]	Performs a judgment.
[NOT]	Judgment is not performed. The result is HI.

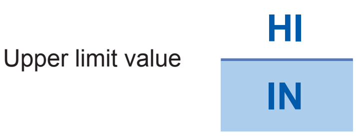
11 **Press [EXIT] to close the setting screen.**

Judgment order

Judgment order	Condition	Judgment display
1	In case of not calibrated (UNCAL)	HI
2	When judging if the measured value is higher than the lower limit value, and the judgment is Fail.	LO
3	When judging if the measured value is lower than the upper limit value, and the judgment is Fail.	HI
4	In case of other than 1, 2 and 3	IN

- When the measured value is not calibrated (**UNCAL**), judgment is performed according to the judgment order if **[JDG EXEC]** has been set as **[DO]**. HI judgment is returned without performing judgment if the setting is **[NOT]**.
- If you interchange the upper limit and lower limit values an error message will not be displayed because the upper and lower limit values are not compared.
- Judgment is possible even if only one of the upper or lower limit value has been set.

When only an upper limit value has been set



When only a lower limit value has been set

7.1.3 Detecting OPEN During 2-terminal Measurement (HIGH-Z Reject Function)

This function outputs a measurement terminal contact error when the measurement result is higher than the set judgment reference. The error is output via the measurement screen and EXT I/O. This error is output as **Hi Z** on the measurement screen. An error is detected when the measured value exceeds the setting value.
See “8 External Control” (p. 195).

1 Press **[SETUP]**.

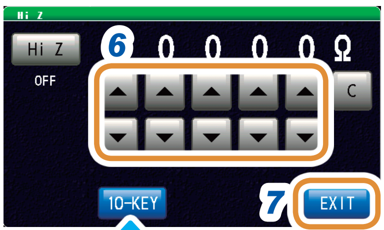
2 Press **[CONTACT]** tab.
Press **[SWEEP]** tab for the ANALYZER mode.

3 Press **[Hi Z]**.

4 Press **[Hi Z]**.

5 Select ON/OFF for the Hi Z reject function.

[OFF]	Disables the Hi Z reject function.
[ON]	Enables the Hi Z reject function.



6 Set the judgment reference value with ▲/▼.
(With the numeric keypad, press **[SET]**.)

Settable range	1 Ω to 10,000 Ω

[C]	Sets to the default value. (Set to 10,000 Ω.)

7 Press **[EXIT]** to close the setting screen.

The numeric keypad can be used for input.

7.1.4 Monitoring the Detection Level (Detection Level Monitoring Function)

This function can detect the abnormal measurement waveforms when there is contact between the test sample and the instrument by monitoring the variations in the r.m.s. value of voltage and the r.m.s. value of current. During analog measurement, the r.m.s. value of voltage and the r.m.s. value of current are calculated several times.
The first-calculated r.m.s. value of voltage and the r.m.s value of current are considered as the reference value respectively. The percentage Δ% of subsequent r.m.s. values of voltage and current relative to the reference value is computed using the following formula.

$$\Delta\% = \frac{\text{(r.m.s. value - Reference value)}}{\text{Reference value}} \times 100\ [\%]$$

An error is detected when Δ% is higher than the set limit value.

1 Press **[SETUP]**.

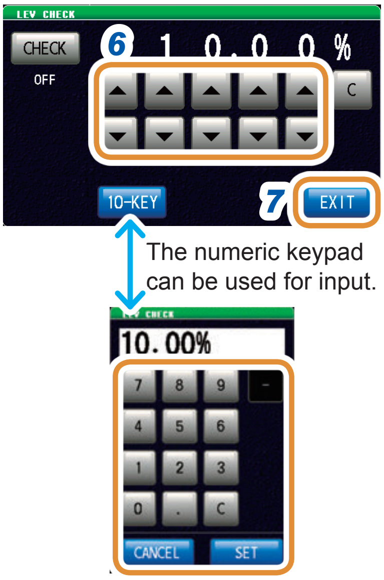
2 Press **[CONTACT]** tab.
Press **[SWEEP]** tab for the ANALYZER mode.

3 Press **[LEV CHECK]**.

4 Press **[CHECK]**.

5 Select ON/OFF for the detection level monitoring function.

[OFF]	Sets the detection level monitoring function to OFF.
[ON]	Sets the detection level monitoring function to ON.



6 **Enter the limit value with ▲/▼.**
Settable range: 0.01% to 100.00%

7 **Press [EXIT] to close the setting screen.**

If a detection level error is detected, “**LEV ERR**” is displayed at the top of the screen.

7.2 Other Functions

7.2.1 Setting the Number of Display Digits

Sets the number of display digits of the measured value.

1 Press **[SETUP]**.

2 Press **[ADVANCED]** tab.

3 Press **[DIGIT]**.

4 **Set the number of display digits with ▲/▼ (For each parameter).**

Settable range	3 to 6 digits

5 **Press [EXIT] to close the setting screen.**

Setting value	Parameters				
	θ	D	Q	Δ%	Other
6	Up to third decimal place	Up to fifth decimal place	Up to second decimal place	Up to third decimal place	Full 6 digits
5	Up to second decimal place	Up to fourth decimal place	Up to first decimal place	Up to second decimal place	Full 5 digits
4	Up to first decimal place	Up to third decimal place	Zero decimal place	Up to first decimal place	Full 4 digits
3	Zero decimal place	Up to second decimal place	Zero decimal place	Zero decimal place	Full 3 digits

The instrument may not be able to display minute values using the set number of display digits.

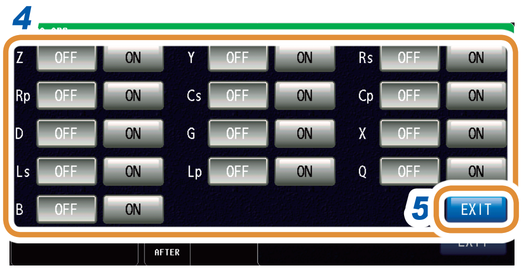
7.2.2 Setting Absolute Values Display (LCR only)

Measured values are displayed as absolute values. (θ excluded.)

1 **Press [SETUP].**

2 **Press [ADVANCED] tab.**

3 **Press [PARA ABS].**



4 Setting for each parameter.

[OFF]	Absolute values are not displayed (Negative values are displayed as negative values.)
[ON]	Absolute values are displayed.

5 **Press [EXIT] to close the setting screen.**

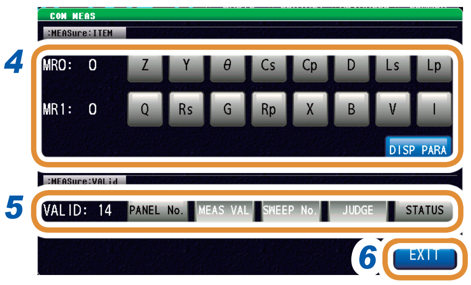
7.2.3 Setting the Communication Measurement Data Type

The types of measurement data to be acquired via communication are specified.
(See the Communication Commands Instruction Manual. **:MEASure:ITEM**, **:MEASure:VALid**)

1 Press **[SETUP]**.

2 Press **[ADVANCED]** tab.

3 Press **[COM MEAS]**.



4 **Select the parameters required for the measured value. (Multiple items can be selected.)**
(**:MEASure:ITEM** setting)

[DISP PARA]	Clears the setting. The measured values to be acquired in this case are the same as the parameters (maximum 4 items) set on the measurement screen.

5 **Select the necessary items for the measurement results. (Multiple items can be selected.)**
(**:MEASure:VALid** setting)

6 **Press [EXIT] to close the setting screen.**

7.3 Common Functions (LCR Mode, ANALYZER Mode)

These settings are common for LCR mode and ANALYZER mode.
These settings provide the same conditions to both modes.

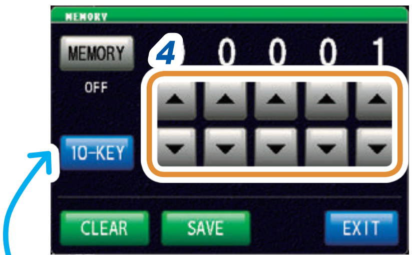
7.3.1 Saving Measurement Results (Memory Function)

The measurement results can be saved in the instrument (Up to 32,000 items for LCR, and 100 sweeps for ANALYZER).
The saved measurement results can be saved to a USB flash drive.
See “11.4.4 Saving Memory Data” (p. 258).
Saved data can also be acquired using a communication command.
The items saved to the memory are in accordance with the **:MEASure:VALid** setting. For details on how to acquire the saved measurement results or how to set **:MEASure:VALid**, refer to LCR Application Disk (Communication Commands).

1 **Press [SETUP].**

2 **Press [COMMON] tab.**
Press [ADVANCED] tab for the ANALYZER mode.

3 **Press [MEMORY].**



The numeric keypad can be used for input.

4 **Set the number of measurement results to save with ▲/▼.**

Settable range	1 to 32,000 (LCR mode) 100 fixed (ANALYZER mode)

Go to the next page.

5 **Press [MEMORY].**

6 **Select [ON]/[IN]/[OFF] from the memory function.**
If the comparator and BIN functions are not set, the operation of IN and ON will be the same.

[OFF]	Disables the memory function.
[IN] (LCR only)	Saves the measured values to the memory only when a pass judgment is made for all of the parameters judged with the comparator and BIN functions. (The measured values are not saved even if one of the comparator results is HI, LO, or the BIN result is OUT-OF-BINS.)
[ON]	Saves all measured values to memory.

[CLEAR]	Clears all the measured values saved in the instrument memory.
[SAVE]	Saves the measured values stored in the instrument memory to a USB flash drive and then clears the measured values from the instrument memory. The measured values are saved to the “MEMORY” folder in the USB flash drive. The file name is automatically assigned from the date and time.

7 **Press [EXIT] to close the setting screen.**

- If the memory function is enabled ([ON]/[IN]), the number of memory items currently saved is displayed in the measurement screen.
  See 

  “13.4 Error Display” (p. 303).
- Save the measurement results stored in the instrument to a USB flash drive or acquire them with the `:MEMory?` command.
- The internal data is lost if the memory function setting is changed.
- The following message appears on the measurement screen when the instrument memory becomes full. If this message appears, subsequent measured values will not be saved. To resume saving, transfer or clear the measured values from the instrument memory.
  

  See “13.4 Error Display” (p. 303).
- If the contact check function has been set, the measured value will not be saved if all four of the following conditions apply.
  Refer to “7.1 Checking Contact Defects and the Contact State (Contact Check Function)” (p. 169)
  - If the contact check timing has been set to [BEFORE] or [BOTH].
  - If LIMIT has been set.
  - If ERR ABORT has been set to ON.
  - If LIMIT judgment detected an error at the timing of BEFORE.

7.3.2 Setting the Screen Display

Set the screen display back light ON/OFF (p. 182)

[OFF]	Turns OFF the LCD display. LCD display turns off after approximately 10 seconds has elapsed since the touch panel was last touched.
[ON]	Sets the LCD display to always on.

Set the background color of the screen. (p. 183)

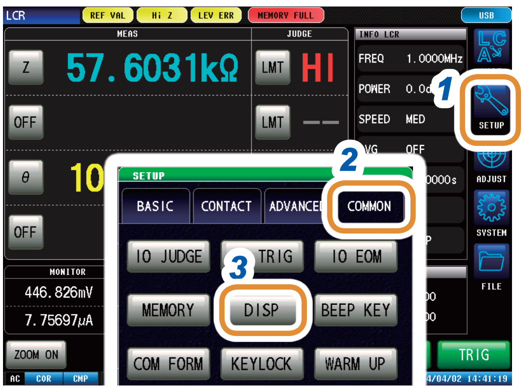
[BLACK]	[WHITE]
Sets the background color of the screen to black. 	Sets the background color of the screen to white. 

Set the waveform and the graph color for each parameter. (p. 184)
Settable number of colors: 25

Set the screen brightness. (p. 183)
Setting range: 0 to 250

Setting the screen display back light ON/OFF

You can turn the LCD display ON/OFF.
Setting the screen display to **[OFF]** saves power because the screen display turns off if the panel is not touched for 10 seconds.



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
(Press [ADVANCED] tab for the ANALYZER mode.)

3 **Press [DISP].**

4 **Press [DISP].**

5 **Select the screen display setting ON/OFF.**

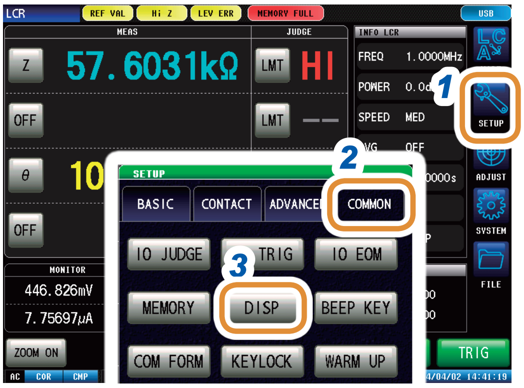
[OFF]	Turns OFF the LCD display. The screen display turns off after approximately 10 seconds has elapsed since the touch panel was last touched.
[ON]	Sets the screen to always on.

If you want to turn the back light on again:

If you touch the touch panel while the back light is off, the back light will turn on again.
The screen display will turn off again if you do not touch the touch panel for about 10 seconds.

6 **Press [EXIT] to close the setting screen.**

Setting the background color



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
(Press [ADVANCED] tab for the ANALYZER mode)

3 **Press [DISP].**

4 **Press [COLOR].**

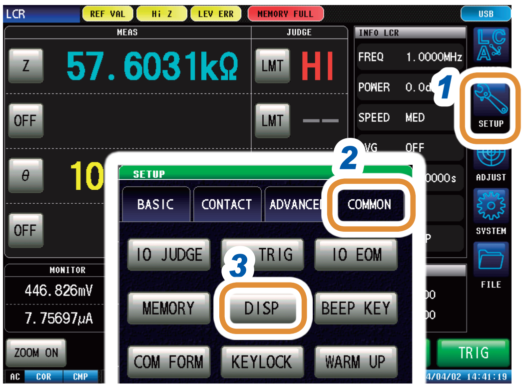
5 **Setting the background color.**

[BLACK]	Sets the background color of the screen to black.
[WHITE]	Sets the background color of the screen to white.

The parameter colors will be initialized in accordance with the background color when the background color is changed.

6 **Press [EXIT] to close the setting screen.**

Setting the screen brightness



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
Press [ADVANCED] tab for the ANALYZER mode.

3 **Press [DISP].**

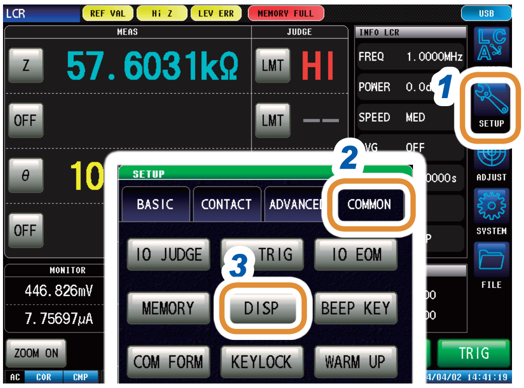
4 **Set the screen brightness with ▲/▼.**

Settable range	0 to 250 (Default value: 130)

5 **Press [EXIT] to close the setting screen.**

Setting the parameter color

Sets the color for the graph of the measured values or measurement results to be displayed on the screen for each parameter.
In addition, you can set a color for each segment in the case of segment sweep.



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
(Press [ADVANCED] tab for the ANALYZER mode.)

3 **Press [DISP].**

4 **Select the parameter to set the color.**
The setting differs based on "4.3.1 Setting the Sweep Method" (p. 76).

5 **Select the color to set.**

6 **Press [EXIT] to close the setting screen.**

All parameters are set in the same way.

When [SEGMENT] is set to [OFF]

If you do not want to set colors:
The graph will not be drawn if you select OFF.

When the [SEGMENT] setting is [SEG ON] or [SEG INTVL]

To set the color of segment 1 to all segments: Press **[SEG1 ALL]**.
To restore the colors of all segments to the initial state:
Press **[AUTO SET]**.

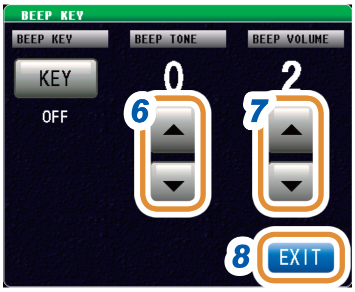
7.3.3 Setting the Beep Sound

You can set the key operation sound.

1 **Press [SETUP].**

2 **Press [COMMON] tab.**
(Press [ADVANCED] tab for the ANALYZER mode.)

3 **Press [BEEP KEY].**



4 **Press [KEY].**

5 **Select the beep sound when a key is pressed.**

[OFF]	A beep sound is not emitted when a key is pressed.
[ON]	A beep sound is emitted when a key is pressed.

6 **Setting the beep tone.**

Settable range	0 to 14

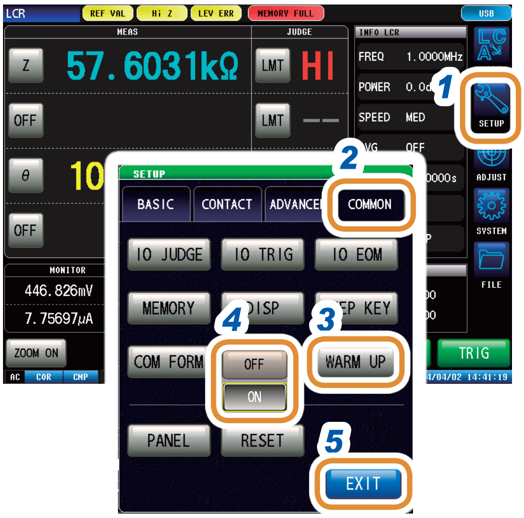
7 **Setting the beep volume.**

Settable range	1 to 3

8 **Press [EXIT] to close the setting screen.**

7.3.4 Display the Warm-up Message

A message indicating the completion of the warm-up time is displayed. The message appears approximately 60 minutes after the power is switched on.



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
(Press [ADVANCED] tab for the ANALYZER mode.)

3 **Press [WARM UP].**

4 **Select if the warm-up message has to be displayed or not.**

[OFF]	Warm-up message is not displayed.
[ON]	Warm-up message is displayed.

5 **Press [EXIT] to close the setting screen.**

Warm-up message

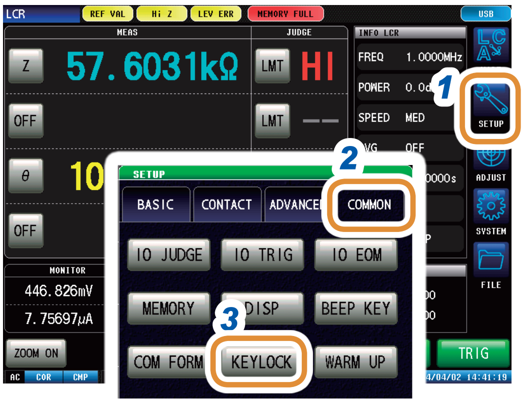
7.3.5 Disabling Key Operation (Key-lock Function)

The key-lock function includes the following two types. Select from these as required for the application.
You can also set a passcode (security code).

FULL key-lock	Disables all setting changes.
SET key-lock	Enables the settings for comparator and BIN judgments, but disables other setting changes.

- The key lock will not be enabled for **[TRIG]** in the case of an external trigger. (p. 33)
- Turning off the power will not cancel the key-lock function.
- Set and check a passcode in advance to set the key-lock.

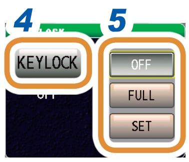
Enables the key-lock function



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
(Press [ADVANCED] tab for the ANALYZER mode.)

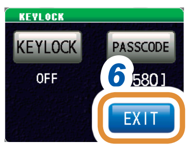
3 **Press [KEYLOCK].**



4 **Press [KEYLOCK].**

5 **Press [FULL].**
(Press [ON] for ANALYZER mode.)
Only **[OFF]** and **[ON]** are displayed for ANALYZER.

[OFF]	Key-lock is not set.
[FULL] **[ON]**	All setting changes except canceling the key-lock are disabled to protect the settings. You can check the measurement conditions with [INFO].
[SET]	• Setting the comparator and BIN judgments • Canceling the key-lock All setting changes except the above are disabled to protect the settings. • You can check the measurement conditions with **[INFO]**. • During comparator judgment, **[LMT]** enables you to check the limit values. • During BIN judgment, **[LMT]** enables you to check the limit values.

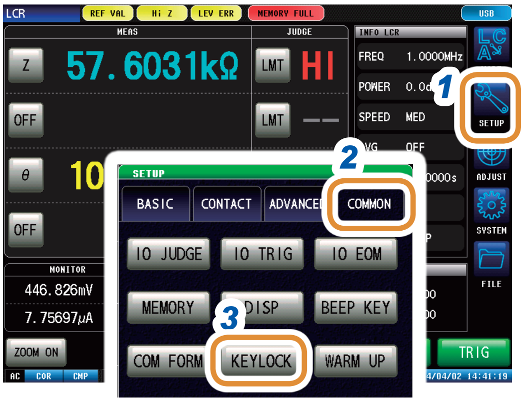


6 **Press [EXIT] to close the setting screen.**

Setting the passcode of the key-lock

You can set a passcode necessary to cancel the key-lock.

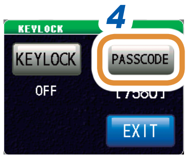
> If a passcode is set, the passcode has to be entered to disable the key-lock.
> Take care not to forget the set passcode.



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
Press [ADVANCED] tab for the ANALYZER mode.

3 **Press [KEYLOCK].**

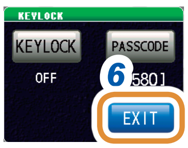


4 **Press [PASSCODE].**

5 **Set the passcode with the numeric keypad and press [SET].**

Settable range	1 to 4 digits
Initial passcode	7580

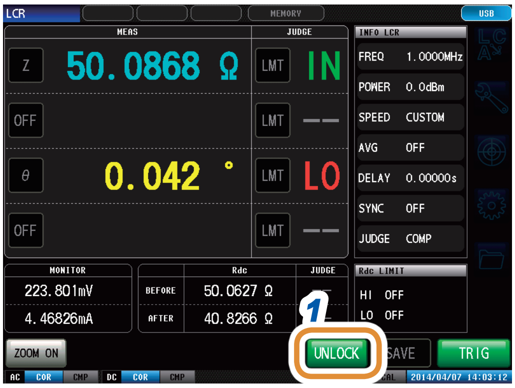
[C]	Repeats the input.
[CANCEL]	Cancels the setting.



6 **Press [EXIT] to close the setting screen.**

Disabling the key-lock

> Perform a full reset to restore the instrument to the factory default settings if you forget the passcode.
> See “Full reset procedure” (p. 301).



1 **Press [UNLOCK] when the key-lock is enabled.**

When a passcode is set

2 **Enter the passcode and press [UNLOCK].**

The passcode entered is displayed as [*] on the screen.

[C]	Repeats the input.
[CANCEL]	Cancels the setting.

When a passcode is not set

Select **[UNLOCK]** without entering anything when a passcode is not set.

In case of key-lock disable error

Check the following items if the below error is displayed.

Cause	Solution
[UNLOCK] was pressed before you entered the passcode.	Press **[C]**, and enter the passcode.
The passcode entered is incorrect.	Press **[C]** and enter the passcode again.

In case of an external trigger

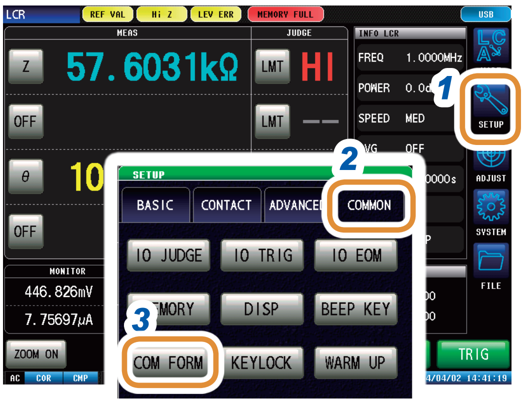
(When **[EXT]** was selected for **[BASIC]** - **[TRIG]**.)

In the case of an external trigger, the key lock is not enabled for **[TRIG]**.

7.3.6 Setting the Communication Measurement Data Type

Setting of items for the measurement data to be acquired via communication.
For more information, see the Communication Commands Instruction Manual.

Set the measured value automatic output function (`:MEASure:OUTPut:AUTO` command) (LCR only)



1 Press **[SETUP]**.

2 Press **[COMMON]** tab.

3 Press **[COM FORM]**.

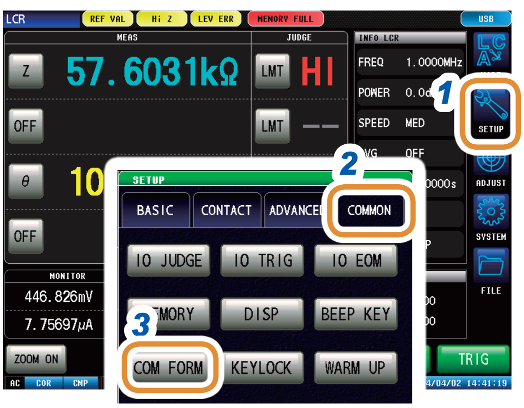
4 Press **[AUTO OUT]**.

5 Select if the measured values are to be output automatically or not.

OFF	Measured values are not output automatically after completion of measurement.
ON	Measured values are output automatically after completion of measurement.

6 Press **[EXIT]** to close the setting screen.

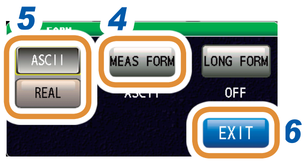
Set the data transfer format (`:FORMat:DATA` command)



1 Press **[SETUP]**.

2 Press **[COMMON]** tab.
Press **[ADVANCED]** tab for the ANALYZER mode.

3 Press **[COM FORM]**.



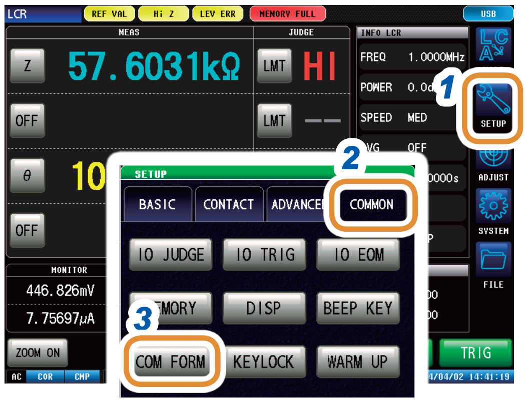
4 **Press [MEAS FORM].**

5 **Select the data transfer format.**

[ASCII]	Transfers data in ASCII format.
[REAL]	Transfers data in binary format.

6 **Press [EXIT] to close the setting screen.**

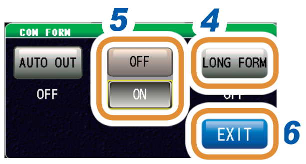
Set the long format for data transfer (`:FORMat:LONG` command)



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
Press [ADVANCED] tab for the ANALYZER mode.

3 **Press [COM FORM].**



4 **Press [LONG FORM].**

5 **Select the data transfer format.**

[OFF]	Transfers the data in standard format.
[ON]	Transfers the data in long format.

6 **Press [EXIT] to close the setting screen.**

7.3.7 Initializing the Instrument

Initialization of the setting is performed as follows.
Check “Instrument malfunction” (p. 297) if the instrument malfunctions.
Perform a system reset to restore the instrument to its factory default settings if the cause is not known.
See “Appx. 8 Initial Settings Table” (p. A15).
A system reset can also be performed with the ***RST**, **:PRESET**, **:SYStem:RESet** communication command.
See the included LCR Application Disk. - Communication Commands “***RST**”, “**:PRESET**”, “**:SYStem:RESet**”

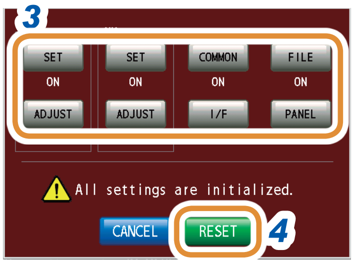
⚠ CAUTION

Performing a system reset causes the instrument to return to its default factory settings. Disconnect the measurement sample before performing a system reset.

Perform a full reset if the initialization screen cannot be displayed. (p. 301)

1 **Press [SETUP].**

2 **Press [COMMON] tab.**
Press [ADVANCED] tab for the ANALYZER mode.



3 **Select reset ([ON])/no reset ([OFF]) for each item.**
See “Appx. 8 Initial Settings Table” (p. A15).

[SET]	Resets the item set with [SETUP].
[ADJUST]	Resets the item set with [ADJUST].
[COMMON]	Resets the item set with [COMMON]. (The configuration of the measurement mode is also reset.)
[FILE]	Resets the item set with [FILE].
[PANEL]	Resets the item set with [PANEL].
[I/F]	Resets the item set with [I/F].
[CANCEL]	Cancels the system reset.

4 **Press [RESET].**
Restores the factory default settings and automatically returns to the measurement screen.

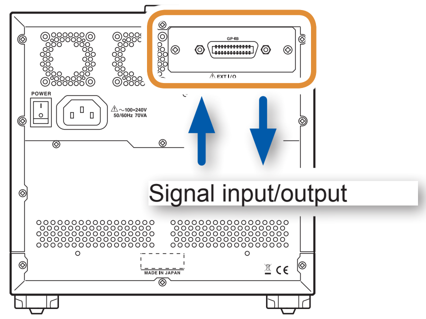
8 External Control

The EXT I/O connector on the rear of the instrument can control the instrument by providing output of the end-of-measurement and comparator decision signals, as well as accepting input of measurement trigger and panel load signals.
All signals are isolated by optocouplers. (Common connector (ISO_COM) is shared by input and output.)

Check the input and output ratings, understand the safety precautions for connecting a control system, and use correctly.

Connect the EXT I/O connector of this instrument to the signal output or input device. → **Make instrument settings** →

Rear



8.1 External Input/Output Connector and Signals

⚠ WARNING

To avoid electric shock or damage to the equipment, always observe the following precautions when connecting to EXT I/O terminals.

- **Always turn off the power to the instrument and to any devices to be connected before making connections.**
- **During operation, a wire becoming dislocated and contacting another conductive object can be serious hazard. Use screws to secure the EXT I/O terminals.**
- **Ensure that devices and systems to be connected to the EXT I/O terminals are appropriately isolated.**

⚠ CAUTION

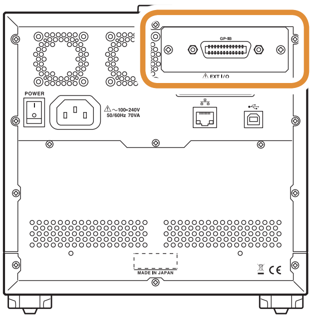
Observe the following to avoid damage to the instrument.

- Do not apply voltage or current that exceeding the ratings to the EXT I/O terminals.
- Do not short-circuit ISO_5V with ISO_COM.
  Refer to “Signal pinouts (instrument)” (p. 196)

- Install diodes to absorb counter-electromotive force when relays are used.

Connector type

Rear

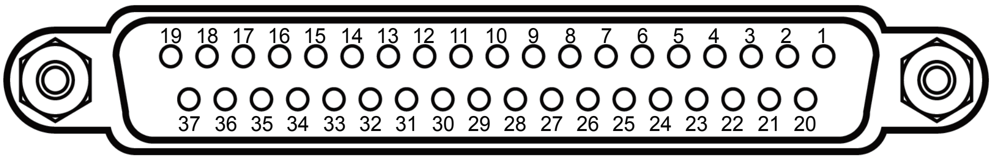


Instrument connector:
37-pin D-sub female with #4-40 inch screws

Mating connectors:
• DC-37P-ULR (solder type)
• DCSP-JB37PR (crimping type)
Japan Aviation Electronics Industry Ltd.

Signal pinouts (instrument)

- LCR mode (p. 196)
- ANALYZER mode (p. 198)
- CONTINUOUS measurement mode (p. 202)



The connector shell is connected (conductive) to the instrument case (metal) and the protective earth pin of the power supply inlet. Note that it is not isolated from ground.

LCR mode

Pin	I/O	Signal name: Common	Signal name: COMP	Signal name: BIN	Function	Logic	
1	IN	$\overline{\text{TRIG}}$			External trigger (p. 203)	Pos/ Neg	Edge
2	IN	(Unused)			-	-	-
3	IN	(Unused)			-	-	-
4	IN	$\overline{\text{LD1}}$			Select panel No. (p. 203)	Neg	Level
5	IN	$\overline{\text{LD3}}$			Select panel No. (p. 203)	Neg	Level
6	IN	$\overline{\text{LD5}}$			Select panel No. (p. 203)	Neg	Level
7	IN	(Unused)			-	-	-
8	-	$\overline{\text{ISO\_5V}}$			Isolated 5-V power output	-	-
9	-	$\overline{\text{ISO\_COM}}$			Isolated power supply common	-	-
10	OUT	$\overline{\text{ERR}}$			Output when a measurement error, contact error, Hi Z reject error or detection level error occurs.	Neg	Level
11	OUT		$\overline{\text{PARA1-HI}}$		Output if the first parameter comparator judgment result is HI.	Neg	Level
				$\overline{\text{BIN1}}$	Output if the BIN judgment result is BIN1.		
12	OUT		$\overline{\text{PARA1-LO}}$		Output if the first parameter comparator judgment result is LO.	Neg	Level
				$\overline{\text{BIN3}}$	Output if the BIN judgment result is BIN3.		
13	OUT		$\overline{\text{PARA2-IN}}$		Output if the second parameter comparator judgment result is IN.	Neg	Level
				$\overline{\text{BIN5}}$	Output if the BIN judgment result is BIN5.		

Pin	I/O	Signal name			Function	Logic	
		Common	COMP	BIN			
14	OUT		$\overline{\text{AND}}$		• Outputs results obtained by applying an AND operation to the judgment results for measurement results of the four parameters. • Output if all the judgment results is IN (parameters not for considered for judgment are excluded).	Neg	Level
				$\overline{\text{BIN7}}$	Output if the BIN judgment result is BIN7.		
15	OUT		$\overline{\text{PARA3-IN}}$		Output if the third parameter comparator judgment result is IN.	Neg	Level
				$\overline{\text{BIN9}}$	Output if the BIN judgment result is BIN9.		
16	OUT		$\overline{\text{PARA4-HI}}$		Output if the fourth parameter comparator judgment result is HI.	Neg	Level
17	OUT		$\overline{\text{PARA4-LO}}$		Output if the fourth parameter comparator judgment result is LO.	Neg	Level
18	OUT	(Unused)			-	-	-
19	OUT			$\overline{\text{OUT\_OF\_BINS}}$	BIN judgment results	Neg	Level
20	IN	(Unused)			-	-	-
21	IN	(Unused)			-	-	-
22	IN	$\overline{\text{LD0}}$			Select panel No. (p. 203)	Neg	Level
23	IN	$\overline{\text{LD2}}$			Select panel No. (p. 203)	Neg	Level
24	IN	$\overline{\text{LD4}}$			Select panel No. (p. 203)	Neg	Level
25	IN	$\overline{\text{LD6}}$			Select panel No. (p. 203)	Neg	Level
26	IN	$\overline{\text{LD\_VALID}}$			Execute panel load (p. 203)	Neg	Level
27	-	ISO_COM			Isolated power supply common	-	-
28	OUT	$\overline{\text{EOM}}$			Measurement complete signal (When this signal is output, the comparator judgment results have been finalized.)	Neg	Edge
29	OUT	$\overline{\text{INDEX}}$			• Signal that indicates measurement (calculations and judgment have not been processed) has been completed. • The sample can be switched once this signal changes from HIGH (OFF) to LOW (ON).	Neg	Edge
30	OUT		$\overline{\text{PARA1-IN}}$		Output if the first parameter comparator judgment result is IN.	Neg	Level
				$\overline{\text{BIN2}}$	Output if the BIN judgment result is BIN2.		
31	OUT		$\overline{\text{PARA2-HI}}$		Output if the second parameter comparator judgment result is HI.	Neg	Level
				$\overline{\text{BIN4}}$	Output if the BIN judgment result is BIN4.		
32	OUT		$\overline{\text{PARA2-LO}}$		Output if the second parameter comparator judgment result is LO.	Neg	Level
				$\overline{\text{BIN6}}$	Output if the BIN judgment result is BIN6.		
33	OUT		$\overline{\text{PARA3-HI}}$		Output if the third parameter comparator judgment result is HI.	Neg	Level
				$\overline{\text{BIN8}}$	Output if BIN judgment result is BIN8.		
34	OUT		$\overline{\text{PARA3-LO}}$		Output if the third parameter comparator judgment result is LO.	Neg	Level
				$\overline{\text{BIN10}}$	Output if BIN judgment result is BIN10.		
35	OUT		$\overline{\text{PARA4-IN}}$		Output if the fourth parameter comparator judgment result is IN.	Neg	Level
36	OUT	(Unused)			-	Neg	Level
37	OUT	(Unused)			-	Neg	Level

8

External Control

ANALYZER mode

Pin	I/O	Signal name: Common	AREA	PEAK		Function	Logic	
1	IN	TRIG				External trigger (p. 203)	Pos/ Neg	Edge
2	IN	(Unused)				-	-	-
3	IN	(Unused)				-	-	-
4	IN	LD1				Select panel No. (p. 203)	Neg	Level
5	IN	LD3				Select panel No. (p. 203)	Neg	Level
6	IN	LD5				Select panel No. (p. 203)	Neg	Level
7	IN	(Unused)				-	-	-
8	-	ISO_5V				Isolated 5-V power output	-	-
9	-	ISO_COM				Isolated power supply common	-	-
10	OUT	ERR				Outputs when a measurement error, contact error, Hi Z reject error or detection level error occurs.	Neg	Level
11	OUT		PARA1-HI			AREA judgment result of first parameter (Outputs when any of the judgment is HI.)	Neg	Level
				1	PARA1_NG	PEAK judgment result of the first parameter (Outputs if any one of the judgment is NG.)		
				2	PARA1_LMAX_ MEASNG	PEAK judgment (local maximum value) result of the first parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
				3	PARA3_LMAX_ MEASNG	PEAK judgment (local maximum value) result of the third parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
12	OUT		PARA1-LO			AREA judgment result of first parameter (Outputs if any of the judgment is LO.)	Neg	Level
				1	PARA2_NG	PEAK judgment result of the second parameter (Outputs if any one of the judgment is NG.)		
				2	PARA1_LMAX_ CONDNG	PEAK judgment (local maximum value) result of the first parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
				3	PARA3_LMAX_ CONDNG	PEAK judgment (local maximum value) result of the third parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
13	OUT		PARA2-IN			AREA judgment result of the second parameter (Outputs if all the judgment results are IN.)	Neg	Level
				1	PARA3_NG	PEAK judgment result of the third parameter (Outputs if any one of the judgment is NG.)		
				2	PARA2_LMAX_ IN	PEAK judgment (local maximum value) result of the second parameter (Outputs if the judgment result is IN.)		
				3	PARA4_LMAX_ IN	PEAK judgment (local maximum value) result of the fourth parameter (Outputs if the judgment result is IN.)		
14	OUT	AND	AND	AND		Comparator judgment result AND	Neg	Level

Pin	I/O	Signal name				Function	Logic	
		Common	AREA	PEAK				
15	OUT		PARA3-IN			AREA judgment result of the third parameter (Outputs if all the judgment results are IN.)	Neg	Level
				1	PARA4_IN	PEAK judgment result of the fourth parameter (Outputs if all the judgment results are IN.)		
				2	PARA1_LMIN_IN	PEAK judgment (local minimum value) result of the first parameter (Outputs if the judgment result is IN.)		
				3	PARA3_LMIN_IN	PEAK judgment (local minimum value) result of the third parameter (Outputs if the judgment result is IN.)		
16	OUT		PARA4-HI			AREA judgment result of the fourth parameter (Outputs when any of the judgment is HI.)	Neg	Level
				1	-	-		
				2	PARA2_LMIN_MEASNG	PEAK judgment (local minimum value) result of the second parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
				3	PARA4_LMIN_MEASNG	PEAK judgment (local minimum value) result of the fourth parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
17	OUT		PARA4-LO			AREA judgment result of the fourth parameter (Outputs if any of the judgment is LO)	Neg	Level
				1	-	-		
				2	PARA2_LMIN_CONDNG	PEAK judgment (local minimum value) result of the second parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
				3	PARA4_LMIN_CONDNG	PEAK judgment (local minimum value) result of the fourth parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
18	OUT	(Unused)				-	-	-
19	OUT	CIRCUIT_NG				Equivalent circuit analysis comparator judgment result output (output when logical AND of judgment result is NG)	Neg	Level
20	IN			C_P0 *1		Switches the PEAK judgment result output.	-	-
21	IN			C_P1 *1		Switches the PEAK judgment result output.	-	-
22	IN	LD0				Select panel No. (p. 203)	Neg	Level
23	IN	LD2				Select panel No. (p. 203)	Neg	Level
24	IN	LD4				Select panel No. (p. 203)	Neg	Level
25	IN	LD6				Select panel No. (p. 203)	Neg	Level
26	IN	LD_VALID				Execute panel load (p. 203)	Neg	Level
27	-	ISO_COM				Isolated power supply common	-	-
28	OUT	EOM				Measurement complete	Neg	Edge
29	OUT	INDEX				Analog measurement complete	Neg	Edge
30	OUT		PARA1-IN			AREA judgment result of first parameter (Outputs if all the judgment results are IN.)	Neg	Level
				1	PARA1_IN	PEAK judgment result of the first parameter (Outputs if all the judgment results are IN.)		
				2	PARA1_LMAX_IN	PEAK judgment (local maximum value) result of the first parameter (Outputs if the judgment result is IN.)		
				3	PARA3_LMAX_IN	PEAK judgment (local maximum value) result of the third parameter (Outputs if the judgment result is IN.)		

Pin	I/O	Signal name: Common	Signal name: AREA	Signal name: PEAK		Function	Logic	
31	OUT		PARA2-HI			AREA judgment result of the second parameter (Outputs when any of the judgment is HI.)	Neg	Level
				1	PARA2_IN	PEAK judgment result of the second parameter (Outputs if all the judgment results are IN.)		
				2	PARA2_LMAX_MEASNG	PEAK judgment (local maximum value) result of the second parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
				3	PARA4_LMAX_MEASNG	PEAK judgment (local maximum value) result of the fourth parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
32	OUT		PARA2-LO			AREA judgment result of the second parameter (Outputs if any of the judgment is LO.)	Neg	Level
				1	PARA3_IN	PEAK judgment result of the third parameter (Outputs if all the judgment results are IN.)		
				2	PARA2_LMAX_CONDNG	PEAK judgment (local maximum value) result of the second parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
				3	PARA4_LMAX_CONDNG	PEAK judgment (local maximum value) result of the fourth parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
33	OUT		PARA3-HI			AREA judgment result of the third parameter (Outputs when any of the judgment is HI.)	Neg	Level
				1	PARA4_NG	PEAK judgment result of the fourth parameter (Outputs if any one of the judgment is NG.)		
				2	PARA1_LMIN_MEASNG	PEAK judgment (local minimum value) result of the first parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
				3	PARA3_LMIN_MEASNG	PEAK judgment (local minimum value) result of the third parameter (Output if the vertical axis (measured value) is out of range or if there is no comparison peak.)		
34	OUT		PARA3-LO			AREA judgment result of the third parameter (Outputs if any of the judgment is LO)	Neg	Level
				1	-	-		
				2	PARA1_LMIN_CONDNG	PEAK judgment (local minimum value) result of the first parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
				3	PARA3_LMIN_CONDNG	PEAK judgment (local minimum value) result of the third parameter (Output if the horizontal axis (sweep point) is out of range or there is no comparison peak.)		
35	OUT		PARA4-IN			AREA judgment result of the fourth parameter (Outputs if all the judgment results are IN.)	Neg	Level
				1	-	-		
				2	PARA2_LMIN_IN	PEAK judgment (local minimum value) result of the second parameter (Outputs if the judgment result is IN.)		
				3	PARA4_LMIN_IN	PEAK judgment (local minimum value) result of the fourth parameter (Outputs if the judgment result is IN.)		
36	OUT	(Unused)	-		-	-	Neg	Level
37	OUT	(Unused)	-		-	-	Neg	Level

*1: PEAK output parameter switching

$\overline{\text{C\_P0}}$	OFF	ON	OFF
$\overline{\text{C\_P1}}$	OFF	OFF	ON
Output	PARA1, 2, 3, 4	PARA1, 2	PARA3, 4

CONTINUOUS measurement mode

Pin	I/O	Signal name		Function	Logic	
		Common	COMP			
1	IN	TRIG		External trigger (p. 203)	Pos/ Neg	Edge
2	IN	(Unused)		-	-	-
3	IN	(Unused)		-	-	-
4	IN	(Unused)		-	Neg	Level
5	IN	(Unused)		-	Neg	Level
6	IN	(Unused)		-	Neg	Level
7	IN	(Unused)		-	-	-
8	-	ISO_5V		Isolated 5 V power output	-	-
9	-	ISO_COM		Isolated power supply common	-	-
10	OUT	ERR		Outputs when a measurement error, contact error, Hi Z reject error or detection level error occurs.	Neg	Level
11	OUT		PARA1-HI	Outputs if the comparator judgment result of the first parameter is HI.	Neg	Level
12	OUT		PARA1-LO	Outputs if the comparator judgment result of the first parameter is LO.	Neg	Level
13	OUT		PARA2-IN	Output if the comparator judgment result of the second parameter is IN.	Neg	Level
14	OUT	AND	AND	Outputs if all panel judgments are IN and the instrument is not OUT_OF_BINS.	Neg	Level
15	OUT		PARA3-IN	Outputs if the comparator judgment result of the third parameter is IN.	Neg	Level
16	OUT		PARA4-HI	Outputs if the comparator judgment result of the fourth parameter is HI.	Neg	Level
17	OUT		PARA4-LO	Outputs if the comparator judgment result of the fourth parameter is LO.	Neg	Level
18	OUT	(Unused)		-	-	-
19	OUT	(Unused)		-	Neg	Level
20	IN		C_P0 [*2]	Switches the judgment result output.	-	-
21	IN		C_P1 [*2]	Switches the judgment result output.	-	-
22	IN	(Unused)		-	Neg	Level
23	IN	(Unused)		-	Neg	Level
24	IN	(Unused)		-	Neg	Level
25	IN	(Unused)		-	Neg	Level
26	IN	(Unused)		-	Neg	Level
27	-	ISO_COM		Isolated power supply common	-	-
28	OUT	EOM		Measurement complete signal When this signal is output, the comparator judgment results have been finalized.	Neg	Edge
29	OUT	INDEX		• Signal that indicates measurement (calculations and judgment have not been processed) has been completed. • The sample can be switched once this signal changes from HIGH (OFF) to LOW (ON).	Neg	Edge
30	OUT		PARA1-IN	Outputs if the comparator judgment result of the first parameter is IN.	Neg	Level
31	OUT		PARA2-HI	Outputs if the comparator judgment result of the second parameter is HI.	Neg	Level

Pin	I/O	Signal name		Function	Logic	
		Common	COMP			
32	OUT		PARA2-LO	Outputs if the comparator judgment result of the second parameter is LO.	Neg	Level
33	OUT		PARA3-HI	Outputs if the comparator judgment result of the third parameter is HI.	Neg	Level
34	OUT		PARA3-LO	Outputs if the comparator judgment result of third the parameter is LO.	Neg	Level
35	OUT		PARA4-IN	Outputs if the comparator judgment result of the fourth parameter is IN.	Neg	Level
36	OUT	(Unused)		-	Neg	Level
37	OUT	(Unused)		-	Neg	Level

*2: COMP output parameter switching

C_P0	OFF	ON	OFF	ON
C_P1	OFF	OFF	ON	ON
Output	AND	LCR1	LCR2	LCR3

Default is AND across the parameters.
Separate AND for separate LCR.

Function details of each signal

You can select rising or falling for the valid edge of a trigger.
Refer to “8.6.2 Setting Valid Edge of Trigger Input (Trigger Edge)” (p. 216)

Do not connect input signal lines that will not be used.

Input

Signal line	Contents
TRIG	• When the trigger setting is an external trigger **[EXT]**, measurement is performed once with the falling (ON) or rising (OFF) edge of the TRIG signal. Edge direction can be set in the setting screen. (Initial value: Falling (ON)) If the trigger source is set to an internal trigger **[INT]**, trigger measurement is not performed. • Enable or disable can be set for the TRIG signal input during measurement (during output of the EOM signal (HI)).
LD0 to LD6	Select a panel No. to be loaded. If the trigger signal is input in external trigger mode, the selected panel is loaded and used for measurement.

0: (HIGH: 5 V to 24 V), 1: (LOW: 0 V to 0.9 V)

PIN No.	LD6	LD5	LD4	LD3	LD2	LD1	LD0
Panel 1	0	0	0	0	0	0	1
Panel 2	0	0	0	0	0	1	0
Panel 4	0	0	0	0	1	0	0
Panel 8	0	0	0	1	0	0	0
Panel 16	0	0	1	0	0	0	0
Panel 32	0	1	0	0	0	0	0
Panel 46	0	1	0	1	1	1	0

LD-VALID	Inputs a negative logic signal from an external device so that the selected panel No. is recognized as valid. After TRIG input, maintain a LOW level until INDEX is output.

Error output

Measurement Error	ERR pin	Judgment pin	Remarks
Normal	No error (HI)	Normal judgment	
Out of Hi Z reject limit (Hi Z)	Error (LO)	Normal judgment	
Detection level error (LEV ERR)			
Contact error (DC measurement judgment)			
Out of guaranteed accuracy range (REF VAL)	No error (HI)	HI judgment	In case of no judgment (JUDGE EXEC = NOT)
Not calibrated (UNCAL)		Normal judgment	In case of judgment (JUDGE EXEC = DO)
Measurement error	Error (LO)	HI judgment	

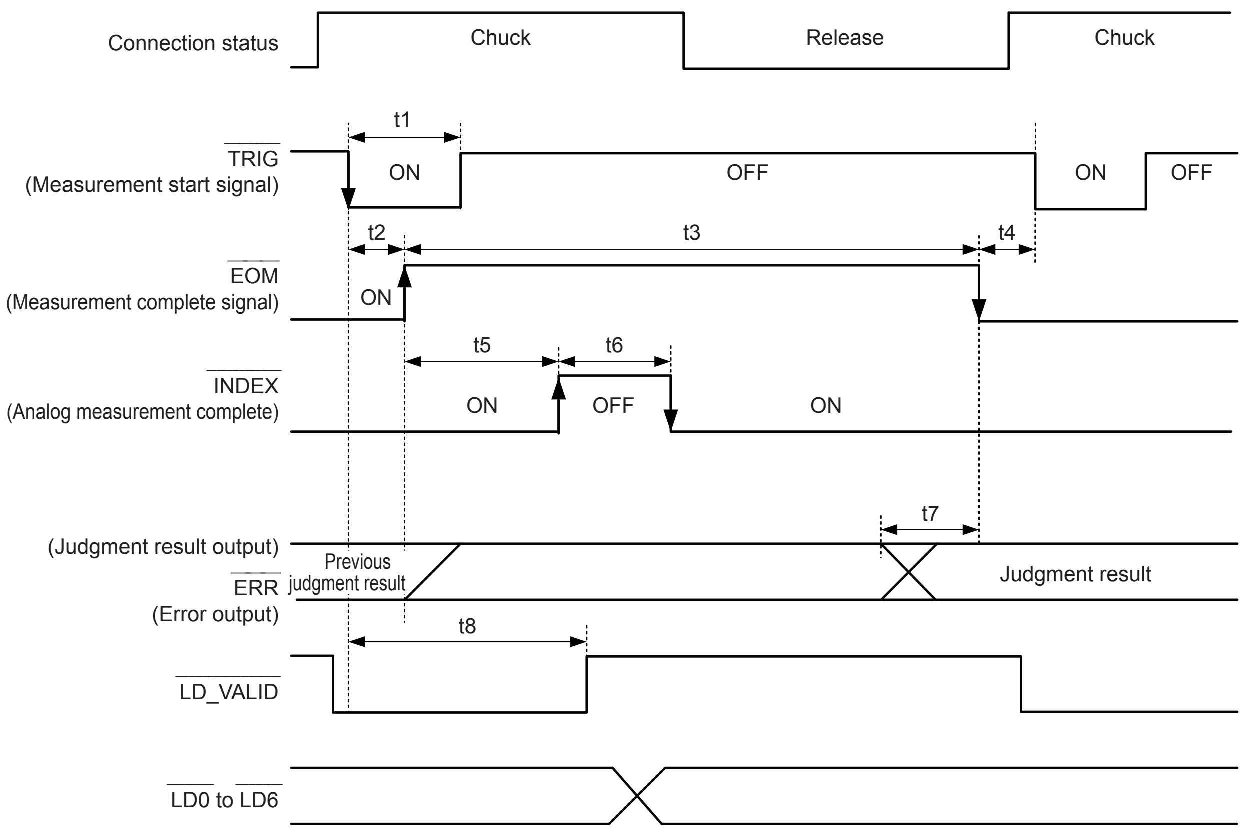
8.2 Timing Chart

8.2.1 LCR Mode

If you set the judgment condition for the comparator (trigger setting is external trigger) and in that state if a trigger signal is input from the EXT I/O or **[TRIG]** is pressed in the screen, the judgment result is output from the signal line for comparator result output of the EXT I/O after measurement is completed.
Furthermore, if the panel No. has been selected with the panel load signal when a trigger signal is input from the EXT I/O, measurement is performed after the measurement condition of that panel No. is loaded.

Examples of the measurement timing:

In the timing example, the valid edge of the TRIG signal is set to falling (ON).



EOM:OFF From trigger to the end of measurement
INDEX:OFF Probe chuck period (Do not disengage the probe.)

Whether the judgment results of comparator and BIN judgment are reset when the signal changes to EOM (HIGH) or updated when measurement is completed, can be selected on the instrument or by a communication command.
See "8.6.3 Setting Reset of Judgment Results (Judgment Result Signal Reset)" (p. 217).
See LCR Application Disk - Communication Commands (`:IO:RESult:RESET`).

8 External Control

Timing chart interval descriptions

Item	Contents	Time (Approximate)
t1	Trigger pulse width (LOW time)	2 µs or more
t2	Trigger response time	5 µs or more
t3	Measurement time (Measurement speed: FAST, during comparator judgment)	630 µs
t4	Minimum time from completion of measurement to next trigger	2 µs or more
t5	Time until analog measurement starts	6 µs
t6	Minimum chuck time (Measurement speed: FAST)	500 µs
t7	Judgment EOM delay time (if set value is 0.00000 s)	25 µs
t8	Panel No. identification time	2 µs or more

- Because the speed of the rise (LOW to HIGH) of the comparator/BIN judgment result differs depending on the circuit configuration connected to the EXT I/O, there is a possibility of an incorrect judgment if the level of the comparator/BIN judgment result acquired immediately after EOM output is used. To prevent this, a delay time (t1) from the comparator/BIN judgment result until the EOM judgment result output can be set. Furthermore, if the judgment result signal line of the EXT I/O is set to be reset simultaneously with the measurement start signal, and a forced transition to the HIGH level is performed at the same time as TRIG, the transition from LOW to HIGH when the judgment result is output after measurement ends is eliminated. As a result, the delay time between the judgment result and the EOM can be set to a minimum level. However, note that the judgment result confirmation interval will be until the next trigger is accepted.
- During measurement, trigger input from an EXT/IO or communication from an interface may lead to a wider variation in the delay time between comparator or BIN judgment result output and EOM. Avoid controlling from external sources during measurement as far as possible. See “8.6.4 Setting the EOM Output Method (EOM Mode)” (p. 218).LCR Application Disk - Communication Commands (`:IO:OUTPut:DELay`) and (`:IO:RESult:RESETUP`)
- The shorter the measurement time, the shorter the time that INDEX and EOM are HIGH (OFF). If the HIGH (OFF) time is too short due to the input circuit characteristics while receiving INDEX or EOM, the instrument can be configured to maintain the LOW (ON) state for a preset time once EOM changes to LOW (ON) before returning the signal to HIGH (OFF) after the completion of measurement.
  The signal transitions to high (off) when measurement starts if trigger input received at EOM: LOW and INDEX: LOW.

Setting the INDEX and EOM output method

See “8.6.4 Setting the EOM Output Method (EOM Mode)” (p. 218).
See LCR Application Disk - Communication Commands (`:IO:EOM:MODE`).

Setting the pulse width for which LOW (ON) is held by EOM

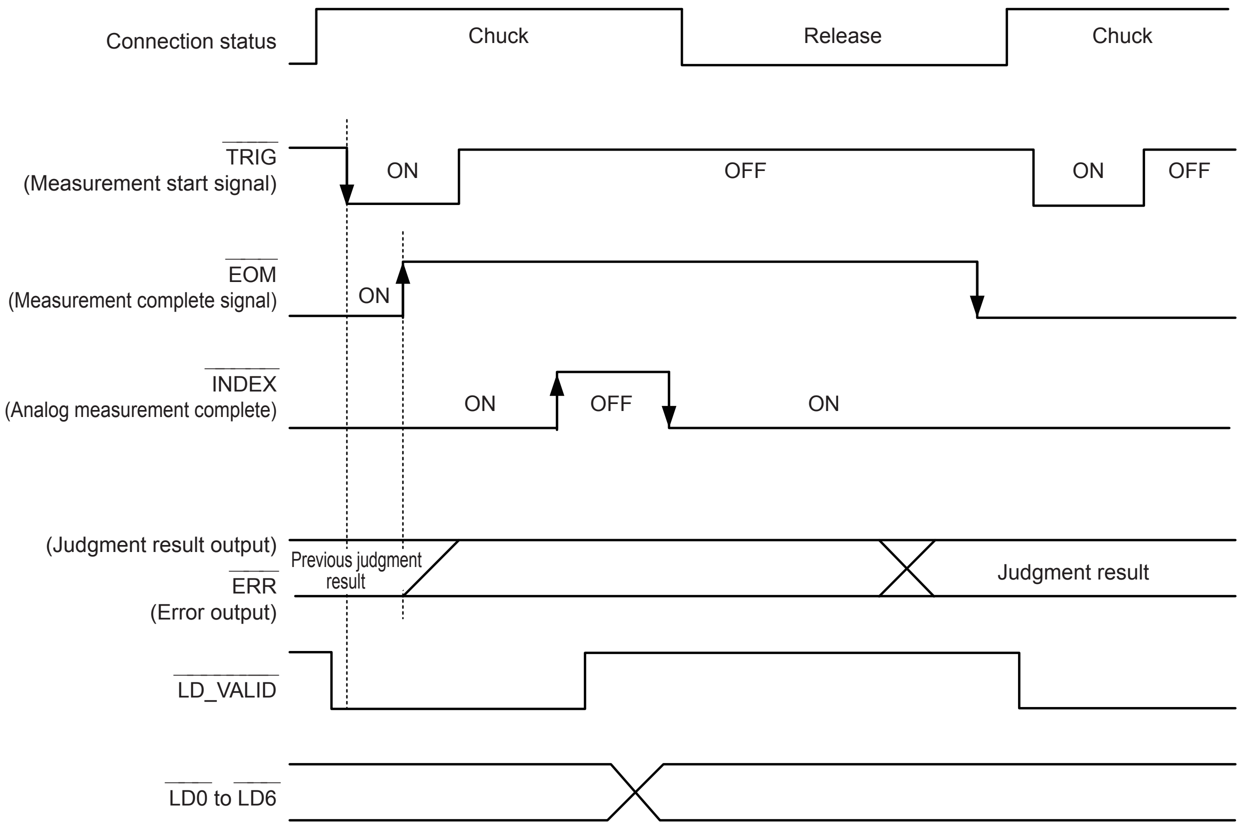
See “8.6.4 Setting the EOM Output Method (EOM Mode)” (p. 218).
See LCR Application Disk - Communication Commands (`:IO:EOM:PULSe`).

8.2.2 ANALYZER Mode

In ANALYZER mode, if a trigger signal is input from the EXT I/O or **[TRIG]** is pressed in the screen, the judgment results are output from the signal line for comparator result output of the EXT I/O.

Furthermore, if the panel No. is selected with the panel load signal when a trigger signal is input from the EXT I/O,measurement is performed after the measurement condition of that panel No. is loaded.

The following is a measurement timing example when the trigger setting is **[SEQ]** or **[REPEAT]**.
In this timing example, the valid edge of the TRIG signal is set to falling (ON).



EOM:OFF From trigger to the end of measurement
INDEX:OFF Probe chuck period (Do not disengage the probe.)

Signal line	Contents
$\overline{\text{INDEX}}$	The transition to HIGH is performed when measurement of the first sweep point starts after trigger signal input and the transition to LOW is performed when the analog measurement of the last sweep point is completed. (HIGH level is maintained during sweep measurement.)
$\overline{\text{EOM}}$	The transition to HIGH is performed when measurement of the first sweep point starts after trigger signal input and the transition to LOW is performed after measurement of the last sweep point is completed and the judgment result has been output. (HIGH level is maintained during sweep measurement.)

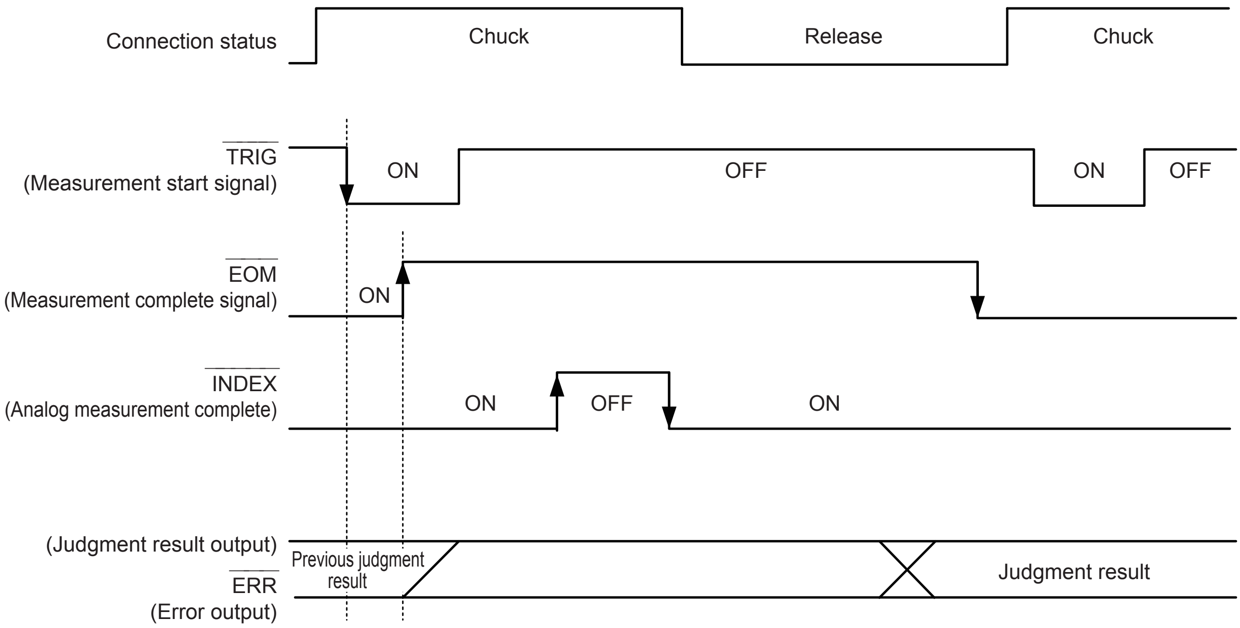
- If the trigger setting is set to STEP, $\overline{\text{INDEX}}$ and $\overline{\text{EOM}}$ transition to LOW every time the measurement for each point is completed, and transitions to HIGH if there is trigger input. $\overline{\text{ERR}}$ also transitions to LOW each time measurement is completed if a measurement error occurs.
- Whether the judgment results of comparator measurement are reset at the time of the measurement start signal or updated when measurement is completed, can be selected on the instrument or by a communication command. See “8.6.4 Setting the EOM Output Method (EOM Mode)” (p. 218).LCR Application Disk - Communication Commands (**`:IO:RESult:RESET`**).
- For each time of other timing charts, refer to Refer to “8.2.1 LCR Mode” (p. 205).

8.2.3 CONTINUOUS Measurement Mode

If a trigger signal input from EXT I/O or by touching on the screen in CONTINUOUS measurement mode, the judgment results will be output from the signal lines of EXT I/O comparator result output after measurement of all panel No.'s set to be executed on the screen.

The following are examples for the measurement timing.
In the timing example, the valid edge of the TRIG signal is set to falling (ON).

Example: Continuous measurement using panel No. 1, 2, and 4



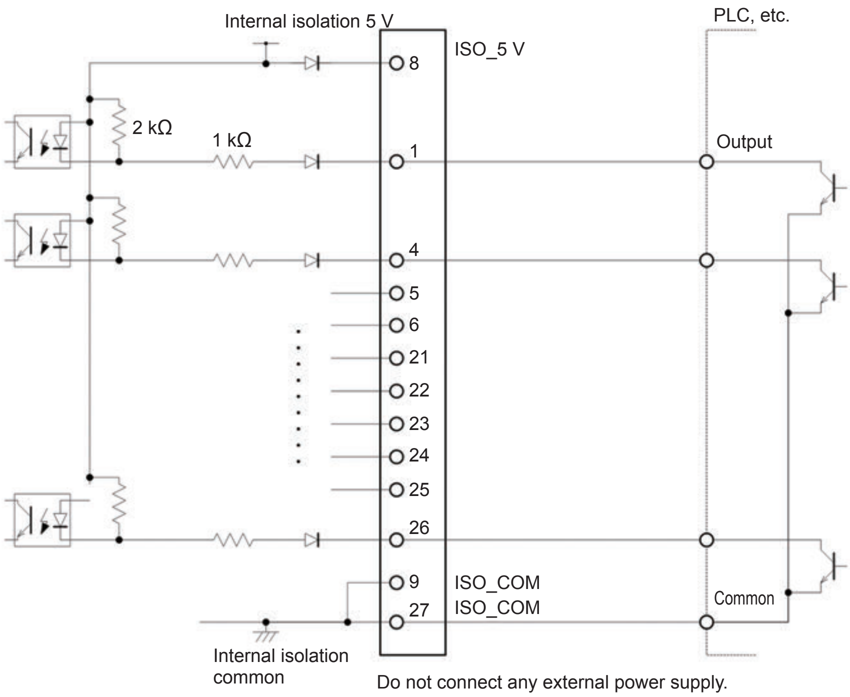
EOM:OFF From trigger to the end of measurement
INDEX:OFF Probe chuck period (Do not disengage the probe.)

Signal line	Contents
$\overline{\text{INDEX}}$, $\overline{\text{EOM}}$	For both INDEX and EOM, transition to HIGH is performed when the first panel measurement starts after the trigger signal is input, and transition to LOW is performed after measurement of the last panel is completed and the judgment result has been output. (HIGH level is maintained during continuous measurement.)
$\overline{\text{AND}}$	LOW is output if the judgment results for all panels are IN.

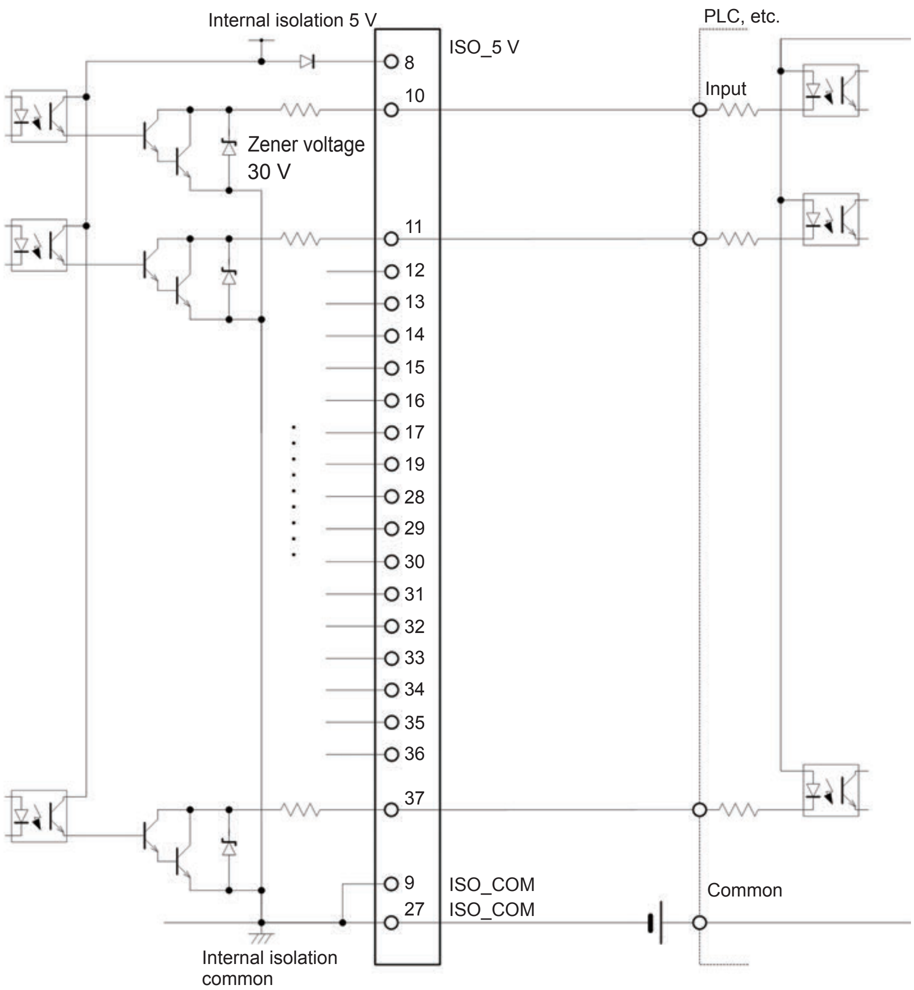
- In the continuous measurement screen, comparator result output signals other than AND and panel load signals (LD-VALID, LD0 to LD6) cannot be used.
  Refer to “Continuous Measurement Function” (p. 161)
- Whether the comparator judgment results are reset when the signal changes to EOM (HIGH) or updated when measurement is completed, can be selected on the instrument or by a communication command. See
  “8.6.4 Setting the EOM Output Method (EOM Mode)” (p. 218).
  LCR Application Disk - Communication Commands (**:IO:RESult:RESET**).
- For each time of other timing chart times, refer to “LCR mode” (p. 196).

8.3 Internal Circuit

Input circuit



Output circuit

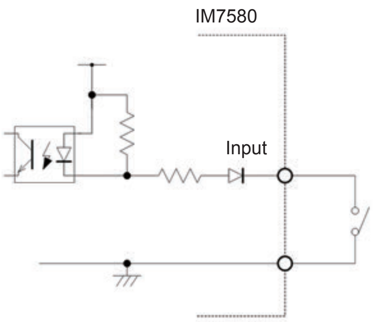


Electrical specifications

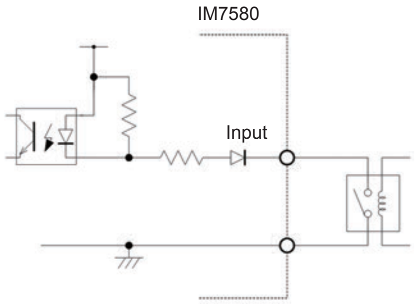
Input Signals	Input type	Isolated, non-voltage contact input (compatible with current sink output, active-low)
	Input asserted (ON) voltage	0.9 V or lower
	Input de-asserted (OFF) voltage	Open or 5 V to 24 V
	Input asserted (ON) current	3 mA/ch
	Maximum applied voltage	30 V
Output Signal	Output type	Isolated npn open-collector output (current sink, active-low)
	Maximum load voltage	30 V
	Maximum output current	50 mA/ch
	Residual voltage	1 V (10 mA), 1.5 V (50 mA)
Internal Isolated Power supply	Output Voltage	4.5 V to 5.0 V
	Maximum output current	100 mA
	External power input	None

Connection examples

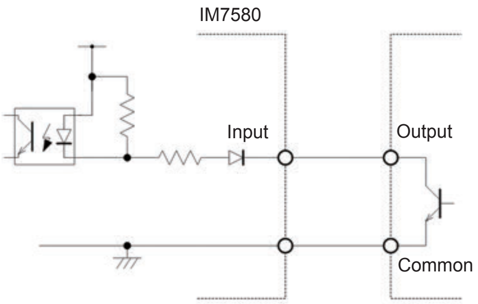
Input circuit connection examples:



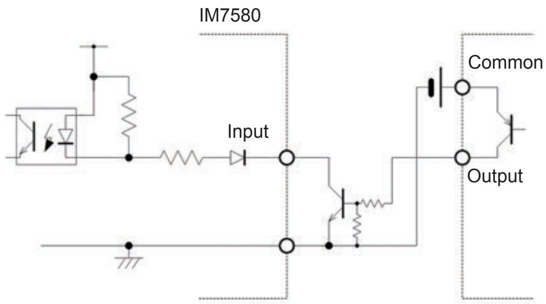
Connection with switch



Connection with relay

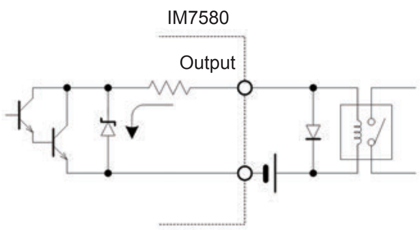


Connection with PLC output (negative common output)

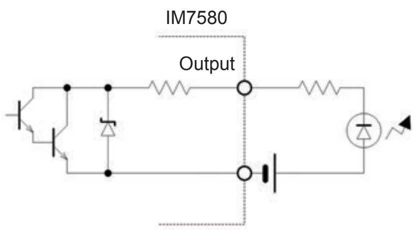


Connection with PLC output (positive common output)

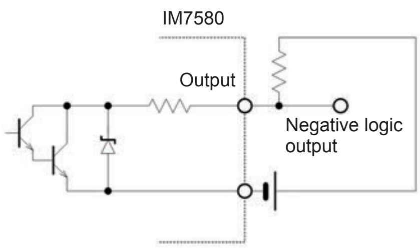
Output circuit connection examples:



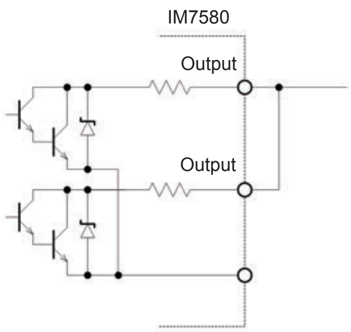
Connection with relay



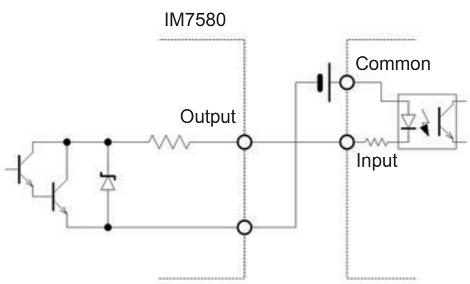
Connection with LED



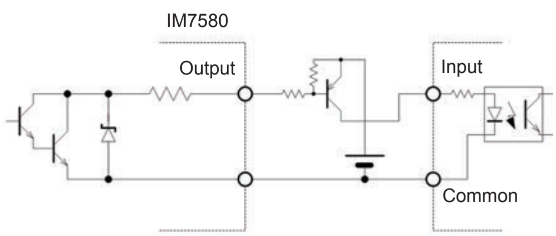
Negative logic output



Wired-OR



Connection with PLC output (positive common output)



Connection with PLC output (negative common output)

8.4 External Control Q&A

Common Questions	Solution
How do I connect an external trigger input?	Short the $\overline{\text{TRIG}}$ input pin to an ISO_COM pin using a switch or an open-collector output.
Which pins are the common ground for input and output signals?	ISO_COM pins.
Are the common (signal ground) pins shared by both inputs and outputs?	Common ground pins can be shared by both inputs and outputs.
How do I confirm if output signals have been sent?	Check the voltage waveforms with a memory HiCORDER and oscilloscope. To do this, voltage level has to be confirmed by pulling up the output signals of EOM and the comparator judgment result (through several kΩ) to the power supply.
How do I troubleshoot input (control) signal issues?	For example, if triggering does not operate properly, bypass PLC control and short the TRIG pin directly to an ISO_COM pin. Take sufficient care not to short the power supply.
Are the comparator decision signals (HI, IN and LO) retained during measurement (or do they turn OFF)?	They are set at the end of measurement during initial settings and turned OFF once measurement starts. However, it is possible to change the settings so that the previous judgment results are also stored during measurement. See “8.6.3 Setting Reset of Judgment Results (Judgment Result Signal Reset)” (p. 217).
When are measurement error signals displayed?	An error is displayed in the following cases. • Measurement error • Contact error • HIGH-Z reject error • Detection level error
Are connectors and flat cables required for connection provided?	Connectors and cables are not supplied, these have to be arranged by the customer.
Is a direct connection to the PLC possible?	Direct connection is supported for relay and open-collector outputs, and positive-ground optocoupler inputs. (Confirm that voltage and current ratings will not be exceeded before connecting.)
Can external I/O be used at the same time as RS-232C or other communications?	It is possible to control measurement with a $\overline{\text{TRIG}}$ signal while acquiring measurement data via a communications interface after setting up measurement conditions with the communications interface.
How should external power supply be connected?	The external I/O input and output signals of this instrument operate from an internal isolated power source of this instrument. Therefore, power supply from PLC is not required.

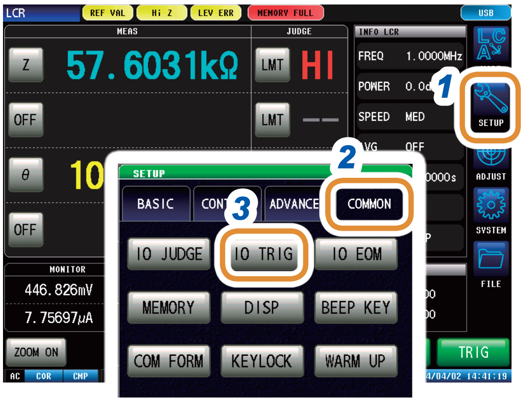
8.5 Measurement Using a Computer

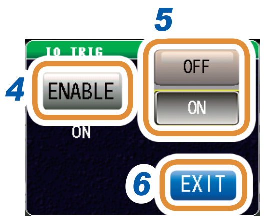
You can control this instrument with communication commands from a computer via the USB, GP-IB, RS-232C, LAN interfaces.
To enable communication, the communication conditions need to be set on the instrument.
Refer to “10.1 Setting the Interface” (p. 231) for details on the communication condition settings.
Refer to the supplied Communication Instruction Manual (LCR Application Disk) for the details on the communication control procedure.

8.6 External Control I/O Settings

8.6.1 Enabling Trigger Input During Measurement (Trigger Enabled)

You can select whether to enable or disable trigger input from the EXT I/O during measurement (during EOM (HI) output after trigger is received). Incorrect inputs due to chattering can be prevented by disabling trigger input during measurement.
See LCR Application Disk - Communication Commands (`:IO:TRIGger:ENABle`).





1 **Press [SETUP].**

2 **Press [COMMON] tab.**
([ADVANCED] tab for ANALYZER)

3 **Press [IO TRIG].**

4 **Press [ENABLE].**

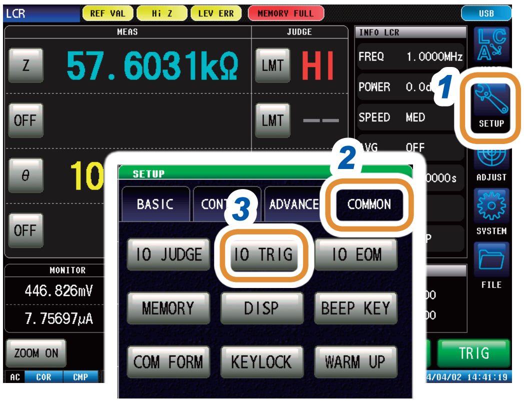
5 **Selecting enable/disable for trigger input.**

[OFF]	Disables trigger input from the EXT I/O during measurement (during EOM (HI) output after trigger is received).
[ON]	Enables trigger input from the EXT I/O during measurement (during EOM (HI) output after trigger is received).

6 **Press [EXIT] to close the setting screen.**

8.6.2 Setting Valid Edge of Trigger Input (Trigger Edge)

Either the rising edge or falling edge can be selected as the valid edge for trigger input from the EXT I/O.
See LCR Application Disk - Communication Commands (`:IO:TRIGger:EDGe`).



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
([ADVANCED] tab for ANALYZER)

3 **Press [IO TRIG].**

4 **Press [EDGE].**

5 **Selecting Valid Edge of Trigger Input.**

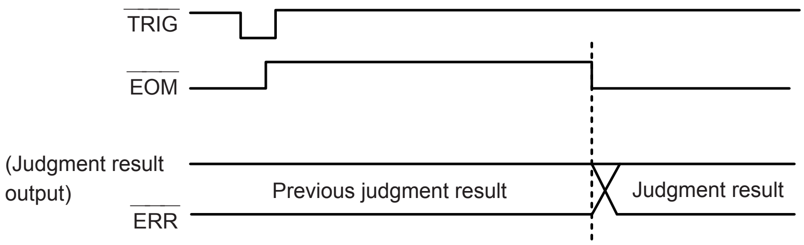
[DOWN]	Sets the falling edge as the valid edge for trigger input.
[UP]	Sets the rising edge as the valid edge for trigger input.

6 **Press [EXIT] to close the setting screen.**

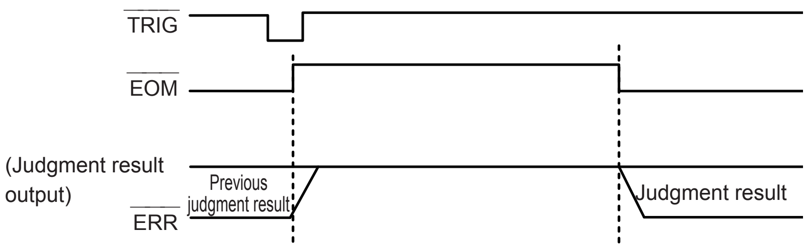
8.6.3 Setting Reset of Judgment Results (Judgment Result Signal Reset)

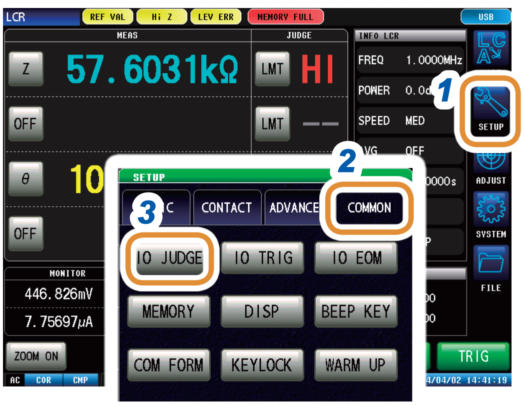
You can select whether to reset the judgment results when the signal changes to $\overline{\text{EOM}}$ (HIGH).
See LCR Application Disk - Communication Commands (`:IO:RESult:RESET`).

JUDGE RESET function: OFF



JUDGE RESET function: ON

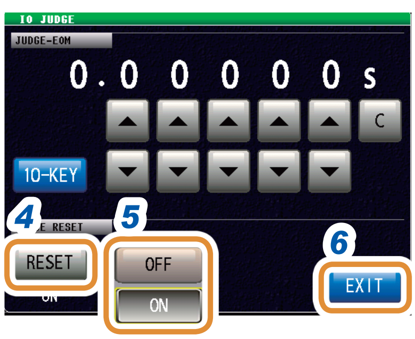




1 Press **[SETUP]**.

2 Press **[COMMON]** tab.
(**[ADVANCED]** tab for ANALYZER)

3 Press **[IO JUDGE]**.



4 Press **[RESET]**.

5 Selecting reset/no reset for judgment results.

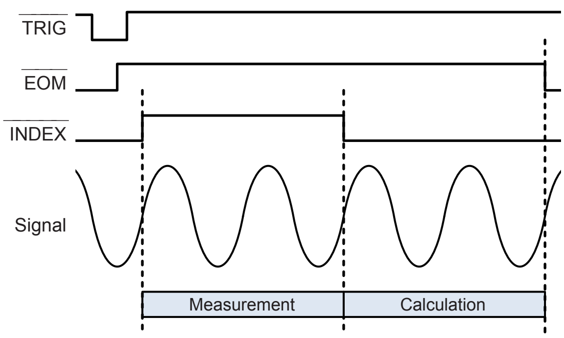
[OFF]	Stores the previous judgment results until the next judgment results are output.
[ON]	Resets the judgment results when the signal changes to $\overline{\text{EOM}}$ (HIGH).

6 Press **[EXIT]** to close the setting screen.

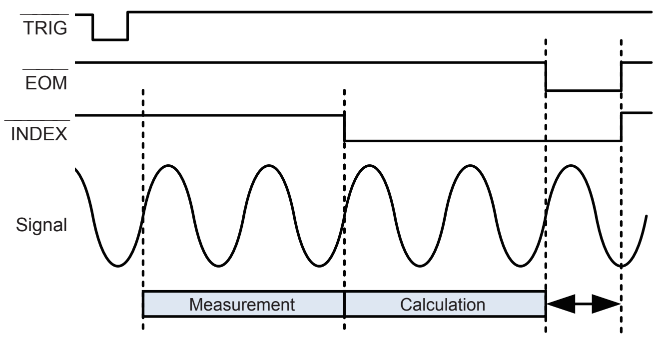
8.6.4 Setting the EOM Output Method (EOM Mode)

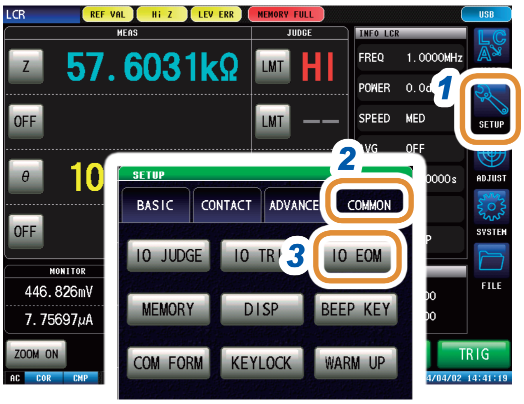
If the HIGH (OFF) time is too short due to the input circuit characteristics while receiving INDEX or EOM, the instrument can be configured to maintain the LOW (ON) state for a preset time once EOM changes to LOW (ON) before returning the signal to HIGH (OFF) after the completion of measurement. The INDEX output method can be changed in the same way.

IO EOM function: HOLD



IO EOM function: PULSE





1 **Press [SETUP].**

2 **Press [COMMON] tab.**
([ADVANCED] tab for ANALYZER)

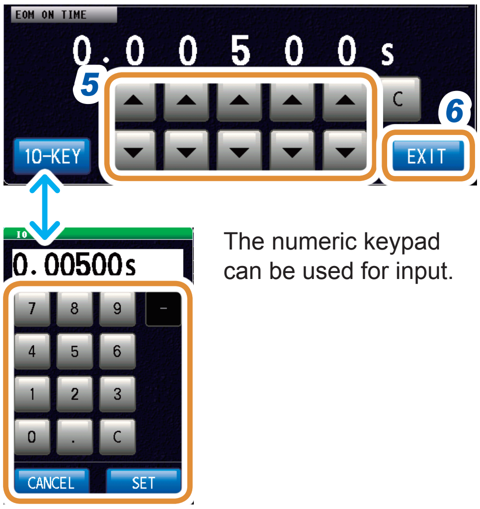
3 **Press [IO EOM].**

4 **Press [MODE].**

5 **Selecting the EOM output method.**

[HOLD]	EOM will be LOW (ON) after the measurement is completed.
[PULSE]	EOM will be LOW (ON) after the measurement is completed and HIGH (OFF) after a time that has been set elapsed.

(Set only if the output method has been set to PULSE in Step 2.)



The numeric keypad can be used for input.

6 Set the output method to **[PULSE]** before setting the output time.
Set the EOM output time for PULSE with ▲/▼ or the numeric keypad.
(With the numeric keypad, press **[SET]**.)

Settable range	0.00001 s to 0.99999 s

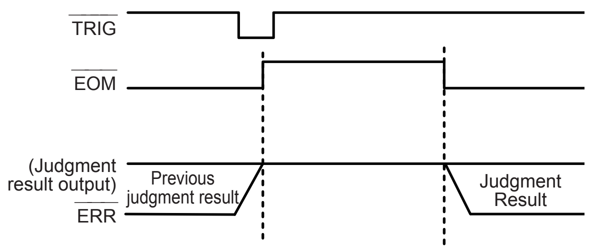
[C]	Re-enter the numerical value.

7 **Press [EXIT] to close the setting screen.**

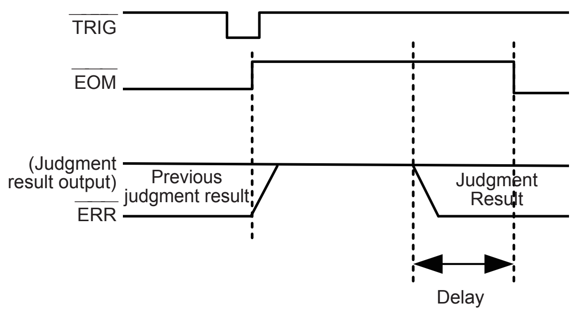
8.6.5 Setting Delay Time from Judgment Results Output until Output of EOM (LOW) (JUDGE-EOM)

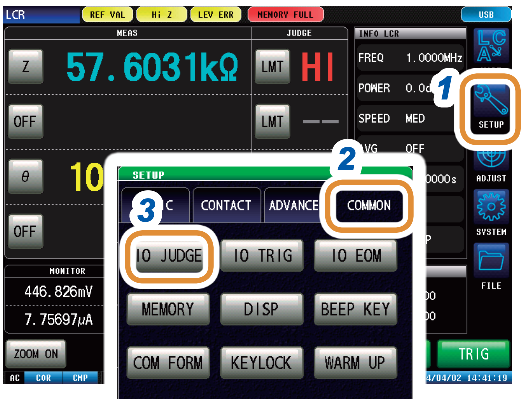
You can set a delay time between the judgment result output from the EXT I/O and the output of EOM (LOW).
See LCR Application Disk - Communication Commands (`:IO:OUTPut:DELay`).

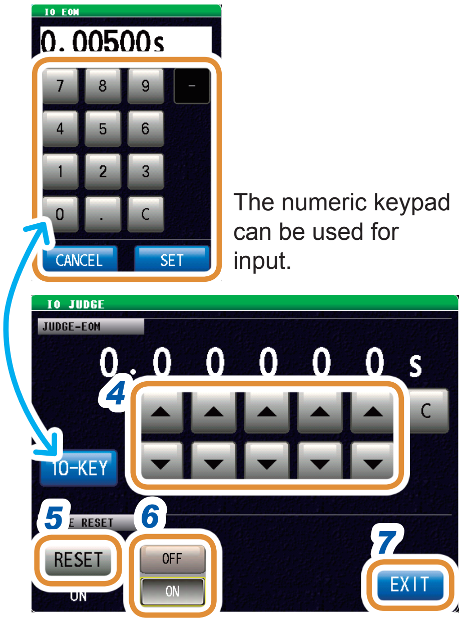
JUDGE EOM function: OFF



JUDGE EOM function: ON







1 **Press [SETUP].**

2 **Press [COMMON] tab.**
([ADVANCED] tab for ANALYZER)

3 **Press [IO JUDGE].**

4 **Set a delay time from the judgment result output until EOM (LOW) output with ▲/▼ or the numeric keypad.**
(With the numeric keypad, press **[SET]**.)

Settable range	0.00000 s to 0.99999 s

[C]	Repeats the input.
[CANCEL]	Cancels the setting.

5 **Press [RESET].**

6 **Select whether to reset the comparator judgment results when the signal changes to EOM (HIGH).**

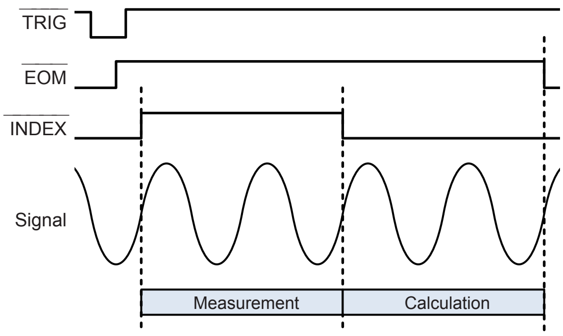
[OFF]	Stores the previous judgment results until the next judgment results are output.
[ON]	Resets the judgment results when the signal changes to EOM (HIGH).

7 **Press [EXIT] to close the setting screen.**

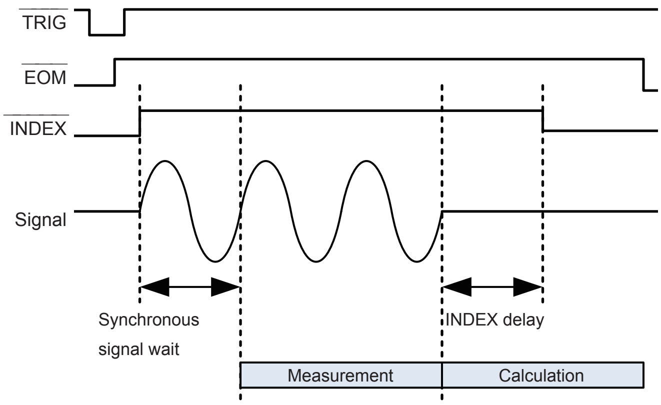
8.6.6 Set a Delay for INDEX Signal Output (INDEX Delay)

This instrument has a trigger synchronous output function called “4.2.4 Applying the Signal to the Sample during Measurement Only (Trigger Synchronous Output)” (p. 72). This function outputs the measurement signal output after the trigger input and applies the signal to the sample only during measurement. This function allows INDEX signal output after the measurement signal is completely OFF (0 V) (INDEX delay) after measurement.
See Refer to “3.2.4 Applying the Signal to the Sample During Measurement Only (Trigger Synchronous Output)” (p. 35) for the setting procedure.

Trigger synchronous output: OFF



Trigger synchronous output: ON



9 Saving and Loading Panel Information

This section describes how to save data (measurement conditions and compensation values) to the instrument's memory and how to subsequently load this data.
(Saves data at the moment **[SAVE]** is pressed.)
These operations are possible in both LCR mode and ANALYZER mode.

Saving data (panel save function)	▶	Saves the measurement conditions and compensation values. (p. 224)
Reading data (panel load function)	▶	Loads the measurement conditions and compensation values. (p. 227)
Editing saved data	▶	Allows you to edit the panel name saved. (p. 229) Deletes the saved panel. (p. 230)

Save screen

Displays the number of panels currently saved .
The color of the text changes based on the number of data items currently saved as shown below.

MODE	LCR	ANALYZER
White	0 to 14	0 to 7
Yellow	15 to 29	8 to 15
Red	30	16

Displays the contents of the panel as a list.

Panel No.	1 to 46	
Panel Name	Up to 10 characters	
Save Type	**[SET+ADJ]**	Measurement conditions and compensation values
	[SET]	Measurement condition only
	[ADJ]	Compensation conditions and compensation values

Displays saved information.

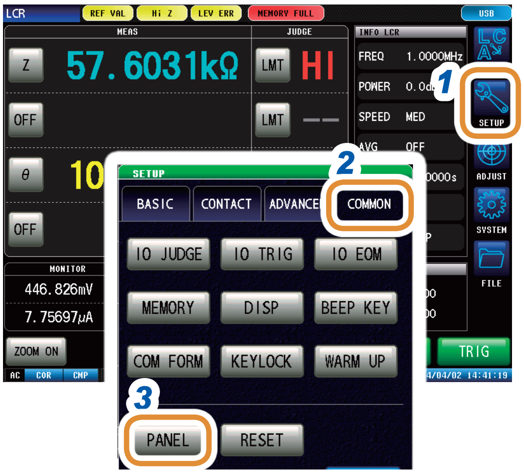
[LOAD]	Loads saved measurement condition.
[SAVE]	Saves the measurement condition.
[RENAME]	Allows you to changes the panel name.
[DELETE]	Deletes the panel.

9.1 Saving Measurement Conditions (Panel Save Function)

Saves the measurement conditions and compensation values.

Type	Number of saves allowed
LCR measurement condition	Up to 30
ANALYZER measurement condition	Up to 16

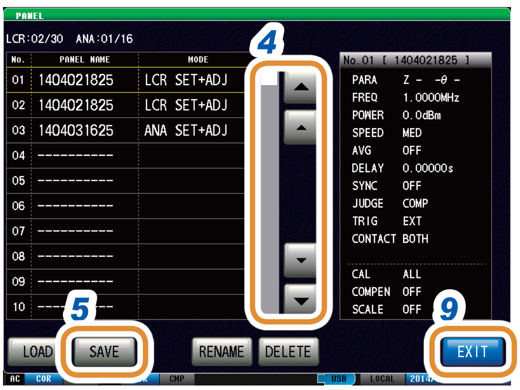
Saving measurement conditions



1 Press **[SETUP]**.

2 Press **[COMMON]** tab.
(**[ADVANCED]** tab for ANALYZER)

3 Press **[PANEL]**.



4 Select the Panel No. to be saved with ▲/▼ or by scrolling.
Display range: No. 001 to No. 46

5 Press **[SAVE]**.

When save is executed, "**PANEL SAVE**" is displayed in red at the right bottom position of the screen where time is displayed.
Do not turn off the power when this is displayed.

6 Press **[SAVE TYPE]**.

7 Select the type to save.
(ANALYZER consists of **[SET + ADJ]** only)

[SET+ADJ]	Saves both the measurement conditions and compensation values.
[SET]	Saves measurement conditions only.
[ADJ]	Saves measurement conditions and compensation values only.

8 Press **[SAVE]**.

[CANCEL]	Use this key to cancel the setting.

9 Press **[EXIT]** to close the setting screen.

Changing panel name to be saved

1 Press **[RENAME]** before Step 6 of "Saving Measurement Conditions".

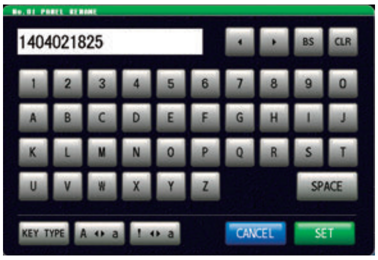
2 Enter the name to be saved.

[CLR]	Deletes all input characters.
[BS]	Deletes the last character.
[KEY TYPE]	Changes the keyboard type.
[A◀ ▶a]	Switches between upper case and lower case characters.
[!◀ ▶a]	Switches between character and symbol.
[CANCEL]	Use this key to cancel the setting.

3 Press **[SET]**.

Keyboard type

[KEY TYPE]

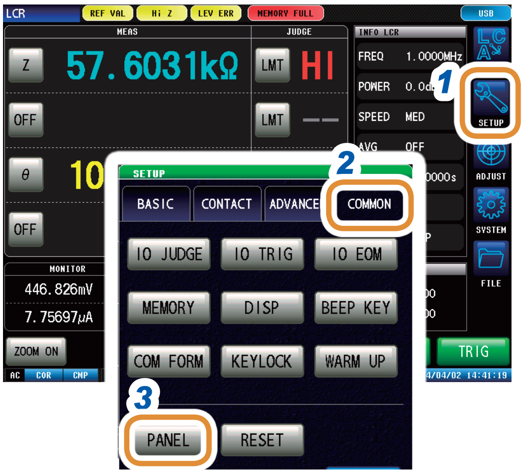


[A◀ ▶a]

[!◀ ▶a]

9.2 Loading Measurement Conditions (Panel Load Function)

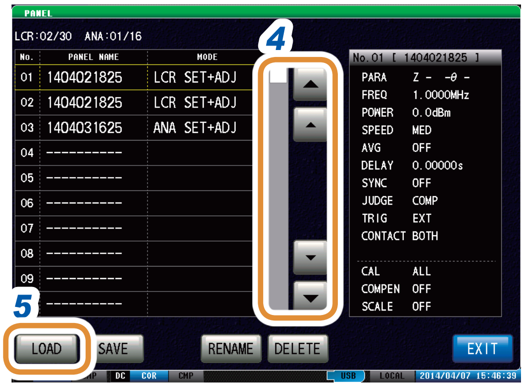
Loads measurement condition saved.



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
([ADVANCED] tab for ANALYZER)

3 **Press [PANEL].**

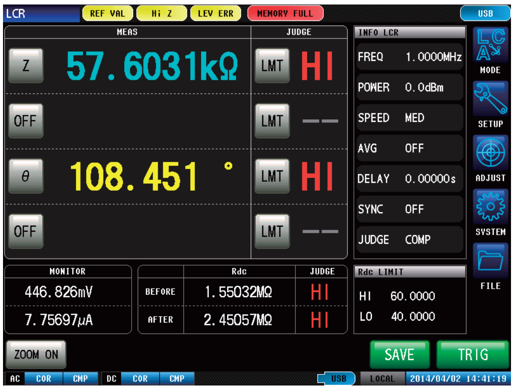


4 **Select a panel No. to be loaded with ▲/▼ or by scrolling.**
Display range: No. 001 to No. 46

5 **Press [LOAD].**
Displays information on the data to be loaded next.

6 **Press [LOAD].**
Loads the measurement conditions of the selected panel No.

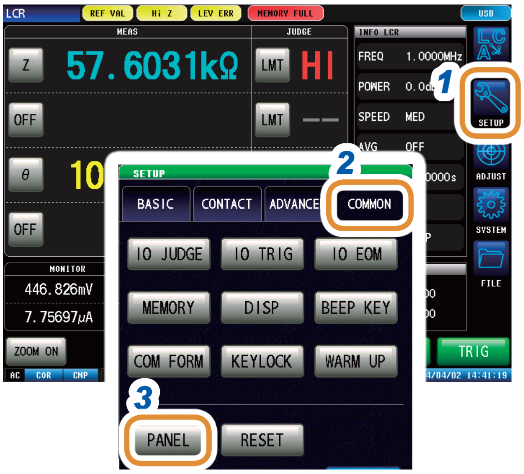
[CANCEL]	Use this key to cancel the setting.



Measurement screen is displayed automatically once the measurement conditions have been loaded.

9.3 Changing a Panel Name

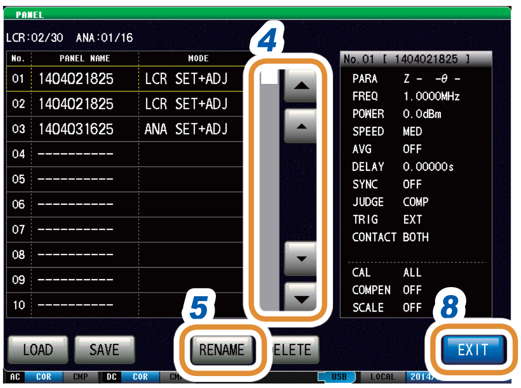
You can change the name of the panel saved in the instrument.



1 Press **[SETUP]**.

2 Press **[COMMON]** tab.
(**[ADVANCED]** tab for ANALYZER)

3 Press **[PANEL]**.



4 Select a panel No. for its name to be changed with ▲/▼ or by scrolling.

5 Press **[RENAME]**.

6 **Enter a new save name.**

[CLR]	Deletes all input characters.
[BS]	Deletes the last character.
[KEY TYPE]	Changes the keyboard type.
[A◀ ▶a]	Switches between upper case character and lower case character.
[!◀ ▶a]	Switches between character and symbol.

See “Keyboard type” (p. 226).

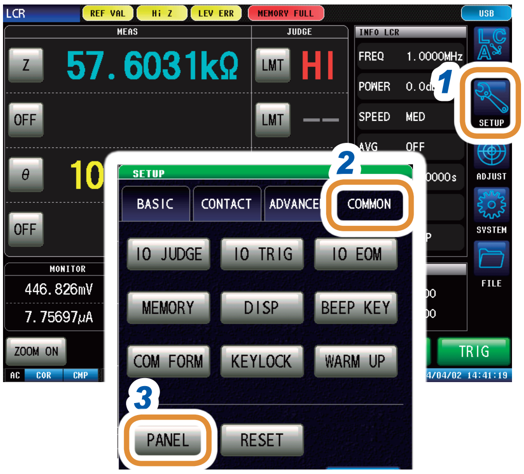
7 Press **[SET]** to confirm the name after you enter the new save name.

[CANCEL]	Use this key to cancel the setting.

8 Press **[EXIT]** to close the setting screen.

9.4 Deleting a Panel

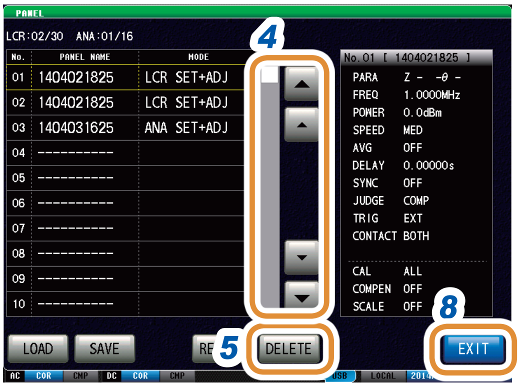
You can delete a panel saved in the instrument.



1 **Press [SETUP].**

2 **Press [COMMON] tab.**
([ADVANCED] tab for ANALYZER)

3 **Press [PANEL].**



4 **Select a panel No. to be deleted with ▲/▼ or by scrolling.**

[CANCEL]	Use this key to cancel the setting.

5 **Press [DELETE].**
Some of the information saved in the panel is displayed.

6 **Check details of a panel to be deleted.**

A panel cannot be restored once it is deleted.

7 **Press [DELETE].**

[CANCEL]	Use this key to cancel the setting.

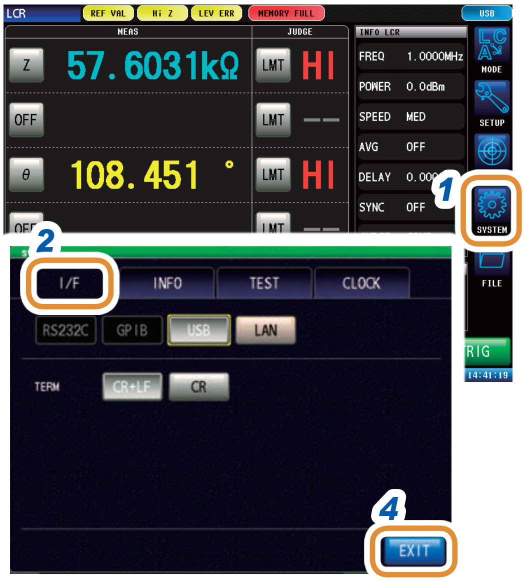
8 **Press [EXIT] to close the setting screen.**

10 Setting the SYSTEM

10.1 Setting the Interface

You can control the instrument from a computer via the USB, LAN, GP-IB and RS-232C interfaces.

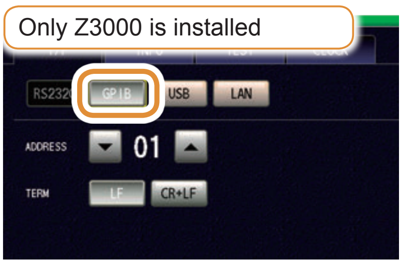
> GP-IB and RS-232C settings can be configured only if the optional Z3000 (GP-IB) or Z3001 (RS-232C) is installed.



1 Press **[SYSTEM]**.

2 Press **[I/F]** tab.
Usually only **[UBS]** and **[LAN]** are displayed.

3 **Select the interface type.**
See the Communication Instruction Manual (LCR Application Disk) for more information on the settings.



4 Press **[EXIT]** to close the setting screen.

10.2 Checking the Instrument Version

1 **Press [SYSTEM].**

2 **Press [INFO] tab.**

Displays the version of the instrument.

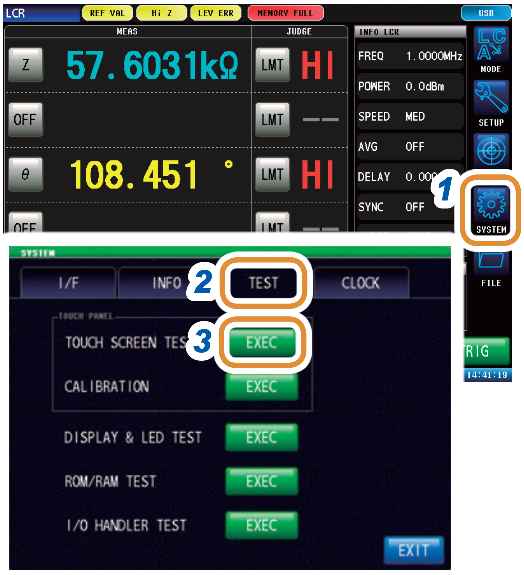
3 **Press [EXIT] to close the setting screen.**

10.3 Self Checks (Self Diagnosis)

You can check the display screens of the instrument.

10.3.1 Panel Test

You can check the touch panel.



1 **Press [SYSTEM].**

2 **Press [TEST] tab.**

3 **Press [EXEC] of TOUCH SCREEN TEST.**

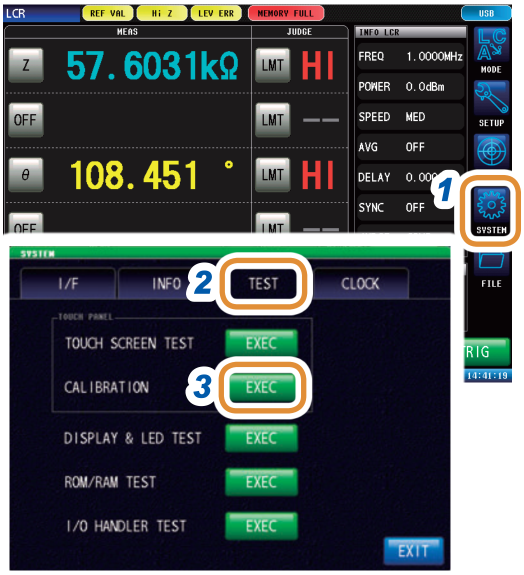
4 It is working correctly if it is highlighted when (gray color) is pressed.

> Perform panel compensation if it is not highlighted or (red) is displayed.
> There is a possibility of malfunction if there is an error after panel compensation. Contact your authorized Hioki distributor or reseller.

5 **Press [EXIT] to close the setting screen.**

10.3.2 Panel Compensation

You can perform position compensation of the touch panel.

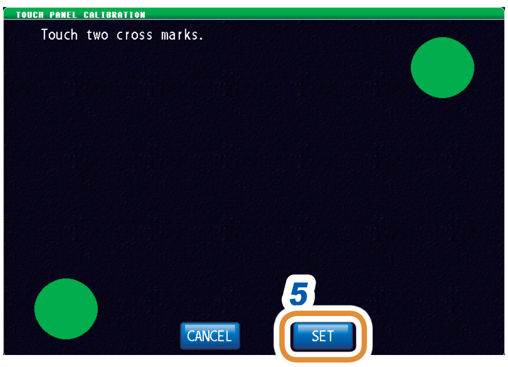


1 Press **[SYSTEM]**.

2 Press **[TEST]** tab.

3 Press **CALIBRATION** of **[EXEC]**.

4 Press center of  until  (green color) appears (2 points).



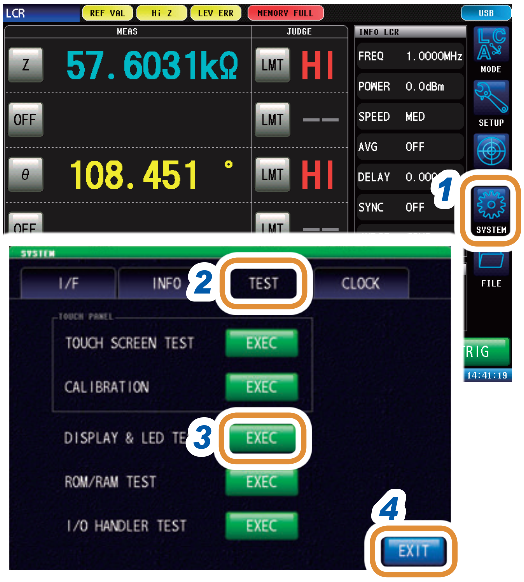
5 Press **[SET]**.

> The instrument needs to be repaired if **[SET]** is not displayed.
> Contact your authorized Hioki distributor or reseller.

[CANCEL]	Cancels position compensation.

10.3.3 Screen Display Test

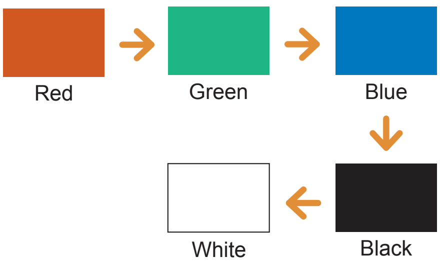
Checks the display state of the screen and lit state of the LED.



1 **Press [SYSTEM].**

2 **Press [TEST] tab.**

3 **Press [EXEC] of DISPLAY & LED TEST.**



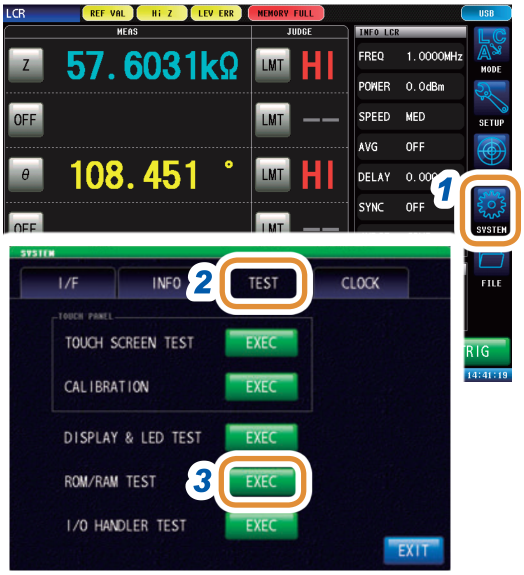
Pressing the screen will change the screen color in the order shown on the left.

> The instrument has to be repaired if the entire screen color is not uniform.
> Contact your authorized Hioki distributor or reseller.

4 **Press [EXIT] to close the setting screen.**

10.3.4 ROM/RAM Test

Checks the internal memory (ROM and RAM) of this instrument.



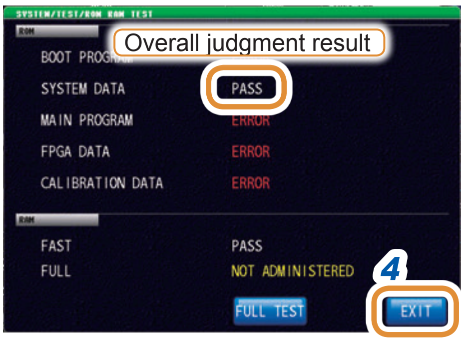
1 Press **[SYSTEM]**.

2 Press **[TEST]** tab.

3 Press **[EXEC]** of ROM/RAM TEST.

ROM/RAM TEST starts automatically. (Testing time: Approximately 15 minutes)

None of the operations is possible during the ROM/RAM test.



If the overall judgment result indication is [PASS], the test terminates normally.

If the display for overall judgment result is “NOT ADMINISTRATED”, press **[FULL TEST]** to check the details of RAM.

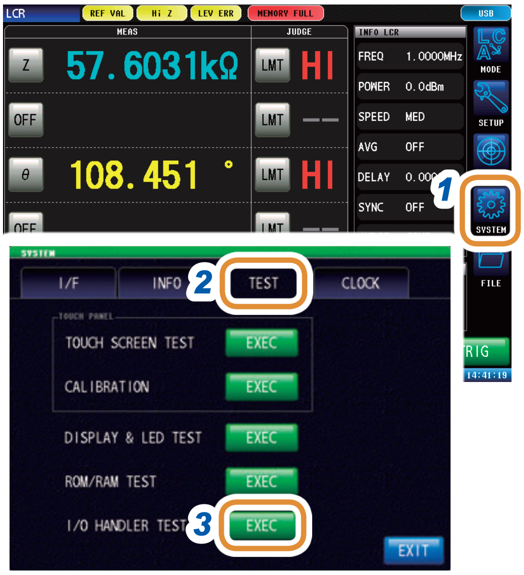
[YES]	The instrument is restarted to conduct detailed RAM tests.
[NO]	Detailed RAM tests will not be executed.

This instrument needs to be repaired if the overall judgment result displayed is [NG]. Contact your authorized Hioki distributor or reseller.

4 Press **[EXIT]** to close the setting screen.

10.3.5 I/O Test

Check if the output signal is output normally from the EXT I/O, and if the input signal is read normally.



1 **Press [SYSTEM].**

2 **Press [TEST] tab.**

3 **Press [EXEC] of I/O HANDLER TEST.**

To test output signal:
Press the key with the name of the signal for which you want to check the output.

To test input signal:
The signal line name of the input signal being input (LOW) is displayed in the input signal test window.

4 **Press [EXIT] to close the setting screen.**

10.4 Setting Date and Time

You can set the date and time of this instrument. Data is recorded and managed based on the set date and time.

1 **Press [SYSTEM].**

2 **Press [CLOCK] tab.**

3 **Set the date and time with ▲/▼.**

Settable range:

00:00:00, January 1, 2000, to 23:59:59, December 31, 2099

4 **Press [SET] to complete.**

5 **Press [EXIT] to close the setting screen.**

11 Using USB Flash Drive

11.1 Overview

You can save measured values and instrument settings to a USB flash drive. You can also load the saved data.

Saving data ▶	You can save data from this instrument to a USB flash drive. • Measured values (text format, binary format) • Measurement screen • Memory data • Instrument settings • Instrument settings and panel settings
Reading data ▶	You can load data from a USB flash drive to this instrument. • Instrument settings • Instrument settings, panel settings and measured values (binary format)
File operation ▶	• You can format (initialize) a USB flash drive. (p. 265) • You can create a folder. (p. 267) • You can change a file name or folder name. (p. 268) • You can delete a file or folder. (p. 270)

Specifications of compatible USB flash drives

Connector	USB type A connector
Electrical specifications	USB2.0
Power supply	Maximum 500 mA
No. of ports	1
Compatible USB device	USB Mass Storage Class

⚠ CAUTION

- Hioki cannot recover or analyze data from damaged or faulty storage media. We cannot compensate for such data loss, regardless of the contents or cause of the failure or damage. We recommend you to make a backup of all important data in a computer or other devices.
- When transporting this instrument, remove the USB flash drive. There is a possibility that this instrument or the media could be damaged.
- Some USB flash drives are easily affected by static electricity. Handle the USB flash drive with care as there is a possibility of the drive getting damaged or the instrument malfunctioning due to static electricity.

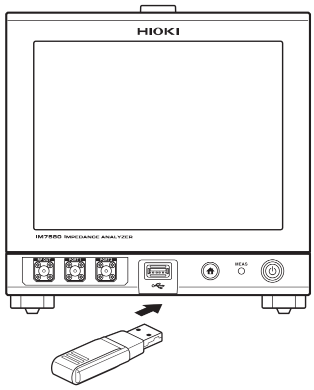
⚠ CAUTION

- Avoid inserting the USB flash drive with the wrong orientation. This can damage the USB flash drive or instrument.
- When a USB flash drive is being accessed, the color of the USB icon changes from blue to red. Do not turn off the power of the instrument while the USB flash drive is being accessed. Also, do not remove the USB flash drive from the instrument while it is being accessed. This may result in loss of data stored in the USB flash drive.

Reference
USB flash drives have limited usable lifetime. Data reading and writing will fail after long-term use. Replace the USB flash drive in this case.

11.2 Inserting and Removing USB Flash Drive

Front



Inserting USB flash drive

Insert the USB flash drive into the USB port on the front panel.

- Do not insert an USB flash drive that is not compatible with Mass Storage Class.
- Some commercially available USB flash drives are not compatible.
- If an USB flash drive is not recognized, try using a different USB flash drive.

Removing an USB flash drive

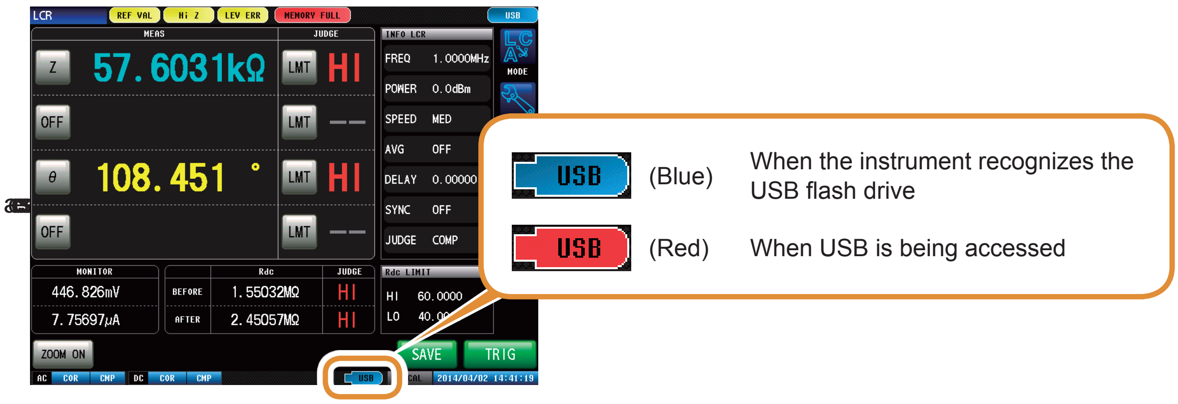
Remove an USB after checking that the USB flash drive is not being accessed (saving, reading, etc.) by this instrument.

A remove operation need not be performed in the instrument.

Icon display when using USB

When an USB flash drive has been recognized properly, the USB flash drive icon is displayed at the bottom of the measurement screen.

The icon is red while the USB flash drive is being



File types handled by the instrument

- This instrument cannot display double-byte characters (Japanese, etc.). Double-byte characters are replaced by “??”.
- Up to 1,000 files can be displayed on the screen of the instrument.

Data	Type	Extension
-	Folder	-
Measurement data	CSV file	.CSV
	Binary file	.ANA
Screen copy	BMP file	.BMP
Instrument settings data	Settings file	.SET
Panel save data	Panel settings file	.PNL

11.3 Screen Display When Using USB

The display is as follows when a USB flash drive is being used.
You can configure settings such as save format, save destination, and text save format for the files.

Screen

File name File size File save date and time

You can change the sorting order of files.
The number of **+** and **-** signs shows the sorting priority.
Extension will be given priority for the sorting order of files with **EXT**.

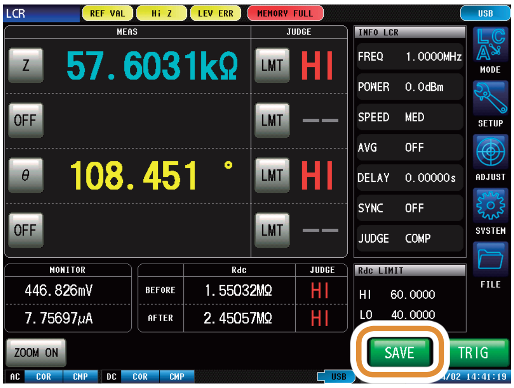
You can check the usage rate and type of file system of the USB flash drive.

Filesystem	File system type
All	Total size
Used	Space used
Avail	Free space

Allows advanced setting for file save.

11.4 Saving Data to USB Flash Drive

Pressing **[SAVE]** saves data as of that moment.



11.4.1 Saving Measurement Result as Text

Saves the measurement data to a USB flash drive in CSV format. File extension is ".CSV".

- When you save measurement data in ANALYZER mode as binary data, press **[SAVE]** on the file screen and select the data to be saved.
- In case of ANALYZER mode, set **[TRIG]** to **[SEQ]**.
  A single sweep will not be stored because sweep will be repeated when **[TRIG]** is set to **[REPEAT]**.
  See "4.2.2 Starting Measurement at Any Arbitrary Timing (Trigger)" (p. 70).

LCR mode	Saves the measured values displayed in the current screen in CSV format.
ANALYZER mode	Saves the measured values of one sweep in CSV format. (Set **[TRIG]** to **[SEQ]**.)
CONTINUOUS measurement mode	Saves the measurement results of each panel in CSV format.

Measurement results are saved in the following order: measuring instrument information, save time and date, measurement conditions, measurement parameters, and measured values.
Text file header (save time and date, measurement conditions and measurement parameters), delimiter, and quotation mark type can be configured.

Save examples:

Settings: DATE: ON, SET: ON, PARA: ON, DELIM: “ , “ (comma), QUOTE: “ (double quotation mark)

In case of LCR mode

```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“DATE”,”14-05-08”
“TIME”,”15:17:10”

“TRIG”,”EXT”
“TRIG DELAY”,”0.00000”,”s”
“SYNC”,”OFF”,””
“TRIG SYNC WAIT”,”0.00100”,”s”
“TRIG SYNC INDEX WAIT”,”0.00000”,”s”
“FREQ”,” 1.0000E+06”,”Hz”
“POWER”,”0.0”,”dBm”
“SPEED”,”MED”,””
“AVG”,”001”,””
“RDC”,”OFF”
“WAVE”,”0001”
“DC WAIT”,”0.00000”,”s”
“AC WAIT”,”0.00000”,”s”
“SCALING”,”OFF”

“Z[ohm]”,”OFF”,”PHASE[deg]”,”OFF”
“5.98718E+00”,””,”175.604”,””
```

In case of CONTINUOUS measurement mode

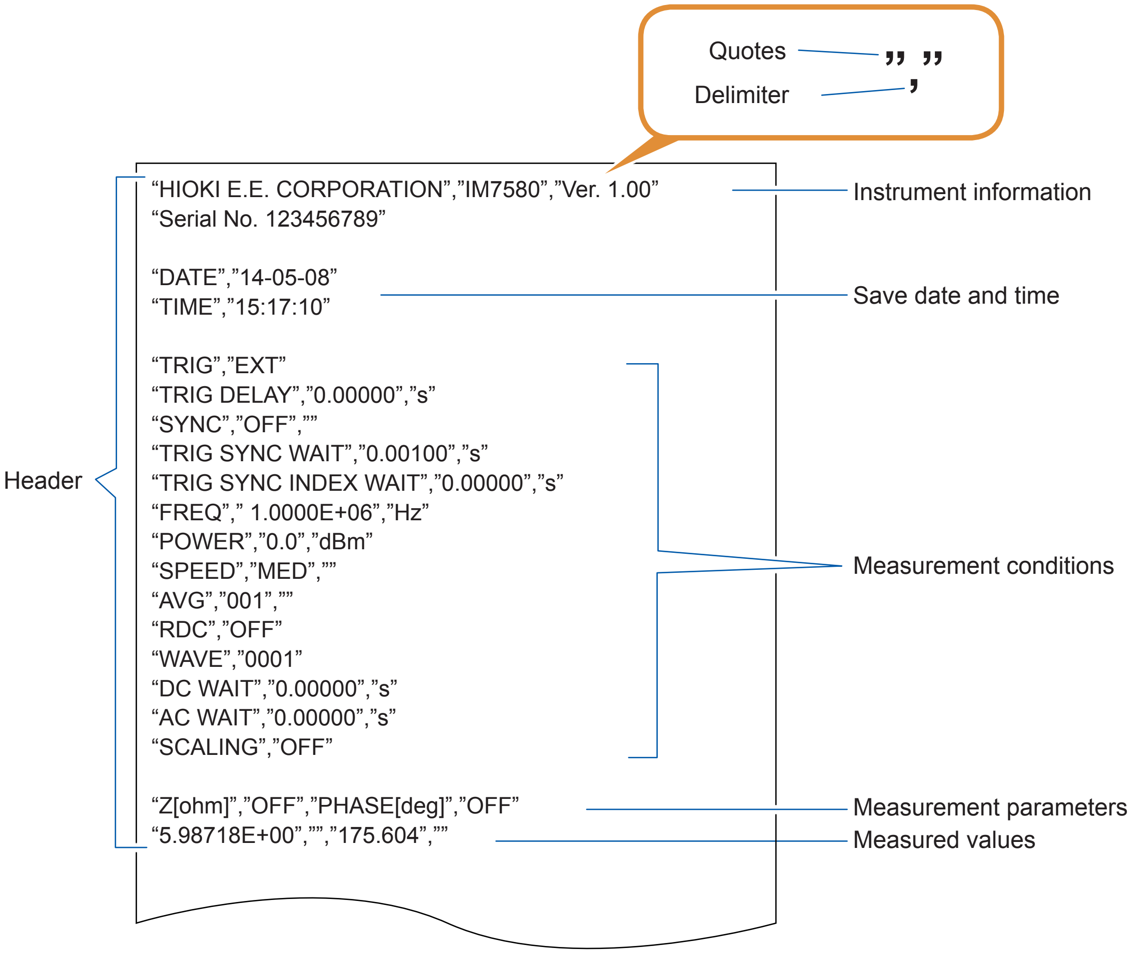
```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“DATE”,”14-05-08”
“TIME”,”15:21:57”

“LCR”,”1”,”1405081406”

“TRIG”,”EXT”
“TRIG DELAY”,”0.00000”,”s”
“SYNC”,”OFF”,””
“TRIG SYNC WAIT”,”0.00100”,”s”
“TRIG SYNC INDEX WAIT”,”0.00000”,”s”
“FREQ”,” 1.0000E+06”,”Hz”
“POWER”,”0.0”,”dBm”
“SPEED”,”MED”,””
“AVG”,”001”,””
“RDC”,”OFF”
“WAVE”,”0001”
“DC WAIT”,”0.00000”,”s”
“AC WAIT”,”0.00000”,”s”
“SCALING”,”OFF”

“Z[ohm]”,”OFF”,”PHASE[deg]”,”OFF”
“5.98677E+00”,””,”175.605”,””
```

In case of ANALYZER mode

```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“DATE”,”14-05-08”
“TIME”,”15:17:16”

“SOURCE”,”FREQ”
“TRIG”,”SEQ”
“TRIG DELAY”,”0.00000”,”s”
“TRIG SYNC”,”OFF”
“TRIG SYNC WAIT”,”0.00100”,”s”
“TRIG SYNC INDEX WAIT”,”0.00000”,”s”
“RDC”,”OFF”
“WAVE”,”0001”
“DC WAIT”,”0.00000”,”s”
“AC WAIT”,”0.00000”,”s”
“SCALING”,”OFF”

“No.”,”FREQ[Hz]”,”LEVEL”,””,”SPEED”,”AVG”,”DELAY”,”Z[ohm]”,”PHASE[deg]”,”Rs[ohm]”,”X[ohm]”
“1”,” 1.0000E+06”,”0.0”,”dBm”,”MED”,”001”,”0.00000s”,”5.98703E+00”,”175.598”,”-5.96937E+00”,”459.52E-03”
“2”,” 1.0289E+06”,”0.0”,”dBm”,”MED”,”001”,”0.00000s”,”6.00294E+00”,”175.729”,”-5.98627E+00”,”447.03E-03”
“3”,” 1.0587E+06”,”0.0”,”dBm”,”MED”,”001”,”0.00000s”,”6.01893E+00”,”175.858”,”-6.00321E+00”,”434.69E-03”
“4”,” 1.0893E+06”,”0.0”,”dBm”,”MED”,”001”,”0.00000s”,”6.03107E+00”,”175.982”,”-6.01625E+00”,”422.57E-03”
“5”,” 1.1208E+06”,”0.0”,”dBm”,”MED”,”001”,”0.00000s”,”6.04609E+00”,”176.100”,”-6.03209E+00”,”411.20E-03”
“6”,” 1.1533E+06”,”0.0”,”dBm”,”MED”,”001”,”0.00000s”,”6.05984E+00”,”176.217”,”-6.04664E+00”,”399.83E-03”
“7”,” 1.1866E+06”,”0.0”,”dBm”,”MED”,”001”,”0.00000s”,”6.07116E+00”,”176.324”,”-6.05867E+00”,”389.28E-03”
```

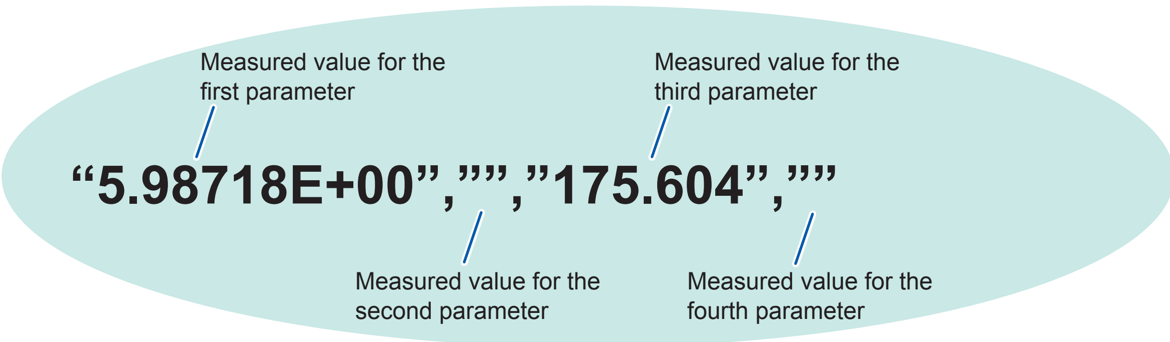
How to understand CSV files

DATE (save time and date): ON, SET (measurement condition): ON, PARA (measurement parameter): ON, DELIM (delimiter): “ , “ (comma), QUOTE: “ (double quotation mark)

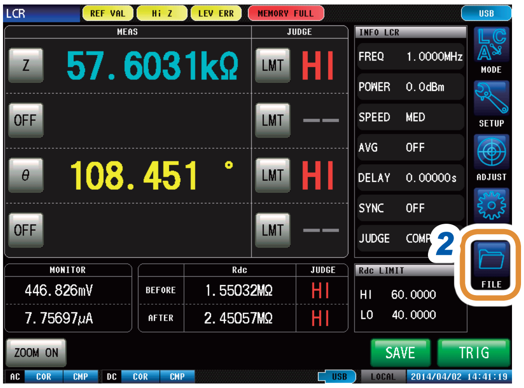


How to understand measured values

Examples: First parameter: Z (impedance (Ω)), second parameter: OFF, third parameter: θ (impedance phase angle (°)) and fourth parameter: OFF



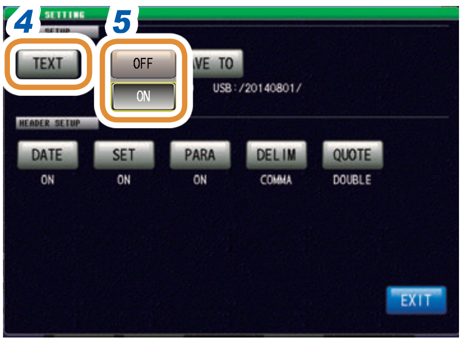
The above shows that the first parameter is “5.98718 Ω”, the third parameter is “175.604°”. Measured values for the second and fourth parameters are not displayed as they are OFF.



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

3 **Press [SETUP].**



4 **Press [TEXT].**

5 **Enable setting for text save.**

[OFF]	Disables the text file type.
[ON]	Saves measured values as text data.

6 **Select settings for header, delimiter, and quotation.**

[DATE]	Turns the save date and time ON/OFF.
[SET]	Turns the measurement condition ON/OFF.
[PARA]	Turns the measurement parameter ON/OFF.
[DELIM]	Sets the delimiter type.
[QUOTE]	Sets the quotation mark type.

7 **Press [EXIT] to close the setting screen.**

Go to the next page.

8 **Press [SAVE] in the measurement screen.**

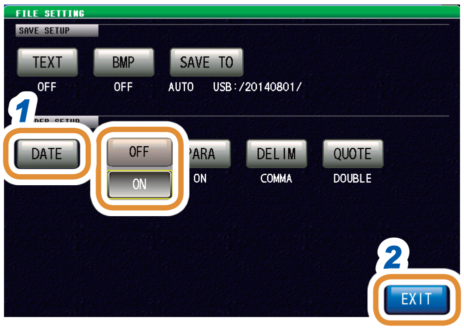
Measurement data is saved in the USB flash drive.

- Auto save (default): Measurement data is saved.
- For manual save: See “Setting Save Folder” (p. 256).

- Auto save (default setting) automatically creates a folder in the USB flash drive and saves the file in the folder.
  The folder name is created with the date and time of saving.
  Example: Saved on July 30, 2014 -> 20140730
- For manual save: See “11.4.3 Setting Save Folder” (p. 256).
- Name of the file is automatically assigned from the date and time for both auto save and manual save modes.
  Example: Saved at 16:31:44 on July 30, 2014 -> 140730163144.csv

Settings header, delimiter, and quotation

(1) [DATE] Save date and time



1 **Select record/no record for save date in a text file.**

[OFF]	Does not record the save date and time.
[ON]	Records the save date and time.

2 **Press [EXIT] to close the setting screen.**

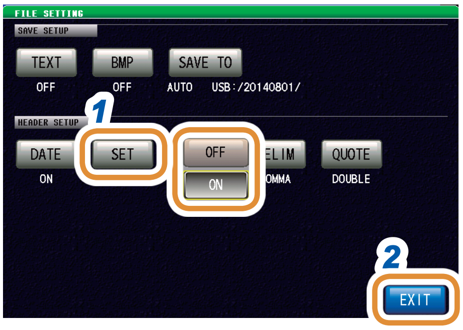
When ON

```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“DATE”,”14-05-08”
“TIME”,”15:17:10”

“TRIG”,”EXT”
“TRIG DELAY”,”0.00000”,”s”
“SYNC”,”OFF”,””
“TRIG SYNC WAIT”,”0.00100”,”s”
“TRIG SYNC INDEX WAIT”,”0.00000”,”s”
“FREQ”,” 1.0000E+06”,”Hz”
“POWER”,”0.0”,”dBm”
“SPEED”,”MED”,””
“AVG”,”001”,””
“RDC”,”OFF”
“WAVE”,”0001”
“DC WAIT”,”0.00000”,”s”
“AC WAIT”,”0.00000”,”s”
“SCALING”,”OFF”

“Z[ohm]”,”OFF”,”PHASE[deg]”,”OFF”
“5.98718E+00”,””,”175.604”,””
```

When OFF

```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“TRIG”,”EXT”
“TRIG DELAY”,”0.00000”,”s”
“SYNC”,”OFF”,””
“TRIG SYNC WAIT”,”0.00100”,”s”
“TRIG SYNC INDEX WAIT”,”0.00000”,”s”
“FREQ”,” 1.0000E+06”,”Hz”
“POWER”,”0.0”,”dBm”
“SPEED”,”MED”,””
“AVG”,”001”,””
“RDC”,”OFF”
“WAVE”,”0001”
“DC WAIT”,”0.00000”,”s”
“AC WAIT”,”0.00000”,”s”
“SCALING”,”OFF”

“Z[ohm]”,”OFF”,”PHASE[deg]”,”OFF”
“5.98718E+00”,””,”175.604”,””
```

(2) [SET] Measurement condition



1 **Select record/no record for measurement condition in a text file.**

[OFF]	Measurement condition is not recorded.
[ON]	Measurement condition is recorded.

2 **Press [EXIT] to close the setting screen.**

When ON

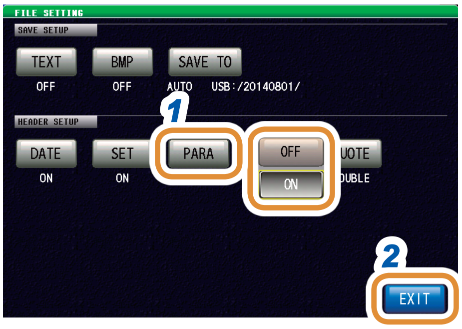
```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“DATE”,”14-05-08”
“TIME”,”15:17:10”

“TRIG”,”EXT”
“TRIG DELAY”,”0.00000”,”s”
“SYNC”,”OFF”,””
“TRIG SYNC WAIT”,”0.00100”,”s”
“TRIG SYNC INDEX WAIT”,”0.00000”,”s”
“FREQ”,” 1.0000E+06”,”Hz”
“POWER”,”0.0”,”dBm”
“SPEED”,”MED”,””
“AVG”,”001”,””
“RDC”,”OFF”
“WAVE”,”0001”
“DC WAIT”,”0.00000”,”s”
“AC WAIT”,”0.00000”,”s”
“SCALING”,”OFF”

“Z[ohm]”,”OFF”,”PHASE[deg]”,”OFF”
“5.98718E+00”,””,”175.604”,””
```

When OFF

```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“DATE”,”14-05-08”
“TIME”,”15:17:10”

“Z[ohm]”,”OFF”,”PHASE[deg]”,”OFF”
“5.98718E+00”,””,”175.604”,””
```

(3) [PARA] Measurement parameters

> The measurement parameters "θ", "σ" and "ε" are displayed as "PHASE," "S,"and "E," respectively.



1 **Select record/no record for measurement parameter in a text file.**

[OFF]	Measurement parameter is not recorded.
[ON]	Measurement parameter is recorded.

2 **Press [EXIT] to close the setting screen.**

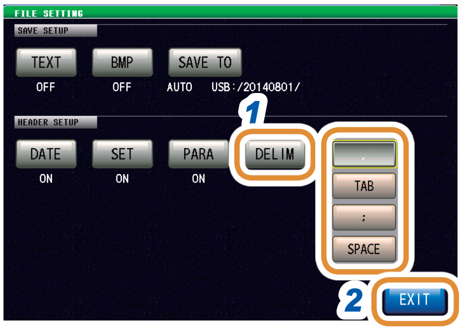
When ON

```
"HIOKI E.E. CORPORATION","IM7580","Ver. 1.00"
"Serial No. 123456789"

"DATE","14-05-08"
"TIME","15:17:10"

"TRIG","EXT"
"TRIG DELAY","0.00000","s"
"SYNC","OFF",""
"TRIG SYNC WAIT","0.00100","s"
"TRIG SYNC INDEX WAIT","0.00000","s"
"FREQ"," 1.0000E+06","Hz"
"POWER","0.0","dBm"
"SPEED","MED",""
"AVG","001",""
"RDC","OFF"
"WAVE","0001"
"DC WAIT","0.00000","s"
"AC WAIT","0.00000","s"
"SCALING","OFF"

"Z[ohm]","OFF","PHASE[deg]","OFF"
"5.98718E+00","","175.604",""
```

When OFF

```
"HIOKI E.E. CORPORATION","IM7580","Ver. 1.00"
"Serial No. 123456789"

"DATE","14-05-08"
"TIME","15:17:10"

"TRIG","EXT"
"TRIG DELAY","0.00000","s"
"SYNC","OFF",""
"TRIG SYNC WAIT","0.00100","s"
"TRIG SYNC INDEX WAIT","0.00000","s"
"FREQ"," 1.0000E+06","Hz"
"POWER","0.0","dBm"
"SPEED","MED",""
"AVG","001",""
"RDC","OFF"
"WAVE","0001"
"DC WAIT","0.00000","s"
"AC WAIT","0.00000","s"
"SCALING","OFF"

"5.98718E+00","","175.604",""
```

(4) [DELIM] Delimiter



1 Select a setting for delimiter.

[,]	Sets the delimiter to a comma (,).
[TAB]	Sets the delimiter to a tab.
[;]	Sets the delimiter to a semicolon (;).
[SPACE]	Sets the delimiter to a space.

2 Press [EXIT] to close the setting screen.

For comma

```
"HIOKI E.E. CORPORATION","IM7580","Ver. 1.00"
"Serial No. 123456789"

"DATE","14-05-08"
"TIME","15:29:04"

"TRIG","EXT"
"TRIG DELAY","0.00000","s"
"SYNC","OFF",""
"TRIG SYNC WAIT","0.00100","s"
"TRIG SYNC INDEX WAIT","0.00000","s"
"FREQ"," 1.0000E+06","Hz"
"POWER","0.0","dBm"
"SPEED","MED",""
"AVG","001",""
```

For tab

```
"HIOKI E.E. CORPORATION"	"IM7580"	"Ver. 1.00"
"Serial No. 123456789"

"DATE"	"14-05-08"
"TIME"	"15:29:12"

"TRIG"	"EXT"
"TRIG DELAY"	"0.00000"	"s"
"SYNC"	"OFF"	""
"TRIG SYNC WAIT"	"0.00100"	"s"
"TRIG SYNC INDEX WAIT"	"0.00000"	"s"
"FREQ"	" 1.0000E+06"	"Hz"
"POWER"	"0.0"	"dBm"
"SPEED"	"MED"	""
"AVG"	"001"	""
```

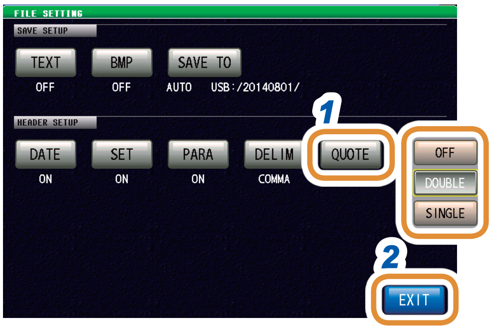
For semicolon

```
"HIOKI E.E. CORPORATION";"IM7580";"Ver. 1.00"
"Serial No. 123456789"

"DATE";"14-05-08"
"TIME";"15:29:17"

"TRIG";"EXT"
"TRIG DELAY";"0.00000";"s"
"SYNC";"OFF";""
"TRIG SYNC WAIT";"0.00100";"s"
"TRIG SYNC INDEX WAIT";"0.00000";"s"
"FREQ";" 1.0000E+06";"Hz"
"POWER";"0.0";"dBm"
"SPEED";"MED";""
"AVG";"001";""
```

For space

```
"HIOKI E.E. CORPORATION" "IM7580" "Ver. 1.00"
"Serial No. 123456789"

"DATE" "14-05-08"
"TIME" "15:29:22"

"TRIG" "EXT"
"TRIG DELAY" "0.00000" "s"
"SYNC" "OFF" ""
"TRIG SYNC WAIT" "0.00100" "s"
"TRIG SYNC INDEX WAIT" "0.00000" "s"
"FREQ" " 1.0000E+06" "Hz"
"POWER" "0.0" "dBm"
"SPEED" "MED" ""
"AVG" "001" ""
```

(5) [QUOTE] Quote



1 **Selects a setting for quote.**

[OFF]	No quotation marks are added.
[“]	Sets quote to “ (double quotation mark).
[‘]	Sets quote to ‘ (single quotation mark).

2 **Press [EXIT] to close the setting screen.**

When OFF

```
HIOKI E.E. CORPORATION,IM7580,Ver. 1.00
Serial No. 123456789

DATE,14-05-08
TIME,15:29:42

TRIG,EXT
TRIG DELAY,0.00000,s
SYNC,OFF,
TRIG SYNC WAIT,0.00100,s
TRIG SYNC INDEX WAIT,0.00000,s
FREQ, 1.0000E+06,Hz
POWER,0.0,dBm
SPEED,MED,
AVG,001,
```

For double quotation mark

```
“HIOKI E.E. CORPORATION”,”IM7580”,”Ver. 1.00”
“Serial No. 123456789”

“DATE”,”14-05-08”
“TIME”,”15:29:50”

“TRIG”,”EXT”
“TRIG DELAY”,”0.00000”,”s”
“SYNC”,”OFF”,””
“TRIG SYNC WAIT”,”0.00100”,”s”
“TRIG SYNC INDEX WAIT”,”0.00000”,”s”
“FREQ”,” 1.0000E+06”,”Hz”
“POWER”,”0.0”,”dBm”
“SPEED”,”MED”,””
“AVG”,”001”,””
```

For single quotation mark

```
‘HIOKI E.E. CORPORATION’,’IM7580’,’Ver. 1.00’
‘Serial No. 123456789’

‘DATE’,’14-05-08’
‘TIME’,’15:29:53’

‘TRIG’,’EXT’
‘TRIG DELAY’,’0.00000’,’s’
‘SYNC’,’OFF’,’’
‘TRIG SYNC WAIT’,’0.00100’,’s’
‘TRIG SYNC INDEX WAIT’,’0.00000’,’s’
‘FREQ’,’ 1.0000E+06’,’Hz’
‘POWER’,’0.0’,’dBm’
‘SPEED’,’MED’,’’
‘AVG’,’001’,’’
```

Error measurement results

Priority order	Measurement error	Error display	Measurement status	Measured values Upper portion: Text save and memory function (short format), Lower portion: Memory function (long format)	When saved by memory function Comparator judgment Logical product	 Parameter judgment result	 BIN judgment BIN No.
High	Measurement error	MEAS ERR MEAS ERR	2	999999E+28 9999999999E+28	0	1*1	-1
	Not calibrated	UNCAL UNCAL	3	Normal measured values Normal measured values	*2	*2	*2
	Detection level error	LEV ERR LEV ERR	4	Normal measured values Normal measured values	0	1*1	Normal measure-ment
	Contact error	HI or LO	5	Normal measured values Normal measured values Use the following values in case of before contact check error 999999E+28 9999999999E+28	0	1*1	Normal measure-ment
	Outside Hi Z reject limit range	Hi Z Hi Z	8	Normal measured values Normal measured values	Normal measure-ment	Normal measurement	Normal measure-ment
	Outside display area	DISP OUT DISP OUT	9	Normal measured values Normal measured values	Normal measure-ment	Normal measurement	Normal measure-ment
	Outside of guaranteed accuracy range	REF VAL REF VAL	10	Normal measured values Normal measured values	*2	*2	*2
	Normal	Measured values	0	Normal measured values Normal measured values	Normal measure-ment	Normal measurement	Normal measure-ment
Low	Not measured	No display	1	999999E+28 9999999999E+28	0	2	-2

*1 The judgment result will be 2 when comparator judgment is not made.
*2 Depends on the [JUDGE EXEC] setting.
[DO] Normal judgment
[NOT] Logical product: 0 BIN Number: -1 Parameter judgment result: 1

Output format of measurement statuses is determined based on the setting for communication measurement data type after saving with the memory function.
See “7.2.3 Setting the Communication Measurement Data Type” (p. 179).

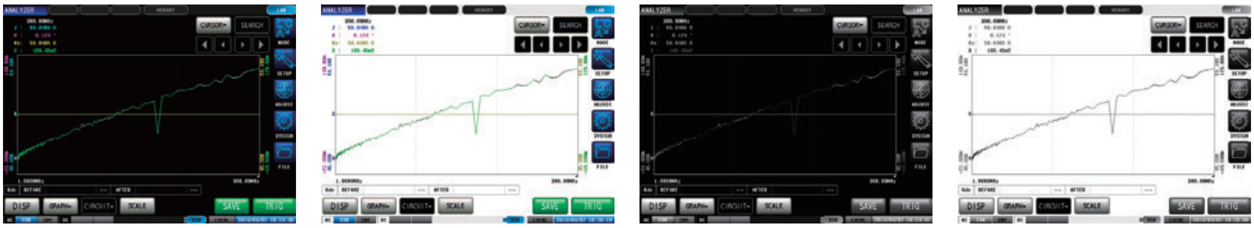
11.4.2 Saving Measurement Screen (Screen Copy)

You can save the screen currently displayed to the USB flash drive in bmp file format (full color or gray scale (black and white gray scale)).
The file extension is ".BMP".

Example of BMP file:

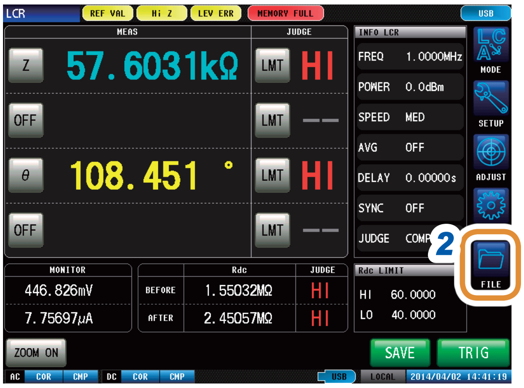
In case of LCR mode

In case of ANALYZER mode



In case of CONTINUOUS measurement mode

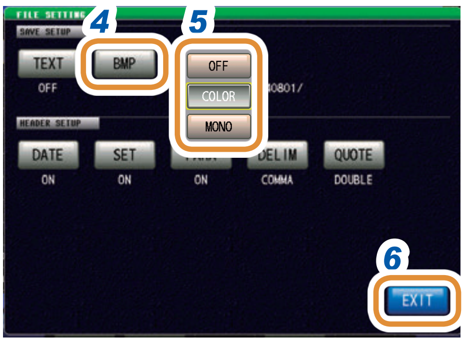
- Auto save (default setting) automatically creates a folder in the USB flash drive and saves the file in the folder.
  The folder name is created with the date and time of saving.
  Example: Saved on July 30, 2014 -> 20140730
- For manual save: See "11.4.3 Setting Save Folder" (p. 256).
- Name of the file is automatically assigned from the date and time for both auto save and manual save modes.
  Example: Saved at 16:31:44 on July 30, 2014 -> 140730163144.csv



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

3 **Press [SETUP].**

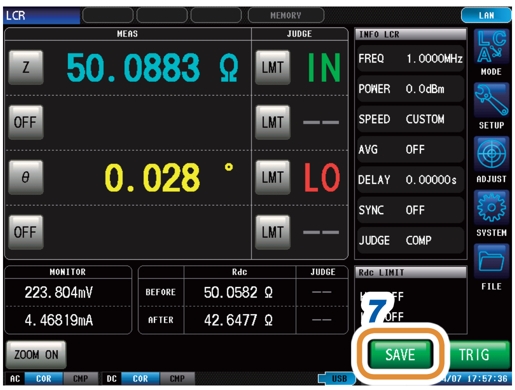


4 **Press [BMP].**

5 **Select save setting.**

[OFF]	Disables the screen copy function.
[COLOR]	Saves a copy of the screen as a full color BMP file.
[MONO]	Saves a copy of the screen as a gray scale BMP file.

6 **Press [EXIT] to close the setting screen.**

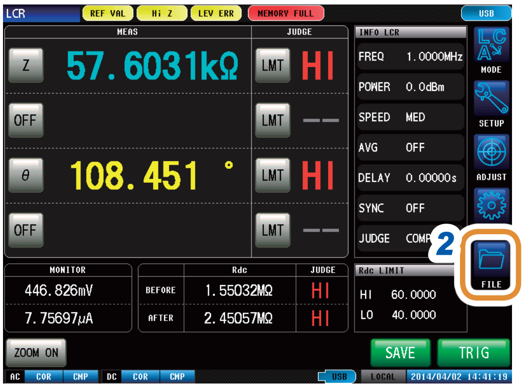


7 **Press [SAVE] in the measurement screen.**
A copy of the screen is saved to the USB flash drive.

- Auto save (default): Measurement data is saved.
- For manual save: See “Setting Save Folder” (p. 256).

11.4.3 Setting Save Folder

Select the save destination for data.
There are 2 types of save method: (1) Save to a folder automatically created (**[AUTO]**), (2) Save to a folder specified by the user (**[MANUAL]**).



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

3 **Press [SETUP].**

4 **Press [SAVE TO].**

5 **Press [MODE].**

6 **Select the setting procedure of the save folder.**

[AUTO]	Creates a folder automatically with today's date, and saves the data in the folder.
[MANUAL]	Allows you to specify an arbitrary folder and saves the data.

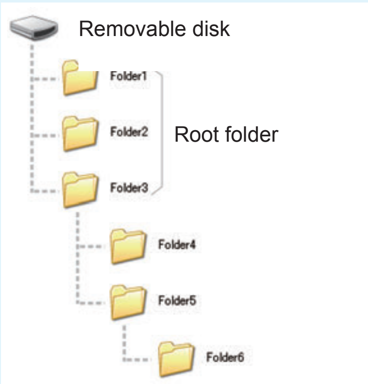
7 **Press [EXIT] to close the setting screen.**
Go to the next page.

8 **Press [SAVE] in the measurement screen.**
A copy of the screen is saved to the USB flash drive.

- Auto save (default): Measurement data is saved.
- For manual save: See “Setting Save Folder” (p. 256).

- **Folders that can be specified with [MANUAL]** are as follows:
  - Folders in the root* directory of the USB flash drive
  - Folders with their name assigned with single-characters only (folders containing double-byte characters such as Japanese cannot be specified)
  - Folders with 12 characters or less in their name
- If the folder specified as the save destination has been deleted, a folder is created at the time of saving.

*The root directory refers to the top-most directory in the hierarchy of the USB flash drive.

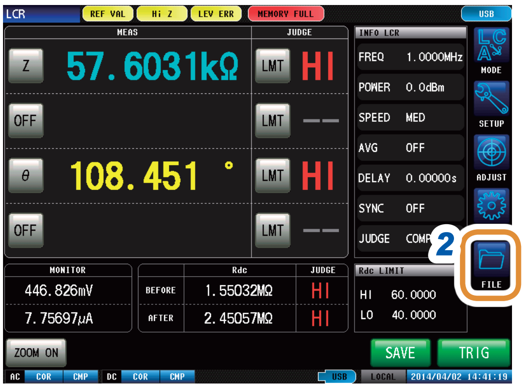


11.4.4 Saving Memory Data

You can save the measurement results stored in the internal memory of the instrument to a USB flash drive in CSV format. File extension is ".CSV".

Measurement results are saved in the following order: measuring instrument information, save time and date, and measured values.
Measured values that will be stored depend on the settings of COM MEAS.
The header (save time and date), delimiter, and quotation mark type of the text file can be configured.

Measurement results stored in the internal memory of the instrument is deleted after they are saved in the USB flash drive.

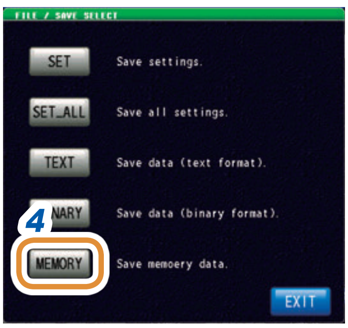


Example: Continuous measurement

1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

3 **Press [SAVE].**

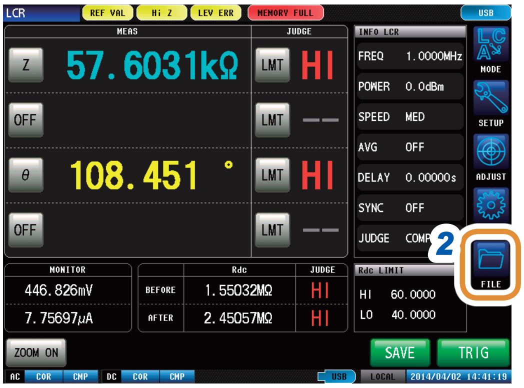


4 **Press [MEMORY].**
Measurement data is saved in the USB flash drive.

11.5 Saving Instrument Settings to USB Flash Drive

11.5.1 Saving Instrument Settings

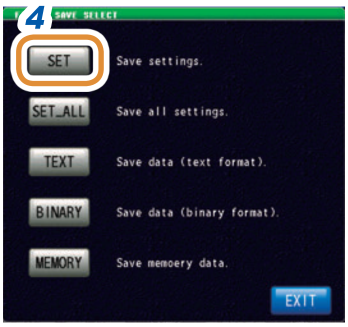
Saves various setting information of this instrument as a setting file to the USB flash drive.
The extension of the setting file is “.SET”. This function is useful to back up the setting state of this instrument.
Refer to “Appx. 8 Initial Settings Table” (p. A15) for information on saved settings.



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

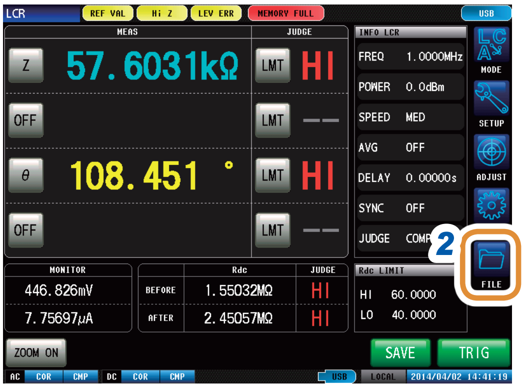
3 **Press [SAVE].**



4 **Press [SET].**
Various setting information of this instrument is saved to the USB flash drive.
- The setting file is saved to the **[SETTING]** folder in the USB flash drive.
- Name of the file saved is automatically assigned from the date and time.

11.5.2 Saving All Settings of Instrument (ALL SAVE Function)

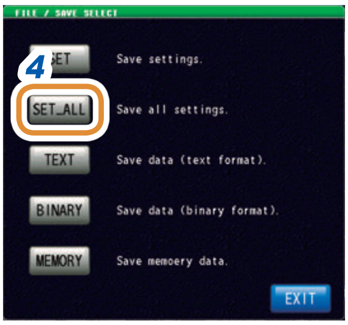
Saves various setting information of this instrument including the panel save information as a setting file to the USB flash drive.
The extension of the setting file and panel save is “**.PNL**”.
Refer to “Appx. 8 Initial Settings Table” (p. A15) for information on saved settings.



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

3 **Press [SAVE].**



4 **Press [SET ALL].**
Various setting information of this instrument is saved to the USB flash drive.
- The setting information is saved to the **[SETTING]** folder in the USB flash drive.
- Name of the file saved is automatically assigned from the date and time.

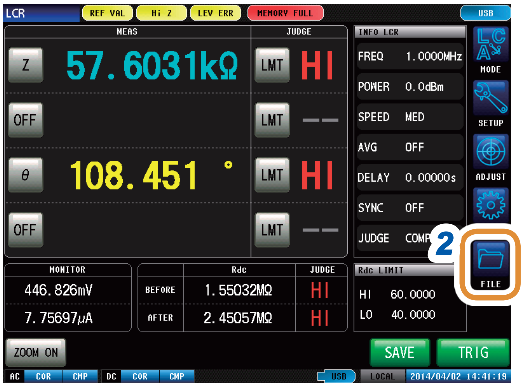
11.6 Loading Binary Data from USB Flash Drive

11.6.1 Loading Measurement Data (ANALYZER Function)

This section describes how to load analyzer measurement data saved to the USB flash drive of this instrument and display it as a graph or use it to perform equivalent circuit analysis.

See: “9 Saving and Loading Panel Information” (p. 223)
“11.4 Saving Data to USB Flash Drive” (p. 243)

When measurement data of analyzer measurement is loaded, instrument settings are changed to the setting at the time of measurement. Settings used for panel save are not changed.



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

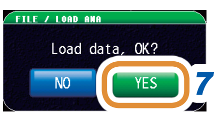
2 **Press [FILE].**

3 **Select the folder in which the measurement data was saved with ▲/▼ or by scrolling.**

4 **Press [SELECT].**

5 **Select measurement data to be loaded with ▲/▼ or by scrolling.**

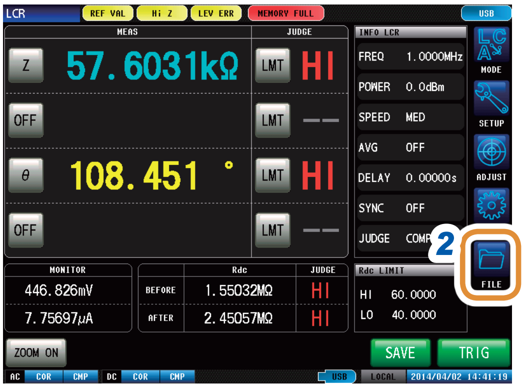
6 **Press [LOAD].**



7 **Press [YES] on the load confirmation screen.**
The measurement data is loaded to the USB flash drive and incorporated as measured values.

11.6.2 Loading Instrument Settings

Reads a setting file or panel save file saved in the USB flash drive, and restores the settings.

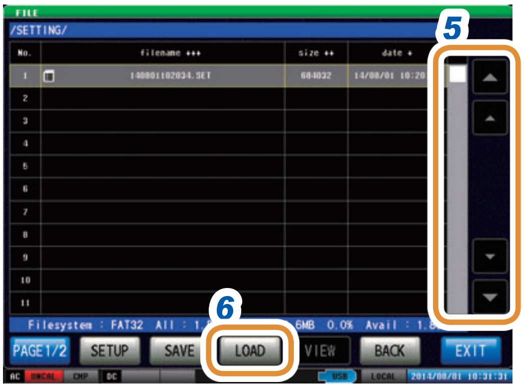


1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

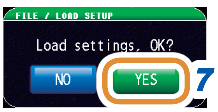
3 **Select the [SETTING] folder with ▲/▼ or by scrolling.**

4 **Press [SELECT].**



5 **Select a setting file or panel save file to be loaded with ▲/▼ or by scrolling.**

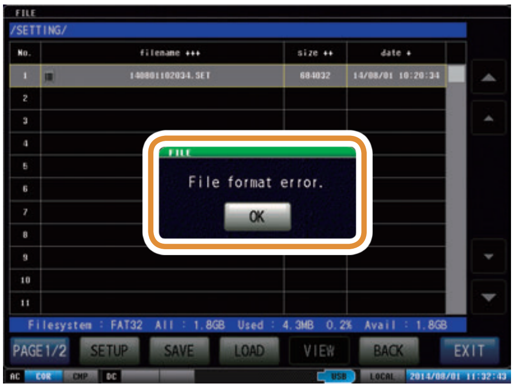
6 **Press [LOAD].**



7 **Press [YES] on the load confirmation screen.**
The measurement data is loaded to the USB flash drive and incorporated as measured values.

If the read confirmation screen is displayed

If an error is displayed, the likely cause is one of the following.

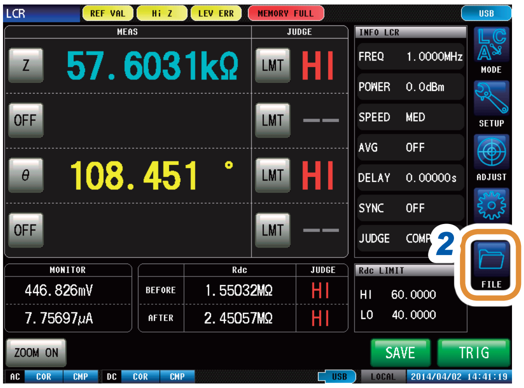


- The settings file is damaged.
- Setting file is not a type that can be read by the instrument.

11.6.3 Loading All Settings (ALL LOAD Function)

Loads and restores instrument settings, including panels saved to USB memory using the ALL SAVE function.
See “11.5.2 Saving All Settings of Instrument (ALL SAVE Function)” (p. 260).

- Information currently saved in this instrument is deleted if **[LOAD]** is executed.
- A beep will be sounded if the instrument is unable to load the settings file.

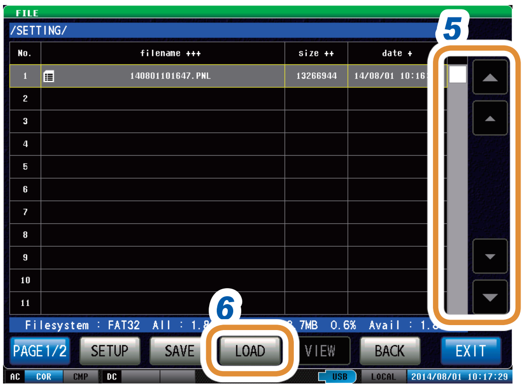


1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

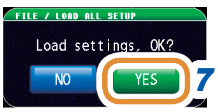
3 **Select the [SETTING] folder with ▲/▼ or by scrolling.**

4 **Press [SELECT].**



5 **Select a file with its extension “.PNL” with ▲/▼ or by scrolling.**

6 **Press [LOAD].**



7 **Press [YES] on the load confirmation screen.**
All measurement data saved in the folder will be loaded and incorporated as the current settings.

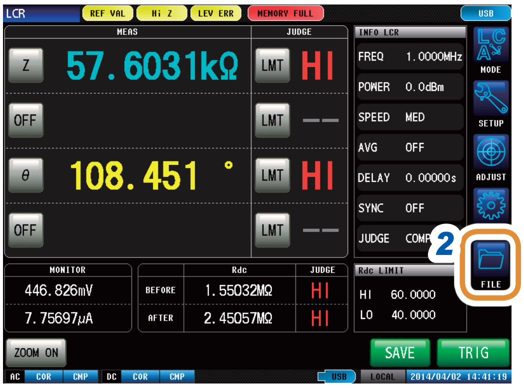
11.7 Editing Data Saved in USB Flash Drive

You can edit files and folders saved in the USB flash drive.

11.7.1 Formatting a USB Flash Drive

Perform this operation if the USB flash drive to be used is not formatted (initialized).
Insert the USB flash drive to be formatted into the USB port (at the front panel) and start the format.
This instrument formats drives with the FAT32 or FAT16 format.

- When you format, all the data saved in the USB flash drive will be deleted and cannot be restored. Carefully check the contents before you perform a format.
- We recommend backing up important data on a USB flash drive.



1 Insert the USB memory stick into the USB connector (at the front of the instrument).

2 Press **[FILE]**.

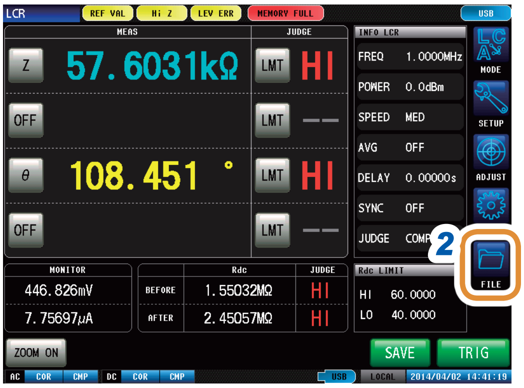
3 Press **[PAGE1/2]** and change to **[PAGE2/2]**.

4 Press **[FORMAT]**.

5 **Press [YES] on the confirmation screen.**
(This confirmation appears twice to prevent operational error.)

> Operations are not possible during formatting.
> The file list screen is refreshed on completion of screening.

11.7.2 Creating a Folder in USB Flash Drive



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

3 **Press [PAGE1/2] and change to [PAGE2/2].**

4 **Press [FOLDER].**

5 **Enter the folder name.**

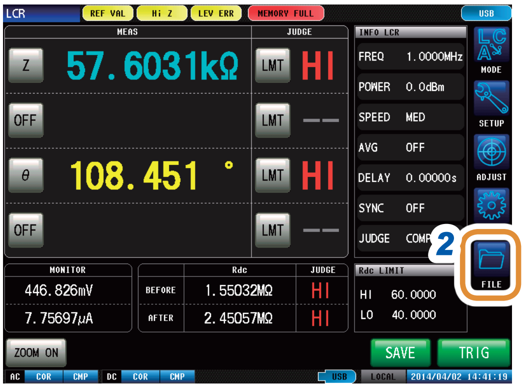
[CLR]	Deletes all input characters.
[BS]	Deletes the last character.
[KEY TYPE]	Changes the keyboard type.
[A◀ ▶a]	Switches between upper case and lower case characters.
[!◀ ▶a]	Switches between character and symbol.

See “Keyboard type” (p. 226).

6 **Press [SET].**

7 **Press [EXIT] to close the setting screen.**

11.7.3 Changing Folder Name or File Name in USB Flash Drive



1 Insert the USB memory stick into the USB connector (at the front of the instrument).

2 Press [FILE].

3 Press [PAGE1/2] and change to [PAGE2/2].

4 Specify a folder or file to be changed.

5 Press [RENAME].

Go to the next page.

6 **Enter a folder name or file name to be changed.**

[CLR]	Deletes all input characters.
[BS]	Deletes the last character.
[KEY TYPE]	Changes the keyboard type.
[A◀ ▶a]	Switches between upper case and lower case characters.
[!◀ ▶a]	Switches between character and symbol.

See “Keyboard type” (p. 226).

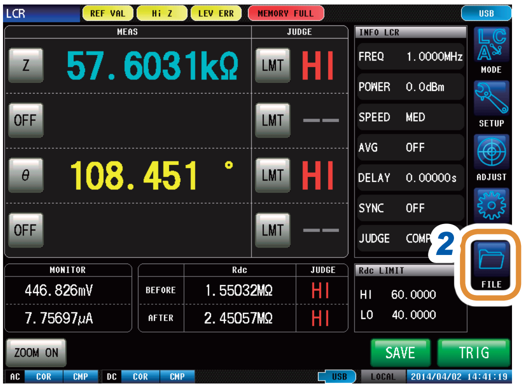
7 **Press [SET].**

8 **Press [EXIT] to close the setting screen.**

11.7.4 Deleting a File or Folder in USB Flash Drive

You can delete a file or folder saved in the USB flash drive.

A deleted file or folder cannot be restored once it is deleted.



1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

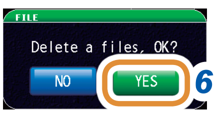
2 **Press [FILE].**

3 **Select a file or folder to be deleted with ▲/▼ or by scrolling.**

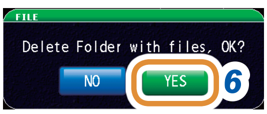
4 **Press [PAGE1/2] and change to [PAGE2/2].**

5 **Press [DELETE].**

In case of file



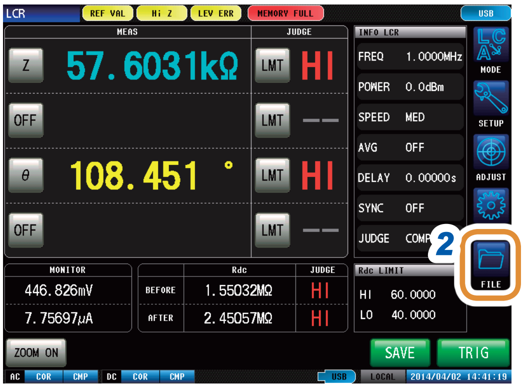
In case of folder



6 **Press [YES] on the confirmation screen.**

11.7.5 Checking the Contents of Files

You can check measurement data files (**TXT**, **CSV**) and screen copy files (**BMP**) on the screen that are saved in a USB flash drive.



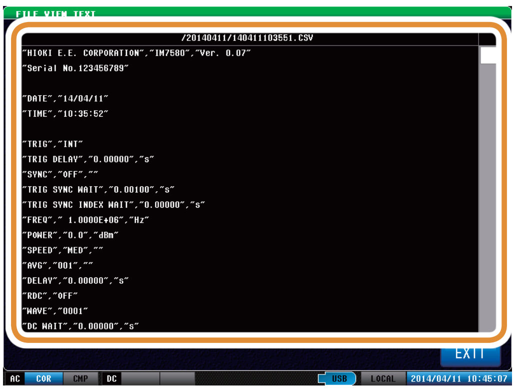
1 **Insert the USB memory stick into the USB connector (at the front of the instrument).**

2 **Press [FILE].**

3 **Select a file with ▲/▼ or by scrolling.**

4 **Press [VIEW].**
[SELECT] is displayed and moves to inside the folder when a folder is selected.

CSV file display



BMP file display

5 **Press [EXIT] to close the setting screen.**

12 Specifications

12.1 General Specifications

(1) Basic Specification

Measurement mode	• LCR meter mode: Measurement with single condition • Analyzer mode: Sweep measurement, equivalent circuit analysis • CONTINUOUS measurement mode: Continuous measurement with saved conditions
Measurement items	Z (impedance), Y (admittance), θ (phase angle), Rs (equivalent series resistance, ESR), Rp (equivalent parallel resistance), X (reactance), G (conductance), B (susceptance), Ls (equivalent series inductance), Lp (equivalent parallel inductance), Cs (equivalent series capacitance), Cp (equivalent parallel capacitance), Q (Q factor), D (loss coefficient, tan δ)
Display range	See table below. If a value exceeds the upper limit, **DISP OUT** is displayed. This instrument has absolute measured value display function (θ and Δ% are not included) only for LCR meter mode.
Measurement frequency	1. Frequency range 1 MHz to 300 MHz 2. Setting resolution 1.0000 MHz to 9.9999 MHz: 100 Hz step 10.000 MHz to 99.999 MHz: 1 kHz step 100.00 MHz to 300.00 MHz: 10 kHz step 3. Frequency accuracy ±0.01% or less from setting value
Output impedance	50 Ω±10 Ω (10 MHz)

Display range:

Parameters	Display range (6 digits)
Z	(0.00 mΩ to 9.99999 GΩ)
Y	(0.000 nS to 9.99999 GS)
θ	±(0.000° to 999.999°)
Rs, Rp, X	±(0.00 mΩ to 9.99999 GΩ)
G, B	±(0.000 nS to 9.99999 GS)
Cs, Cp	±(0.00000 pF to 9.99999 GF)
Ls, Lp	±(0.00000 nH to 9.99999 GH)
D	±(0.00000 to 9.99999)
Q	±(0.00 to 9999.99)
Δ%	±(0.000% to 999.999%)

Measurement signal level	1. Level range: -40.0 dBm to +7.0 dBm 2. Setting resolution: 0.1 dB step 3. Accuracy: ±2 dB (23°C±5°C) ±4 dB (0°C to 40°C) 4. Setting method Power (dBm) mode: Specified with the power of a 50 Ω load connected to the measurement terminal. Range: -40.0 dBm to +7.0 dBm Voltage (V) mode: Specified with the voltage during open connection with the measurement terminal. Range: 4 mV to 1001 mV, with dBm notation guide Current (I) mode: Specified with the current during shorted connection with the measurement terminal. Range: 0.09 mA to 20.02 mA, with dBm notation guide
Monitor functions	1. Monitor voltage Monitor range: 0.0 mV to 1000.0 mV (reference value) 2. Monitor current Monitor range: 0.000 mA to 20.000 mA (reference value)
Measurement range	Guaranteed accuracy range: 100 mΩ to 5 kΩ When out of range, **REF VAL** is displayed (out of guaranteed accuracy range).
Basic accuracy	Z: 0.72%rdg θ: 0.41° (typical)
Guaranteed accuracy period	1 year (Ensure open / short / load calibration are performed daily before measurement.)
Warm-up time	At least 60 minutes
Measurement time	Approx. 0.6 ms (measurement speed: FAST)
Terminal structure	2-terminal structure
Clock backup	Approx. 1 year when unused (reference value)
Product warranty period	1 year

(2) LCR function

Measurement with single condition

Average	1. Method: Internal trigger: Moving average External trigger: Arithmetic mean 2. Setting range: 1 to 256 (1 step)
Trigger	1. Internal trigger: Automatic 2. External trigger: Manual, communication commands, I/O
Trigger delay	Delay time from trigger to measurement 0.00000 s to 9.99999 s (resolution: 10 μs)
Trigger synchronous output	Applies measurement signal during analog measurement only. Stabilizing wait time setting: 0.00000 s to 9.99999 s (resolution: 10 μs) INDEX signal delay time setting: 0.00000 s to 0.10000 s (resolution: 10 μs)
BIN judgment	10 classifications for 4 items, OUT OF BINS EXT I/O output available 1. Upper lower limit value judgment Upper lower limit setting range: -9.99999 G to +9.99999 G 2. Percent (%) judgment Reference setting range: -9.99999 G to +9.99999 G Upper lower limit setting range: -999.999% to +999.999% 3. Deviation percentage (Δ%) judgment Measurement values are indicated as deviations (Δ%) from the reference values. Reference setting range: -9.99999 G to +9.99999 G Upper lower limit setting range: -999.999% to +999.999%
Comparator	Hi/IN/Lo for 4 items EXT I/O output available 1. Upper lower limit value judgment Upper lower limit setting range: -9.99999 G to +9.99999 G 2. Percent (%) judgment Reference setting range: -9.99999 G to +9.99999 G Upper lower limit setting range: -999.999% to +999.999% 3. Deviation percentage (Δ%) judgment Measurement values are indicated as deviations (Δ%) from the reference values. Reference setting range: -9.99999 G to +9.99999 G Upper lower limit setting range: -999.999% to +999.999%
Magnification display function	The display of measurement values and comparator judgment results can be magnified.

(3) Analyzer function

Sweep measurement, equivalent circuit analysis

Sweep measurement	Frequency, level (dBm, V, I)
Time interval measurement	Interval: 0.00000 s to 1000.00 s, max. 801 points
Sweep point	1 to 801 points
Sweep method	1. Regular sweep: Up to 801 points Settings: START-STOP/CENTER-SPAN/START-STEP/INTERVAL/CUSTOM 2. Segment sweep: Up to 20 segments (total 801 points) • Settings: START-STOP/INTERVAL • Sub-parameters: Frequency, level, speed, average, point delay
Measurement items (4 items)	Z (impedance), Y (admittance), θ (phase angle), Rs (equivalent series resistance, ESR), Rp (equivalent parallel resistance), X (reactance), G (conductance), B (susceptance), Ls (equivalent series inductance), Lp (equivalent parallel inductance), Cs (equivalent series capacitance), Cp (equivalent parallel capacitance), Q (Q factor), D (loss coefficient, tan δ), V (monitor voltage), I (monitor current)
Trigger	Sequential, repeat, step
Average	1. Method: Arithmetic mean 2. Setting range: 1 to 256 (1 step)
Trigger delay	0.00000 s to 9.99999 s (resolution: 10 μs)
Point delay	0.00000 s to 9.99999 s (resolution: 10 μs) Disabled during interval measurement
Trigger synchronous output	Applies measurement signal during analog measurement only. Stabilizing wait time setting: 0.00000 s to 9.99999 s (resolution: 10 μs) INDEX signal delay setting: 0.00000 s to 0.10000 s (resolution: 10 μs)
Measurement value display	List display: Numerical value display Graph display: 1 window, 4 windows X-Y graph display: 1 window, 2 windows (Cole-Cole plots and admittance circular graphs supported) Judgment result display: Detailed judgment result display 1. Overwrite function Overwrite start timing control, clearing function available 2. Graph scaling • Linear/log scale display Vertical/horizontal scaling available • Auto scaling Automatic and manual available 3. Waveform color 25 colors available

Comparator	1. Area comparator 4 parameters Hi/IN/Lo judgment across sweep range Judgment condition setting based on best product data available Upper lower limit setting range: -9.99999 G to +9.99999 G 2. Peak comparator 4 parameters Peak range judgment (local maximum and local minimum) Upper lower limit setting range: -9.99999 G to +9.99999 G Range setting: Full frequency range (for frequency sweep), full level range (for level sweep)
Cursor function	Reading measurement values on the graph screen A/B tracing cursors (2 numbers)
Search function (2 types at the same time)	Maximum value, minimum value, target (with slope specification), local maximum value and local minimum value Automatic search function after measurement available
Equivalent circuit analysis	1. Circuit model Equivalent circuit models for circuit element components 3-element models: 4 types; 4-element models: 1 type See “4.9 Equivalent Circuit Analysis Function” (p. 124). 2. Circuit model selection method AUTO (automatic selection), HOLD (fixed) 3. Measurement items 3-element model L1 (inductance), C1 (capacitance), R1 (resistance), Qm (sharpness of resonance), and sum of squares of residual error between observed values and ideal frequency characteristics 4-element models L1 (inductance), C1 (capacitance), R1 (resistance), C0 (parallel capacitance), Qm (sharpness of resonance [mechanical quality factor]), K (electromechanical coupling coefficient), and sum of squares of residual error between observed values and ideal frequency characteristics 4. Equivalent circuit analysis execution AUTO (executed after frequency sweep operation is completed) and MANU (executed at user-specified timing) 5. Limitation on the sweep range used in equivalent circuit analysis Normal sweep: Analysis is performed in the sweep range defined by the analysis start frequency and the analysis stop frequency. Segment sweep: Analysis is performed using the sweep range for the set segment No. 6. Comparator Implement comparator for analysis result L1, C1, R1, C0, Qm: HI/IN/LO and absolute value setting 7. Resonance Frequency The frequency (resonance frequency or antiresonance frequency) at which the measurement value for the following measuring items is the local maximum or local minimum can be retrieved by communication. Z (impedance), G (conductance), B (susceptance) and Rs (equivalent series resistance)

(4) Continuous measurement function
Measurements are continued with measurement conditions saved.

1.	Up to 46 ways LCR mode: Up to 30 ways, ANALYZER mode: Up to 16 ways Continuous measurements with LCR mode mixed with ANALYZER mode is possible
2.	Judgment result from EXT.I/O has an overall judgment result and more than one output pattern.

(5) Function

Contact check	1. 2-terminal contact check (DCR measurement) Performs a contact (contact state) check between High and Low. Judgment is allowed by entering upper and lower limit for DCR values. A function that aborts subsequent measurements when the judgment result is FAIL available. Check timing can be changed. BEFORE: Contact check performed before measurement AFTER: Contact check performed after measurement BOTH: Contact checks performed before and after measurement Measurement a. Range 0.1 Ω to 100 Ω b. ±1.6% rdg. (typical) Measurement signal Level: 1 mA or less Number of waveforms: 1 to 9,999 (8 μs to 79992 μs) Wait time Wait before DC measurement: 0 s to 9.99999 s Wait before AC measurement: 0 s to 9.99999 s AC signal superimpose available 2. Hi-Z reject function (detection of OPEN state during 2-terminal measurement) When the measurement value is higher than the judgment reference, a contact error is output. Judgment standard: Setting 1 Ω to 10 kΩ (resolution: 1 Ω) available Error output: Error output from EXT I/O 3. Waveform identification function (chattering detection) Effective values of subsequent waveforms is compared with the effective value of the waveform that is read first. A contact error is output if fluctuation of the subsequent waveform exceeds the judgment reference. Judgment reference: Setting 0.01% to 100.00% (0.01% resolution) with respect to the reference value is possible. Error output: Error is displayed on the LCD display and error is output from EXT I/O
Panel save and load function	Full measurement condition: Saving 30 types (LCR mode) and 16 types (ANALYZER mode) of setting conditions are possible. Compensation value only: Saving 30 types (LCR mode) of compensation values are possible. Arbitrary measurement conditions can be read by key operations or a control signal via the EXT I/O.
Display digits setting function	Number of display digits for measurement values can be set to 3, 4, 5, and 6. However, differs based on the parameter. (default: 6 digits)
Display Setting function	1. LCD display ON/OFF (no drawing in case of OFF) 2. Back light brightness adjustment 3. Measurement screen color customization (color with white background or black background)

Parameter color change function	This function enables display colors to be changed for measurement values.
Absolute measurement value display function	Absolute measurement value display function for measurement values (θ and Δ% excluded)
Key-lock function	Can be enabled and disabled by front panel key operation. Key lock is released by entering a passcode.
Memory function	32000 LCR measurements and 100 ANALYZER sweeps can be saved in this instrument. (Reading via RS-232C, GP-IB, USB, LAN or USB flash drive is possible.)
Beep sound	Beep sound for the comparator judgment result (IN or NG) can be set to ON/OFF. Beep sound for key input can be set to ON/OFF. 15 types of beep sounds are available.
I/O judgment output delay function	1. Delay from judgment result output to EOM 0.00000 s to 0.99999 s 2. Judgment result output reset timing modification function
IO trigger	1. This function enables trigger input during measurement. 2. Edge selection (rising, falling)
I/O EOM	EOM signal output method (pulse, hold) 0.00001 s to 0.99999 s
Warm-up function	A message appears 60 min after power-on.

(6) Compensation

Open/short/load calibrations (compensation to test head)	ALL and SPOT available, compensation value check, compensation value read/write possible (ANALYZER: SPOT only) Number of SPOT compensations: 5 (LCR), 801 (ANALYZER)
Open/short compensations (compensation to test fixture)	ALL and SPOT available, compensation value check, compensation value read/write possible Number of SPOT compensations: 5 (LCR), 801 (ANALYZER) ALL compensation or SPOT compensation works with open/short/load calibration.
Electrical length compensation	Compensation range: 0.00 mm to 100.00 mm
Correlation compensation	Enter the compensation coefficients a and b for the following expression. [Measurement value after compensation] = a × [measurement value] + b Setting range for a: -999.999 to +999.999 Setting range for b: -9.99999 G to +9.99999 G

(7) Interface

Display	8.4-inch color TFT, touch panel	
Handler interface (standard equipment)	Connector	37-pin D-sub female with #4-40 inch screws
	Input signals	Isolated, non-voltage contact inputs Input asserted (ON) voltage: 0 V to 0.9 V Input de-asserted (OFF) voltage: OPEN or 5 V to 24 V
	Output signals	Isolated npn open-collector outputs Maximum load voltage: 30 V Maximum output current: 50 mA/ch Residual voltage: 1 V or less (10 mA), 1.5 V or less (50 mA)
	Internal isolated power supply	Voltage: 4.5 V to 5 V Maximum output current: 100 mA Floating from protective ground potential and measurement circuit
	Pin and signal arrangement	Refer to “Signal pinouts (instrument)” (p. 196)
Communications interface	1. LAN Interface (standard equipment)	
	Connector	RJ-45 connector
	Transmission system	10BASE-T/100BASE-TX/1000BASE-T
	Protocol	TCP/IP
	Terminator	CR+LF, CR
	2. USB (HI SPEED) interface (standard equipment)	
	Connector	USB Type B connector
	Electrical specifications	USB2.0 (High Speed)
	Terminator	CR+LF, CR
	3. GP-IB interface (option)	
	Connector	24-pin, Centronics type connector
	Conformance standard	IEEE-488.1 1987
	Reference Standard	IEEE-488.2 1987
	Terminator	LF, CR+LF
	4. RS-232C interface (optional)	
	Connector	9-pin D-sub connector
	Flow control	Software
	Terminator	CR+LF, CR
	Communication speed	9600, 19200, 38400, 57600 bps
USB flash drive (standard equipment)	Connector	USB Type A connector
	Electrical specifications	USB2.0 (High Speed)
	Power supply	Maximum 500 mA
	No. of ports	1
	Compatible USB device	USB Mass Storage Class
	Measurement conditions, measurement values, and screens can be saved. Measurement conditions can be loaded. Display of measurement values saved and screen is available. File deletion, folder creation, formatting and renaming	

(8) Environmental and safety specifications

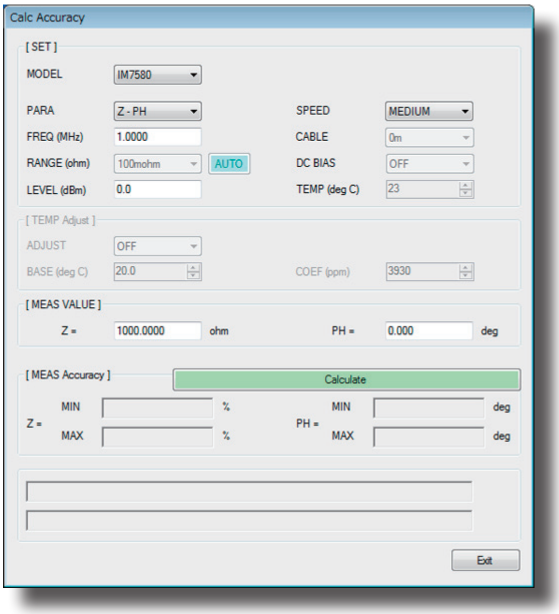
Operating temperature and humidity range	0°C to 40°C (32°F to 104°F), 20% RH to 80% RH (no condensation) See “12.2.1 Impedance Measurement” (p. 283) for guaranteed accuracy range.
Storage temperature and humidity range	-10°C to 50°C (14°F to 122°F), 20% RH to 80% RH (no condensation)
Operating environment	Indoors, altitude up to 2,000 m (6,562 ft.), pollution degree 2
Rated power supply voltage	100 V to 240 V AC (±10%)
Rated power supply frequency	50 Hz/60 Hz
Maximum rated power	70 VA
Dimensions	Instrument: Approx. 215W × 200H × 268D mm (8.46″W × 7.87″H × 10.55″D) (excluding protrusions) Test head: Approx. 61W × 55H × 24D mm (2.40″W × 2.17″H × 0.94″D) (excluding protrusions)
Mass	Instrument: Approx. 6.5 kg (229.2 oz.) Test head: Approx. 175 g (6.2 oz.)
Standards	EMC EN61326 Class A EN61000-3-2 EN61000-3-3 Safety EN61010
Dielectric strength	Between the power wire and ground wire: 1.62 kV AC for 1 minute

(9) Contents of product

Contents of instrument	Instrument ×1 Cable (IM7580: 1 m, IM7580-02: 2m) ×1 Test head ×1
Accessories	See “Verifying Package Contents” (p. 1).
Options	See “Options (Sold separately)” (p. 2).

12 Specifications

Basic accuracy can be calculated with a computer.



Basic accuracy can be calculated with the supplied application software.
Measurement accuracy is displayed if the measurement conditions and measurement results are entered. This allows easy evaluation for accuracy of measurement values.
See Hioki's web site for additional information.

12.2 Measurement Accuracy

12.2.1 Impedance Measurement

Accuracy guaranteed temperature and humidity range	0°C to 40°C (32°F to 104°F), 20% RH to 80% RH (no condensation) * 30°C (86°F) or more, wet-bulb temperature 27°C (80.6°F) or less However, within ±5°C (±9°F) of the calibration temperature.
Calibration temperature range	Based on the operating temperature of calibration kit.
Guaranteed accuracy period	1 year (Ensure open/short/load calibration are performed daily before measurement.)
Warm-up time	At least 60 minutes
Calibration face	7-mm terminal face of Model IM9906 Adapter (3.5 mm/7 mm) attached to the 3.5-mm terminal of test head (After performing open/short/load calibration with calibration kit)
Measurement conditions	Frequency, power and speed points where open/short/load calibration was implemented
Calibration kit	When products with the following specifications or equivalent are used LOAD (50 Ω): VSWR=1.005 max OPEN: Reflection coefficient 0.995 max SHORT: Reflection coefficient 0.995 max
Measurement accuracy	Z: ±(Ea + Eb) [%] θ: ±0.58 × (Ea + Eb) [°]

Ea = 0.5 + Er

Er: Power = between -7 dBm and +7 dBm

Frequency	FAST	MED	SLOW	SLOW2
1 MHz to 100 MHz	0.09	0.06	0.036	0.03
100.01 MHz to 300 MHz	0.108	0.078	0.039	0.036

Er: Power = between -40 dBm and -7.1 dBm

Frequency	Er	Eoff			
		FAST	MED	SLOW	SLOW2
1 MHz to 100 MHz	$3 \times 10^{(-0.046P + Eoff)}$	-1.8	-2	-2.15	-2.3
100.01 MHz to 300 MHz	$3 \times 10^{(-0.048P + Eoff)}$	-1.75	-1.9	-2.1	-2.25

P: Power setting value [dBm]

$$Eb = \left(\frac{Zs}{|Zx|} + Yo \cdot |Zx| \right) \times 100$$ [%] (|Zx|: Measurement value of Z Unit: [Ω])

$$Zs = \frac{(20 + Zsr + 0.5 \times F)}{1000}$$ [Ω] (F: Measurement frequency [MHz])

Zsr: Power = between -7 dBm and +7 dBm

FAST	MED	SLOW	SLOW2
13.5	9	5.1	3.9

Zsr: Power = between -40 dBm and -7.1 dBm

Zsr	Zoff			
	FAST	MED	SLOW	SLOW2
$3 \times 10^{(-0.048P + Zoff)}$	0.35	0.2	0	-0.15

P: Power setting value [dBm]

$$Yo = \frac{(30 + Yor + 0.15 \times F)}{1000000}$$ [S] F: Measurement frequency [MHz]

Yor: Power = between -7 dBm and +7 dBm

FAST	MED	SLOW	SLOW2
7.5	5.7	3.3	2.4

Yor: Power = between -40 dBm and -7.1 dBm

Yor	Yoff			
	FAST	MED	SLOW	SLOW2
$3 \times 10^{(-0.046P + Yoff)}$	0.1	0	-0.2	-0.4

P: Power setting value [dBm]

12.2.2 Example: Calculation of Accuracy

Impedance, accuracy for Z = 50 Ω

Example: Measurement frequency = 50 kHz, measurement signal level = -10 dBm, measurement speed = SLOW2

1 **Obtain Ea.**

From measurement conditions and accuracy specification:

$\mathrm{Er} = 3 \times 10^{(-0.046P + Eoff)}$

$\mathrm{P} = -10$ (measurement signal level [dBm])

$\mathrm{Eoff} = -2.3$

With the above, Ea is calculated as follows:

$\mathrm{Ea} = 0.5 + \mathrm{Er} = 0.5 + 3 \times 10^{(-0.046 \times (-10) - 2.3)} = 0.543$

2 **Obtain Zs.**

From measurement conditions and accuracy specification:

$\mathrm{Zsr} = 3 \times 10^{(-0.048P + Zoff)}$

$\mathrm{P} = -10$ (measurement signal level [dBm])

$\mathrm{Zoff} = -0.15$

$\mathrm{F} = 50$ (measurement frequency [MHz])

With the above, Zs is calculated as follows:

$$\begin{aligned} Zs &= 20 + Zsr + 0.5 \times F \\ &= 20 + 3 \times 10^{(-0.048 \times (-10) -0.15)} + 0.5 \times 50 \\ &= 51.41 \quad [\text{m}\Omega] \end{aligned}$$

3 **Obtain Yo.**

From measurement conditions and accuracy specification:

$Yor = 3 \times 10^{(-0.046P + Yoff)}$

$P = -10$ (measurement signal level [dBm])

$Yoff = -0.4$

$F = 50$ (measurement frequency [MHz])

With the above, Yo is calculated as follows:

$$\begin{aligned} Yo &= 30 + Yor + 0.15 \times F \\ &= 30 + 3 \times 10^{(-0.046 \times (-10)-0.4)} + 0.15 \times 50 \\ &= 40.94 \quad [\mu\text{S}] \end{aligned}$$

4 **Obtain Eb with Zs, Yo and measurement value Zx.**

$$\begin{aligned} Eb &= \left(\frac{Zs}{|Zx|} + Yo \cdot |Zx| \right) \times 100 \\ &= \left(\frac{51.41}{1000} \times \frac{1}{50} + \frac{40.94}{1000000} \times 50 \right) \times 100 \\ &= (0.001028 + 0.002025) \times 100 \\ &= 0.3075 \end{aligned}$$

5 **With Ea and Eb, obtain accuracy of Z and θ.**

Z accuracy

$= \pm(Ea + Eb)$ [%]

$= \pm 0.851$ [%]

θ accuracy

$= \pm 0.58 \times (Ea + Eb)$ [°]

$= \pm 0.493°$

12

Specifications

Accuracy of inductor Ls = 150 nH

Example: Measurement frequency = 100 MHz, measurement signal level=+1 dBm, measurement speed = FAST

1 **Z and θ of the sample are measured and we assume that the measurement values are as follows.**

$Z = 94.292\ \Omega \qquad \theta = 88.25°$

2 **Obtain Ea.**

From measurement conditions and accuracy specification:

$Er = 0.09$

$Ea = 0.5 + Er = 0.59$

3 **Obtain Zs.**

From measurement conditions and accuracy specification:

$Zsr = 13.5$

$F = 100$ (measurement frequency [MHz])

With the above, Zs is calculated as follows:

$$\begin{aligned} Zs &= 20 + Zsr + 0.5 \times F \\ &= 20 + 13.5 + 0.5 \times 100 \\ &= 83.5 \quad [\mathrm{m\Omega}] \end{aligned}$$

4 **Obtain Yo.**

From measurement conditions and accuracy specification:

$Yor = 7.5$

$F = 100$ (measurement frequency [MHz])

With the above, Yo is calculated as follows:

$$\begin{aligned} Yo &= 30 + Yor + 0.15 \times F \\ &= 30 + 7.5 + 0.15 \times 100 \\ &= 52.5 \quad [\mu\mathrm{S}] \end{aligned}$$

5 **Obtain Eb with Zs, Yo and measurement value Zx.**

$$Eb = \left(\frac{Zs}{|Zx|} + Yo \cdot |Zx| \right) \times 100 \qquad [\%]$$

$$= \left(\frac{83.5}{1000} \times \frac{1}{94.292} + \frac{52.5}{1000000} \times 94.292 \right) \times 100$$

$$= (0.000886 + 0.004950) \times 100$$

$$= 0.5836$$

6 **With Ea and Eb, obtain accuracy of Z and θ.**

Z accuracy

$= \pm(Ea + Eb)$ [%]

$= \pm 1.18$ [%]

θ accuracy

$= \pm 0.58 \times (Ea + Eb)$ [°]

$= \pm 0.685°$

7 **Calculate the possible range for Z and θ.**

$Zmin = 94.292 \times (1 - 1.18/100) \approx 93.179$

$Zmax = 94.292 \times (1 + 1.18/100) \approx 95.405$

$\theta min = 88.25 - 0.685 = 87.565°$

$\theta max = 88.25 + 0.685 = 88.935°$

8 **Calculate the range that Z and θ can be acquired.**

(For more information on Ls calculation formula, see “Appx. 1 Measurement Parameters and Calculation Formula” (p. A1).)

$$Ls\,\min = \frac{Z\,\min \times \sin\theta\,\min}{\omega} = 148.165nH \quad .\,.\,.\,.\,-1.23\%$$

$$Ls\,\max = \frac{Z\,\max \times \sin\theta\,\max}{\omega} = 151.816nH \quad .\,.\,.\,.\,+1.21\%$$

($\omega = 2 \times \pi \times f$ f: Frequency [Hz])

9 **Accuracy of Ls will be in the range -1.23% to +1.21%.**

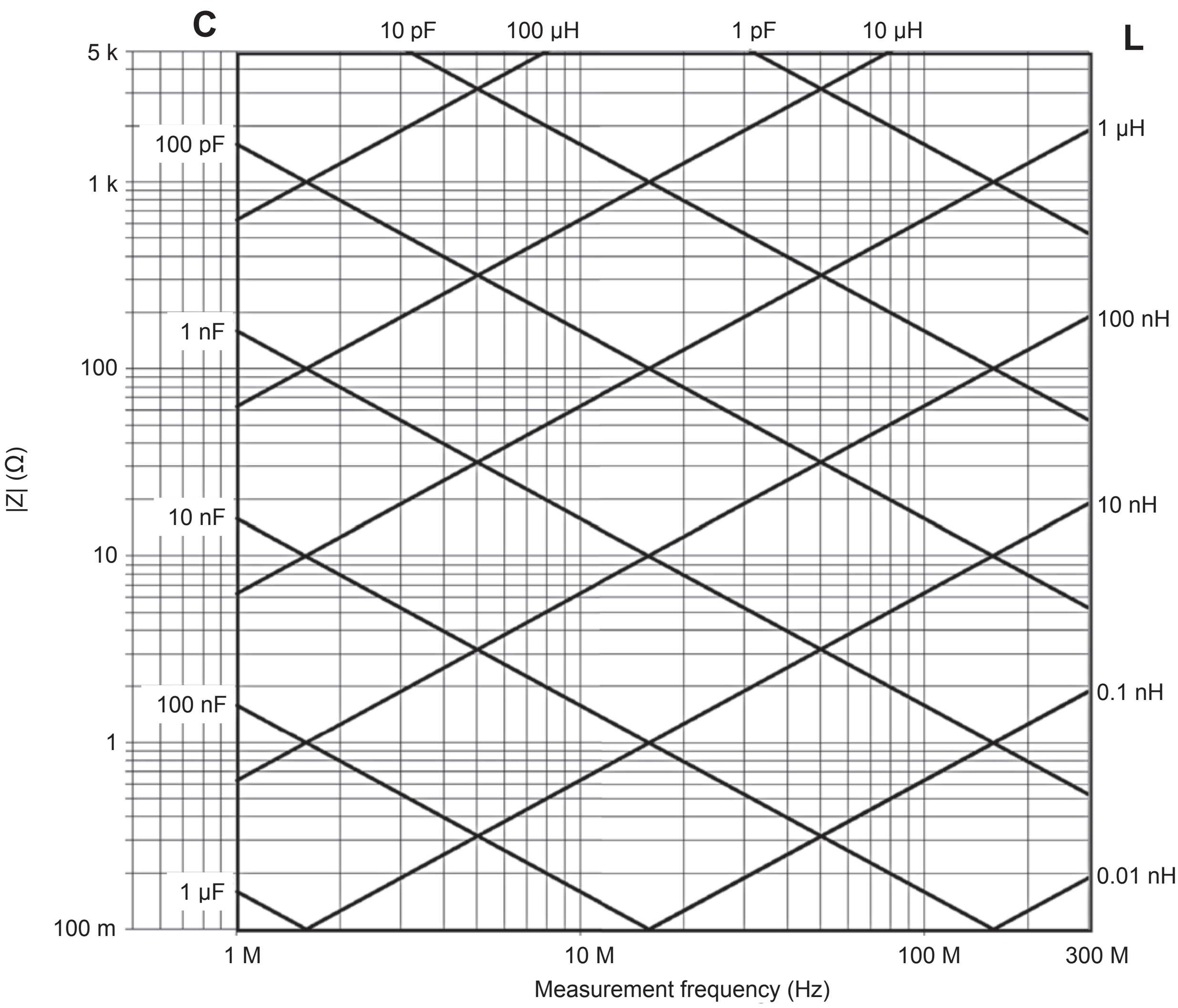
12

Specifications

12.2.3 DCR Measurement

Accuracy guaranteed temperature and humidity range	0°C to 40°C (32°F to 104°F), 80% RH or less (no condensation) However, within ±5°C (±9°F) of the calibration temperature.
Calibration temperature range	Based on the operating temperature of calibration kit.
Guaranteed accuracy period	1 year (Ensure open/short/load calibration are performed daily before measurement.)
Warm-up time	At least 60 minutes
Calibration face	7 mm terminal face of IM9906 Adapter (3.5 mm/7 mm) attached to the 3.5 mm terminal of test head (After performing open/short/load calibration with calibration kit)
Calibration kit	When products with the following specifications or equivalent are used LOAD: 50 Ω ±0.5% OPEN: 100 kΩ or more SHORT: 10 mΩ or less
Measurement accuracy	$\pm\left\{1+\left(\frac{0.05}{Rdut}+\frac{Rdut}{10000}\right)\times 100\right\}$ [%] (Rdut: DC resistance measurement value Unit: [Ω]) (Number of waveforms: 128)

12.2.4 Conversion Table



12.3 Measurement Time

Measurement time differs depending on the measurement conditions. Refer to the following values.

All the values are reference values. Note that they may differ depending on the operating environment.

12.3.1 LCR Mode

Analog measurement signal (INDEX)

Analog measurement time = A + B + C

Measurement time (EOM)

Measurement time = INDEX + D + E + F + G

A. Analog measurement time

FAST	MED	SLOW	SLOW2
0.5 ms	0.9 ms	2.1 ms	3.7 ms

Tolerance ±0.1 ms

B. Trigger synchronous output
Trigger synchronous output wait time + INDEX delay time

C. Contact check (DC measurement)
30 μs + 8 μs × Number of WAVEs + DC wait time + AC wait time
Takes double the time if TIMING is BOTH.

D. LCR calculation time
MAX 80 μs

E. Trigger delay time

F. JUDGE-EOM delay time

G. Judgment

Comparator	MAX 50 μs
BIN	MAX 150 μs

12.3.2 Analyzer Mode

Analog measurement signal (INDEX)
    Analog measurement time = (A + D + E) × Number of points + B + C

Measurement time (EOM)
    Measurement time = INDEX + F + G + H + I

A. Analog measurement time

Tolerance ±0.1 ms

B. Trigger synchronous output
Trigger synchronous output wait time + INDEX delay time

C. Contact check (DC measurement)
30 μs + 8 μs × Number of WAVEs + DC wait time + AC wait time
Takes double the time if TIMING is BOTH.

D. Point delay time

E. Time required to switch setting
MAX 50 μs

F. ANALYZER calculation time
MAX 200 μs

G. Trigger delay time

H. JUDGE-EOM delay time

I. Equivalent circuit analysis
MAX 25 ms

13 Maintenance and Service

13.1 Inspection, Repair and Cleaning

Please read “Instrument malfunction” (p. 297) and Section “13.4 Error Display” (p. 303) before requesting instrument repair or inspection.

Calibration

IMPORTANT
Periodic calibration is necessary in order to ensure that the instrument provides correct measurement results of the specified accuracy.

The calibration frequency varies depending on the status of the instrument or installation environment. We recommend that the calibration frequency is determined in accordance with the status of the instrument or installation environment and that you request that calibration be performed periodically.

Inspection and repair

⚠ WARNING

Customers are not allowed to modify, disassemble, or repair the instrument. Doing so may cause fire, electric shock, or injury.

- If the fuse blows, do not attempt to replace the fuse or repair the instrument: contact your authorized Hioki distributor or reseller.
- If no measurement value is displayed even when the probes are shorted together, an internal fuse may have blown. Contact your authorized Hioki distributor or reseller.
- If damage is suspected, check the section “Instrument malfunction” (p. 297) before contacting your authorized Hioki distributor or reseller. However, in the following cases, immediately stop using the instrument, unplug the power cord and contact your authorized Hioki distributor or reseller.
    - When the nature of the damage is clearly evident.
    - When measurement is not possible.
    - After long-term storage in adverse conditions such as high temperature or humidity.
    - When subject to severe shock during transport.
    - After severe exposure to water, oil, or dust (internal insulation can be degraded by oil or water, increases risk of electric shock or fire hazards).

Replaceable Parts and Operating Lifetimes

The characteristics of some of the parts used in the product may deteriorate with extended use.
To ensure the product can be used over the long term, it is recommended to replace these parts on a periodic basis.
When replacing parts, please contact your authorized Hioki distributor or reseller.
The service life of parts varies with the operating environment and frequency of use. Parts are not guaranteed to operate throughout the recommended replacement cycle.

Part name	Recommended replacement period	Remarks/Conditions
Electrolytic capacitors	Approximately 10 years	Printed circuit board on which the concerned components are mounted must be replaced.
LCD back light (half-life of brightness)	Approximately 8 years	24 hours/day use

To transport this instrument

- Pack the instrument so that it will not sustain damage during shipping, and include a description of existing damage. We do not take any responsibility for damage incurred during shipping.
- Use the original packing materials when transporting the instrument, if possible.

Cleaning

- To clean the instrument, wipe it gently with a soft cloth moistened with water or mild detergent. Never use solvents such as benzene, alcohol, acetone, ether, ketones, thinners or gasoline, as they can deform and discolor the case. (coaxial connectors excluded (p. A6))
- Wipe the LCD gently with a soft, dry cloth.
- Clean the vents periodically to avoid blockage. If a vents becomes clogged, the instruments internal cooling is impeded, and damage may result.

13.2 Disposal

This instrument contains a built-in backup lithium battery for the clock, etc.
When disposing of this instrument, remove the lithium battery and dispose of battery and instrument in accordance with local regulations.

⚠ WARNING

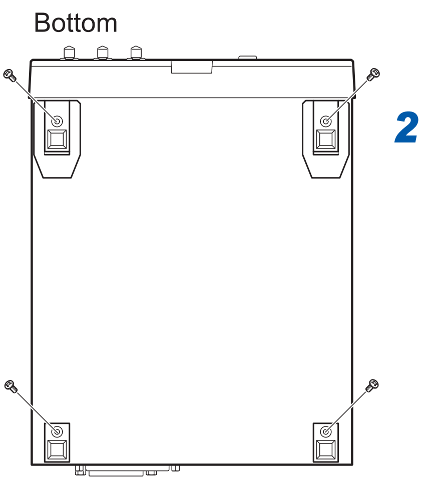
To avoid electric shock, turn off the power switch and disconnect the power cord and probes or fixture before removing the lithium battery.
Battery may explode if mistreated. Do not short-circuit, recharge, disassemble or dispose of in fire.
Keep batteries away from children to prevent accidental swallowing.

⚠ CAUTION

- If the protective functions of the instrument are damaged, either remove it from service or mark it clearly so that others do not use it inadvertently.
- Take care not to short the + and - whey you use nippers for cutting.
  Doing so may cause sparks.

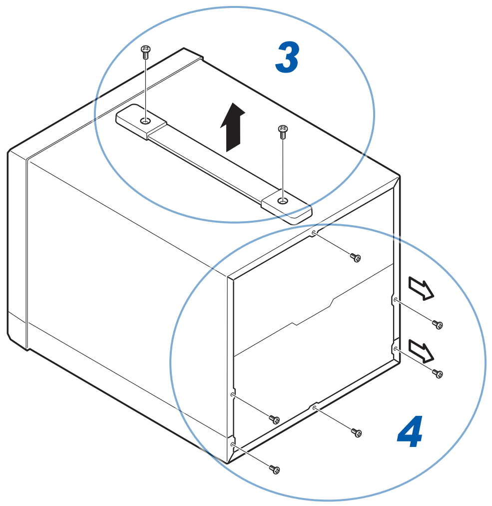
Lithium battery removal

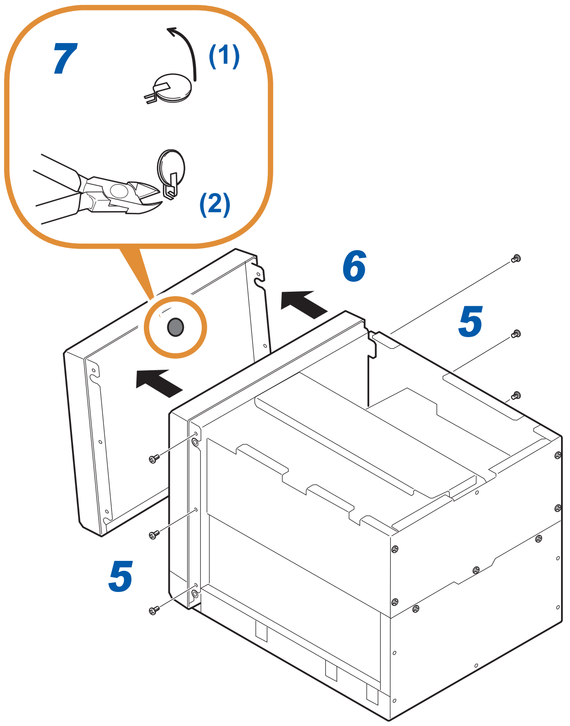
Required tools:
- Philips screwdriver (No. 1): 1
- Tweezers
- Nipper: 1 (to remove lithium battery)



1 **Verify that the power is OFF, and disconnect the connection cables and power cord.**

2 **Remove the screws fastening the four legs at the bottom of the instrument.**





3 **Remove two screws at the top to detach the handle.**

4 **Remove six screws at the rear to detach the upper and lower cases.**

5 **Remove six screws at the side of front panel.**

6 **Pull the front panel to the front.**

7 **Remove the battery from the printed circuit board at the back of the display.**

(1) Cut the positive (+) lead of the battery with a nipper.

(2) Lift the battery to cut the negative (-) lead under the battery with a nipper.

13.3 Troubleshooting

For more information about external control, see "8 External Control" (p. 195).

Instrument malfunction

Symptoms	Check item or cause	Solution/Reference
The screen is not displayed even if the power supply is turned ON.	• Is the power supply cord disconnected? • Is the power supply cord connected properly?	Confirm that the power cord is connected properly. (p. 20)
Keys do not function.	Are the keys locked?	Release the key lock. (p. 187)
	Is the instrument operated remotely from an external device using the communication cable?	Switch to the local state. See "Remote Mode" of the Communication Instruction Manual (LCR Application Disk).
A key other than the one pressed gets pressed.	Have you performed panel compensation?	Perform panel compensation. (p. 234)
Instrument doesn't work. You do not know how to operate this instrument.	Have you read the Instruction Manual?	Check the appropriate section of the Instruction Manual.
	Are you using the instrument as part of an automated system?	Consult the administrator or the manager of the instrument or the automated system that contains the instrument.
Nothing is displayed on the screen.	• Is the LCD display set to automatically turn off after a set time? • Is the instrument in the inactive state?	• If you touch the touch panel, the back light will turn on again. (p. 182) • Cancel the inactive state. (p. 24)
Key response and screen refresh are slow.	Is the measurement value automatic output function enabled?	If the measurement value automatic output function is enabled, key response and screen refresh may become slow in order to give priority to measurement and measurement value output. See Communications Commands in the included LCR Application Disk.

Symptoms	Check item or cause	Solution/Reference
Measurement values are exhibiting excessive variations.	Is the signal level setting too low?	Change the signal level setting. (LCR: p. 38, ANALYZER: p. 89)
	Is an error from “13.4 Error Display” (p. 303) being displayed?	Check the item indicated by the error display, address the cause, and perform measurement.
		• If **REF VAL** is being displayed, check measurement conditions such as the frequency and signal level, and select conditions for which **REF VAL** will not be displayed. See “Measurement range” (p. 274). • If the instrument has not been calibrated (**UNCAL**), perform calibration first.
	Are you using the instrument in a high-noise environment?	If you are using the instrument in a high-noise environment, consider taking the following measures: • Install guards. • Implement anti-noise measures. • Separate the sample, measurement cables, and this instrument from the source of the noise (motor, inverter, electromagnetic switch, power line and equipment generating sparks, etc.) or perform the measurement in a separate room. • Use a power source from an outlet that is grounded properly. • Use a separate power supply that is not connected to the device generating the noise.
	Are the cables between test head and this instrument, the test head and fixture properly connected?	• Check the wiring method and correct if required. • Use specified cables.
	Did you perform open and short compensation?	Perform open and short compensation properly. (p. 139)
	Are you using an extended cable from DUT port to the test sample?	Use shortest possible routing for the cable extension the DUT port to the test sample.

Symptoms	Check item or cause	Solution/Reference
You are unable to perform measurement properly.	Is an error from “13.4 Error Display” (p. 303) being displayed?	Check the item indicated by the error display, address the cause, and perform measurement.
	Does the measurement value for an element with a low DC resistance (inductors) show a high Rdc?	Proper contact is not established with the sample. Check the contact status of the contact points. Check the wiring for disconnections or poor contact. (p. 21), (p. 169)
	Are you measuring an element that generates its own voltage, for example a battery?	If there is a high DC voltage, you may damage the instrument. Stop measuring the sample.
	Are you measuring an element on a printed circuit board?	• You can measure an element on a printed circuit board if the target element is isolated from external connections. However, if the target element is connected to other components or external circuits, you will not be able to obtain proper measurements. • You may not be able to measure components in circuits that are generating a voltage due to the flow of current or to which a voltage is being applied .
	Is a high-impedance element influenced by noise being measured?	Use guarding.
	Is there a time lag between the trigger timing and measurement timing?	• Ensure that there is an appropriate trigger delay and trigger synchronization output wait time. (LCR: p. 35, ANALYZER: p. 72) • Confirm if the valid edge of the trigger input has been set correctly.(p. 216)
The measurement values differ when a known test sample is measured.	Does the measurement conditions of the known test sample and measurement conditions of the instrument match?	Make sure the measurement conditions match.
	Is **UNCAL** displayed?	Perform open/short/load calibration. (p. 139)
	Have you made proper open and short compensations?	Perform open and short compensation again. (p. 139)
	Have you entered correct definition values for open/short/load calibration?	Check the definitions of your calibration kit and enter correct definition values and offset delay values for open/short/load calibration. (p. 139)
	Have you entered correct definition values for open/short compensation?	Enter correct definition values for open/ short compensation. (p. 139)
	Are you using electrical length compensation?	Check the electrical length defined in the fixture and enter the correct electrical length. (p. 139)
	Is the wait time (stabilizing time) from connecting the test sample until performing measurement sufficient?	Ensure there is an appropriate trigger delay and trigger synchronization output wait time (stabilizing time). (LCR: p. 35, ANALYZER: p. 72)
The LCD display is blurred.	Are you pressing the LCD display screen too hard?	Press the LCD display screen gently. Slight blurring may occur but this is normal.

Symptoms	Check item or cause	Solution/Reference
Open/short/load calibration or open/short compensation has an error.	Are you using the instrument in a high-noise environment?	If you are using the instrument in a high-noise environment, consider taking the following measures: • Install guards. • Separate the sample, measurement cables, and instrument from the source of the noise (motor, inverter, electromagnetic switch, power line, equipment generating sparks, etc.) or perform the measurement in a separate room. • Use a power source from an outlet that is grounded properly. • Use a separate power supply from the device that is generating the noise.
Error beep continues to sound.	Is the measurement value automatic output function enabled?	When the measurement value automatic output function is enabled without being received by the PC, it causes a transmission error in the measurement instrument resulting in continuous transmission error sounding in case the internal trigger is activated. Perform the receive operation on the PC followed by measurement on the measuring instrument, or disable the measurement value automatic output function. See Communications Commands in the included LCR Application Disk.
EXT I/O output signal is not obtained.	You don’t know what type of output circuit is being used.	The instrument’s EXT I/O functionality generates open collector output. Connect the wiring correctly to the open collector. (p. 195)
You are unable to communicate using RS-232C.	Are you using a straight cable?	Use a cross cable.
	Are you using the wrong COM port?	Check if the settings on the computer’s match with the connected COM port. Connect the cable to the proper COM port.
		Check the settings of the computer. The COM port may be selected at the OS level, driver level, or within the application. Check the settings of each.
	The computer has no COM port.	Consider using a commercially available USB/RS-232C conversion cable.
	The instrument is unable to communicate with the application.	Check if the instrument is turned ON. Turn ON the instrument and complete any interface connections before launching the computer application.

If no apparent cause can be established

Perform a system reset.
This will return all settings to their factory defaults.

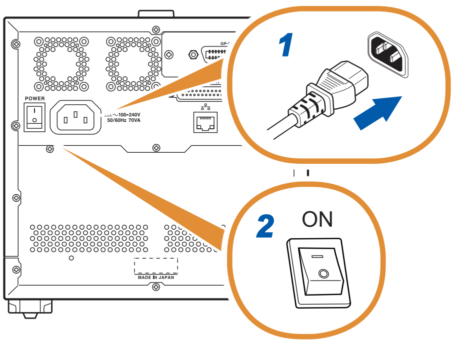
Full reset procedure

Performing a full reset will restore all the settings to the factory default settings.
Perform a full reset only in the following cases.

- When the normal reset screen cannot be displayed because of a problem with this instrument. (After the full reset, perform a self check to confirm that there are no problems (p. 233).)
- When you have forgotten the passcode for the key lock.

> - Disconnect the measurement sample before performing a full reset.
>   Particularly when the sample is a battery, failure to do so may damage the instrument or battery.
> - If the instrument still does not operate normally after the full reset, it needs to be repaired. Contact your dealer, or a Hioki representative if you are not sure where the instrument was purchased.

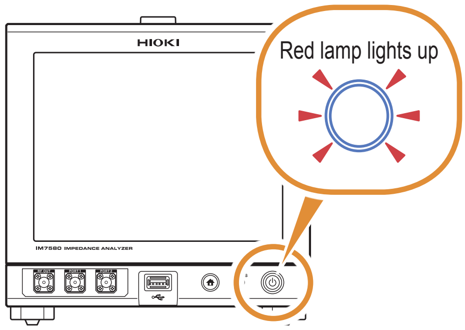
Rear



1 **Connect the power cable.**

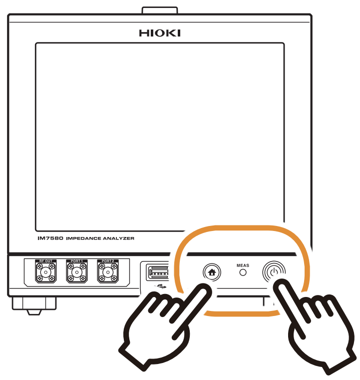
2 **Turn ON the main power supply switch on the back panel.**

Front



3 **Put the instrument into inactive state.**

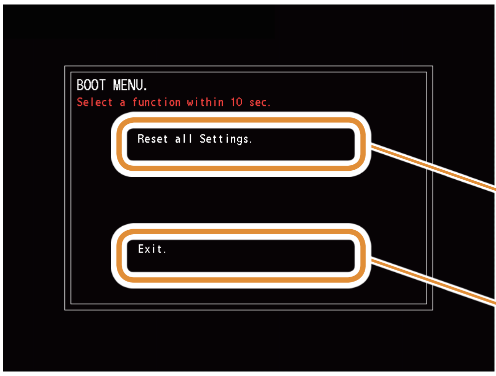
Front



4 **Press the start-up button while pressing HOME button.**

5 **Release your finger when the measurement lamp lights up in red.**

Go to the next page.



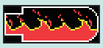
6 **Select yes/no for full reset.**

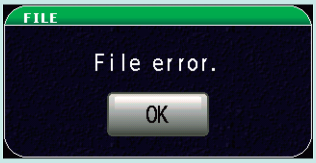
Reset all Settings.
Perform a full reset.

Exit.
Full reset is not performed.

13.4 Error Display

If any of the following are displayed on the screen, check the corresponding reference page.

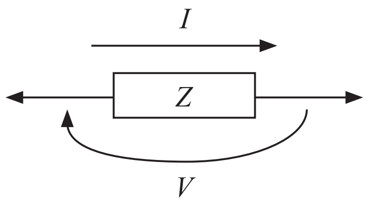
Error display	Description	Solution/Reference
REF VAL REF VAL	Measurement value is outside the guaranteed accuracy range.	Check the measuring range. (p. 274)
MEAS ERR MEAS ERR	Measurement error.	Check if the measurement cable has been disconnected or connected incorrectly. If an error is still displayed, the instrument may be damaged. Contact your authorized Hioki distributor or reseller.
DISP OUT DISP OUT	Measurement value is outside the display range.	Check the display range. “Display range” (p. 273)
Hi Z Hi Z	The measurement result is higher than the judgment reference set for the Hi Z reject function.	Check the connection. “Detecting OPEN During 2-terminal Measurement (HIGH-Z Reject Function)” (p. 174)
LEV ERR LEV ERR	This is displayed when abnormal detection level is detected while detection level monitoring function is enabled.	Check the connection. “Monitoring the Detection Level (Detection Level Monitoring Function)” (p. 175)
MEMORY FULL MEMORY FULL	This is displayed when the set number of measurement results have been stored in the instrument memory.	Load measurement values stored in the instrument memory with the memory function or clear the memory. “Saving Measurement Results (Memory Function)” (p. 180)
	The internal temperature has exceeded the operating range or the cooling fan has stopped.	Switch OFF the power supply at once. Check the installation environment of the instrument. Check the condition of the instrument’s cooling fan. There is a possibility of failure. Contact your authorized Hioki distributor or reseller.
ERROR 	The current consumption of the front USB terminal exceeds 500 mA.	Use a different type of USB flash drive.
? ?	Format of the USB flash drive is not compatible with this instrument.	Use a different type of USB flash drive or backup existing files in the USB flash drive and format the drive before use.
File format error. 	File cannot be loaded. • File is damaged. • File is not supported by this instrument.	Check if file is corrupted or USB flash drive is damaged.
Media space error. 	USB flash drive does not sufficient free memory space.	Use a different USB flash drive or increase free space.

Error display	Description	Solution/Reference
File error. 	An error is occurred during file processing.	Use a different type of USB flash drive or backup existing files in the USB flash drive and format the drive before use.
UNCAL 	Calibration is invalid. Not calibrated or calibration has become invalid due to a change in the setting.	Perform calibration. “5 Calibration and Compensation” (p. 139)

Appendix

Appx. 1 Measurement Parameters and Calculation Formula

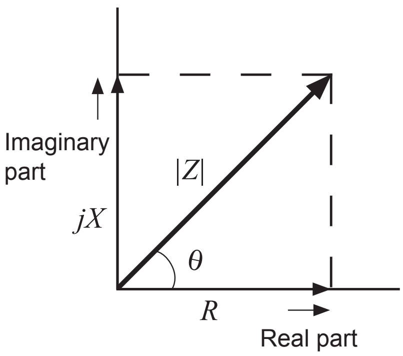
In general, impedance Z is used to evaluate the characteristics of circuit components.
This instrument measures the voltage and current vectors of circuit components for AC measurement frequency signals and uses these values to determine the impedance Z and phase difference θ. The following values can be determined from impedance Z by mapping impedance Z to the complex plane.



$$Z = R + jX$$

$$\theta = tan^{-1}\frac{X}{R}$$

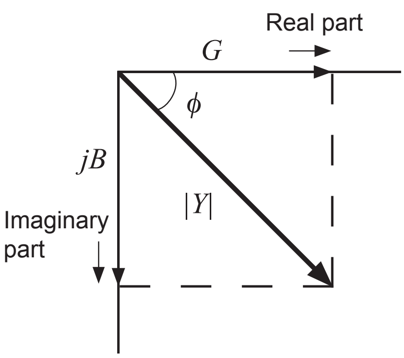
$$|Z| = \sqrt{R^2 + X^2}$$



Z Impedance (Ω)
θ Phase angle (deg)
R Resistance (Ω)
X Reactance (Ω)
$|Z|$ Absolute value of impedance (Ω)

In addition, admittance Y, the reciprocal of impedance Z can also be used depending on the characteristics of the circuit components. The following values can also be determined from admittance Y by mapping admittance Y to the complex plane in the same way as impedance Z.

$$Y = G + jB$$



$$\phi = tan^{-1}\frac{B}{G}$$

$$|Y| = \sqrt{G^2 + B^2}$$

Y Admittance (S)
ϕ Phase angle (deg) = -θ
G Conductance (S)
B Susceptance (S)
$|Y|$ Absolute value of admittance (S)

The instrument uses following calculation formulas to calculate each item.

> The phase angle θ is shown with impedance Z as reference. When measuring with the admittance Y as reference, the sign of the phase angle θ of the impedance Z will be reversed.

Ls, Cs, Rs: Indicates the measured values of L, C, R in series equivalent circuit mode.
Lp, Cp, Rp: Indicates the measured values of L, C, R in parallel equivalent circuit mode.

Item	Series equivalent circuit mode	Parallel equivalent circuit mode
Z	$\lvert Z\rvert = \sqrt{R^2 + X^2}$	
Y	$\lvert Y\rvert = \frac{1}{\lvert Z\rvert}\left(= \sqrt{G^2 + B^2}\right)$	
R	$R_S = ESR = \lvert Z\rvert \cos\theta$	$R_P = \frac{1}{\lvert Y\rvert \cos\phi}\left(= \frac{1}{G}\right)$
X	$X = \lvert Z\rvert \sin\theta$	-
G	-	$G = \lvert Y\rvert \cos\phi$
B	-	$B = \lvert Y\rvert \sin\phi$
L	$L_S = \frac{X}{\omega}$	$L_P = -\frac{1}{\omega B}$
C	$C_S = -\frac{1}{\omega X}$	$C_P = \frac{B}{\omega}$
D	$D = \frac{\cos\theta}{\lvert \sin\theta\rvert}$	
Q	$Q = \frac{\lvert \sin\theta\rvert}{\cos\theta}\left(= \frac{1}{D}\right)$	

* ϕ: Phase angle (ϕ = -θ) of admittance (Y)

Appx. 2 Countermeasures to Prevent Entry of External Noise

This instrument has been designed not to malfunction even when there is entry of noise due to the measurement cables and the power supply line.
However, measurement errors or malfunctions can result in case of significantly high levels of interference. Refer to the examples given below for countermeasures that can be taken with respect to noise in case of a malfunction.

Countermeasures to prevent entry of noise from the power supply line

You can use the following countermeasures to reduce the entry of noise from the power supply line.

Grounding using a protective ground wire

This instrument has been provided with a structure such that the ground wire of the power cable can be used as protective grounding for the instrument.
Protective grounding plays an important role in not only the prevention of electrical accidents but also the use of an internal filter to eliminate the entry of noise from the power supply line.
Use the supplied 2-pole grounding type power cord, and connect to a commercial power supply with a ground wire that has been grounded without fail.

Attaching a noise filter to the power supply line

Connect a commercial plug-in noise filter to the power outlet and connect the instrument to the output of the noise filter in order to suppress the entry of noise from the power line.
Plug-in noise filters are commercially available from various manufacturers.

Inserting an EMI suppression ferrite core to the power cord

Pass the power cord through a commercially available EMI suppression ferrite core and secure the core as close as possible to the AC power inlet of the instrument in order to suppress the entry of noise from the power supply line.
Suppression is more effective if the EMI suppression ferrite core is attached close to the power plug of the power supply.
If a toroidal ferrite core or split ferrite core with sufficiently large internal diameter is used, the amount of noise suppression can be increased by passing the power cord through the core several times. EMI ferrite cores and ferrite beads are commercially available from various specialist manufacturers.

Countermeasures to prevent entry noise from the measurement cables

If interference is producing noise in the measurement cables, its influence can be moderated by the following countermeasure.

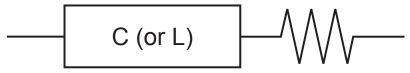
Attaching an EMI suppression ferrite core to commercially available cables

Pass the test cables through a commercially available anti-interference ferrite core, and fix it close to the measurement terminals, this will suppress noise from the measurement cables.
Moreover, if there is margin in the internal diameter of the ferrite core, the amount of noise can be further reduced by winding the measurement cables several times around the ferrite core (as with the power cord as described above).

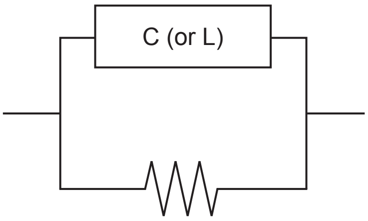
Appx. 3 Series Equivalent Circuit Mode and Parallel Equivalent Circuit Mode

The instrument measures the current flowing to the test sample and the voltage at both ends of the test sample, and determines Z and Ω. Other measurement items such as L, C, and R are calculated from Z and Ω. At this time, the calculation mode is series equivalent circuit mode if the resistance components for C (or L) are assumed to be in series, and the mode is parallel equivalent circuit mode if the resistance components for C (or L) are assumed to be in parallel. Therefore, it is necessary to select the correct equivalent circuit mode to reduce errors because the calculation formula differs for series equivalent circuit mode and parallel equivalent circuit mode.

Generally, a series equivalent circuit mode will be selected for measurement of a low impedance device (approximately less than 100 Ω) of large capacitance capacitor and low inductance. While, a parallel-equivalent circuit mode will be selected for a high impedance device (approx. more than 10 kΩ) of small capacitance capacitor and high inductance. When you are not sure about selection of circuit mode (ex. an impedance approx. between 100 Ω and 10 kΩ), check with the parts manufacturer.



Series equivalent circuit



Parallel equivalent circuit

Measurement values of both modes can be displayed because measurement value in each equivalent circuit mode is obtained by calculation. However, please note that the appropriate equivalent circuit depends on the test sample.

Appx. 4 Selecting the Equivalent Circuit Model

When using the equivalent circuit function, it is important to select an appropriate equivalent circuit model.
The following table provides examples of measuring objects and equivalent circuit models using circuit element Model A to Model E.

Measuring object		Corresponding equivalent circuit model
Inductor	Inductor with high core loss and low ESR	A
	Comparatively high ESR	B
Capacitor	Significant leak resistance effect	C
	Typical capacitor	D
Resistor	Low resistance value, significant inductance effect	B
	High resistance value, significant stray capacitance effect	C
Piezoelectric element	-	E

Because the models for which parameters can be accurately acquired varies depending on the observed values, perform a simulation for estimated results and select the equivalent circuit model based on the comparison with observed values.
When automatically selecting the equivalent circuit model, it will not be possible to select the optimal model if the acquisition of frequency characteristics fails to yield local extreme values. Therefore, set the sweep range so that resonance characteristics can be accurately acquired.

Appx. 5 Maintenance of Coaxial Connector

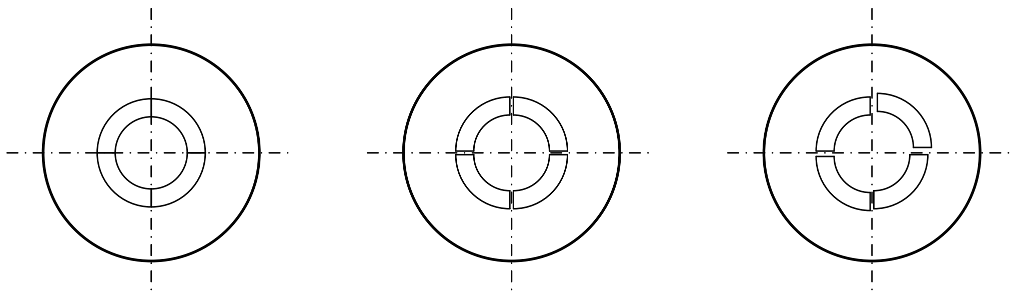
Because the coaxial connector is highly accurate, reproducibility will deteriorate even in case of small bends, damages and dust etc.
Connecting a coaxial connector with dust or defects may damage the connector of the instrument.
Do not use a coaxial connector with defects.

Before measurement, visually inspect the connector to make sure that the coaxial connector is not defective.

Visual inspection of the connector

(Using a magnifying glass is recommended.)

Screw	Must not have any burrs or metal fragments attached, crushed, or have scratches.
Nut	Smooth movement.
Outer conductor	The contact surface must be free from dust, dirt, or scratches.
Inner conductor	• The contact surface must be free from dust, dirt, scratches or defects.
	• The contact must be free from extreme bending or opening.
	• Must not be eccentric with respect to the outer conductor.



Full contact

Slight opening of the contact (Resistant to normal use)

Excessive bend of the contact (Cannot be used)

Connector cleaning

- Blow low-pressure air.
- Apply little alcohol to a cotton swab, and clean the contact surface and the screw thread.

Appx. 6 Rack Mounting

Rack mounting brackets can be attached to the instrument.

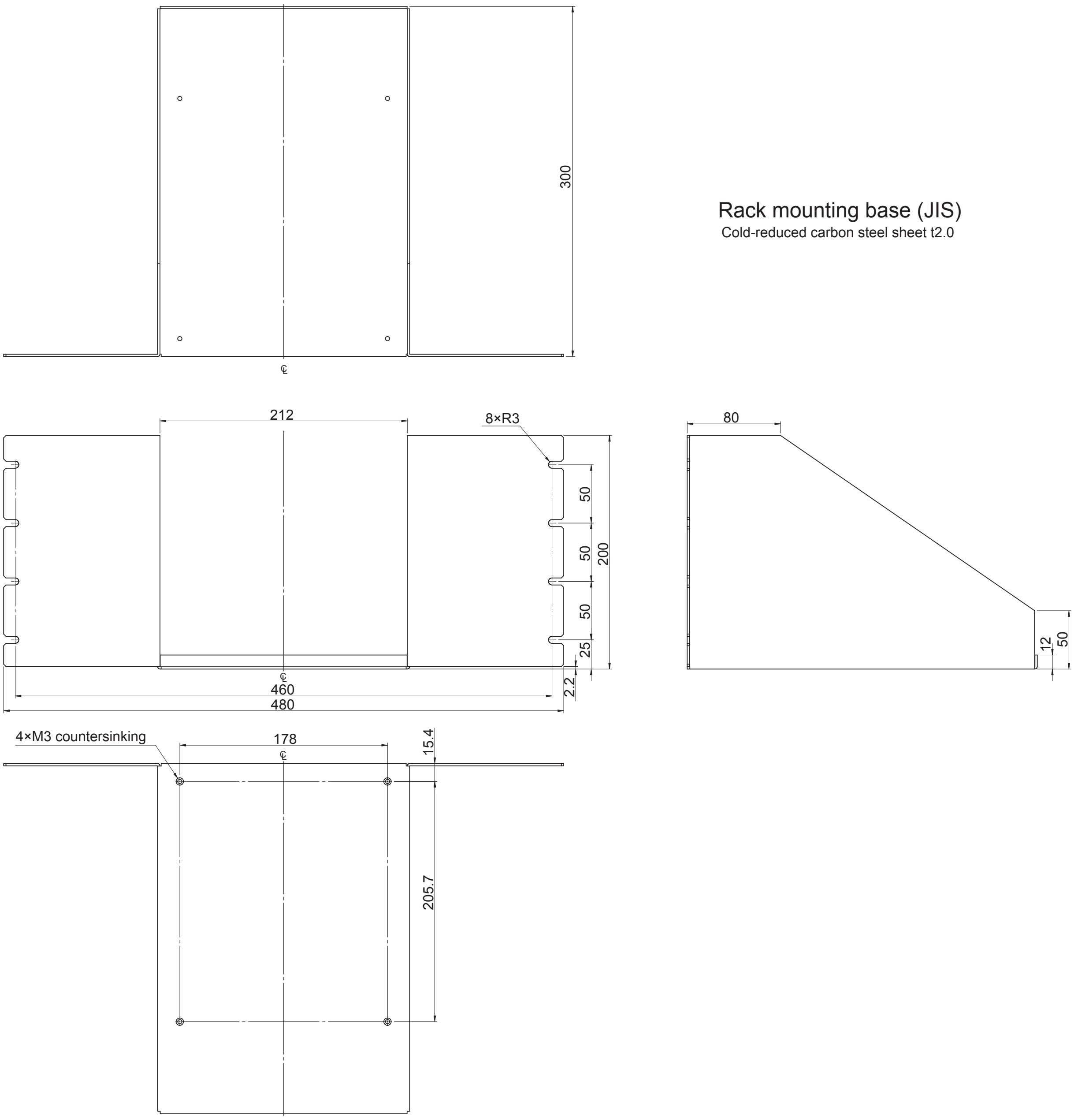
⚠ WARNING

Observe the following precautions for the mounting screws to avoid instrument damage and electric shock accidents.

- **When installing the instrument on a rack, remove the four legs from the bottom of the instrument, and use the screws removed from the legs (M3 × 10 mm) and the screw holes. (For example, place the instrument on a storage rack and fasten it from the back of the rack with screws.)**
  However, if the plate thickness of the storage rack exceeds 4 mm, use screws with a length that allows the screws to be inserted to a depth of 6 mm to 10 mm from the bottom to the interior of this instrument (M3 × Plate thickness + 6 mm to 10 mm).
  If a rack mounting plate of the same shape as the JIS rack base described in p. A8 is used, do not use the screws removed from the legs, and fasten the instrument with flat countersunk head screws of M3 × 6 mm to 10 mm from the bottom of the plate.
- **If screws have been lost or damaged, contact your authorized Hioki distributor or reseller.**

Plate dimension

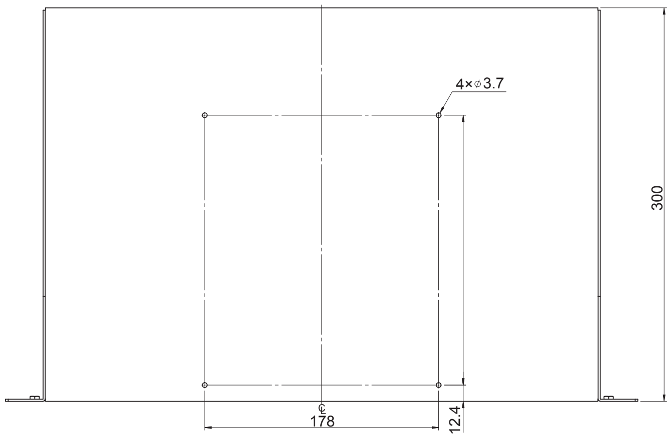
JIS



Rack mounting base (JIS)
Cold-reduced carbon steel sheet t2.0

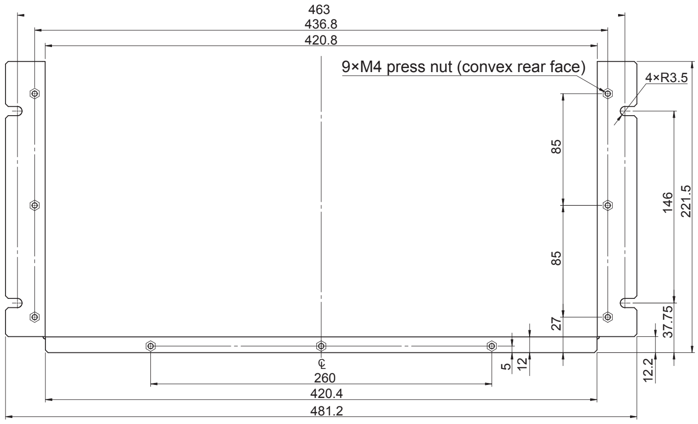
(Units: mm)

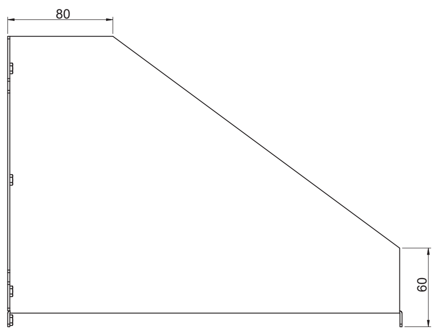
EIA



Rack mounting base (EIA)

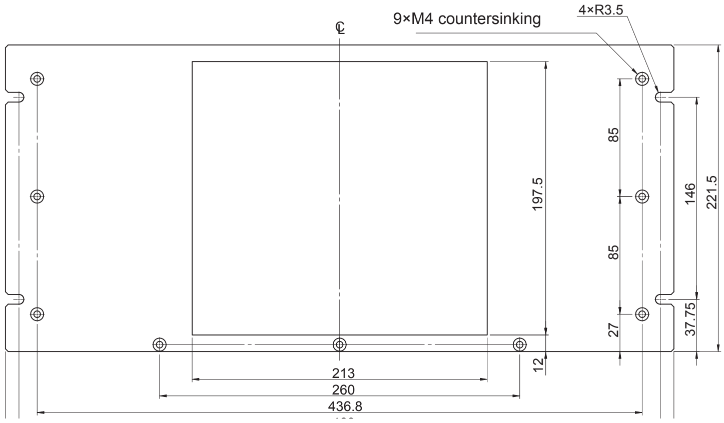
Cold-reduced carbon steel sheet t1.6

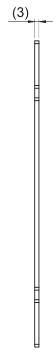




Rack mounting panel (EIA)

SPCC t3.0



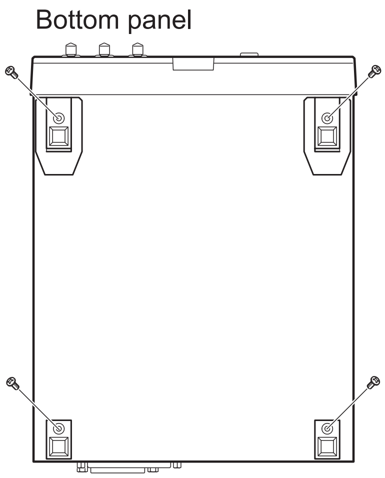


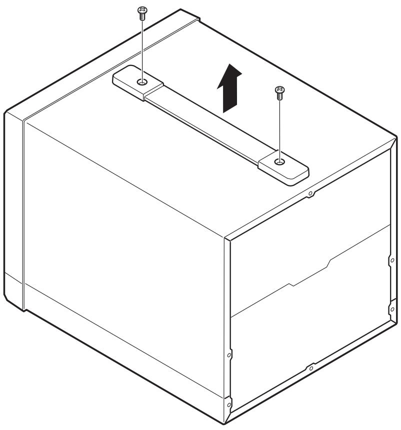
(Units: mm)

Installation procedure

When installing into a rack, reinforce the installation with a commercially available support stand.

JIS

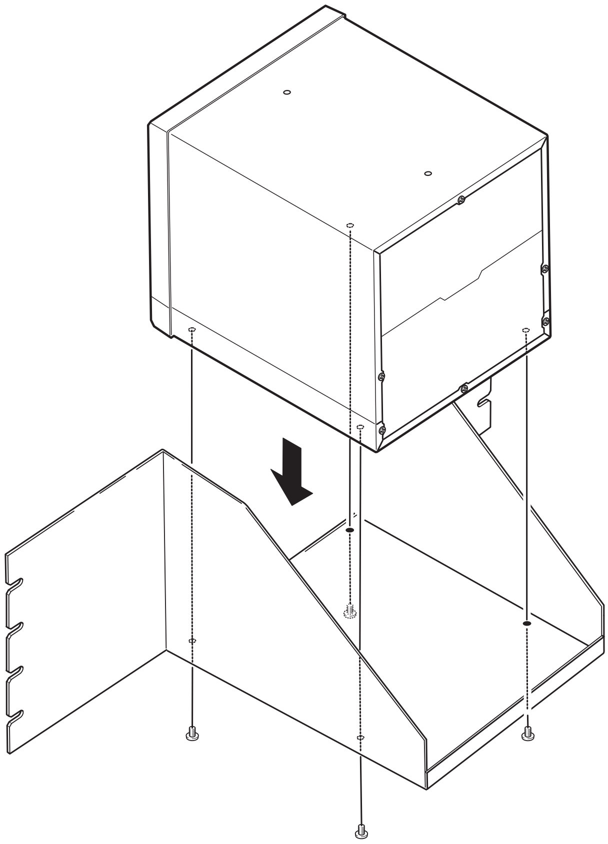




1 **Verify that the power supply is switched OFF, and remove the connection cables and the power supply cord.**

2 **Remove the screws fastening the four legs at the bottom of the instrument.**

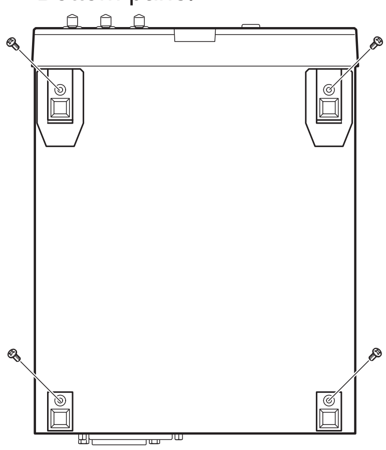
3 **Remove the two screws at the top of the instrument to detach the handle.**



4 **Install the spacers on both sides of the instrument, affix the rack mounting plate with the screws removed from the legs (M3 × 10 mm).**

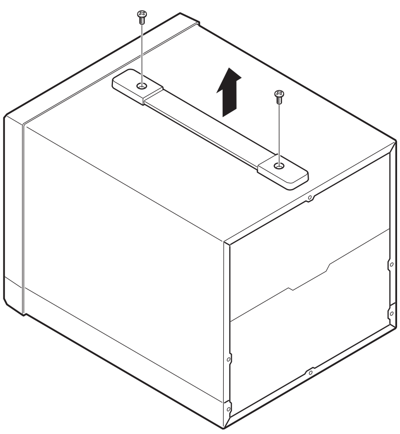
5

EIA

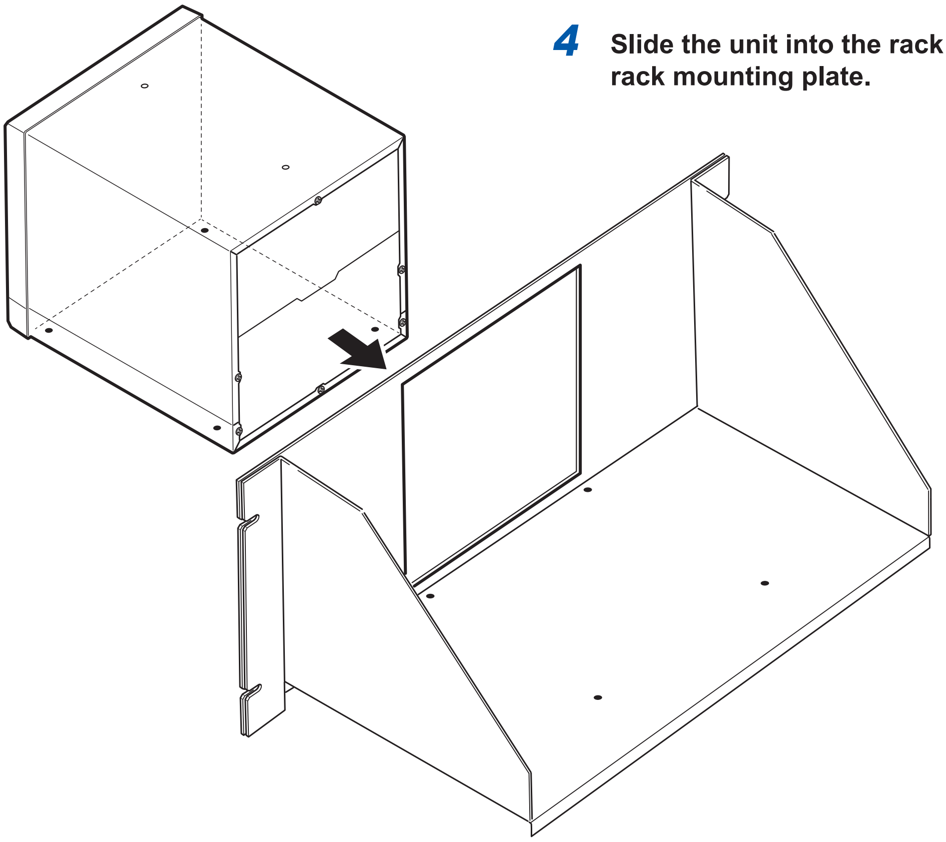


1 **Verify that the power supply is switched OFF, and remove the connection cables and the power supply cord.**

2 **Remove the screws fastening the four legs at the bottom of the instrument.**



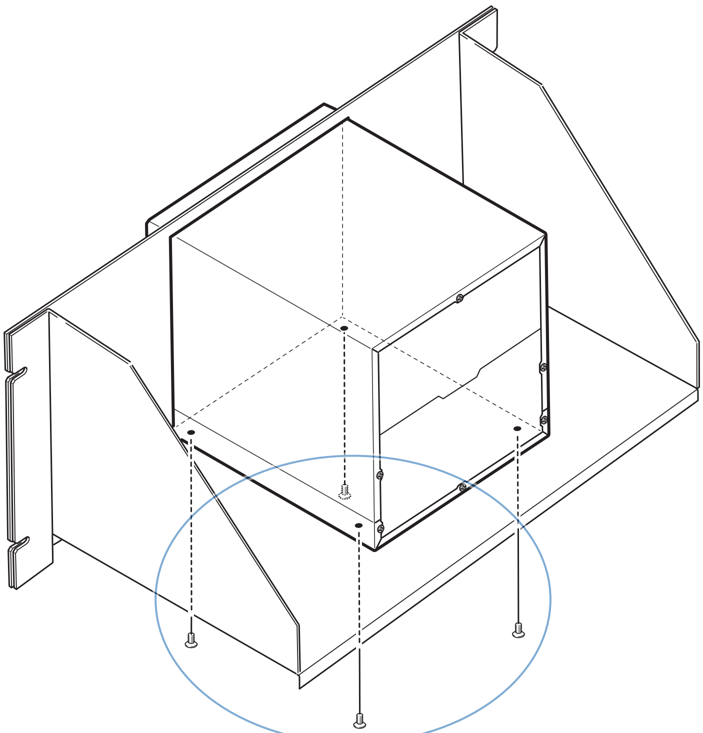
3 **Remove the two screws at the top of the instrument to detach the handle.**



4 **Slide the unit into the rack from the front of the rack mounting plate.**

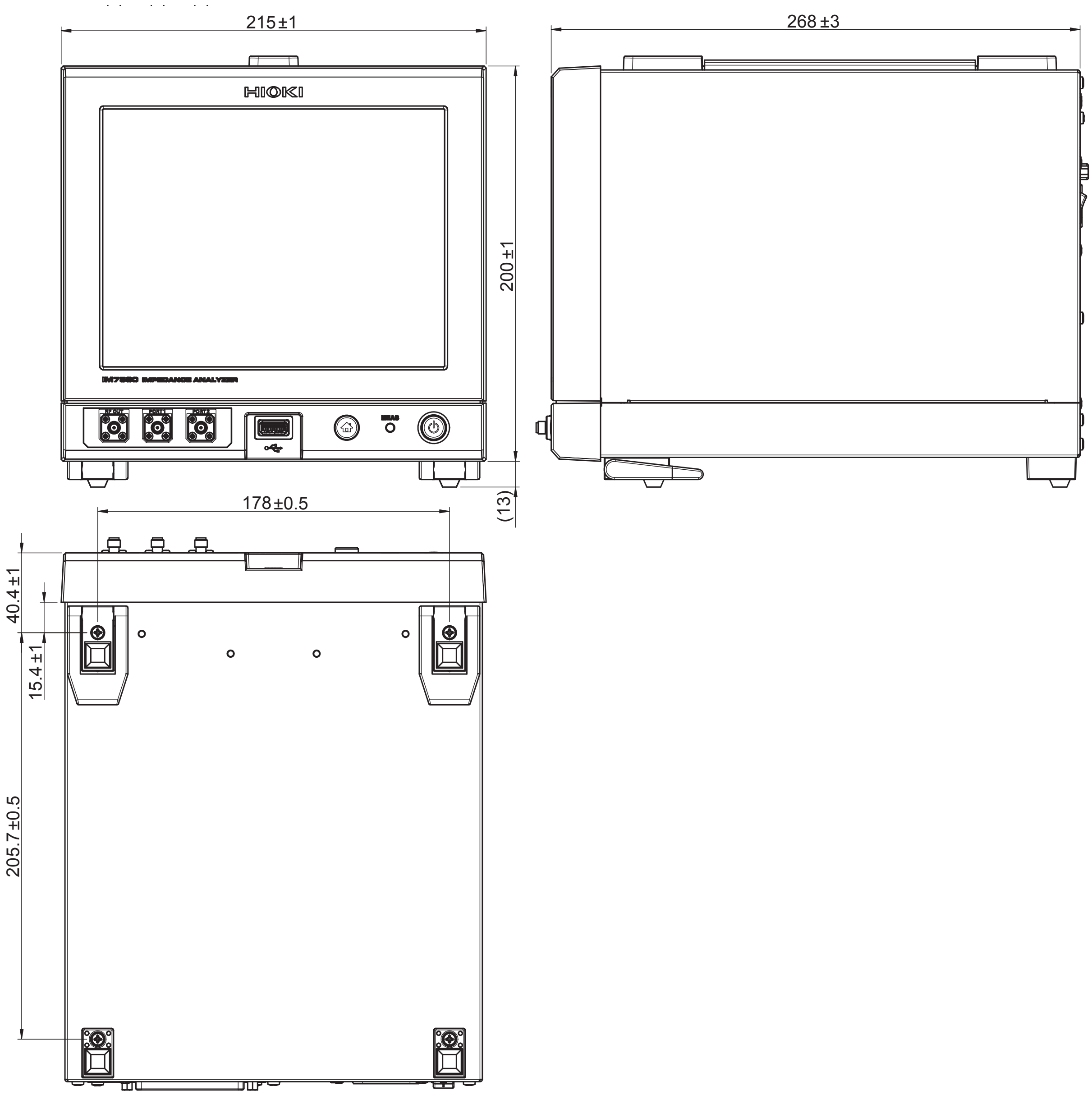
5 **Use the screws removed from the legs (M3 × 10 mm) and the corresponding screw holes to fasten the instrument.**
(For example, place the instrument on a storage rack and fasten it from the back of the rack with screws.)

If the plate thickness of the storage rack exceeds 4 mm, use screws with a length that allows the screws to be inserted to a depth of 6 mm to 10 mm from the bottom to the interior of this instrument (M3 × Plate thickness + 6 mm to 10 mm).

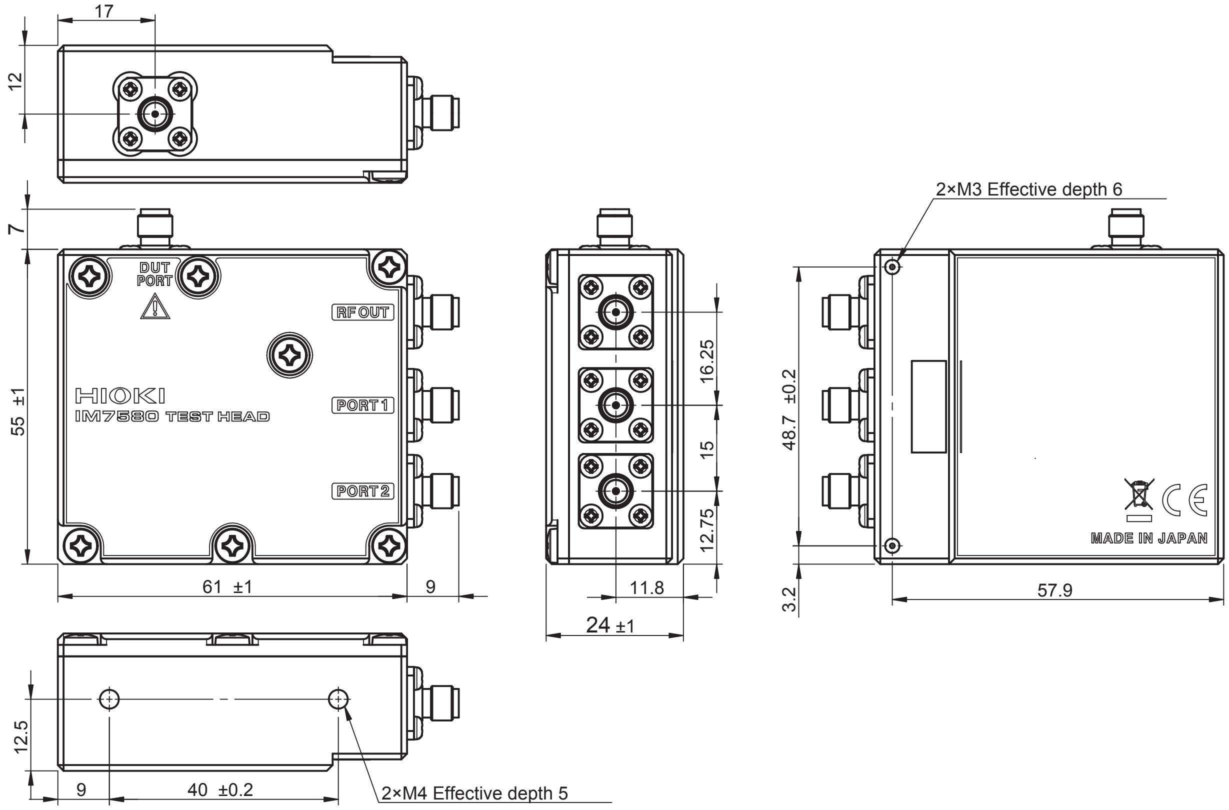


Appx. 7 Dimensional Diagram

Instrument



Test head


17
12
7
DUT
PORT
RF OUT
PORT 1
PORT 2
HIOKI
IM7580 TEST HEAD
55 ±1
61 ±1
9
16.25
15
12.75
11.8
24 ±1
2×M3 Effective depth 6
48.7 ±0.2
3.2
57.9
MADE IN JAPAN
12.5
9
40 ±0.2
2×M4 Effective depth 5

Appx. 8 Initial Settings Table

✔: Enabled *: Selected -: Disabled

Setting Items				Initial Setting	Instrument: Full reset (When power is turned on)	Instrument: Reset	Communication: :SYStem :RESet	Communication: *RST	Communication: :PRESet	Return to initial settings when power is turned on	Panel save/load	File save/load
Measurement Mode				LCR	✔	*	✔	✔	✔	-	✔	✔
LCR Setting	Basic settings	Measurement parameters		Z/OFF/θ/OFF	✔	*	✔	✔	✔	-	✔	✔
		Trigger mode		INT								
		Trigger delay		0s								
		Trigger synchronous output	ON/OFF	OFF								
			Wait time	0.001 s								
			INDEX delay	0 s								
		Measurement frequency		1 MHz								
		Measurement signal	Mode	POWER								
			Level	0 dBm								
		Measurement speed		MED								
			The number of waveforms	8								
		The number of averaging times		1								
	Contact check	DC measurement	Timing	OFF								
			The number of waveforms	1								
			Upper limit value	OFF								
			Lower limit value	OFF								
			Judgment by UnCal	DO								
			Judgment error abort	OFF								
			AC output	OFF								
			DC wait	0.001 s								
			AC wait	0 s								
		Hi Z reject	ON/OFF	OFF								
			Judgment reference value	10000 Ω								
		Detection level judgment	ON/OFF	OFF								
			Judgment reference value	10%								
	Application function	Number of display digits		6								
		Absolute measurement value display		OFF								
		Communication	MEAS:ITEM	0,0								
			MEAS:VALID	14								
	Judgment	Judgment function	Type	OFF								
			Judgment outside the guaranteed accuracy range	NOT								
			Judgment beep sound	NG								
			Type of judgment beep sound	0								
			Judgment beep sound volume	2								
	Comparator	Mode		ABS								
		Absolute value mode	Upper limit value	OFF								
			Lower limit value	OFF								
		% mode Δ% mode	Reference value	10								
			Upper limit value	OFF								
			Lower limit value	OFF								
	BIN measurement	Mode		ABS								
		Absolute value mode	Upper limit value	OFF								
			Lower limit value	OFF								
		% mode Δ% mode	Reference value	10								
			Upper limit value	OFF								
			Lower limit value	OFF								

Appx.

✔: Enabled *: Selected -: Disabled

Setting Items				Initial Setting	Instrument: Full reset (When power is turned on)	Instrument: Reset	Communication: :SYStem :RESet	Communication: *RST	Communication: :PRESet	Return to initial settings when power is turned on	Panel save/load	File save/load
LCR Calibration/Compensation	Scaling	Scaling		OFF	✔	*	✔	✔	✔	-	✔	✔
		a		1								
		b		0								
	Calibration/compensation	Calibration		OFF								
		Offset delay		0 s								
		Calibration range	Start frequency	1 MHz								
			Stop frequency	300 MHz								
		Calibration Rdc limit	Lower OPEN limit	OFF								
			Upper LOAD limit	OFF								
			Lower LOAD limit	OFF								
			Upper SHORT limit	OFF								
		Electrical length		0.00 mm								
		Compensation		OFF								
		Compensation Rdc	Lower OPEN limit	OFF								
			Upper SHORT limit	OFF								
		display format	OPEN	G-Cp								
			SHORT	Rs-Ls								
			LOAD	Rs-Ls								
	ALL calibration data	Measurement speed		MED								
			The number of waveforms	8								
		Definition value	OPEN	0 S, 82 fF								
			SHORT	0 Ω, 0 H								
			LOAD	50 Ω, 0 H								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
			LOAD	OFF								
	SPOT calibration data	Frequency		OFF								
		Signal		OFF								
		Measurement speed		OFF								
			The number of waveforms	OFF								
		Definition value	OPEN	0 S, 82 fF								
			SHORT	0 Ω, 0 H								
			LOAD	50 Ω, 0 H								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
			LOAD	OFF								
	DC calibration data	Definition value	OPEN	0 S								
			SHORT	0 Ω								
			LOAD	50 Ω								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
			LOAD	OFF								
	ALL compensation data	Definition value	OPEN	0 S, 0 F								
			SHORT	0 Ω, 0 H								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
	SPOT compensation data	Definition value	OPEN	0 S, 0 F								
			SHORT	0 Ω, 0 H								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
	DC compensation data	Definition value	OPEN	0 S								
			SHORT	0 Ω								
		Measurement value	OPEN	OFF								
			SHORT	OFF								

✔: Enabled *: Selected –: Disabled

Setting Items				Initial Setting
ANALYZER Settings	Basic settings	Measurement parameters		Z/θ/Rs/X
		Sweep parameters		FREQ
		Trigger delay		0 s
		Trigger synchronous output	ON/OFF	OFF
			Wait time	0.001 s
			INDEX delay	0 s
		Trigger mode		REPEAT
		Segment sweep		OFF
		The number of measurements		201
		Measurement frequency		1MHz to 300MHz
		Measurement signal	Mode	POWER
			Level	0 dBm
		Measurement speed		MED
			The number of waveforms	8
		The number of averaging times		1
		Point delay		0 s
	Sweep display	Graph display		1 GRAPH
		Horizontal	Overwrite	OFF
			Horizontal	LOG
			Span	SINGLE
		Vertical	Scale	LINEAR
			Scale mode	AUTO
		X-Y display	Vertical axis reversal	OFF
		Grid display	Parameters	PARA1
			Scaling method	INDIVIDUAL
	Comparator	Judgment function	Type	OFF
			Judgment outside the guaranteed	NOT
			Judgment beep sound	NG
			Type of judgment beep sound	0
			Judgment beep sound volume	2
		Judgment parameters		OFF
		Judgment area display		PARA1/PARA3
		Peak No. to judge		1
		Filter		ON
		Area judgment	Upper limit value	OFF
			Lower limit value	OFF
		Peak ludgment	Upper range limit	OFF
			Lowe range limit	OFF
			Upper limit value	OFF
			Lower limit value	OFF
	Cursor and search	Cursor	Tracing cursor is used	OFF
			Cursor to move	A
		Search	Search & trace	PARA1
			Search mode	L-MAX
			Target range	0
			Target slope	UP
			Filter	ON
			Auto search	OFF
	Equivalent circuit	Model selection method		OFF
		Circuit model		A
		Auto model selection		OFF
		Analysis execution method		AUTO
		Analysis result display position		UPPER-LEFT
		Analysis start frequency		1 MHz
		Analysis end frequency		300 MHz
		Segment to analyze		ALL
		Electromechanical coupling coefficient (K)	Oscillation mode	KR
			Frequency type	fs-fp
			Calculation coefficient related to Poisson's ratio	0.395
			Calculation coefficient related to Poisson's ratio	0.574
		R1		0
		L1		0
		C1		0
		C0		0
	Equivalent circuit	Comparator		OFF
		Upper/lower limit values L1, C1, R1, Qm, C0, K		OFF
	Contact check	DC measurement	Timing	OFF
			The number of waveforms	1
			Upper limit value	OFF
			Lower limit value	OFF
			Judgment by UnCal	DO
			Judgment error abort	OFF
			AC output	OFF
			DC wait	0.001 s
			AC wait	0 s
		Hi Z reject	ON/OFF	OFF
			Judgment reference value	10000 Ω
		Detection level judgment	ON/OFF	OFF
			Judgment reference value	10%

Instrument		Communication			Return to initial settings when power is turned on	Panel save/load	File save/load
Full reset (When power is turned on)	Reset	:SYStem :RESet	*RST	:PRESet			
✔	*	✔	✔	✔	–	✔	✔

Appx.

Initial Settings Table

✔: Enabled *: Selected -: Disabled

Setting Items				Initial Setting	Instrument: Full reset (When power is turned on)	Instrument: Reset	Communication: :SYStem :RESet	Communication: *RST	Communication: :PRESet	Return to initial settings when power is turned on	Panel save/load	File save/load
ANALYZER Settings	Application function	Number of display digits		6	✔	*	✔	✔	✔	-	✔	✔
		Communication	MEAS:ITEM	0,0								
			MEAS:VALID	14								
ANALYZER Calibration/Compensation	Scaling	Scaling		OFF	✔	*	✔	✔	✔	-	✔	✔
		a		1								
		b		0								
	Calibration/compensation	Calibration		OFF								
		Offset delay		0 s								
		Calibration Rdc limit	Lower OPEN limit	OFF								
			Upper LOAD limit	OFF								
			Lower LOAD limit	OFF								
			Upper SHORT limit	OFF								
		Electrical length		0.00 mm								
		Compensation		OFF								
		Compensation Rdc	Lower OPEN limit	OFF								
			Upper SHORT limit	OFF								
		Display format	OPEN	G-Cp								
			SHORT	Rs-Ls								
			LOAD	Rs-Ls								
	SPOT calibration data	Frequency		OFF								
		Signal		OFF								
		Measurement speed		OFF								
			The number of waveforms	OFF								
		Definition value	OPEN	0S,82fF								
			SHORT	0 Ω, 0 H								
			LOAD	50 Ω, 0 H								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
			LOAD	OFF								
	DC calibration data	Definition value	OPEN	0 S								
			SHORT	0 Ω, 0 H								
			LOAD	50 Ω								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
			LOAD	OFF								
	SPOT compensation data	Definition value	OPEN	0 S, 0F								
			SHORT	0 Ω, 0 H								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
	DC compensation data	Definition value	OPEN	0 S								
			SHORT	0 Ω								
		Measurement value	OPEN	OFF								
			SHORT	OFF								
Continuous Measurement	Continuous measurement	Judgment error abort		OFF	✔	✔	✔	✔	✔	-	-	✔

✔: Enabled *: Selected -: Disabled

Setting Items				Initial Setting	Instrument		Communication			Return to initial settings when power is turned on	Panel save/load	File save/load
					Full reset (When power is turned on)	Reset	:SYStem :RESet	*RST	:PRESet			
Common Settings	Common functions	Judgment result	Judgment result - delay between EOMs	0 s	✔	*	✔	✔	✔	-	-	✔
			Reset	ON								
		IO trigger	ENABLE	ON								
			Edge	DOWN								
		I/O EOM	Mode	HOLD								
			EOM output time	0.005 s								
		Memory function	OFF/IN/ON	OFF								
			LCR ANALYZER	1000 100								
		Zoom (LCR)		OFF								
		Display		ON								
		Backlight brightness		130								
		Customized screen color		BLACK								
		Parameter color		Blue/Pink/ Yellow/Green								
		Key beep sound		ON								
			Type of sound	0								
			Volume	2								
		Warm-up message		OFF								
		Key lock	OFF/FULL/SET	OFF								
			Password	7580								
		Communication	Automatic output of measurement values	OFF								
			Transfer format	ASCII								
			Long format	OFF								
	File	Save format		OFF	✔	*	✔	✔	✔	-	-	✔
		Save folder		AUTO								
		Header	Date and time	ON								
			Measurement conditions	ON								
			Measurement parameters	ON								
			Delimiter	, (Comma)								
			Quote	" (Double quote)								
	Interface	Type		USB	✔	*	-	-	-	-	-	✔
		USB	Delimiter	CF+LF								
		GPIB	Address	1								
			Delimiter	LF								
		RS232C	Transmission rate	9600								
			Delimiter	CF+LF								
			Flow control	OFF								
		LAN	IP address	192.168.0.1								
			Subnet mask	255.255.255.000								
			Default gateway	0.0.0.0								
			Port	3500								
			Delimiter	CF+LF								
		Header		OFF	✔	*	✔	✔	✔	✔	-	-
		Status byte register		0	-	-	-	-	-	✔	-	-
		Event register		0								
		Enable register		0								
Panel				No save	✔	*	✔	-	-	-	-	ALL SAVE
Touch Panel Compensation				No compen-sation	✔	-	-	-	-	-	-	-
Clock				-	-	-	-	-	-	-	-	-

Appx.

Appx. 9 Device Compliance Statement

"Information on compliance to standards" based on the IEEE 488.2 standard

Item		Contents
1	IEEE 488.1 interface functions	See Communication user manual in the included LCR Application Disc, "GP-IB specifications".
2	Operation with address other than 0 to 30	Such settings are not possible.
3	Recognition of change in address that was set by the user initially	Change of address is recognized immediately after the change.
4	Device setting when power supply is turned on	Status information is cleared. All other items are backed up. However, the header and response message terminator are initialized.
5	Description of message switching options	• Input buffer capacity and operation See included LCR Application Disk. Queries to which multiple response messages are returned :BIN:FLIMit:ABSolute?.................. 2 :BIN:FLIMit:DEViation?................ 2 :BIN:FLIMit:PERcent?.................. 2 :BIN:SLIMit:ABSolute?................. 2 :BIN:SLIMit:DEViation?................ 2 :BIN:SLIMit:PERcent?.................. 2 :BIN:ABSolute?........................ 2 :BIN:DEViation?....................... 2 :BIN:PERcent?......................... 2 :CCHeck:LIMit?........................ 2 :CIRCuit:ANALysis:FREQuency?.......... 2 :CIRCuit:ANALysis:K:COEFficient .... 2 :COMParator:FLIMit:ABSolute?.......... 2 :COMParator:FLIMit:DEViation?......... 3 :COMParator:FLIMit:PERcent?........... 3 :COMParator:SLIMit:ABSolute?.......... 2 :COMParator:SLIMit:DEViation?......... 3 :COMParator:SLIMit:PERcent?........... 3 :COMParator:ABSolute?................. 2 :COMParator:DEViation?................ 3 :COMParator:PERcent?.................. 3 :COMParator:AREA:FIX?................. 4 :COMParator:AREA:LIMit?............... 2 :COMParator:AREA:MEAS?................ 3 :COMParator:PEAK?..................... 4 :COMParator:PEAK:NO?.................. 2 :COMParator:CIRCuit:ANALysis:ABSolute? .. 3 :CORRection:CALIbration:OPEN:REFerence? . *1 :CORRection:CALIbration:SHORt:REFerence? *1 :CORRection:CALIbration:LOAD:REFerence? . *1 :CORRection:CALIbration:LOAD:LIMit?... 2 :CORRection:CALIbration:OPEN:DATA?.... *2 :CORRection:CALIbration:SHORt:DATA?... *2 :CORRection:CALIbration:LOAD:DATA? ... *2 :CORRection:COMPensation:OPEN:REFerence? *1 :CORRection:COMPensation:SHORt:REFerence? *1 :CORRection:COMPensation:OPEN:DATA?... *2 :CORRection:COMPensation:SHORt:DATA? . *2 :CORRection:SCALe:DATA?............... 2 :CORRection:LIMit:POINt?.............. 2 :FILE:INFOrmation? 5

	Item	Contents
5		:GRAPh:VERTical:CENTerdiv?............ 2 :GRAPh:VERTical:UPPerlower?........... 2 :LIST:STARt:STOP?.................... 3 :LIST:STARt:STEP?.................... 3 :LIST:CENTerspan?.................... 3 :LIST:INTerval?...................... 3 :MEASure?........................... *2 :MEASure:RDC?....................... *2 :MEASure:COMParator:PEAK:LMAX? .... 3 :MEASure:COMParator:PEAK:LMIN? .... 3 :MEASure:CURSor? .... 3 :MEASure:POINt?...................... 3 :MEASure:ANALysis:COMParator? .... 6 :MEASure:ANALysis:DELTa? .... 5 :MEASure:ANALysis:PEAK?.............. 2 :MEASure:ANALysis:SIMulation?........ *2 :MEASure:CONTinuous:PEAK? .... *2 :MEASure:ITEM?....................... 2 :MEMory?............................ *2 :MONItor? .... 2 :SYSTem:DATE?........................ 3 :SYSTem:TIME?........................ 3 :SEGMent:STARt:STOP?................. 3 :SEGMent:INTerval? .... 3 :SEARch? .... *3 *1: Differs depending on the argument. *2: Differs depending on the setting. *3: Differs depending on the results. • All queries producing responses when syntax checking is performed will produce responses when syntax checking is performed. • Whether any queries produce responses when read: • There are no queries which produce response messages at the instant they are read in by the controller. • Whether any commands are coupled: There are no relevant commands.
6	Explanation of functional elements used when constructing device specific commands, and whether compound commands or program headers can be used	The following are used. • Program message • Program message terminator • Program message unit • Program message unit separator • Command message unit • Query message unit/Command program header • Query program header • Program data • Character program data • Decimal program data • Compound commands program headers
7	Explanation of buffer capacity limitations for block data	Block data is not used.
8	List of program data elements used in <expressions>, and degree of maximum nesting level allowed in sub-expressions (including syntax restrictions imposed on <expressions> by the device).	Sub-expressions are not used. Character data and decimal data are the only program data elements used.
9	Response syntax for queries	See included LCR Application Disk.
10	Transmission congestion related to device-to-device messages that do not conform to the general principles for basic response messages	There are no device to device messages.

	Item	Contents
11	Response capacity for block data	Block data does not appear in responses.
12	List of standard commands and queries used	See included LCR Application Disk.
13	Device state after the calibration query has been completed successfully	"*CAL?" command is not used.
14	Existence/nonexistence of "*DDT" command	"*DDT" command is not used.
15	Existence/nonexistence of macro command	Macros are not used.
16	Queries related to identification, explanation of the response to the "*IDN?" query	Description of communications commands in the included LCR Application Disk. - "*IDN?"
17	Capacity of the user data storage area reserved to be used if the "*PUD" command and the *PUD?" query are executed	"*PUD" command and "*PUD?" query are not used. In addition, there is no user data storage area.
18	Resources when the "*RDT" command and the "*RDT?" query are used	"*RDT" command and "*RDT?" query are not used. In addition, there is no user data storage area.
19	Conditions that are influenced if "*RST", "*LRN?", "*RCL?", and "*SAV" are used	"*LRN?", "*RCL?", and "*SAV" are not used. "*RST" command returns the instrument to its initial state. Description of communications commands in the included LCR Application Disk. - "*RST?"
20	Scope of the self-testing executed as a result of the "*TST?" query	Description of communications commands in the included LCR Application Disk. - "*TST?"
21	Additional organization of the status data used in a device status report	See included LCR Application Disk.
22	Whether commands are overlap or sequential type	All commands except :CORRection:CALIbration:OPEN, :CORRection:CALIbration:SHORt, :CORRection:CALIbration:LOAD, :CORRection:COMPensation:OPEN, :CORRection:COMPensation:SHORt, and :CORRection:COMPensation:LOAD are sequence commands.
23	Criterion relating to the functions required at the instant a termination message is produced, as a response to each command	Operation is terminated when the command has been parsed.

Index

S

T

V

X

Warranty Certificate

Model	Serial No.	Warranty period One (1) year from date of purchase (___ / ___)

This product passed a rigorous inspection process at Hioki before being shipped.

In the unlikely event that you experience an issue during use, please contact the distributor from which you purchased the product, which will be repaired free of charge subject to the provisions of this Warranty Certificate. This warranty is valid for a period of one (1) year from the date of purchase. If the date of purchase is unknown, the warranty is considered valid for a period of one (1) year from the product's date of manufacture.
Please present this Warranty Certificate when contacting the distributor.
Accuracy is guaranteed for the duration of the separately indicated guaranteed accuracy period.

1. Malfunctions occurring during the warranty period under conditions of normal use in conformity with the Instruction Manual, product labeling (including stamped markings), and other precautionary information will be repaired free of charge, up to the original purchase price. Hioki reserves the right to decline to offer repair, calibration, and other services for reasons that include, but are not limited to, passage of time since the product's manufacture, discontinuation of production of parts, or unforeseen circumstances.
2. Malfunctions that are determined by Hioki to have occurred under one or more of the following conditions are considered to be outside the scope of warranty coverage, even if the event in question occurs during the warranty period:
   a. Damage to objects under measurement or other secondary or tertiary damage caused by use of the product or its measurement results
   b. Malfunctions caused by improper handling or use of the product in a manner that does not conform with the provisions of the Instruction Manual
   c. Malfunctions or damage caused by repair, adjustment, or modification of the product by a company, organization, or individual not approved by Hioki
   d. Consumption of product parts, including as described in the Instruction Manual
   e. Malfunctions or damage caused by transport, dropping, or other handling of the product after purchase
   f. Changes in the product's appearance (scratches on its enclosure, etc.)
   g. Malfunctions or damage caused by fire, wind or flood damage, earthquakes, lightning, power supply anomalies (including voltage, frequency, etc.), war or civil disturbances, radioactive contamination, or other acts of God
   h. Damage caused by connecting the product to a network
   i. Failure to present this Warranty Certificate
   j. Failure to notify Hioki in advance if used in special embedded applications (space equipment, aviation equipment, nuclear power equipment, life-critical medical equipment or vehicle control equipment, etc.)
   k. Other malfunctions for which Hioki is not deemed to be responsible

*Requests
- Hioki is not able to reissue this Warranty Certificate, so please store it carefully.
- Please fill in the model, serial number, and date of purchase on this form.

13-09

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- Please visit our website at http://www.hioki.com for the following:
  - ■ Regional contact information
  - ■ The latest revisions of instruction manuals and manuals in other languages.
  - ■ Declarations of Conformity for instruments that comply with CE mark requirements.
- All reasonable care has been taken in the production of this manual, but if you find any points which are unclear or in error, please contact your supplier or the International Sales and Marketing Department at Hioki headquarters.
- In the interests of product development, the contents of this manual are subject to revision without prior notice.
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HIOKI

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